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UNIVERSITY OF ALBERTA

MICROPROCESSOR BASED REAL-TIME GRAIN LOSS MONITORING AND
PREDICTION SYSTEM FOR AN AXIAL-FLOW COMBINE

by

CHENGQI LIU



A THESIS

SUBMITTED TO THE FACULTY OF GRADUATE STUDIES AND RESEARCH
IN PARTIAL FULFILMENT OF THE REQUIREMENTS FOR THE DEGREE
OF MASTER OF SCIENCE

DEPARTMENT OF AGRICULTURAL ENGINEERING

EDMONTON, ALBERTA

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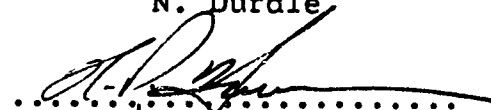
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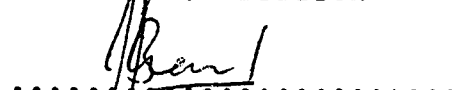
The undersigned certify that they have read, and recommend to the Faculty of Graduate Studies and Research, for acceptance, a thesis entitled MICROPROCESSOR BASED REAL-TIME GRAIN LOSS MONITORING AND PREDICTION SYSTEM FOR AN AXIAL-FLOW COMBINE submitted by CHENGQI LIU in partial fulfilment of the requirements for the degree of MASTER OF SCIENCE.


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ABSTRACT

The objective of this project was to develop and test a high-performance, microprocessor-based data acquisition system to monitor the grain loss from an axial-flow combine in real time.

To achieve this objective nine acoustic sensors were located underneath the separating grate section of an axial flow harvester to detect the grain impacts.

Signal conditioners were built to distinguish between grain and non-grain impacts and were suitably interfaced to a data acquisition system.

Data acquisition interfaces were built which were connected to the outputs of the sensor signal conditioners. These consisted of counters which could count the grain impacts accurately. Under the control of the software, multiple channel data acquisition could be conducted simultaneously.

A real time regression analysis program was developed in assembly language. Using the least square method, separation distribution curves were obtained in longitudinal and arc directions in real time. Care was taken to minimize the interference of real time calculation with data acquisition, so that the data acquisition and processing could be conducted independently.

Laboratory facilities were built for sensor calibration and simulation of rotor separation distribution.

Threshing experiments were carried out and the actual loss calculated in real time. The actual loss data could be displayed on a LCD (liquid crystal display unit) or printed by a printer. The results were compared with measured losses and confirmed the feasibility of the design of hardware and software.

A linear regression of actual versus predicted losses gave a high correlation ($R^2=0.92$) and a slope of close to one (1.02). The comparison of calculated to measured losses showed a statistically significant correlation ($\alpha=0.05$) with the data over all the runs.

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LIST OF SYMBOLS

Symbol	Description	Units
A	constant	
B	attenuation coefficient of exponential curve	m^{-1}
a, b	edge locations of apertured part of the grate in the grate arc direction	m
A_j, B_j, C_j	coefficients determining shape of curves	
C	width of the rotor apertures part in grate section	m
count1,		
count2	initial counts loaded in counter registers CR1 and CR2.	
\bar{E}	mean of the errors (%)	
e	base of the natural logarithm	
f_p	PCLOCK frequency	MHz
G_0	grain initially passed onto the walkers	kg
GL	actual grain loss number of kernels	
H_0	null hypothesis of Student's 'T' test	
H_1	alternative hypothesis of Student's 'T' test	
i	location number of a sensor in a row	
j	row number of sensor matrix	
K	coefficient of the predicted grain loss	m^{-1}
K_1	reciprocal of the effective sampling area of each sensor	m^{-2}
K_2	a calibration coefficient obtained in threshing calibration test	
L	distance to the end of the straw walkers	m

L_w	straw walker grain loss	kg
l	axial distance from the front of the rotor	m
M	mean of loss ratios (actual/predicted) sampled from the population	
N	number of kernels	
N_a	number of kernels (actual)	
N_t	number of kernels (tested)	
n	sample size	
R^2	regression correlation	
$R_n(b)$	the truncation error in Taylor Series	
S	the sum of the squares of deviations from the curve	
S_p	Point Separation	$\text{kg m}^{-2}\text{s}^{-1}$
$S_w(L)$	the separation rate occurring at the end of the straw walkers	$\text{kg m}^{-2}\text{s}^{-1}$
$S_w(X)$	separation rate at a distance from the front of the straw walkers	$\text{kg m}^{-2}\text{s}^{-1}$
$S1-S9$	sensor counts stored in memory	
s	standard deviation of samples	
T_s	sampling duration	s
T_1	Timer/Counter1 (TC1) 1 bit counting time	s
W	the weight of kernels in each collection box	g
W_{tk}	weight of thousand kernels	
g		
X	coordinate along walker	m
X_i	location coordinate of the i_{th} sensor around the grate in a same sensor row	m
Y_j	location of the sensor rows	m

Y_0	coordinate of the rotor end	m
Z	point separation rate (impact count)	
Z_0	analytical initial separation rate (impact count)	
Z_i	impact count on the i th ($i=1,2,3$) sensor at axial position j ($j=1, 2, 3$)	
\bar{Z}_i	mean of impact counts on j th sensor row ($j=1, 2, 3$)	
\bar{Z}	mean separation distribution in the axial direction	
α	level of significance	
$\beta_0, \beta_1, \beta_2$	parameters determining shape of the curve	
ϵ_i	curve deviation from the true value	
μ_0	specified population mean	

1. INTRODUCTION

Modern grain harvesters, or combines, are complex, efficient and expensive machines that are widely used in grain farming operations. To cope with changing harvesting conditions, manufacturers and farmers have attempted to achieve optimum performance from their grain harvesters for years.

The performance of a combine is affected by many factors such as grain and straw yield, crop type and variety, cutting width and crop height, moisture content and even local climatic conditions (PAMI 1980). This complexity gives rise to the problem of how to properly adjust a combine to harvest a crop at the maximum rate while maintaining an acceptable grain loss level. Many suggestions have been well documented since the 1960's.

One method used to realize optimum operation is to adjust the ground speed in response to the perceived grain loss level. A grain loss monitor would be able to provide useful information for the combine operator to control the ground speed.

Users reported that the most valuable aspect provided by monitors was that they indicated when grain loss began due to overloading or misadjustment and that sudden changes

in loss rate indicated the need for corrective action to be taken (Reed 1977). Without monitors it was virtually impossible for the combine operator to know whether the combine was operating near or above maximum separating capacity. The careful operator also became aware of the need and the benefit derived from adjusting threshing cylinder speed, concave clearance and other parts to improve the separating performance.

1.1 Grain Loss Terminology

Grain losses are classified according to their sources and include all field losses attributable to the machine (ASAE 1990). For clarity, grain loss terminology is reviewed below:

Gathering Loss Rate:

The weight of grain per unit of time which has been missed or dropped by the header or pickup. Gathering losses are expressed as a percentage of the sum of the grain feed rate and gathering loss rate.

Processing Loss Rate:

The weight per unit of time of detached grain and grain in unthreshed heads remaining in the straw and chaff after completion of the threshing, separating and cleaning processes. Processing losses are expressed as a percentage of

the grain feed rate.

Leakage Loss:

Any involuntary loss of grain from the combine other than those described above. This is expressed as a percentage of the grain feed rate.

ASAE (1987) define the combine capacity as the maximum sustained total feed rate at which the processing loss, with the machine in field operation on level ground, is between one to three percent, depended on the crops and conditions. Apparently, the processing loss is a significant loss of the three kinds of losses.

Three terminologies (MOG feed rate, grain feed rate and total feed rate) mentioned above also are explained below:

MOG Feed Rate:

The weight of material-other-than-grain (MOG) passing through the machine per unit of time (tonnes/hour).

Grain Feed rate:

The weight of grain, including processing loss, passing through the machine per unit of time (tonnes/hour).

Total Feed Rate:

The sum of grain feed rate and material-other-than-grain (MOG) feed rate (tonnes/hour).

1.2 Harvesting Principle

Harvesting processes consist of several steps. Crop threshing and separation distribution are different when different types of harvesters are selected. In order to design a suitable grain loss monitor for these complex machines, harvesting principles and grain separation distributions in the harvesters must be reviewed.

1.2.1 Conventional Combines

Conventional combines (i.e., those using straw walkers) are very popular in Western Canada as well as the other regions in North America. Most grain loss monitors are used to measure grain loss from conventional combines.

1.2.1.1 Conventional Combine Operating Principles

Figure 1.1 illustrates the operation of a typical conventional grain combine. Crop is fed tangentially into a cross-mounted cylinder and concave assembly. Threshing occurs largely by impact of the cylinder bars on the incoming crop, while considerable separation occurs through the open grate concave. Separation of the remaining grain from the straw is accomplished with straw walkers, while a cleaning shoe with chaffer and sieve, is used for scalping and final cleaning.

1.2.1.2 Straw Walker Grain Separation Distribution

The separation distribution along the straw walker was reported as a decaying exponential curve (Huisman, 1983) and the amount of grain separated at a distance X along the straw walker, $S_w(X)$, could be described with the following equation:

$$S_w(X) = -BG_0e^{-BX} \quad (\text{kg/m.s}) \quad 1.1$$

where:

B = constant related to feed rate, G/MOG , walker design, moisture content and other crop properties.

G_0 = grain initially passed onto the walkers (kg).

e = the base of the natural logarithm.

X = coordinate along walker (m).

The separation distribution curve underneath the straw walker is shown in Figure 1.2. The origin of coordinate X was not at the front of the straw walkers but, actually, at a theoretical point where the separation process became exponential.

The actual grain loss could be obtained by integrating this exponential curve from the end of the walkers to infinity.

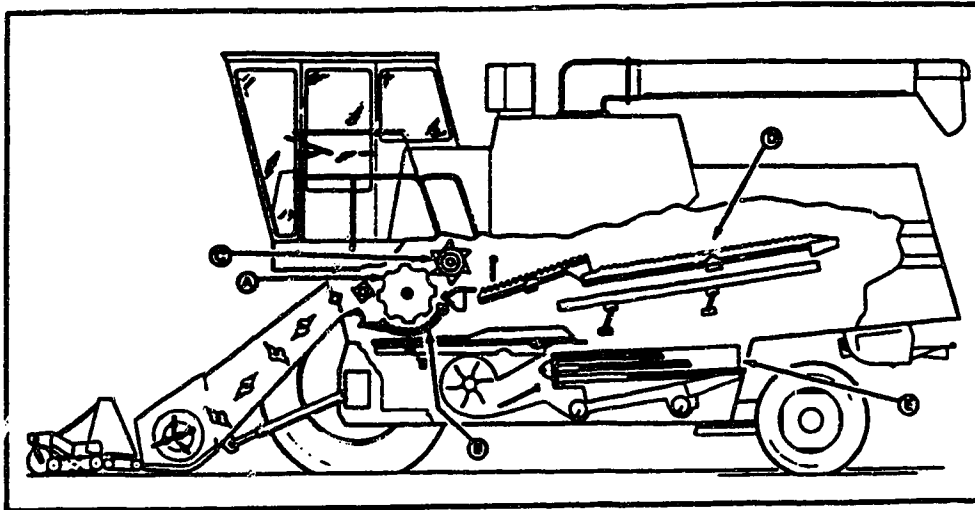


Figure 1.1 A Typical Conventional Combine:

(A) Cylinder, (B) Concave, (C) Beater,

(D) Straw Walkers, (E) Shoe.

(adapted from PAMI 1980)

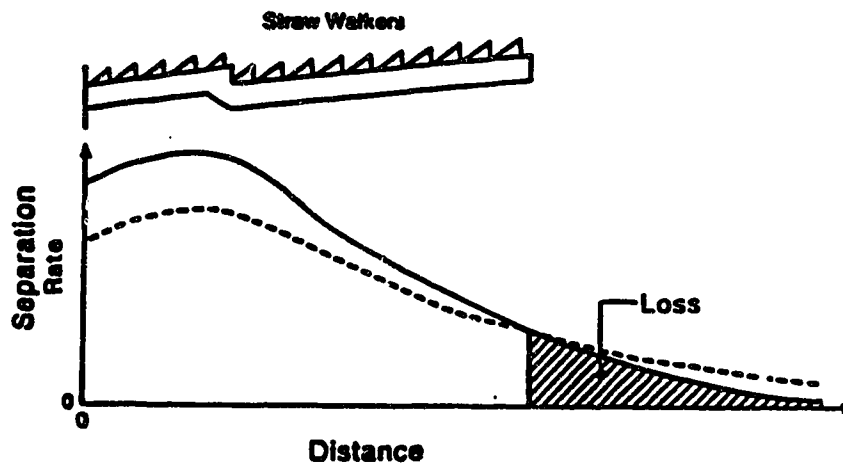


Figure 1.2 The Separation Curve of the Straw

Walkers. (Adapted from Huisman, 1983)

1.2.1.3 Conventional Combine Grain Loss

As stated in section 1.1, the processing losses are significant losses. For a conventional combine, processing losses include walker, shoe and cylinder losses. As shown in Figure 1.3, the straw walker loss not only makes up the greatest portion of the total losses, but also increases more rapidly than other losses when the feed rate increases. If walker loss could be measured and controlled, by reading a loss monitor and adjusting the ground speed, the total loss could be controlled at an acceptable level.

1.2.2 Axial Flow Combines

A number of new types of combines, incorporating different threshing and separating concepts, have recently been introduced. The axial flow harvesters have become popular in recent years because they give less threshing damage and lower losses at normal feed rates than conventional combines (PAMI 1978). However, monitoring grain loss for an axial flow type combine is still necessary.

1.2.2.1 Axial Flow Combine Operation Principles

Figure 1.4 shows the operation of the International Harvester 1460, single-rotor, axial-flow combine. Threshing occurs at the front section of the rotor, while the separa-

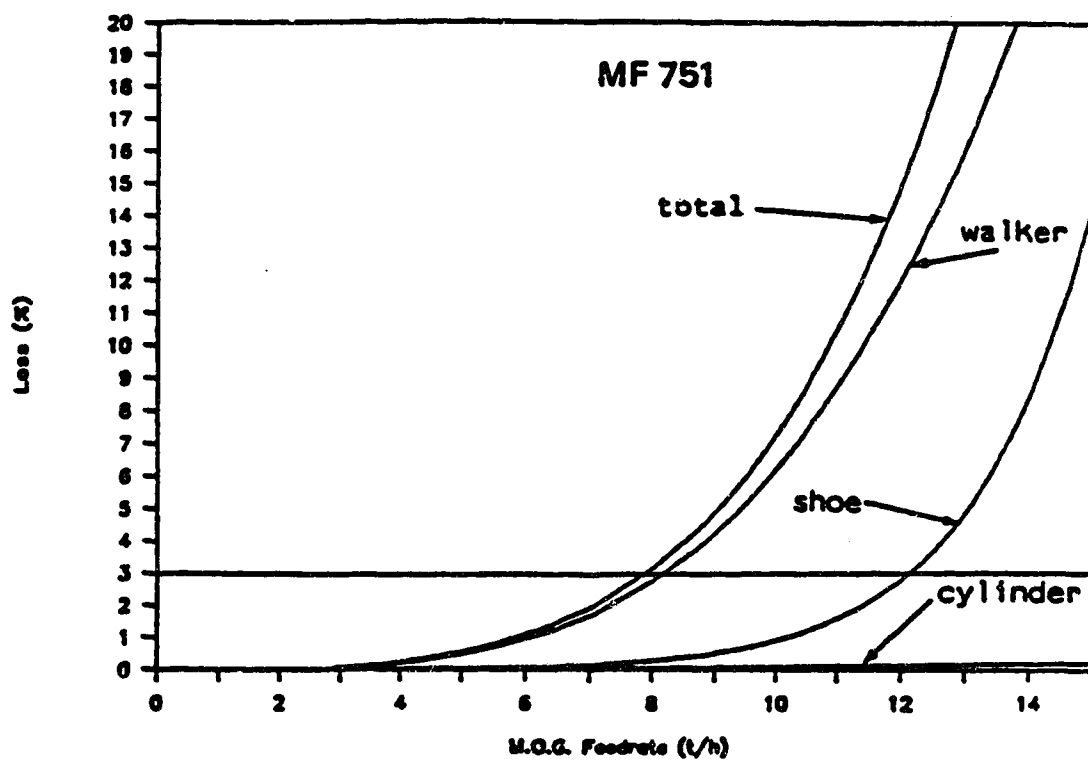


Figure 1.3 Conventional Combine Performance Curves
in Barley (adapted from PAMI, 1979, 1980).

tion of the grain from straw is accomplished along the full rotor length in both the threshing and separation concave. A rear beater aids in straw discharge. A conventional cleaning shoe is used for scalping and final cleaning.

1.2.2.2 Grain Separation in Axial Flow Combine

The structure of axial flow combines is different from that of conventional types. Thus, the movement of material inside the rotor and the separation distribution underneath the rotor have their own characteristics. High speed rotation and the circular shape of the rotor causes the separation distribution around the rotor to be non-uniform.

This fact made separation distribution measurement difficult. However, if the distribution curves around the rotor at different points along axial direction could be found, and the mean distribution values at these points could be derived from these curves, the separation distribution along the axial direction would be similar to that underneath straw walkers (decaying exponential curve, equation 1.1). Therefore, the actual grain loss could be predicted by integrating this curve from the rotor end to infinity.

Bjork (1988) suggested the following expression for separation distribution around the threshing concave and

separation rate for a single rotor combine (International Harvester 1460).

$$S_p = A + Bx + Cx^2 \quad 1.2$$

where:

S_p = Point Separation ($\text{kg m}^{-2}\text{s}^{-1}$),

A, B, C = coefficients determining shape of curve, and

X = coordinate around concave or grate arc
(degrees).

Depending on the signs of coefficients B and C, this function will give an initial peak separation that decays in either a concave or convex manner and a peak separation occurring somewhere in the mid-region of the concave or grate.

1.2.2.3 Axial Flow Combine Grain Loss

Grain losses from an axial flow harvester are of two main types, unthreshed grain still in the head (threshing loss) and threshed grain or seed which is discharged with the straw and chaff (separation and cleaning loss). In field tests (PAMI 1978), grain losses for the International Harvester 1460 were low in wheat crops, but became significant in barley crops at high feed rates. Figure 1.5 shows

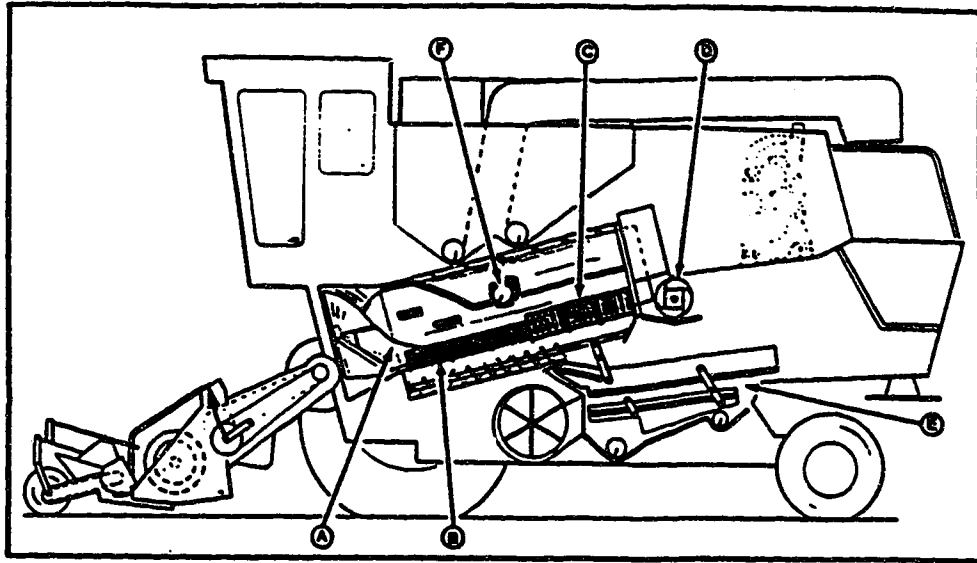


Figure 1.4 International Harvester 1460. (A) rotor, (B) threshing concaves, (C) separation concaves, (D) back beater, (E) shoe, (F) tailings return. (adapted from PAMI, 1980)

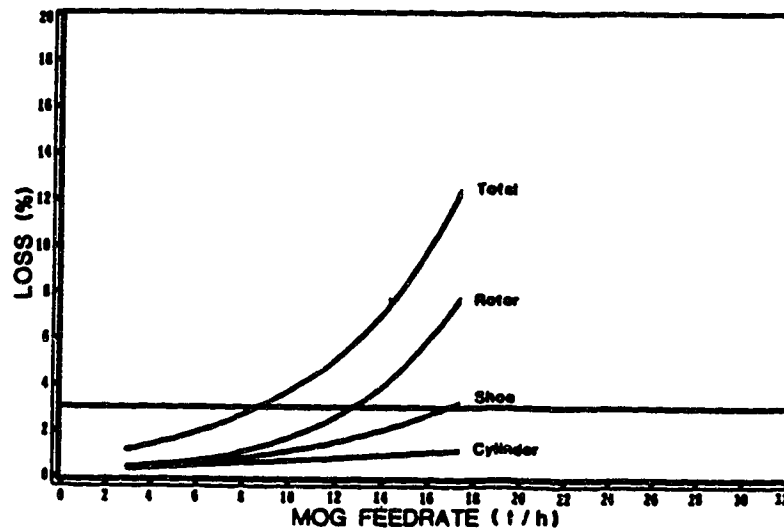


Figure 1.5 International Harvester 1460 Grain loss in Bonanza Barley (adapted from PAMI 1978).

the grain loss from an International Harvester 1460 combine in Bonanza Barley. The rotor (separation) loss is the most significant of all losses.

As with conventional combines, loss monitors on axial flow machines do not give an indication of actual grain loss. However, since the grain separation distribution in these machines could be measured, it seemed reasonable to postulate that an actual grain loss monitoring system could be built. This would be similar in concept to that built by Larson (1987) for conventional combines but would need to be more powerful in order to handle the two-dimensional variation in separation rate.

2. LITERATURE REVIEW

Grain loss monitors are electronic instruments designed to indicate combine grain loss. Sensors, sensitive to seed impacts, are mounted behind the straw walkers, the cleaning shoe and, sometimes, a third sensor is placed at the end of chaffer (Cox, 1982). The signal from these sensors is displayed on a meter at the operator's station. Most loss monitors are not designed to measure the actual amount of grain loss but only to warn the operator of increases or decreases in grain loss rate (PAMI 1978). Figure 2.1 shows a typical grain loss monitor system installed in a conventional combine with straw walkers and cleaning shoe.

An electronic grain loss monitoring device was developed by Feiffer et al. of the German Democratic Republic in 1965 (Reed, 1977). This device removed the chaff from the sample mixture of chaff and lost grain by an air blast before detecting the grain kernels with an acoustic sensor (Reed, 1977).

A device or monitor for detection of grain loss that was believed to be the first grain loss monitor marketed commercially and used by combine operators was developed by Reed et al. (1965) and manufactured by Smith - Roles Limited

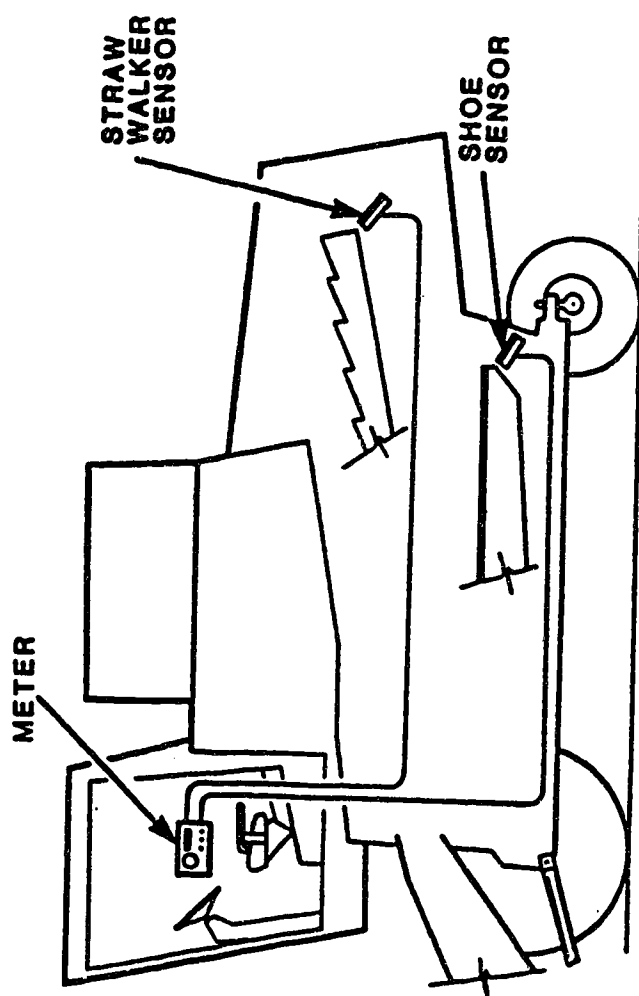


Figure 2.1 Typical Grain Loss Monitor (adapted from PAMI 1978)

of Saskatoon, Saskatchewan, Canada (1968). The monitor was able to determine the grain and non-grain impacts on acoustic sensors (Reed, 1977).

One or two sensor systems could display the decrease or increase of grain loss for conventional or axial-flow combines, but accurate determination of actual grain loss (kg/hectare) could not be obtained.

Huisman (1983) proposed a method of measuring walker loss by measuring the separation rates along the entire walker length (see Figure 1.2). Walker loss then could be obtained by integrating the distribution curve from the walker end to infinity.

Lunty (1986) used a laboratory straw walker assembly and associated data acquisition system to verify Huisman's suggestion.

Sensors were installed at four different positions of the underside of open-bottomed straw walkers to measure grain impacts. The locations of the sensors were selected at the rear section of the straw walkers (for the first sensor $X = 0.66\text{m}$ for the fourth one $X = 2.76\text{m}$). By using the data of each run, the natural logarithms of the sensed separation rates were regressed linearly with the position of the sensors solving for A and B in a separation equation of the following form:

$$S_w(X) = Ae^{-BX} \quad \text{for } X > 0.66m \quad 2.1$$

where:

$S_w(X)$ = separation rate (kg/m².s) at a distance X (m)
from the front of the straw walkers.

A, B = equation parameters.

The actual walker loss could be obtained by integrating the separation curve from the end of the walkers to infinity (see Figure 1.2):

$$L_w = \int_L^{\infty} S_w(x) dx \quad 2.2$$

$$= \int_L^{\infty} Ae^{-Bx} dx$$

$$= \frac{A}{B} e^{-BL}$$

$$L_w = S_w(L) / B \quad 2.3$$

where:

$S_w(L)$ = the rate of separation occurring at the end of
the straw walkers (kg/m².s), and

L = distance to the end of the straw walkers (m).

The separation data from the laboratory apparatus showed that actual loss could be predicted from separation measurements at four points below the walkers.

On the basis of Huisman's suggestion and the results of Lundy's attempt, Larson (1988) developed an 8-bit (MC6800)

microprocessor-based system capable of rapid data acquisition under the harsh conditions of harvest environment. This system was tested in both laboratory and field conditions and was able to provide separation data for the calculation of walker loss. Four sensors were located at 0.686m, 1.373m, 2.059m and 2.745m from the front end of the walkers. Bandpass filters were implemented to reject non-grain impacts, mechanical and electrical noise. A monostable trigger (555 timer module) was used for obtaining single pulses for a single kernel.

The field test measurements of separation curves were performed successfully. The curves of all valid runs were of high-correlation exponential decays with calculated losses statistically close to the actual loss rate. The worst fit had an R^2 of 0.72, while the best was 0.99.

Loss calculations based on separation rate curves were accurate, provided the samples are point-samples of known area and location. The comparison of calculated to measured loss showed a statistically significant correlation at the level of $\alpha=0.10$ with limited data. The calculation of walker loss was simple once the exponentially decaying curve was determined (Larson, 1987).

Due to the limitations of the microprocessor, loss calibration could not be done in real time. Larson (1987)

recommended that software could be developed to calculate the actual loss from the sensor data in real time. To do this, a more powerful 16-bit microprocessor would be needed.

Since the velocity of straw and grain discharged from the end of the combine was high, PAMI (1978) suggested that loss monitors were not suitably designed for use on the new axial-flow threshing combines. When hit by grain and straw at high velocity, most loss monitors could not distinguish grain from straw and they read in error. In 1983 the British company RDS Farm Electronic Ltd., developed the MK81 combine monitor. The MK81 was designed especially for use on axial-flow combines, but could also be used on traditional types of machines (The Green Book, 1983).

Wang (1984) studied the separation characteristics of a Sperry New Holland TR85 rotary combine. The TR85 uses two longitudinally-mounted, axial threshing and separation rotors. Discussions were based on the separation distribution of the left side rotor-concave assembly. Ten acoustic sensing pads were used as grain impact transducers to study the separation characteristics in the longitudinal direction and, also, the lateral direction around the rotor. The sensors were mounted on a metal frame underneath the threshing and separation concaves. Grain impact signals were recorded on a tape recorder. The results showed that the largest

proportion of the separation took place at the threshing concaves. The peak separation rate occurred near the entrance of the thresher and at the right side of the thresher when wheat was combined. By contrast, the peak separation rate occurred at the left side of the thresher and was a little further from the entrance when barley was combined (Wang, 1984).

Bjork (1988) suggested a separation distribution model (equation 1.2) in an axial-flow combine arc direction and this model would give an initial peak separation rate occurring somewhere in the mid-region of the concave or grate followed by exponential decaying in axial direction.

The existence of exponentially decaying separation curves in axial flow machines indicated that the method of Huisman (1983) could be used to determine actual grain loss from these machines. As Larson (1987) suggested a 16-bit microcomputer would be required to do this in real time.

3. OBJECTIVES

The object of this project was to develop and test a 16-bit (Intel 8088), microprocessor-based, nine-sensor grain loss monitor system for an axial flow combine (International Harvester 1460). As a multi-channel data acquisition and processing system, this monitor would be able to distinguish between grain and non-grain impacts on the sensors, count the seed impacts, fit separation curves to the data around the separation arc and in the axial direction, and predict the actual grain loss in real time.

4. SOUNDING BOARD SIGNAL ANALYSIS AND SIGNAL CONDITIONING

Acoustic grain impact sensors were available from several manufacturers. Two kinds of sensors made by different companies were chosen for a comparison experiment and the Baker Electronic Enterprises (Edmonton, AB) product was selected as the key sensing component on the basis of its even sensitivity at different points (except the side edge) of the sensing surface.

The sensor was a rectangular plastic box measuring approximately $160 \times 60 \times 20 \text{ mm}^3$ composed of two parts: an acoustic plate and a base. Between the acoustic plate and the base, there was a rectangular plastic foam buffer to reduce the duration of decaying grain impact signals, so that the maximum impact frequency could be increased. In each sensor, a circular membrane piezoelectric sensor ($R=25.4\text{mm}$) was attached to the acoustic plate. The whole inside surface of the acoustic plate (sounding board) was glued to the buffer foam so that sounding board response to grain impacts at different points tended to be identical. The other side of the buffer foam was also fixed to the plastic base which was fitted with mounting screws for attachment to the combine. A second pair of screws on the

base served as output terminals, which would eventually be connected to sensor signal conditioners. Plate 4.1 shows a photograph of a typical sensor and its inside structure.

4.1 Sounding Board Signal Analysis

Figure 4.1 shows the frequency spectrum from the impacts of rape and its straw and chaff (Baker, 1988). The power spectrum shows that rape kernel impacts caused a peak value near 15KHz. Also, two peak values were produced by the straw and chaff, one close to 15KHz and the other close to 16KHz, but their amplitudes were much lower than that caused by rape kernels. In the low frequency band (0-5KHz), there was another peak point generated by straw and chaff and its amplitude was higher than the peak produced by kernels.

The rape frequency spectrum illustrated that there were two choices to identify grain and non-grain impacts using filtering techniques. In the low frequency band (0-5KHz), a band reject filter may be used to reject the non-grain impact signals and leave the grain impact signals for further use. In the high frequency band, a band pass filter may be designed to amplify grain impact signals and reject non-grain signals. The band pass filter central frequency should equal the frequency of the peak amplitude. The band-

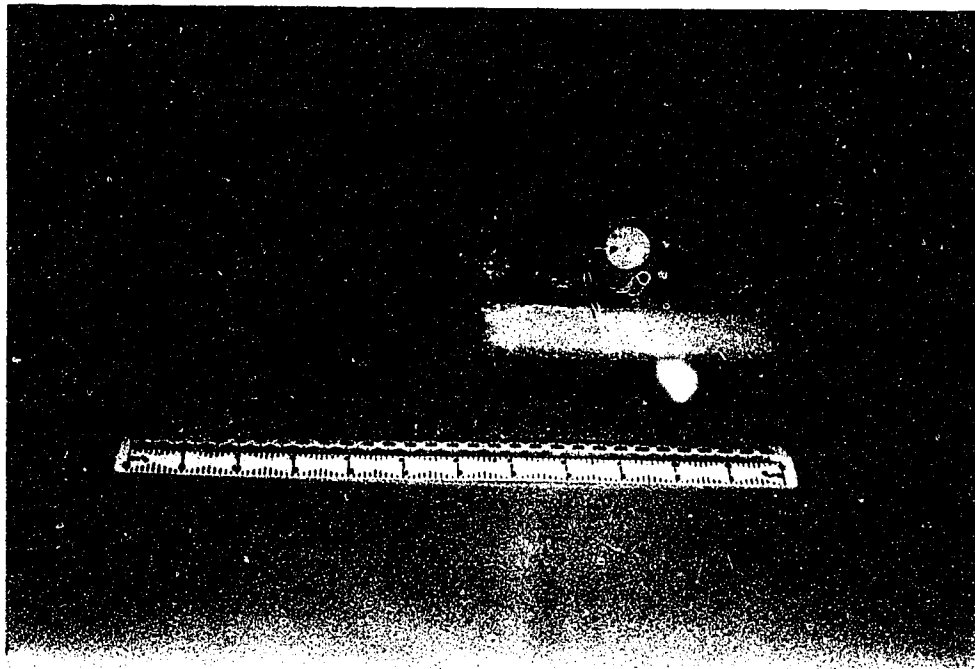


Plate 4.1 A Grain Impact Sensor (left) and
the Sensor inside Structure (right).

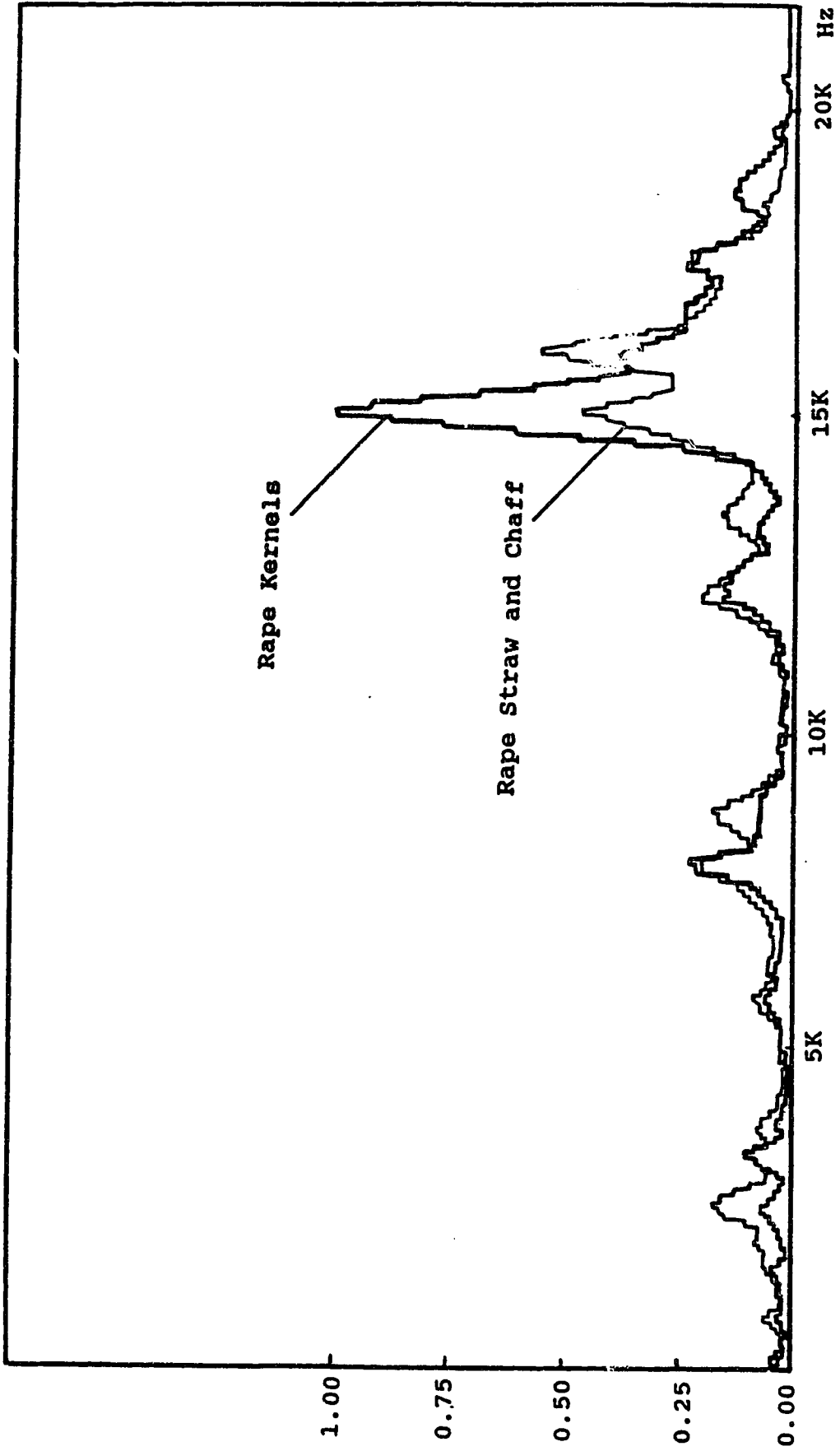


Figure 4.1 The Rape Kernel, Straw and Chaff Signal
 FFT Frequency Spectrum (adapted from Baker, 1988).

pass filter method was preferred because of the stronger signal and obvious amplitude difference between grain and non-grain signals.

Grain impact signals were enhanced and non-grain signals were attenuated by using band-pass filters. Thus, grain impact signals were conditioned to have higher amplitudes and non-grain signals to have lower amplitudes. Thus, the signals were much easier to process using a comparator. The reference voltage of the comparator was so selected that it was lower than the amplitude of the initial part of grain impact signals and higher than all amplitudes caused by non-grain impacts. Therefore non-grain impact signals were rejected and grain impact signals were selected by changing a comparator's output from one extreme value to the other.

Similarly, barley and wheat kernel impacts also have their characteristic peak frequencies.

Preliminary experiments to find out the central frequencies for wheat and barley kernels were made. The signals from the sounding board were amplified by a simple operational amplifier circuit with a gain of 33. The output signals from the circuit were measured with a storage oscilloscope (Tektronix 464). The wheat kernels were quite dry (10% w.b.) but the barley kernels had a moisture content of

13% w.b. Kernels were dropped from different heights to measure the signals. To obtain the best sensitivity, the orientation of the sounding board was 45° to the horizontal.

The waveform decay envelope curves were recorded by hand (see Figure 4.2). The time for the signal amplitude to decay to 2V was almost independent of the height from which kernels were dropped.

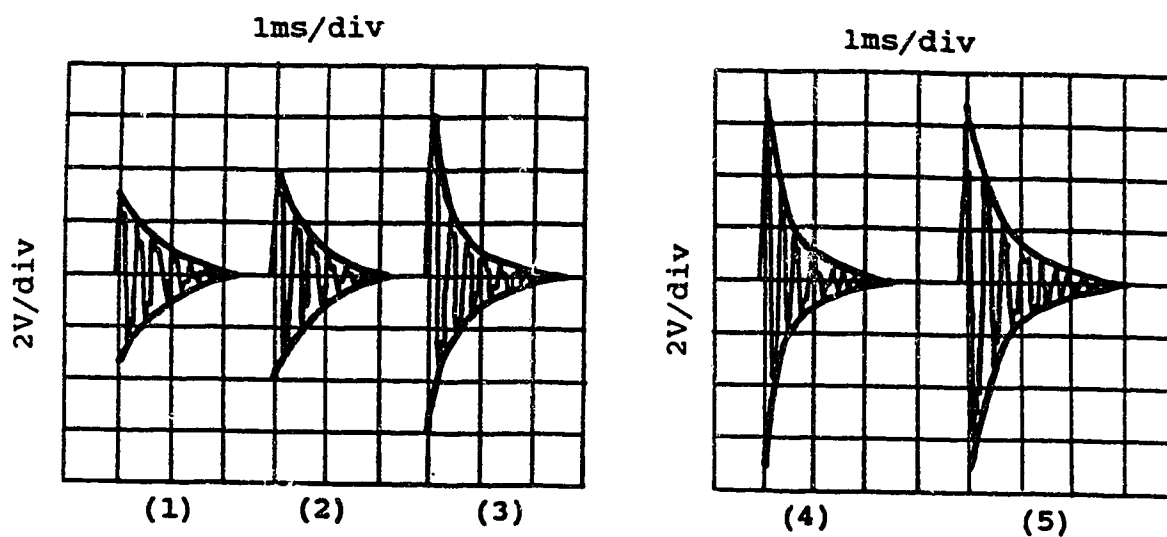
The barley kernels were dropped from 5, 10, and 30cm above the sounding board surface center, the signal decay time kept within 3-5ms (see Figure 4.2 Test 1 Barley) while the frequency of the impact signal was around 3500-5000Hz.

The wheat kernels were dropped from heights of 5, 10, 15, 20, 30, and 60cm and the signal amplitude decayed to 2V within 2-3ms (see Figure 4.2 Test 2 wheat) with a central frequency of about 3000Hz.

With both crops the frequency of signals from straw and chaff impacts was lower (1500-2000Hz) than that from kernel impacts and, thus, filters could be used for impact discrimination.

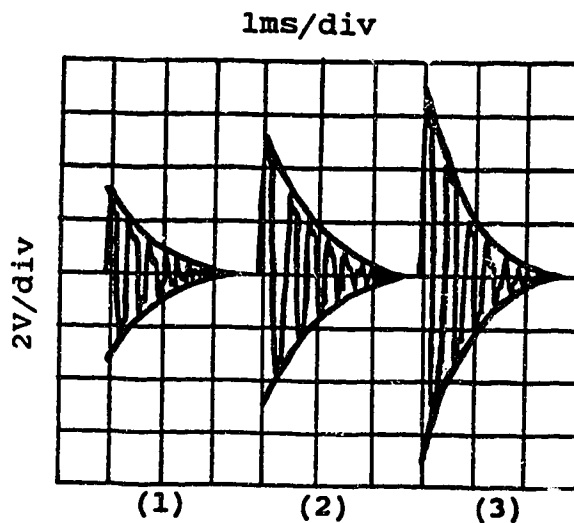
4.2 Signal Conditioning

The sensors and their associated signal conditioners were the key parts of the measurement system since the whole system performance depended on the quality of their signals.



Dorp Height: (1) 5-10cm (2) 15cm (3) 20cm (4) 30cm (5) 60cm

Test 1: Wheat



Dorp Height: (1) 5cm (2) 10cm (3) 30cm

Test 2: Barley

Figure 4.2 The Waveform Envelop Curves of Grain Impacts.

Hence, high quality components (operational amplifiers (op amps), transistors, triggers, resistors etc.) were selected for the circuit design. The signal conditioning circuit is shown in Figure 4.3.

In order to reduce noise interference, the feed wire for weak signals from the sensor outputs to signal conditioner inputs should be as short as possible and the signal conditioner output signals should be as strong as possible. This would increase signal-to-noise ratio when signals were fed along long cables.

The conditioners were designed as independent printed circuit boards attached to sensors so that the weak signal feed wires were only 5cm long. Noise transmitted by electromagnetic induction had few chances to be received by the short wires. Output signals, which consisted of a train of pulses, could be transmitted to a computer along 5 to 8m-long, plastic-insulated wires without significant distortion. The output pulses were able to drive photo-coupled isolators in a computer interface.

A schematic diagram of the signal conditioning circuit is shown in Figure 4.3. Each circuit included an amplifier, a band pass filter, a comparator, Schmitt-triggers, a monostable multivibrator and a voltage follower. Most of the digital integrated circuits (ICs) were CMOS components

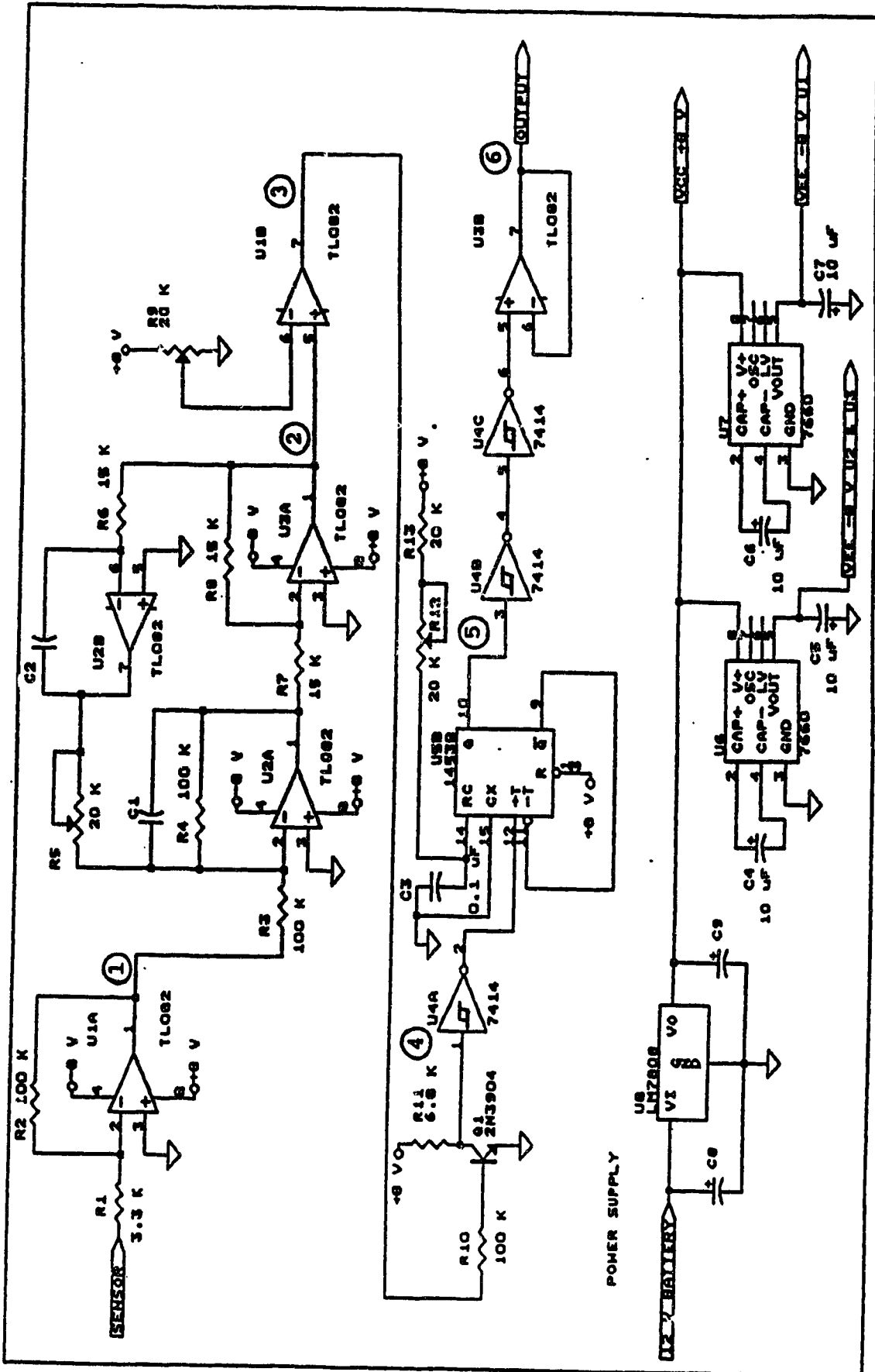


Figure 4.3 Signal Conditioner Circuit.

which were chosen for their flexible power supply requirement and higher level output voltage. A power regulation circuit converted 12V DC battery power to $\pm 8V DC$ as a power supply for op amps and other ICs. Thus, the digital CMOS ICs could provide output pulse signals as high as +8V.

The structure and the function of the key parts of the signal conditioning circuits are as follows:

4.2.1. Bandpass Filter

Biquad bandpass filters were used (Johnson et al. 1980). The selection of this bandpass filter was due to its popular design, and its excellent tuning features. This bandpass filter consisted of op amps (U2A, U2B, U3A in Figure 4.3), capacitors (C1, C2) and resistors (R3-R8). For testing with barley, these were set up to have a central frequency of 5000Hz and a bandwidth of 1000 Hz. The center frequency of the band could be shifted by adjusting a potentiometer (R5). Figure 4.4 shows the frequency response of the band pass filter.

The bandpass filter blocked low frequency straw and chaff signals as well as mechanical noise caused by the rotor rotation. Tests showed that the signal conditioners had excellent mechanical noise immunity for rotor speeds from about 800 to 1000rpm.

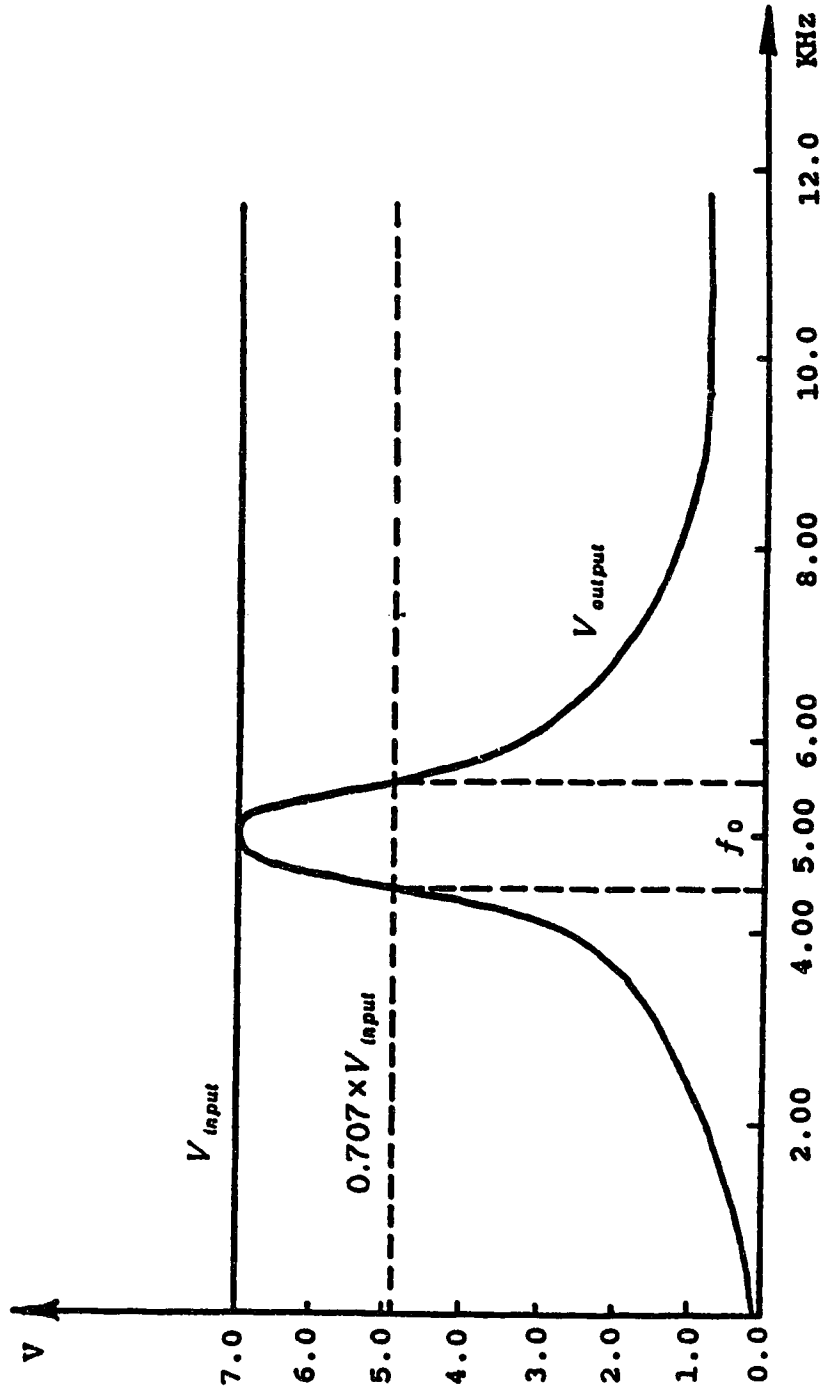
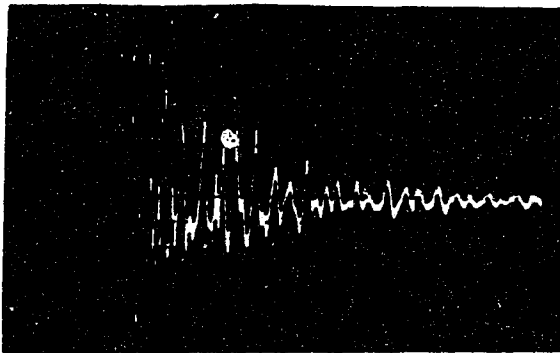
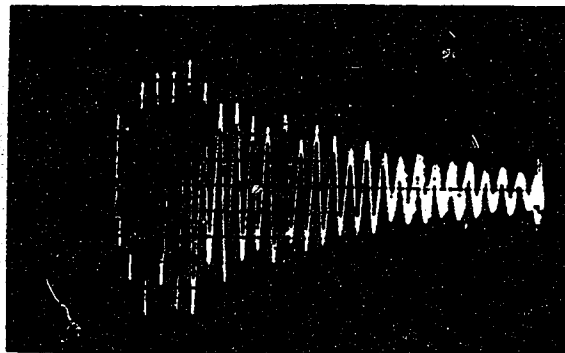


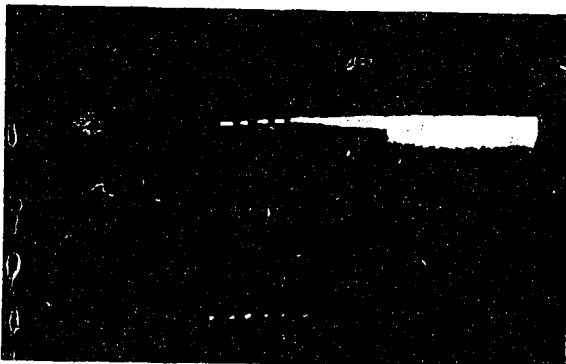
Figure 4.4 Bandpass Filter Frequency Response.



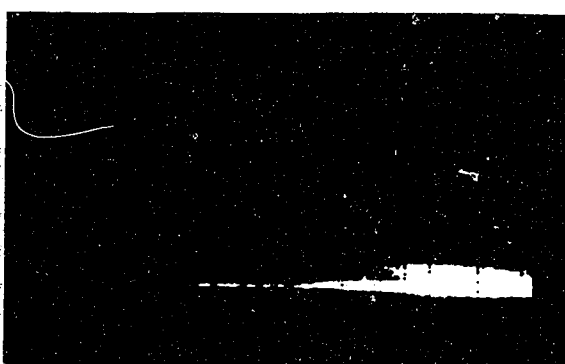
1. Output of Amplifier



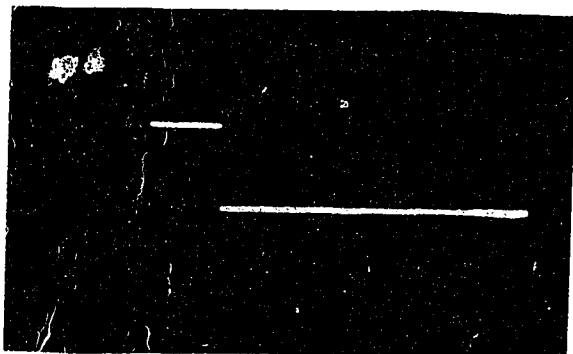
2. Output of Band-Pass Filter



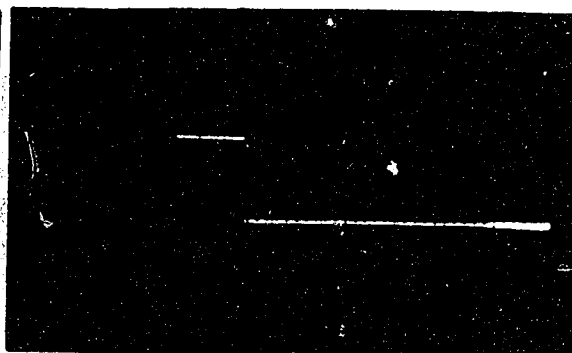
3. Output of Comparator



4. Output of Transistor



5. Output of Monostable Multi-Vibrator



6. Output of Voltage Follower

Plate 4.2 Typical Kernel Signal Waveforms.

Note: 1. - 6. refer to locations on the signal conditioner circuit (Figure 4.3).

Plate 4.2 photo 1 and 2 show the waveforms of bandpass filter input and output signals. Higher and lower frequency components at the input side were attenuated and the output signals became nearly sinusoid and decayed at the frequency of 5000Hz.

4.2.2 Comparator

In addition to frequency discrimination, grain impacts also were identified on the basis of the signal amplitude. Output signals from the bandpass filter were compared with an adjustable reference voltage at two input terminals of the comparator U18. Thus, whenever the amplitudes of decaying impact signals were higher than the reference voltage (obtained from potentiometer R9), the comparator would give a train of positive pulses. Otherwise, the output would remain at the negative saturation voltage of the comparator (see Plate 4.2 photo 3). Adjusting the reference voltage with a potentiometer could increase or decrease the sensitivity of the sensors.

4.2.3 Precision Monostable Multivibrator.

The pulse trains from the comparators could not be used directly to provide grain impact counts. First, the negative part of the signals had to be removed using a high-

speed switching transistor (2N3904) and the processed signals are shown in Plate 4.2 photo 4. Schmitt-triggers (SN74HC14) then were used to sharpen the positive pulses and condition the signals to CMOS levels. Finally, the first increasing edge of a pulse train was used to trigger a monostable multivibrator (HCF4538) that generated a single pulse for the duration of the decaying impact signal. This measure could avoid a single impact creating more than one pulse. HCF4538 is a precision CMOS component which could generate an accurate output pulse over a wide range of widths ($10\mu\text{s} - \infty$). The pulse width was set by external resistor (R12) and a capacitor (C3).

The monostable outputs (see Plate 4.2 photo 5) were fed through two-stage CMOS Schmitt-triggers and a voltage follower and transmitted as 3-5ms width pulses with amplitudes of +8V (see Plate 4.2 photo 6) along plastic-insulated wires to a single-board computer. Because of high signal-to-noise ratio, the system performed with high noise immunity.

4.2.4 Circuit Board Mounting

The signal conditioner printed circuit boards were attached to the base of each sensor in order to provide better signal conditioning and improve the noise immunity. Plate 4.3 shows three sensors with their signal conditioner

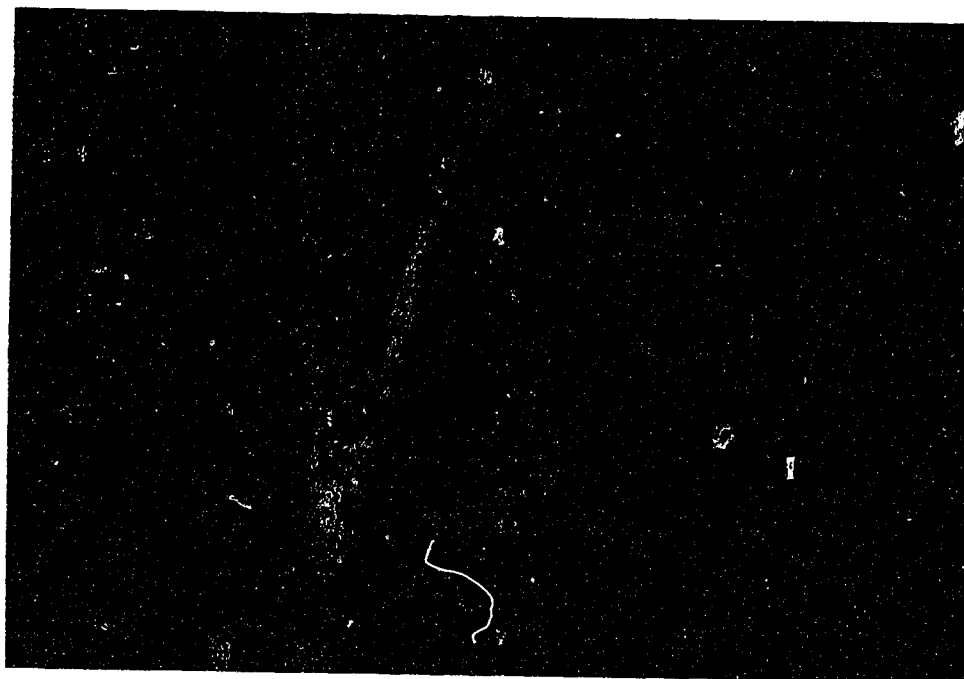


Plate 4.3 Sensors and Signal Conditioners.

printed circuit boards attached. This printed circuit board measured $110 \times 55 \text{ mm}$ and was smaller than the sounding boards. Four small screws fixed the circuit board to a pair of aluminium supports which were fixed to the sensor mounting screws. Plastic insulated washers were used to prevent the screws from contacting the circuit board directly.

A layer of acrylic coating was painted on the surface of these printed circuit boards as well as all the components on the circuit board to protect them while working in harsh threshing environments. These signal conditioners, located underneath a threshing rotor, gave no trouble during threshing tests.

5. MICROPROCESSOR-BASED DATA LOGGER HARDWARE DESIGN

The performance of a combine is affected by many factors. Sometimes the factors vary frequently (the density of the crop, for example). To respond to this situation, the operator has to adjust the ground speed as quickly as possible in order to keep the grain loss to an acceptable level. As the actual grain loss information source, the monitor should respond to the changes of harvesting circumstances quickly and accurately. This indicated that a high performance microprocessor should be selected as the system's central processing unit (CPU).

5.1 Microprocessor Selection

The monitor was a microprocessor-based system which provided multi-channel, high-precision data acquisition and processing; real time regression calculation and an operating system for the coordination of peripheral equipment. The complexity of the system made hardware and software design difficult and complicated. Thus, the system Central Processing Unit (CPU) selection was the most important decision for the monitor hardware design.

An 8-bit microprocessor data acquisition system would be capable of collecting the signals from nine sensors, but

the ability of an 8-bit CPU to conduct complicated regression calculation in real time was questionable. As recommended by Leonard and Larson (1988), a 16-bit microprocessor was needed for the hardware design.

Of the various 16-bit microprocessors on the market, two were available for use:

1. Motorola M68000 16-bit microprocessor.
2. Intel 8086/8088 16-bit microprocessor.

The M68000 instruction set is powerful but relatively simple. Its sophisticated interfacing capabilities, and its ability to strongly support multi-tasking (Clements, 1987) made it a possible selection as a system processor. However, because there were no suitable microprocessor development devices immediately available, the M68000 was not selected for this project.

The Intel 8088 on the other hand is used in the IBM-PC computer and all the software could be programmed, debugged, and modified conveniently on an IBM-PC. Therefore the Intel-8088 was selected as the system CPU. The ready availability of development software was also a reason in making this selection. The feasibility of using an IBM-PC to develop an 8088-based instrumentation system had been confirmed previously (Liu et al. 1988). Details of this application are explained in Chapter 6 (Software Design).

5.2 Single Board Computer

The data acquisition and processing system was built around a 16-bit, single board computer. A photograph of the single board computer and printer are shown in Plate 5.1.

A forty-key, soft touch keyboard (DMC 40-key-Membrane-Switch Kit) and a sixteen-digit liquid crystal display (SHARP Dot-Matrix LCD Unit) were connected to the system to monitor data acquisition and to enter commands. A portable thermal printer (Radio Shack TP-10) was employed to print output files which included the original data from sensors, all the regression model parameters, some important intermediate results and the final predicted grain loss values.

The single board computer (SBC) circuit was built by wire wrapping and had to be able to withstand a hostile testing environment. A block diagram of the SBC and a signal conditioner are shown in Figure 5.1.

Usually, power surges, spikes, and static electricity are great "killers" of computers (Williams, 1988). The power surges and spikes could be avoided by using a voltage regulator to convert 12V from a battery to a 5V power supply. The use of a battery was considered appropriate also because a 12V DC power supply is a standard on combines. Static electricity countermeasures were taken to avoid system malfunction or chip damage during assembly and opera-

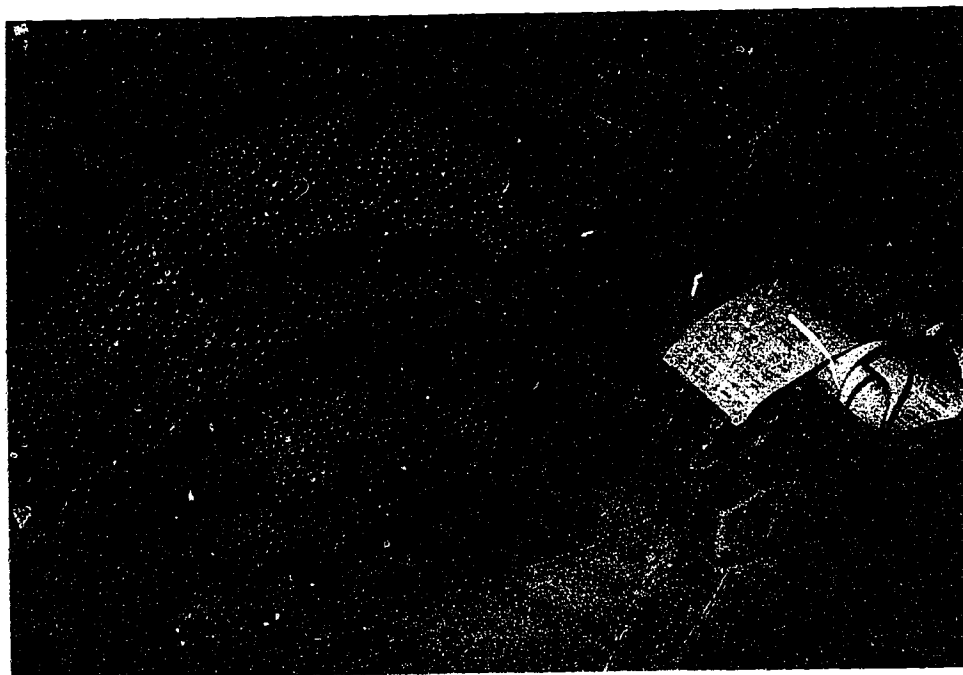


Plate 5.1 A Single Board Computer and a Printer.

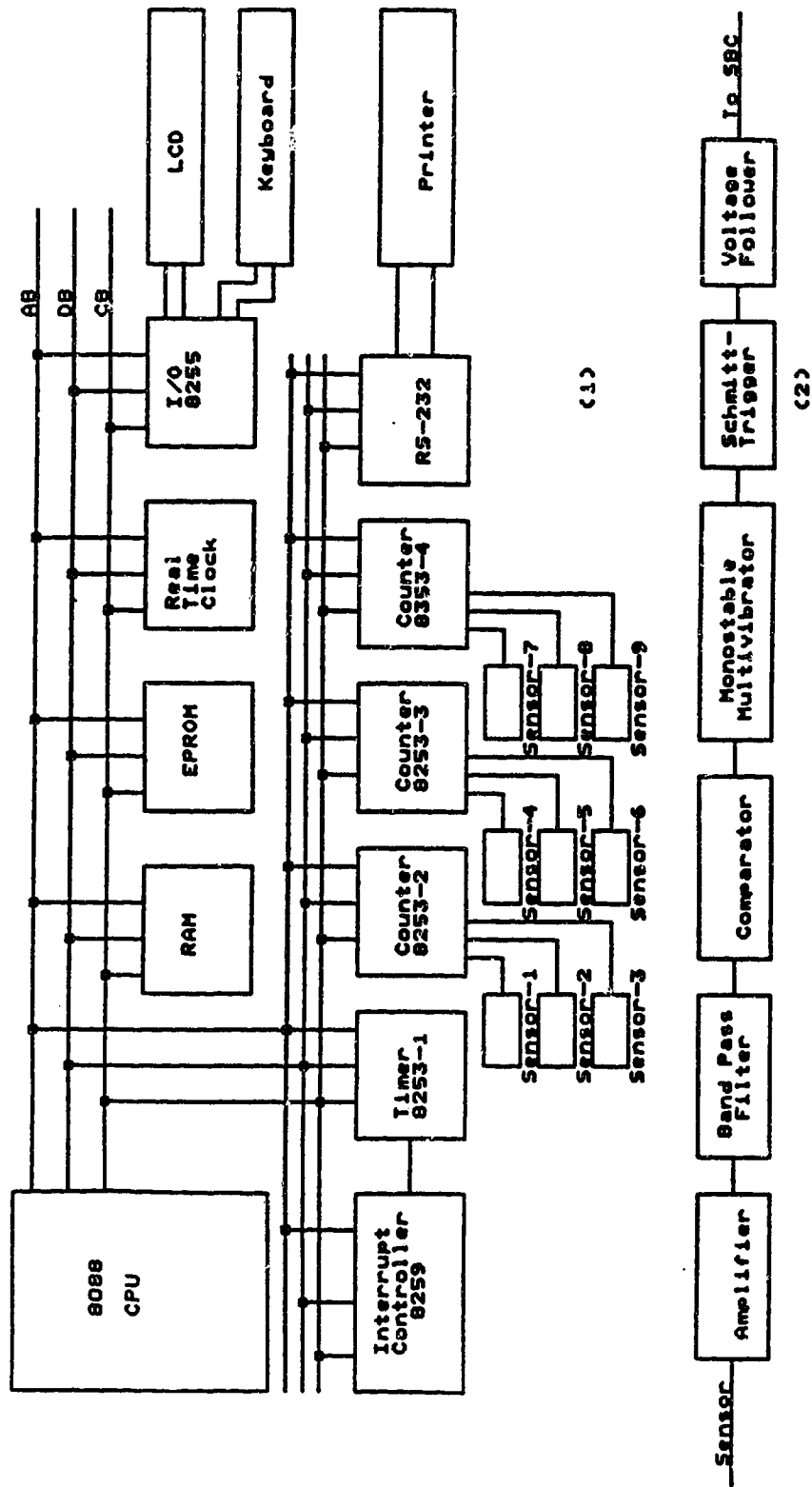


Figure 5.1 A Block Diagram of the Single Board Computer (1) and a Signal Conditioner (2)

tion.

Threshing tests were carried out during late winter and early spring of 1989. Heaters in the test building were working day and night and the air in the building was dry. The threshing equipment (International Harvester 1460 rotor assembly) was set on dry wood blocks and, thus, was insulated from the ground.

Crop materials were rubbed in the rotor and static charge accumulated in the threshing equipment. For the first of several preliminary threshing runs, the monitor system behaved erratically because the SBC was set in a plexiglass box. Static was conveyed to the SBC via the signal feed wires or by dust and, subsequently, interfered with the normal performance of the monitor system. Later, a sheet metal box was built for the SBC and the +5V power supply negative terminal was also connected to the box which was grounded. All the signal input terminals were isolated from the outside environment by opto-isolators (Appendix II 3. Nine-channel Signal Interface) to improve the monitor system noise immunity. No further problems were encountered due to static electricity.

In order to outline the monitor system structure and its main functions clearly, the instrumentation hardware and its functions are listed in Appendix I. Table 1.

The system memory capacity was 26k byte. One 8k EPROM was reserved for the operating system for the keyboard, LCD and printer control, as well as for the real time data processing routines. Another 8k EPROM was used as storage for look-up tables. The remaining 10k was RAM which was used for data acquisition and processing, storage of intermediate results, and system stack. A detailed memory map is shown in Appendix II. 1. Memory Map.

Parallel (8255) and serial (RS-232) interfaces were also employed to connect the SBC with the keyboard, LCD, printer etc. The interface address map also is shown in Appendix II. 2. I/O Map.

5.3 Timer/Counters and Interrupt Controller

The data acquisition system utilized four Timer/Event Counters (8253). Three of these served as counters to collect the pulse signals from each of nine grain impact sensors, while one worked as a timer to control the sampling rate and as a baud rate generator for serial communications.

The programmable Timer/Event Counter (TC) consists of three identical counting circuits, each of which has clock (CLK) and GATE inputs and an output (OUT). Each can be viewed as containing a Control and Status Register pair, a Counter Register (CR) for receiving the initial count, a

Count Element (CE) which performs the counting but is not directly accessible from the processor, and an Output Latch (OL) for latching the contents of the CE so that they can be read (Liu and Gibson, 1986). The internal structure of a single TC is shown in Figure 5.2.

A Programmable Interrupt Controller (8259) was used to control the data acquisition. The interrupt technique was used so that counting kernel impacts and data processing could be conducted independently.

5.3.1 Sampling Rate Signal

Harvesting is a continuous operation and the grain loss varies continuously. In order to improve the accuracy of predicting actual grain loss, the data sampling time should be measured accurately and the gaps between two samples should be as small as possible to avoid losing any grain impact counts.

Figure 5.2 shows the sampling rate signal generator and the counter for channel #1 (for clarity, the other 8 channels were omitted) and its control circuit.

The sampling frequency generator was composed of two Timer/Counters (TC1 and TC2). TC2 OUT2 was connected to TC1 CLK1 and the system PCLOCK (peripheral clock 2.5MHz) was input into TC2 CLK2. TC2 worked as a square wave generator

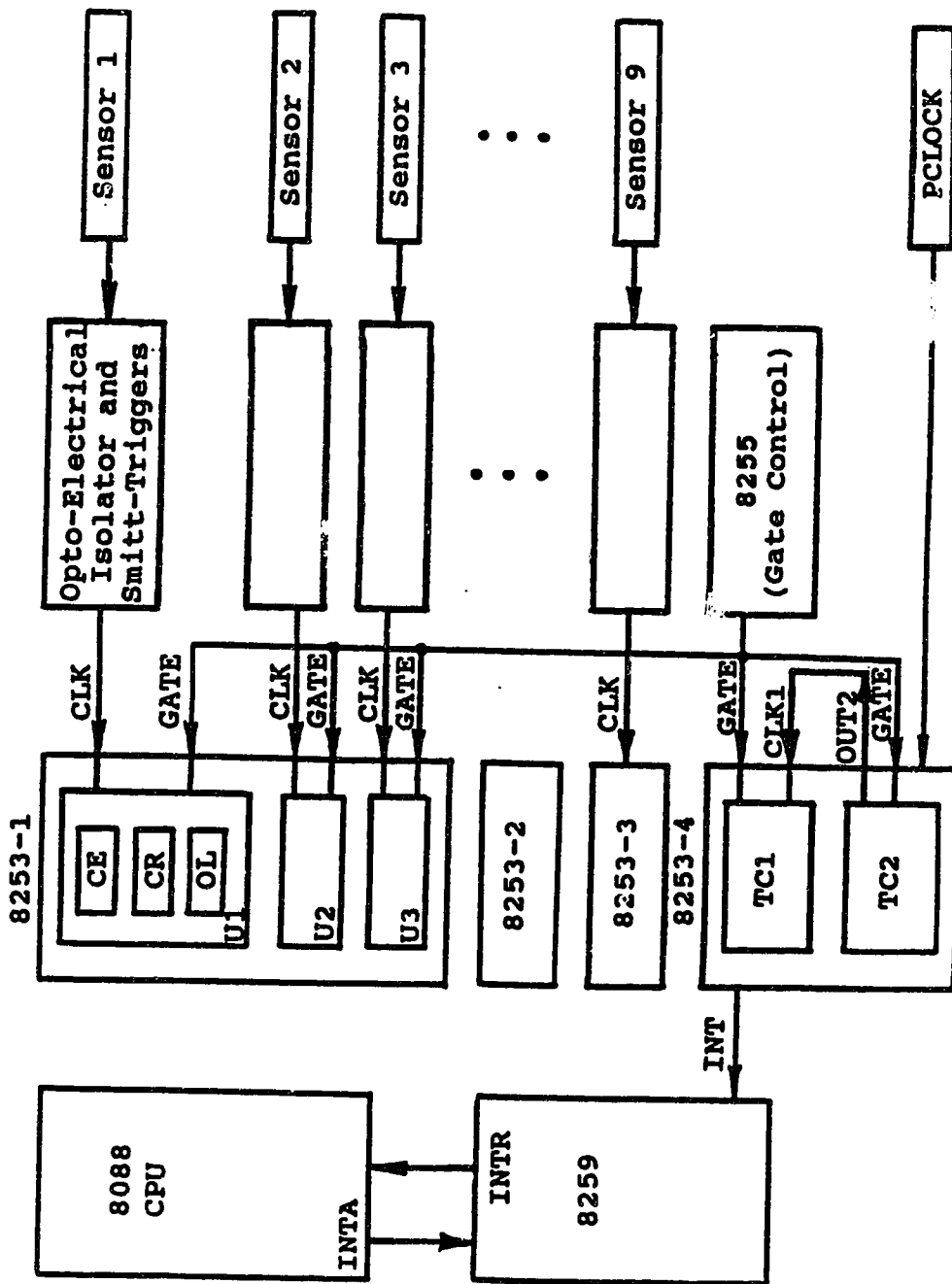


Figure 5.2 Sampling Rate Signal Generator, Counters and their Control Circuits.

(8253 mode 3), and split the 2.5MHz PCLOCK into a lower frequency (25,000Hz) square wave. TC1 provided an interrupt on count termination and split the square waveform further into a 2s sampling rate control signal.

The duration of sampling depended on the counts which were loaded in TC1 and TC2 CRs (Counter Registers) on system initialization. The duration of sampling could be calculated by:

$$T_s = \frac{(\text{count1}) \cdot (\text{count2})}{f_p} \quad 5.1$$

where:

T_s = sampling duration,

f_p = PCLOCK frequency (2.5MHz), and

count1 (100), count2 (50,000) = the initial counts loaded in CR1 and CR2, respectively.

Since the TCs were pulse-edge triggered devices, wide clock cycles increased the timing errors. To obtain an accurate sampling rate, count2 was selected as small as possible while count1 was as big as possible. For this project the sampling rate was 2s and count2 and count1 were 100 and 50,000 respectively. Since PCLOCK was an accurate system clock the only error source was the digital counter which was accurate to ± 1 bit. When these initial counts were loaded in the TCs, the sampling duration time error was:

$$\frac{T_1}{T_s} = \frac{0.04 \times 10^{-3} s}{2s} = 2 \times 10^{-5} \quad 5.2$$

where:

T_1 = TC1 1 bit counting time,

T_s = sampling duration.

5.3.2 Counting Process

When data acquisition started, the sampling rate generator (TC1, TC2) started to count the PCLOCK until TC1 counting terminated. When this occurred, the TC1 OUT terminal sent a two-second timing pulse to the system interrupt controller (8259) as an interrupt request. If the CPU interrupt was enabled, the interrupt was recognized and a service routine was executed. The interrupt service routine included the following steps:

1. Sending a Gate Control signal via parallel interface 8255 to close all the TCs' GATES. Counting and timing were stopped temporarily.
2. Reading the nine sensor grain-impact counts stored in the TCs' Output Latch (OL) registers and writing the data into RAM for further real-time data processing.
3. Loading nine initial zero counts to the TCs' CRs and sending a pulse, via 8255, to clear all the TCs' OLs for the next sample.

4. Initializing the sampling rate generator (TC1 and TC2) and opening all the counters' GATES by sending a Gate Control signal. At this moment, the next sample period started.
5. Conducting the Real Time Data Processing. After the service routine execution was over, the CPU would wait in a loop for the next interrupt.

The interrupt service routine execution time from step 1 through step 4 was the duration of the gap between two samples. This part of the procedure included 156 Intel 8088 assembly language instructions, their execution times are summarized in Appendix I. Table 2.

The 156 instructions to be executed between two samples took 963 system clock cycles. The system clock was 5MHz, giving a total execution time for the 156 instructions of only 0.1926ms. Therefore, compared to the width of a single kernel pulse signal (3-5ms), the gaps between two samples could be ignored. The grain impact signals would only be lost when the signal edges happened to appear at the gap. The possibility of this was only 1×10^{-4} .

The advantage of this kind of sampling was that the system could monitor the combine operation continuously, and the total actual grain loss could be accumulated accurately sample by sample.

An experiment was carried out to verify monitor counting accuracy. A function generator (HP 3312 A, Hewlett Packard) was connected to a universal counter (HP 5314 A, Hewlett Packard) as well as the grain loss monitor counter input terminals (channel#1 through channel#9). The signal from the function generator was adjusted to resemble those from the sounding board signal conditioners. The initial count for sampling time generator TC1 was 50. This corresponded to a sampling duration of 1 second. This was the same sampling period of the universal counter. The counting results of the nine channels were displayed on the LCD in turn. Examination showed that the readings on all channels of the grain loss monitor and on the universal counter were always exactly the same over an input signal frequency range from 5Hz to 65536Hz.

The upper frequency limit of 65536Hz was determined by the counter (8253) 16-bit register capacity. Programming techniques could have raised this upper frequency limit but, for this project, it was not considered necessary.

6. SOFTWARE DESIGN

The object of this project was to design a real-time data-acquisition and processing system. This implied that a large amount of calculation should be conducted within one sampling duration. Because assembly language was very close to machine code, it could execute at high speed and, also, could be loaded onto a target system with a small memory capacity. Therefore, assembly language was selected as the programming language.

Because of the shortage of programming experience for real time data processing, the following general guidelines were developed for program development:

1. The total data-processing program execution time should be no longer than 1 second.
2. Subject to satisfying prerequisite calculation accuracy, the program should be as short as possible.
3. For further time saving, look up table techniques should be adopted.
4. A modular structure was used, so that the program would be constructed from a number of relatively small and simple modules.
5. The real time data processing program would be debugged on an IBM-PC. Some important intermediate and final

results would need to be compared to those data calculated by a BASIC program which possessed the same functions.

6. When the program was loaded onto the target system, sets of sensor impact data should be loaded to test the program executing on the monitor hardware.
7. The real-time data-processing program execution time was to be measured on an IBM-PC in the debug environment.

6.1 Mathematical Method and Calculation Accuracy Analysis

As mentioned previously, Wang et al. (1984) measured point separation with piezoelectric grain sensors mounted underneath one rotor of a rotary combine with two parallel rotors. These authors reported separation of wheat to decay exponentially with axial distance from the rotor front end, but only if the center region of the concave grate arc was considered. The mathematical representation of grain separation was reported as:

$$Z = Z_0 e^{-Bl} \tag{6.1}$$

where:

Z = grain separation rate (impact counts),

Z_0 = analytical initial separation rate
(impact counts),

e = the base of natural logarithms,

B = attenuation coefficient (m^{-1}), and

l = axial distance from the front of the rotor (m).

As mentioned in 1.2.2.2, Bjork (1988) investigated separation around the grate of an axial-flow combine.

Equation 1.2, derived from Bjork (1988), could be written in the form of expression 6.2 to describe the separation distribution around the grate arc:

$$Z = A_j + B_j X + C_j X^2 \quad 6.2$$

where:

Z = point separation (impact counts),

A_j, B_j, C_j = coefficients determining shape of curves,

X = coordinate around concave arcs or grate arc (m),

j = the row number of sensor matrix.

The software design for real time data processing was based on the above equations (6.1 and 6.2) for grain separation distribution in the axial and lateral directions respectively.

6.1.1 Mathematical Models

In this project nine sensors (S1-S9) were located beneath the rotor grate in three rows with three sensors in each row (see Figure 6.1). Data from these sensors were used to obtain regression equations to the separation curves

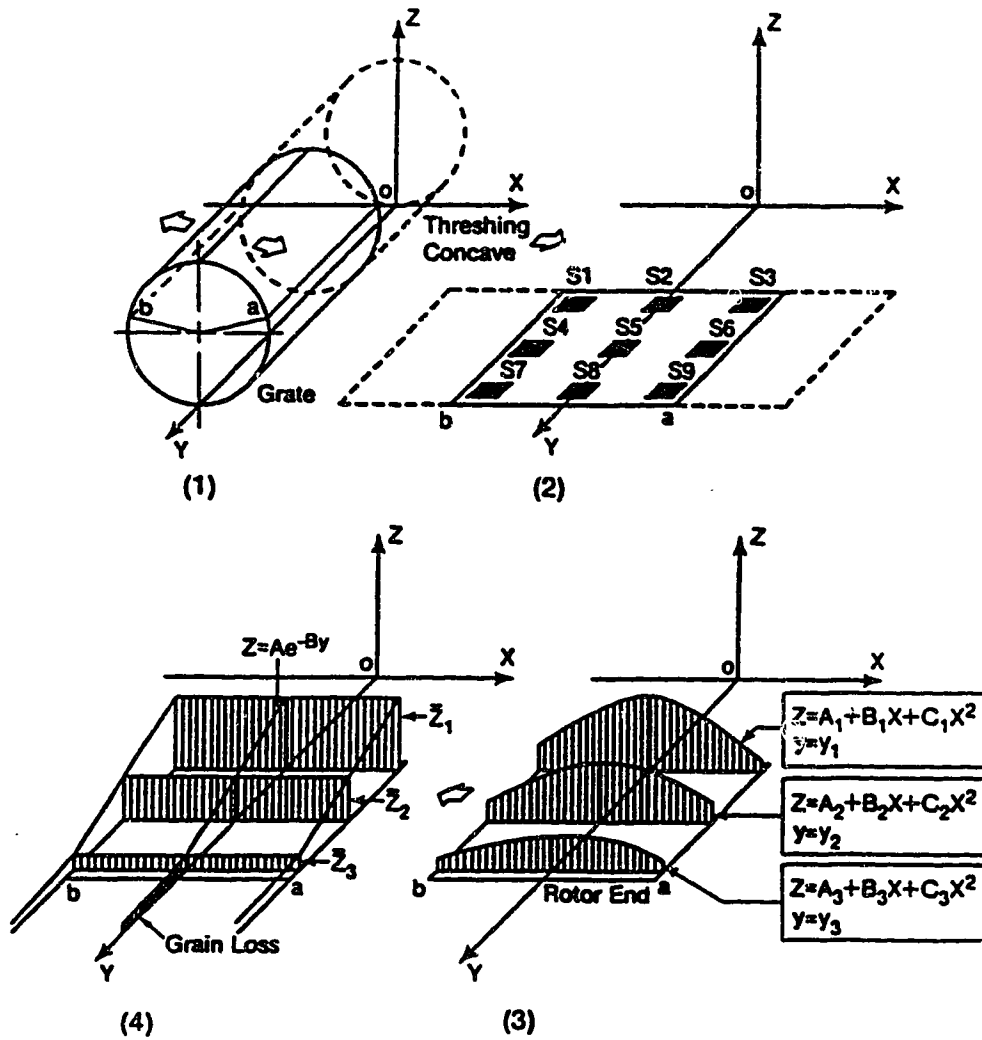


Figure 6.1 The Separation Distribution Underneath the Rotor Grate Section, Sensor Locations and the Mathematical Models.

along and around the grate. These equations were in the form of equations 6.1 and 6.2, respectively.

Mean separation values were determined at each axial distance and these were used to determine the longitudinal separation equation. The latter was integrated from the end of the rotor to infinity to determine the actual grain loss. This procedure is shown schematically in Figure 6.1.

An alternative to the integral mean of equation 6.2 is the arithmetic mean. Though this is simpler, it would not provide as good an estimate of the true mean as the integral mean because of the sensor locations. Therefore the integral mean was calculated for its closeness to reality.

By using the least squares method, equation 6.2 could be expressed as a matrix equation (6.8) to calculate the parameters A_j , B_j , and C_j ($j=1, 2, 3$ indicates the sensor row). For clarity, only A_1 , B_1 , and C_1 will be mentioned in the following explanation of the derivation of equation 6.8.

Equation 6.2 can be written as a second-order linear regression model (Draper and Smith, 1981):

$$Z_i = \beta_0 + \beta_1 x_i + \beta_2 x_i^2 + \epsilon_i \quad 6.3$$

where:

Z_i =the impact count on the i_{th} sensor at axial position 1 ($i=1, 2, 3$ indicates the sensor number),
 $\beta_0, \beta_1, \beta_2$ = parameters determining shape of the curve,
 X_i =location coordinate of the i_{th} sensor around the grate,
 ϵ_i =the curve deviation from the true value.

The sum of the squares of deviations from the curve was:

$$S = \sum_{i=1}^3 \epsilon_i^2 = \sum_{i=1}^3 (Z_i - \beta_0 - \beta_1 x_i - \beta_2 x_i^2)^2 \quad 6.4$$

The estimates A_1 , B_1 , and C_1 were chosen so that the values substituted for $\beta_0, \beta_1, \beta_2$ in equation 6.3 produced the least possible value of S . A_1 , B_1 , and C_1 could be determined by differentiating equation 6.4 with respect to $\beta_0, \beta_1, \beta_2$ and setting the results equal to zero.

$$\frac{\partial S}{\partial \beta_0} = -2 \sum_{i=1}^3 (Z_i - \beta_0 - \beta_1 x_i - \beta_2 x_i^2) = 0$$

$$\frac{\partial S}{\partial \beta_1} = -2 \sum_{i=1}^3 x_i (Z_i - \beta_0 - \beta_1 x_i - \beta_2 x_i^2) = 0 \quad 6.5$$

$$\frac{\partial S}{\partial \beta_2} = -2 \sum_{i=1}^3 x_i^2 (Z_i - \beta_0 - \beta_1 x_i - \beta_2 x_i^2) = 0$$

so that the estimates A_1 , B_1 , and C_1 were given by

$$\sum_{i=1}^3 (Z_i - A_1 - B_1 x_i - C_1 x_i^2) = 0$$

$$\sum_{i=1}^3 x_i (Z_i - A_1 - B_1 x_i - C_1 x_i^2) = 0 \quad 6.6$$

$$\sum_{i=1}^3 x_i^2 (Z_i - A_1 - B_1 x_i - C_1 x_i^2) = 0$$

Rearranging equation 6.6 leads to:

$$3A_1 + B_1 \sum_{i=1}^3 x_i + C_1 \sum_{i=1}^3 x_i^2 = \sum_{i=1}^3 Z_i$$

$$A_1 \sum_{i=1}^3 x_i + B_1 \sum_{i=1}^3 x_i^2 + C_1 \sum_{i=1}^3 x_i^3 = \sum_{i=1}^3 x_i Z_i \quad 6.7$$

$$A_1 \sum_{i=1}^3 x_i^2 + B_1 \sum_{i=1}^3 x_i^3 + C_1 \sum_{i=1}^3 x_i^4 = \sum_{i=1}^3 x_i^2 Z_i$$

which can be written in matrix form as equation 6.8.

$$\begin{pmatrix} 3 & \sum x_i & \sum x_i^2 \\ \sum x_i & \sum x_i^2 & \sum x_i^3 \\ \sum x_i^2 & \sum x_i^3 & \sum x_i^4 \end{pmatrix} \begin{pmatrix} A_1 \\ B_1 \\ C_1 \end{pmatrix} = \begin{pmatrix} \sum Z_i \\ \sum x_i Z_i \\ \sum x_i^2 Z_i \end{pmatrix} \quad 6.8$$

Equation 6.8 could be simplified as equation 6.9.

$$(X) \begin{pmatrix} A_1 \\ B_1 \\ C_1 \end{pmatrix} = \begin{pmatrix} \sum Z_i \\ \sum x_i Z_i \\ \sum x_i^2 Z_i \end{pmatrix} \quad 6.9$$

It could be proved that matrix (\mathbf{X}) was nonsingular ($|\mathbf{X}| \neq 0$), so that the Cramer's rule (Williams, 1978) could be used to determine the unique solution (A_1, B_1 and C_1). Since all the elements in matrix (\mathbf{X}) were constants (sensor fixed locations (or location squared, cubed) in a row) $|\mathbf{X}|$ could be calculated by hand as a constant. Equation 6.10 was used to determine parameter A_1 :

$$A_1 = \frac{1}{|\mathbf{X}|} \begin{vmatrix} \sum Z_i & \sum x_i & \sum x_i^2 \\ \sum x_i Z_i & \sum x_i^2 & \sum x_i^3 \\ \sum x_i^2 Z_i & \sum x_i^3 & \sum x_i^4 \end{vmatrix} \quad 6.10$$

Parameters B_1 and C_1 could be obtained in the same way.

The actual procedure followed by the assembly language program is summarized below.

1. Accumulate and store grain impact counts in memory over a set time interval (2s).
2. Read the data for the sensors S1, S2, and S3 from memory.
3. Conduct the best fit calculation using the least squares method by solving the matrix equation. This procedure provided the coefficients for the separation function

$$Z_1 = A_1 + B_1 x + C_1 x^2 \quad 6.11$$

at $y = y_1$

4. Calculate the mean value of Z_1 using:

$$\bar{Z}_1 = \frac{1}{a-b} \int_b^a (A_1 + B_1 x + C_1 x^2) dx \quad 6.12$$

where:

(a-b) = the length of apertured part of the grate
in the grate arc direction (m).

5. Repeat for the other axial locations $y=y_2$ and $y=y_3$.

The mean separation values (\bar{Z}_1, \bar{Z}_2 and \bar{Z}_3) then
could be used to obtain the longitudinal
equation:

$$\bar{Z} = Ae^{-By} \quad 6.13$$

where:

\bar{Z} = mean separation distribution in the
axial direction.

Equation 6.13 can be linearized in the form:

$$\ln \bar{Z} = \ln A - By \quad 6.14$$

6. A look up table procedure was used to obtain the
logarithms of \bar{Z}_1, \bar{Z}_2 and \bar{Z}_3 .
7. To calculate parameter B, the regression calculation
using least squares was carried out by solving the
equations:

$$-B = \frac{\sum_{i=1}^3 (y_i - \bar{y})(\text{Ln } \bar{Z}_i - \overline{\text{Ln } \bar{Z}})}{\sum_{i=1}^3 (y_i - \bar{y})^2} \quad 6.15$$

and

$$\text{Ln } A = \overline{\text{Ln } \bar{Z}} - B \bar{y} \quad 6.16$$

where:

$$\bar{y} = \frac{1}{3} \sum_{i=1}^3 y_i$$

$$\overline{\text{Ln } \bar{Z}} = \frac{1}{n} \sum_{i=1}^3 \text{Ln } \bar{Z}_i$$

and

Y_i = the location of the sensor rows.

8. The parameter A was calculated using the Taylor series expansion:

$$A = e^T \approx 1 + T + \frac{T^2}{2!} + \dots + \frac{T^8}{8!} \quad T = \text{Ln } A \quad 6.17$$

9. Having determined the coefficients A and B of equation 6.13, the predicted grain loss was determined using the Taylor series and multiplication:

$$GL = K \int_{y_0}^{\infty} A e^{-By} dy = \frac{KA}{B} e^{-By_0} \quad 6.18$$

$$K = K_1 K_2 C$$

where:

GL = grain loss (impacts),

y_0 = the coordinate of the rotor end (0.974m),

$K_1 = \frac{1}{0.07 \times 0.11 m^2} = 129.87 m^{-2}$, the reciprocal of the effective sampling area of each sensor,

K_2 = a calibration coefficient obtained in threshing calibration,

C = the length of the rotor apertures in the grate section arc direction (1.29m), and

$$e^{-By_0} \approx 1 - By_0 + \frac{(By_0)^2}{2!} - \frac{(By_0)^3}{3!} + \dots + \frac{(By_0)^8}{8!} \quad 6.19$$

The assembly language program for this real time data processing included more than three thousand instructions (Appendix IV).

6.1.2 Data Processing Precision Analysis

Assembly language programming was a time consuming and delicate job, but under the condition of real time data acquisition and processing, there were no higher level computer languages that could offer the same high execution speed and ability to access computer hardware directly. In order to reduce the execution time and improve calculation precision, some important techniques were introduced in the software design. These included the calculation of e^T and

$\ln A$.

Only eight terms in the e^T Taylor series were used. This reduced execution time, but the truncation error may increase. When $|T| > 1$, more terms were needed for truncation error reduction. To cope with the conflict of these two aspects, the exponential was divided into integer and decimal fraction parts,

$$e^T = e^a e^b \quad T = a + b \quad 6.20$$

The value

$$e^a \quad (|a| > 1)$$

was found in a look-up table stored in the system EPROM and

$$e^b \quad (|b| < 1)$$

was obtained by Taylor series. The two parts then were multiplied together. The truncation error is given by (Wang et al. 1984).

$$R_n(b) = \frac{b^{n+1}}{(n+1)!} e^{Qb} \quad 0 < Q < 1 \quad 6.21$$

Now, because

$$|b| < 1 \quad 0 < Q < 1$$

then

$$e^{Qb} < e < 3$$

and, because, $b^{n+1} < 1$, it follows that

$$|R_n(b)| < \frac{3}{(n+1)!} \quad 6.22$$

When $n = 8$, the truncation error

$$|R_n(b)| < \frac{3}{9!} \approx 8.27 \times 10^{-6} \quad 6.23$$

For the integer part (a) of the exponential calculation, a was sent to an index register and the first address of the look-up table was sent to the base register. The sum of the base and index registers (both were inside the CPU) provided the effective address where the result was located. The flow charts of look-up tables for both $\ln \bar{Z}$ and e^T are provided in Appendix III 4.

The next step was to call a multi-precision multiplication subroutine to obtain the result e^{a+b} .

The $\ln \bar{Z}$ Taylor series was more complicated than that of e^T . A permanent natural logarithm table was stored in the system EPROM. A look-up table procedure was written to provide the logarithm for an operator range from 1 to 99×10^4 . The integer number was changed into floating point representation following which the look-up table procedure was run followed by multiply and add procedures. For example:

$$\bar{Z} = 926 = 9.26 \times 10^2$$

$$\ln \bar{Z} = \ln 9.26 + 2 \ln 10$$

$\ln 9.26$ and $\ln 10$ could be found in the natural logarithm table, then, by calling multiplication and addition subroutines, $\ln \bar{Z}$ could be obtained. The calculation became easy and fast.

The data in the natural logarithm look up table had four significant digits. Usually the original data from the sensors and the integral mean values were no more than three digits. Thus, no additional error would be accumulated when the look-up table technique was used.

6.2 Software Structure

Almost all programs are structured according to a hierarchy, with the top of the hierarchy being a controlling program module, called the main program, that directs the execution of the modules that lie just below it in the hierarchy. In turn, these principal submodules control the use of their submodules and so on (Liu and Gibson, 1986).

The combine grain loss prediction and monitoring program included 75 modules and their execution was under the direction of two main programs. One was the main program (system initialization) and the other was the interrupt service program. The flowcharts of this two programs are shown in Appendix III. 1 and 2.

The Real Time Data Processing (RTDP) submodule was the biggest module in the hierarchy. It was called in the execution of the interrupt service program when the data from the sensors were ready to be processed. The RTDP submodule subsequently would call its three submodules: arc best fit for parameters A_j , B_j , C_j ; axial regression for parameters A and B; and actual grain loss (GL) prediction. In turn, these modules controlled the use of their submodules. The lowest modules were multi-precision arithmetic routines such as addition, subtraction, multiplication, division, and the submodules of look-up tables, data conversion and transmission etc. The hierarchical diagram for the RTDP submodule is shown in Appendix III 3.

The design sequence of the hierarchy structure was from the top to the bottom, but programming and debugging should be conducted from the bottom to the top. Thus, when programming at higher levels of the hierarchy, the programmer only concentrated on the current level because the lower levels had been well-debugged. This strategy made the programming easier and faster.

6.3 Real Time Data Processing Program Executing Time

The real time data acquisition and processing were conducted in parallel. The real time data processing for

one group of samples had to be finished before the next group of samples was ready to be processed. If the execution time was longer than the sampling duration, then this real time data processing program was useless. Determining the real time data processing program execution time before loading the program onto the target monitor system was, therefore, very important.

A real time clock was available in the IBM-PC and, also, the IBM-PC system ROM-BIOS (Read Only Memory Basic Input Output System) had an interrupt service routine (interrupt #26) to read the clock at any time. The system clock "ticks" by generating an interrupt #8 at specific intervals. On each clock tick, the ROM-BIOS interrupt #8 service routine increases the clock count by 1. The clock ticks at a rate that is almost exactly $1,193,180/64\text{KHz}$, or, roughly, 18.2 times a second. The count is kept as a 4-byte integer at low-memory location hex 46C (Norton, 1985).

A call-subroutine instruction was inserted at the beginning and the end of the RTDP submodule to read the real time clock built in the IBM-PC. By running the RTDP submodule, the current time (which was updated 18.2 times a second) would be read by the clock-read subroutine and then stored in RAM. The RTDP submodule executing time then could be obtained by subtracting two stored times.

The results showed that the clock only updated once or twice which meant that the RTDP execution time was between 54.9 ms and 110 ms. Thus, the CPU would spend more than 89% of its time waiting for the next group of samples to be ready while executing a series of loop instructions.

7. SENSOR LOCATIONS AND INSTALLATION

To obtain separation curves, the sensors were required to be mounted underneath the separation grate section of the rotor and located to measure the separation distribution and, consequently, predict the grain loss. The sensor location scheme was based on supplying sufficient data for the real time regression program to generate three separation distribution curves in the lateral direction and one curve in the axial direction. Figure 6.1 shows the sensor locations and representative separation distribution curves underneath the rotor grate section in both lateral and longitudinal directions.

In arriving at the arrangement shown in Figure 5.1, two aspects were considered. One was the number of sensors required and the other was the sensor locations.

7.1 Sensor Numbers

In this project nine sensors (S1-S9) were located beneath the rotor grate in three rows with three sensors in each row (see Figure 6.1).

For the curve regression, the more sensors used, the higher would be the precision achieved. However, for measurement system installation, maintenance and cost, the

fewer sensors used the better.

There were three parameters (A_j , B_j , C_j) in the second order polynomial model of separation distribution in the lateral direction (equation 6.2), and two parameters (A and B) in the exponential model of axial direction separation distribution (equation 6.13). It is always possible to exactly fit n data points with a polynomial of degree $n-1$ or less (Blank 1980). Thus, a minimum of three sensors were required in the lateral direction to solve the equations and to obtain the parameters A_j , B_j , and C_j . Three mean values, derived from each lateral row of sensors, were used to obtain the exponentially decaying curve in the axial direction (i.e., obtain parameters A and B). The use of three values would result in better curve fits than the use of the minimum two mean values to solve the regression model with two parameters. In turn, this would lead to higher accuracy in the prediction of actual grain loss by the integration of the separation distribution curve from the rotor end to infinity.

7.2 Sensor Locations

Sensor distribution along the full length of the rotor concave and grate sections could supply more information for percentage loss prediction and yield map drawing (Bjork,

1988). However, problems such as high cost, low reliability and difficulty of maintenance might be encountered. The peak separation rate under the threshing concave could lead to impacts at a high enough frequency to saturate sensors and reduce measurement accuracy. Since the distribution underneath the rotor grate segment in the axial direction was expected to be an exponentially-decaying curve, only the grate section of the rotor was considered in the sensor installation.

Figure 7.1 shows a cross section of the rotor grate segment of the International Harvester 1460. The top part of the rotor shell (104° to 256°) was closed while the bottom part had apertures.

Both Wang (1984) and Bjork (1988) observed a peak separation rate near the center of the grate. Wang (1984) believed that the reason for this peak was that the summation of the forces acting on the grain, straw and chaff perpendicular to the concave surface would change as the material moved in a lateral direction. At the central part of the grate the summation of forces was greater than at any other point. Following this reasoning, one sensor was installed at the central point in the lateral direction to detect the peak separation rate.

Although separation processing could not occur along

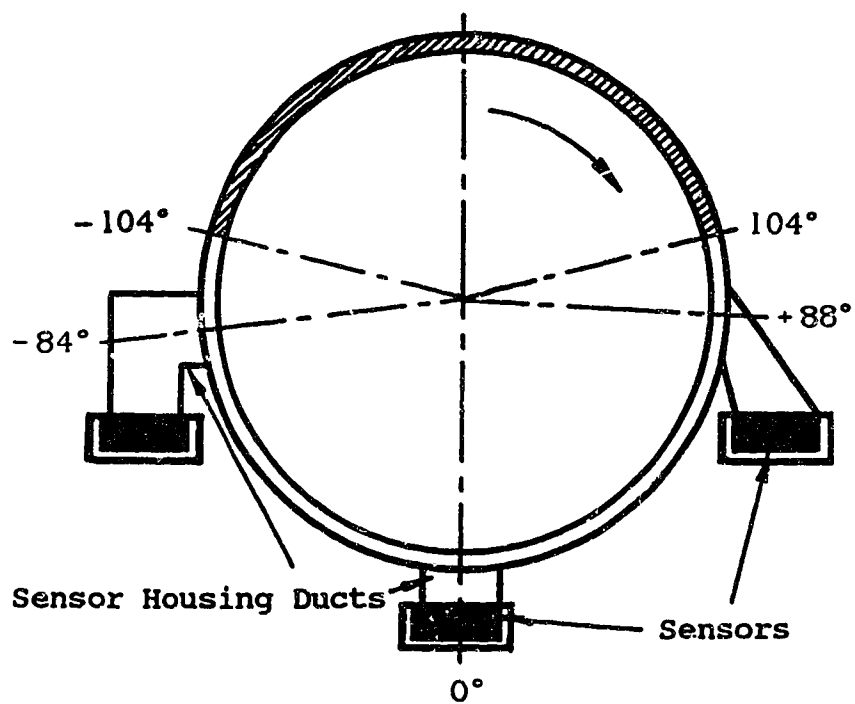


Figure 7.1 Cross Section of the Rotor Grate Segment.

the top of the rotor, the grain could be separated from the straw and chaff mat and gather near the top inside surface of the rotor. This phenomenon would cause the separation value to be non-zero at the border between the closed and apertured parts (Bjork, 1988). Thus, two locations ($+88^\circ$ and -84°), which were close to the border of the closed and apertured regions were selected for sensor installation to measure the separation rate near the border area.

7.3 Sensor Installation

All nine sensors were housed in sheet metal ducts which were attached with screws to the rotor grate at the predetermined positions shown in Figure 7.1 and Figure 7.2. The duct row locations were 0.227, 0.461 and 0.827m from the front end of rotary grate segment. The ducts were based on those used by Bjork (1988) for his rotary combine threshing characteristics study.

Minor modification was needed to add a part at the bottom of every duct to install each sensor and its signal conditioner. Wang (1984) and Larson (1987) studied the optimum orientation of the sensor sounding boards to grain flow. Both authors determined that the sensor orientation affected its sensitivity and accuracy. The best angle between the sounding board and grain flow was determined to

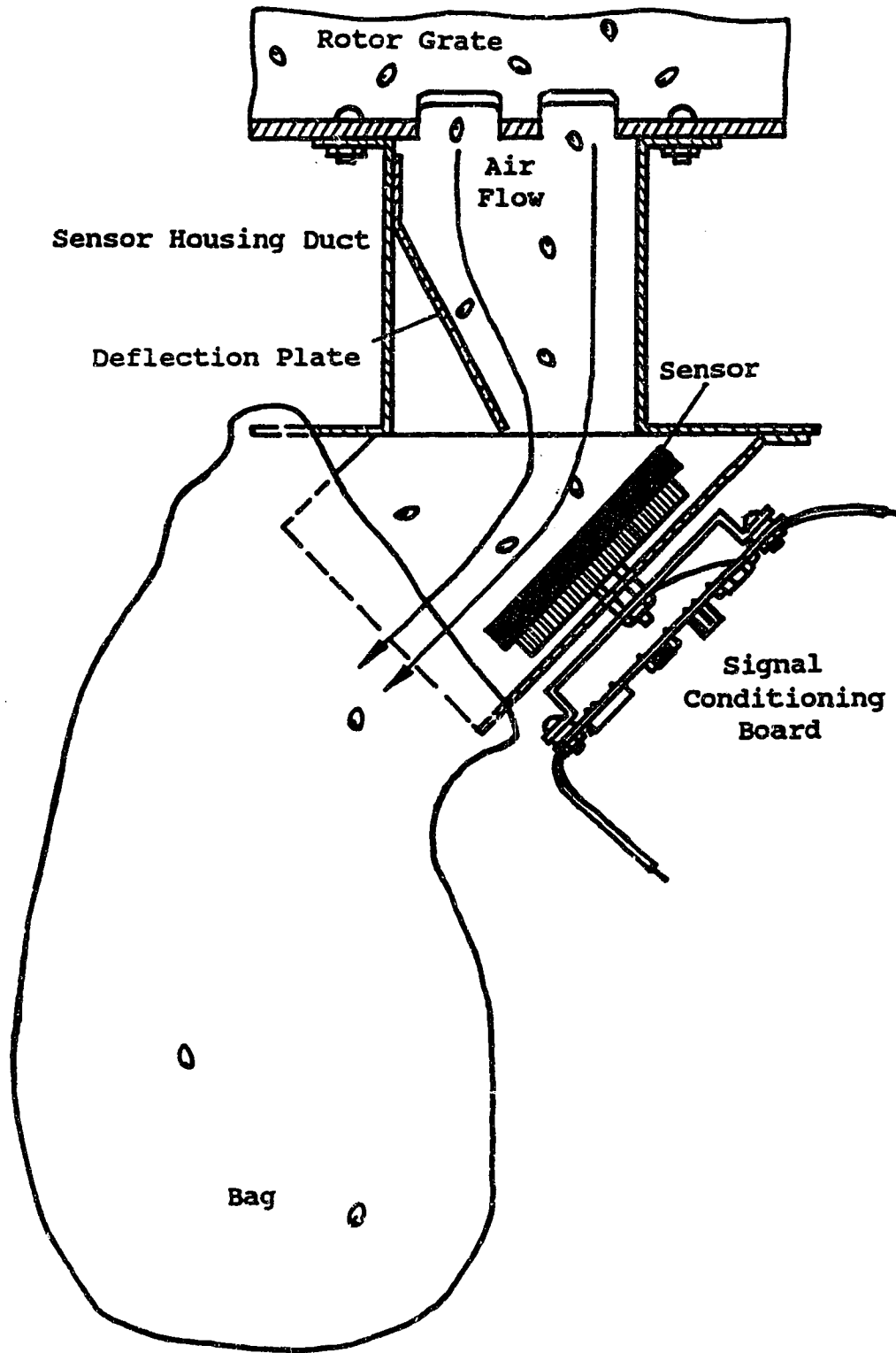


Figure 7.2 Sensor Housing Schematic Layout.

be 40° to 45°. Figure 7.2 shows a schematic layout of the duct, sensor and signal conditioner installation.

The rotor, which was turning at 800 or 1000 rpm for the experimental tests, caused the crop materials between the rotor and the grate to move in nearly spiral path. Ideally, the kernels would leave the rotor in planes perpendicular to the rotor axis. Therefore, the sensor surfaces should make an angle of 45° with these planes. The sensor orientation and row location is shown in Plate 7.1.

In order to obtain the same sampling area, the inlet area of the ducts should be identical. Thus, every inlet covered four grate holes (see Figure 7.3). Calculation of the equivalent area of the inlet was based on the assumption that the measured separation rate was the mean value of all points of the sampling area (see Figure 7.4).

The measured separation rate was the total kernels collected in 70x110mm² sampling area within one sampling period (see equation 7.1). This mean separation rate was taken to represent the central point of sampling area which was also the sensor location.

$$S_p = \frac{N}{0.07 \times 0.11 \times 2 m^2 s} = K_1 N \quad 7.1$$

where:

$$S_p = \text{Separation rate } N/m^2 s,$$



Plate 7.1 Sensor Orientation and Row Location.

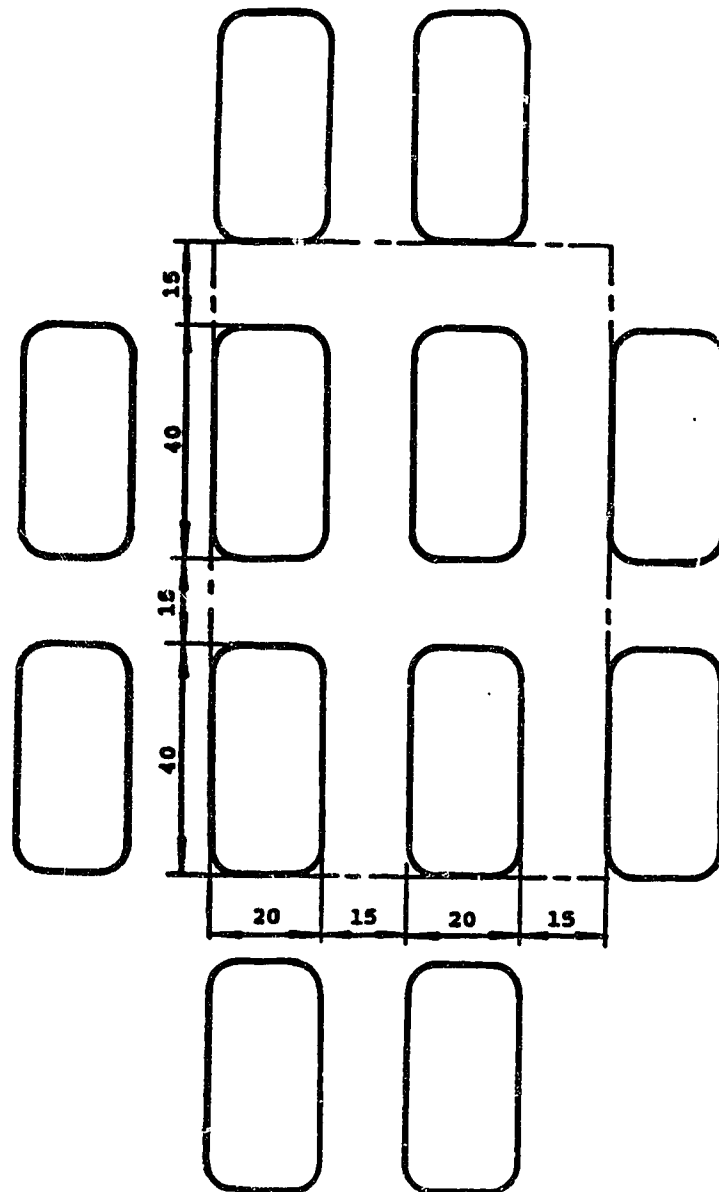


Figure 7.3 The Sampling Area at the Grate Section
(dimensions in mm).

Z =grain separation rate (kernels/m²)

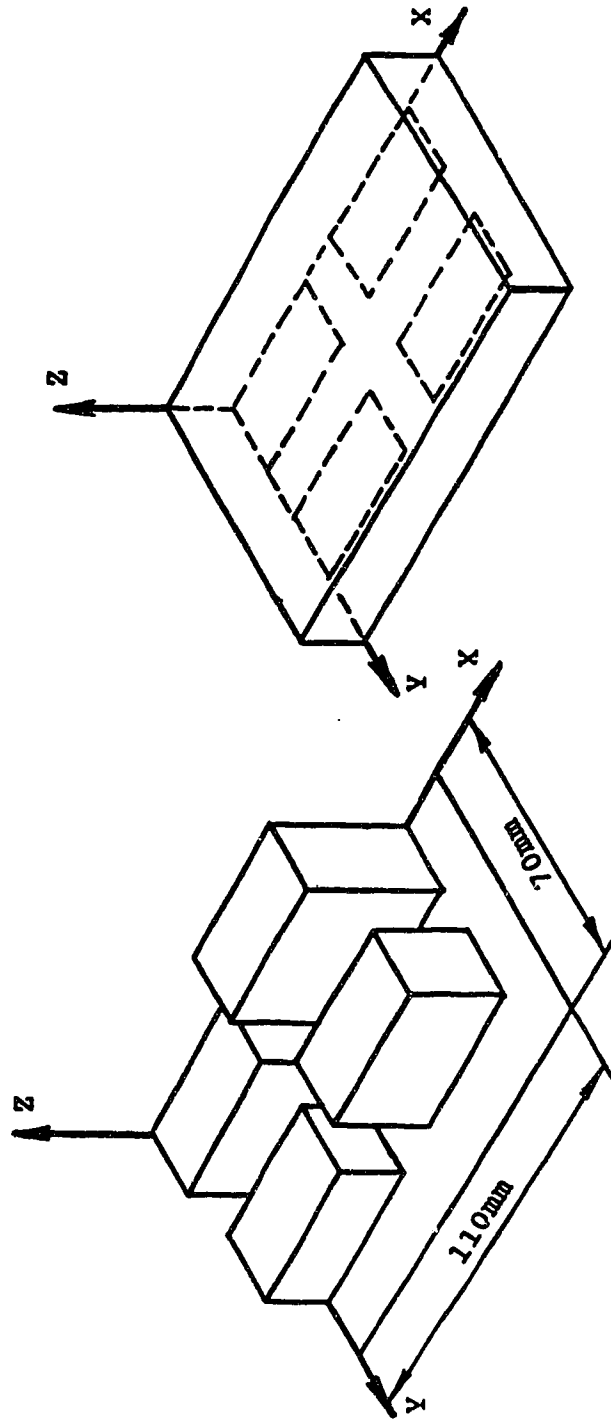


Figure 7.4 Sampling Area Separation Distribution and Assumed Mean Separation Value.

N = the number of kernels.

In each case the inlet area was $70 \times 110 \text{mm}^2$ and the outlet area was $100 \times 40 \text{mm}^2$. The effective sounding board sensing surface was the projected area of duct outlet on the sounding board surface i.e.

$$\frac{100 \times 40}{\cos 45^\circ} = 5657 \text{mm}^2 \quad 7.2$$

This meant that 58.9% of the sounding board surface area ($160 \times 60 \text{mm}^2$) was exposed to the discharged Grain and MOG flow. However, because the length of the sensor surface (160mm) was longer than the length of the duct outlet and, since it was very important that all the seeds coming through the inlet of the duct be detected by the sensor surface, a deflection plate was located inside the duct to control kernel direction (see Figure 7.2).

Using sheet metal ducts to sample separation and to provide sensor housings not only directed the seed flow toward the sounding board but, also, allowed determination of the exact sensor locations and sampling areas.

In addition, other advantages of this system included:

1. Kernels were leaving the rotor and going into the ducts at different speeds and directions. Restrained by the duct walls and the deflection plate, high speed kernels would lose some energy and kernel speeds would tend to be

Uniform impacts would provide uniform signals and enhance signal conditioning.

2. The air flow blowing through the duct would change its direction near the sounding board (see Figure 7.2). Relatively light materials, especially chaff, would be separated from the Grain and MOG mixture mat. Some chaff might no longer contact the sounding board surface and this would improve the sensitivity of the sensor.

No experiments were carried out to verify the above theories, but the results of the threshing experiments confirmed them in a subjective way.

To keep the air and the material flowing smoothly (see Figure 7.2), the outlet of the ducts should not be smaller than the actual apertured area of the grate sampled. In this design, the outlet area of the ducts was 4000mm^2 , and the sampled apertured area was 3200mm^2 .

The Grain and MOG mixture going through the outlet with the equivalent area would do so more easily than going through four small holes on the rotor grate segment. No unexpected choking or blocking of materials happened inside the ducts during a total of 76 threshing runs. The interference of the duct-sensor installation to the threshing performance, therefore, could be ignored.

8. SIMULATION AND THRESHING EXPERIMENT

Equipment for transportation, feeding, threshing, cleaning and weighing was needed for crop threshing experiments. Three to four people also were needed to operate the equipment. Also, the effects of the harsh environmental conditions on the electronic test system had to be considered. Therefore, the experiments were divided into two main parts: simulation experiments and threshing experiments. Thus, unexpected failures and unnecessary labour and time wastage could be avoided.

Simulation Experiment

The hardware and software design of the test system had to be tested before actual threshing experiments in order to confirm the feasibility of the test method and reliability of the system. A threshing simulation experiment was carried out by using a modified grain kernel delivery system, to deliver controlled grain flows to the sensor matrix. The grain flows simulated grain separation distribution underneath the rotor grate section of a combine. This laboratory simulation also allowed the sensors to be calibrated.

8.1.1 Magnetic Feeder Modification

A magnetic vibratory feeder (Syntron BF2A) was utilized to deliver the grain kernels.

Because the grain loss monitor was a multi-sensor measurement system. The single outlet magnetic feeder was not suitable for delivering grain kernels for simultaneous calibration of nine sensors. Furthermore, the reliability of the grain loss monitor system needed to be confirmed using all sensors before actual threshing tests were carried out. A grain delivery system was built (see Plate 8.1) for grain distribution simulation and sensor calibration.

This system could be used to:

1. Preset the grain feed rates to nine sensors,
2. Simulate the separation distribution underneath the rotor at nine specific points where the sensors would be located,
3. Collect the grain which hit individual sensors for calibration, and
4. Allow the sensitivity of different points of any sensor to be measured easily.

A piece of 15mm acrylic sheet with 9 holes ($d=18\text{mm}$) was attached to the outlet of the magnetic vibratory feeder. Nine adjustable slide gates were made which could be used to control the grain delivery rate through each hole. Grain



Plate 8.1 Magnetic Feeder Assembly for Grain
Distribution Simulation and Sensor
calibration.

would drop into nine small hoppers which were located beneath the feeder outlets. Kernels would subsequently be delivered to the nine sensors via nine, semitransparent, soft plastic tubes.

Making an angle of 45° to the horizontal, all the nine sensors, along with their signal conditioners, were set in plastic boxes. After hitting the sounding boards, kernels would fall into the plastic boxes and could be collected for counting.

An acrylic frame with 27 holes was located above the sensors and grain collection boxes to hold kernel delivery tubes. The outlets of kernel delivery tubes were approximately perpendicular to the ground and the kernel stream was kept at 45° to the sounding board surface. On the frame, there were three holes above each sensor so that the kernel delivery tubes could be located to evaluate the sensitivity at the right, the central and the left parts of the sensor surfaces.

The kernel collection boxes were set on a wheeled table so that the upper or lower sides of the sounding boards could also be tested if the table was shifted in the appropriate direction.

8.1.2 Sensor Calibration Using Simulation Equipment

The accuracy of the predicted value of grain loss depends on the accuracy of the sensors. The sensors could be calibrated using three potentiometers (R5, R9 and R12) on each signal conditioner (see Figure 3.3). Proper adjustment of these potentiometers could improve the sensitivity and selectivity of the sensors. However, if all the potentiometers were adjusted at the same time, it would be very difficult to select the point at which the sensor signals were conditioned optimally.

As mentioned in section 3.1, the impact signal frequency was within a narrow band and the time for the signal amplitude to decay to a certain value was independent of the height from which the kernels were dropped. Therefore, two potentiometers were preset. One (R5) was for adjustment of bandpass filter central frequency and the other (R12) was for adjustment of the monostable multivibrator high level output duration. For barley, preset adjustment provided the same central frequency (5000Hz) and the same monostable status duration (3ms) for all the 9 sensor signal conditioners.

Only one potentiometer (R9) needed to be adjusted for the comparator reference voltage during calibration. This made the calibration procedure much easier than adjusting all the potentiometers.

The sensor calibration sequence was as follows:

1. Program an EPROM. The function of this program was to open all nine counter's gates for 10 seconds and count the grain impact pulses. The results were printed out.
2. Barley kernels were put in the hopper of the magnetic feeder and the slide gates were set at the appropriate positions.
3. All the sensors were placed in their grain collection boxes and the grain delivery tube outlet positions were verified to be above the appropriate points of the sounding boards to be tested.
4. The signal conditioner and the SBC were powered and the sounding boards were tapped manually and the signals from conditioners were examined on an oscilloscope (this step was needed only at the beginning of the test to check correct function of the circuitry).
5. When "PRESS F2 TO TEST" was displayed on the SBC's LCD, function key F2 was pressed and, at the same time, a stop watch was started and the magnetic feeder was turned on.
6. At 8-9 seconds from the start time, the magnetic feeder was stopped and all the kernels in the grain delivery tubes would descend on the sensor sounding boards before the time limit (10s).

7. The kernels in the collection boxes were weighed. The numbers of kernels were calculated using the following formula and compared with the numbers in the printed file.

$$N = \frac{W}{W_{tk}} \quad 8.1$$

where:

N =the number of kernels,

W =the weight of kernels (g) in each collection box, and

W_{tk} =the weight (g) of one thousand kernels of grain used.

8. The reference voltages of the signal conditioners were adjusted by means of the potentiometers (R9) to decrease the count errors.
9. The above steps were repeated and the count errors were calculated. By using Students' 't' test (Steele and Torrie, 1980) the errors based on 95% confidence interval could be within $\pm 10\%$.

The count error was defined by:

$$error = \frac{N_a - N_m}{N_a} \times 100\% \quad 8.2$$

where:

N_a = number of kernels (actual),

N_t = number of kernels (tested).

The null and alternative hypothesis for this calibration were:

$$H_0: \bar{E} = 0$$

$$H_1: \bar{E} \neq 0$$

where:

\bar{E} = the mean of the errors (%).

The statistic of the test is

$$t = \frac{\bar{E} - 0}{s/\sqrt{n}} \quad 8.3$$

where:

$n=44$ sample size,

$\bar{E} = -4.486$ sample mean,

$s=19.77$ standard deviation.

The 't' statistic described by equation 8.3 was calculated to be -1.505 with 43 degrees of freedom. The null hypothesis was accepted at the level of $\alpha=0.05$. The 95% confidence interval places the mean of the population (calibration error) between -6.023% and +6.023%.

Calibration results (Appendix I Table 3.1) show that adjusting the reference voltage could change the sensitivities of the sensors. The test error sign could be changed from negative to positive (or vice versa) when the reference voltage of the comparators were increased or decreased (see Appendix I Table 3.1.1 Sensor 2).

8.1.3 Separation Distribution Simulation

Grain separation distribution curves underneath the rotor grate section could be represented by second order polynomials in the arc directions and decaying exponential in the axial direction. By using a modified grain delivery system, simulation tests were carried out to create sensor counts which were close to previously measured separation rates at the proposed sensor locations (Bjork, 1988). To do this, the slide gates of the magnetic feeder were adjusted so that the middle sensors of each row were hit by higher grain flows than the other two sensors in the same row. Similarly, the mean delivery rates in each row were adjusted to simulate the decaying separation distribution in the axial direction.

The grain delivery system was started and the data acquisition system was run for ten seconds. The sensor impact counts and calculated "grain loss" results then were printed out. The symbols of the regression parameters A_j, B_j, C_j and A, B should satisfy the distribution functions as mentioned above.

One sample result from such a run is shown below:

SAMPLE ----- 04

S1 = 0285 S2 = 0495
 S3 = 0204 S4 = 0090
 S5 = 0195 S6 = 0072
 S7 = 0031 S8 = 0079
 S9 = 0060

A1 = +0495.0768 B1 = -0033.5769
 C1 = -0337.5228 $\bar{Z}_1 = 0356.0000$

A2 = +0195.0257 B2 = -0004.3028
 C2 = -0153.9039 $\bar{Z}_2 = 0132.0000$

A3 = +0079.0155 B3 = +001.1118
 C3 = -0034.7235 $\bar{Z}_3 = 0053.0000$

Ln $\bar{Z}_1 = 0005.8721$ Ln $\bar{Z}_2 = 0004.4427$
 Ln $\bar{Z}_3 = 0003.9703$

A= +0533.1630 B= +0003.0043
 GL= K*0010.3149

The above simulation test example shows the collection of sensor counts (S1 to S9) and the results of the regression calculations. The sign of parameter C, determined the

shapes of the distribution curves in the arc direction. Thus, if $C_i > 0$, the shape would be concave and if $C_i < 0$, the shape would be convex. In this sample all the signs of C_i were negative, so that these three curves were convex in shape.

The RTDP program took three mean values \bar{Z}_1 , \bar{Z}_2 and \bar{Z}_3 , which decayed in the axial direction, and found their logarithms in a look-up table. A least-square regression was conducted in the axial direction to calculate the parameters A and B. The sign of parameter B determined the shape of the exponential curve. If parameter $B > 0$, e^{-By} would be a decaying curve in the axial (Y) direction and this was confirmed in all the simulation test results.

In this example the predicted actual grain loss was 1,728. That is 1,728 kernels were "lost" with straw within a 2-second sampling duration.

8.2 Threshing Experiment

The purpose of threshing tests was to confirm feasibility and reliability of the hardware and software design in an actual combine environment. In addition to verifying the stability of the system in a harsh threshing environment, the tests were carried out to calibrate the sensors and to analyze the accuracy of the predicted actual grain loss val-

ues.

8.2.1 Threshing Test Apparatus

The threshing tests were conducted in the Harvesting Laboratory at the University of Alberta's Ellerslie Research Station during the late winter and early spring of 1989. A schematic diagram of the test apparatus is shown in Figure 8.1.

The International 1460 Harvester rotor assembly was used for the threshing tests. The rotor assembly was housed in a plywood box to contain threshed materials and dust. Two removeable walls on each side of the housing box provided access to the rotor assembly for maintenance and sensor calibration. Sensor housing ducts, with the sensors and signal conditioner circuit boards attached, were installed on the rotor grate section as shown in Figures 7.1, 7.2 and Plate 7.1.

A pair of 15.2m crop conveyers was set in front of the rotor to deliver the crop to the feed auger of the combine. The feed speed of the conveyer was controlled by a gear box and the crop feed rate could be controlled further by the amount of crop loaded on the conveyers. The conveyers were driven by an electric motor.

A CASE-International 7130 128KW tractor was located

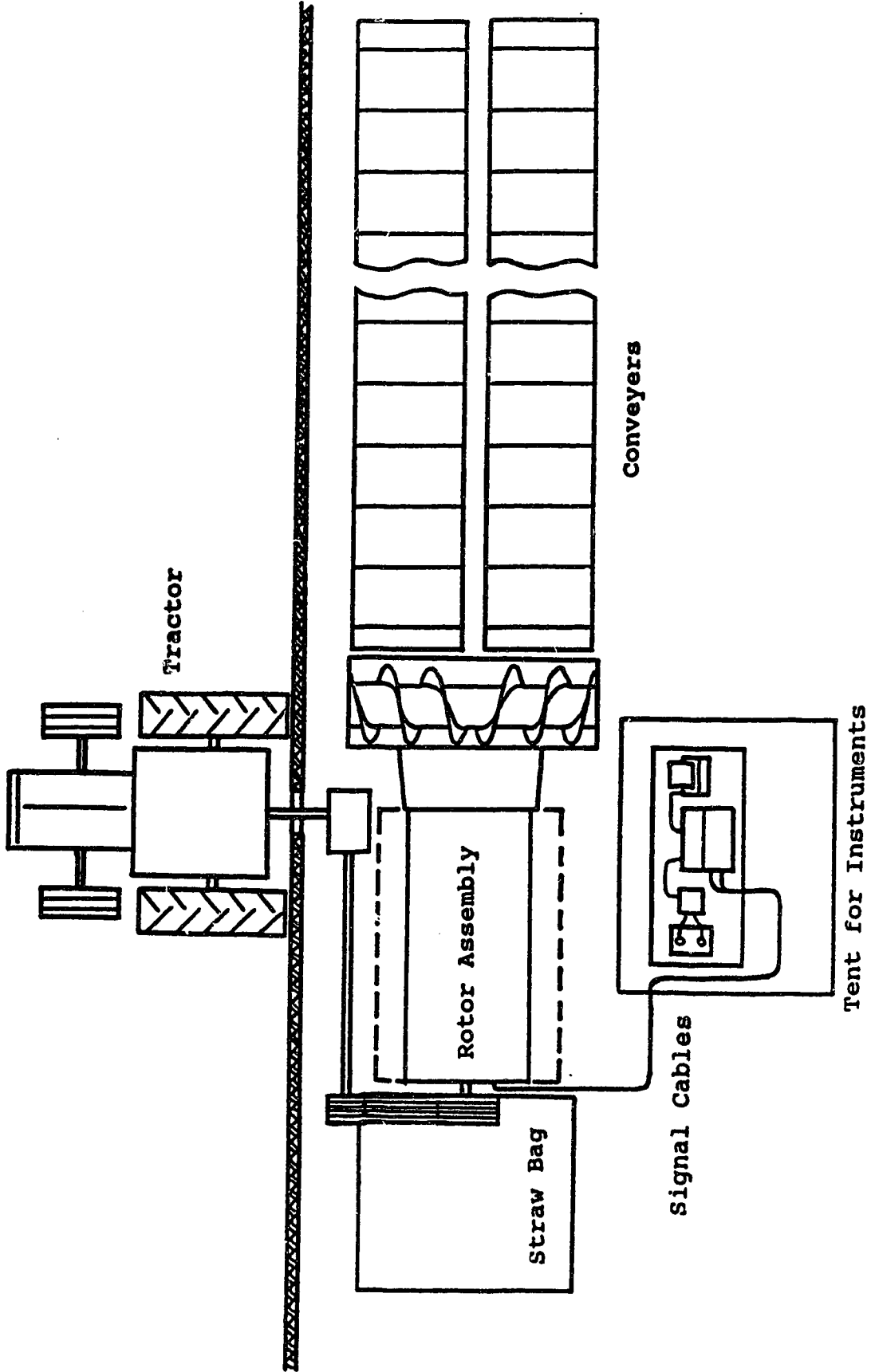


Figure 8.1 Threshing Test Equipment

outside the building with its power takeoff shaft going through a hole in the wall of the building to the rotor assembly transmission system to supply threshing power.

A control panel was mounted on the right side of the rotor assembly near the auger. This panel could control three electrical motors. One DC motor was used to change the rotor transmission ratio (rotor speed) and the other two AC motors were used to drive the conveyers and the elevator which lifted the crop from the auger table and fed it into the rotor.

The test equipment, which consisted of a single board computer, portable printer, 12V battery and power supply regulator, was set in a 2×2.5×2 m plastic tent to protect the equipment from dust. To cope with interference from static electricity, as mentioned in section 4.2, a piece of antistatic sheet, which was well grounded, was laid underneath the SBC on a table. A piece of steel (10×4×3cm) with a piece of wire connected to the metal case of the SBC was also set on the sheet to discharge any possible static on the SBC.

A 1.5×1.5×1.5m cloth bag was hung on a metal frame at the straw discharge outlet of the rotor to collect threshed straw, chaff and lost grain. A straw cleaning machine, designed and built by the Prairie Agricultural Machinery

Institute (PAMI), was used to clean the straw and collect the lost kernels.

Threshed grain, chaff and a small amount of straw were collected by 18 pails located underneath the rotor. This material was cleaned and used to determine G/MOG ratios (see Appendix I Table 7).

A small set of aspirated sieves (SEEDBURO 618W) was used to clean samples of separated material for sensor calibration.

Mechanical scales were used to weigh the crop material on to the conveyers and the straw, chaff and grains that were collected during threshing.

8.2.2 Description of the Material for Threshing

Preharvested whole crop (barley), which was piled outside the laboratory building, was the threshing test material. The selection was based on the availability of this crop from other experiments. However, significant loss rates had been observed in barley with a similar rotary combine (section 1.2.2.3) and barley was considered more difficult to detect with impact sensors than, say, wheat. It was, therefore, a good test crop.

The crop bundles were moved into the building and set with the heads upright a couple of weeks before the thresh-

ing tests started, thus the moisture content tended to be uniform. Later, the straw samples were weighed before and after drying in a microwave oven to measure the moisture contents. The results (see Appendix I. Table 4.) showed that highest and lowest straw moisture contents were 9.7% and 16.8% with a mean value of 14.2% w.b. Grain samples also were tested by using a CENCO Moisture Balance (Appendix I Table 5) and their moisture contents were between 11.0% and 13.0% with a mean value of 11.9%w.b. Since the heads of the crop were exposed to warm dry air inside the building for two weeks, grain moisture contents were lower and more uniform than that of the straw.

The mass of one thousand grain kernels was obtained from four samples and the mean was 36g (see Appendix I Table 6).

8.2.3 System Noise Immunity Test and Sensor Calibration

Mechanical vibration, audio-frequency noise and electromagnetic noise would be generated when the rotor and elevator were operating. These could influence system operation and sensor sensitivity, and the influence of the above factors needed to be established before conducting the final threshing tests.

8.2.3.1 System Noise Immunity Test

The function of an acoustic sensor, which is very sensitive to vibration and audio-frequency noise, is similar to the function of a microphone. Although the central frequency of the band pass filters in signal conditioners was several times higher than rotor fundamental frequency, harmonic frequencies of the vibration and noise possibly could still be selected by the signal conditioners and eventually form false pulses. The nine eight-meter-long signal feed wires and one common signal ground wire were insulated with plastic without shielding. Therefore, electrical noise generated by equipment in the building was easily picked up by these wires. A noise signal (50mv p-p) was detected near the SBC interface due to the long signal feed wires (see Plate 8.2). Although the opto-electric isolators and Schmitt-triggers at the interface of the SBC had high noise immunity, this still needed to be tested in the harsh threshing environment.

The system immunity test was important and simple to conduct:

The rotor was run at the speeds which would be used in threshing tests. No crops were fed into the rotor (empty run). Data acquisition equipment was started and the elevator and conveyer switches were turned on and off continuously. After data acquisition stopped, the sensor data

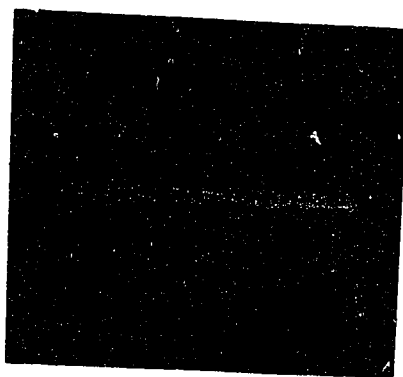


Plate 8.2 Noise at the Long Signal Feed Wires

in the printed file were checked. If the system performed with high noise immunity, all the sensor data would be zero.

After the first test run, only one non-zero count was found. The reason was that one sensor housing mounting screw was too long and its end was just touching the sounding board surface. When this screw was replaced by a short one, no false data were found in subsequent noise immunity tests.

8.2.3.2 Sensor Calibration Using Threshing Equipment

As stated in section 8.1.2, the material used for sensor calibration with the modified grain delivery feeder, was barley seeds. Calibration accuracy was $\pm 10\%$ for a 95% confidence interval. However, in actual threshing conditions, a grain, chaff and straw mixture would contact the sounding boards and the sensitivity of the sensors could be reduced. Lower reference voltages would, therefore, need to be selected to maintain reasonable sensitivity. Thus, further calibration of the sensors was carried out after installation on the combine rotor.

Calibration was carried out using grain-collection bags hung on the outlet of the sensor housing ducts. Two triangular holes were left in both sides of the outlet (see Figure 6.2) to provide a passage for air flow and to minimize the

bag interference.

The crop feed rate was 7.2T/h and rotor speeds were 1000 and 800 rpm for sensor calibration. After threshing, material in the bags was cleaned and the samples were counted by hand.

The calibration results are shown in Appendix I Table 3.2.1 to Table 3.2.3.

Threshing tests for sensor calibration were repeated six times. The counted numbers of kernels were compared with the predicted numbers and sensitivity was adjusted by changing the reference voltages accordingly. The best reference voltage, which is printed in bold letters, was selected for the formal threshing tests.

A straight line (tested impact counts vs actual impact counts) was fitted and the slope of this straight line was obtained. Ideally, this slope should always be equal to one, but in real situation it only could be statistically close to one. Steeper slopes meant that sensors were too sensitive or vice versa.

A calibration coefficient (K_2 in equation 6.18) was then derived from this slope (reciprocal). It could be verified that this calibration coefficient could improve the grain loss prediction accuracy and reduce the error due to imperfect sensor calibration. If all the sensor counts were

multiplied by this coefficient (K_2), the predicted grain losses would be affected as if the coefficient (K_2) was in equation 6.18. The reason was that the sensitivity of sensors could only affect the axial regression model parameter A (equation 6.16) but not parameter B (equation 6.14), so that the sensor sensitivity error could be adjusted linearly.

This calibration coefficient could be entered into the test system before the threshing test and the results showed that this coefficient was very important to improve the accuracy of the predicted grain losses.

8.2.4 Experimental Design and Threshing Test

The threshing time could be divided into three stages: rotor filling time (about 1-2s), stable time (depended on the crop feed time) and rotor emptying time (2-4s). To raise the test accuracy and reduce the influence of the transient stages (1 and 3), the length of the stable stage was required to be much longer than that of the transient stages.

Initial threshing tests (Liu and Leonard, 1989) using a short crop feeding time of 6s gave a low regression correlation between predicted and actual losses (0.67). This was due to the limited threshing duration which, in turn,

depended on the length of the crop conveyers and the crop feed time. A longer threshing duration was needed to eliminate interference of the transient stage and to improve the accuracy of predicted losses.

A long crop feed time (12s) was adopted for the final threshing tests. The total data acquisition time for each run was 20s, which was 8s longer than the crop feed time. Therefore, no unexpected grain impact signals would be lost due to the transient time of stages 1 and 3.

Two rotor speeds (800 and 1000rpm) and two feed rates (6T/h and 12T/h) were selected. There were four combinations (12T/h-800rpm, 12T/h-1000rpm, 6T/h-800rpm and 6T/h-1000rpm). Each combination included three replicates giving a number of total threshing tests of twelve. The sequence of these 12 runs (shown in Table 8.1) was random.

Weighed crop material was evenly distributed on both conveyers with the heads toward the combine auger. This crop orientation and distribution was close to real situations when a combine is harvesting in the field.

When all the preparations were complete, the elevator and the conveyers were started and the crops were fed into the rotor. Function key F2 on the keyboard of the SBC was pressed to start the real time data acquisition and processing when the crop reached the auger.

Straw and lost grain were collected by straw bag (section 8.2.1) for determination of actual lost grain. The crop feed time was recorded by a stop watch. The regression parameters and predicted losses were printed out on the portable printer after each test run.

To evaluate the test system, a meaningful hypothesis was formulated. The null hypothesis of the 't' test for this experiment was that the mean of the ratio of actual and predicted grain losses which were obtained in all test runs was equal to one. An alternative hypothesis would be that the mean of above ratio was not equal to one.

The null and the alternative hypothesis were:

$$H_0: \quad \mu = 1$$

$$H_1: \quad \mu \neq 1$$

To test the null hypothesis $H_0: \mu = 1$, assuming that the population was normally distributed and, the test criterion is given by equation 8.3 (Steele and Torrie, 1980)

$$t = \frac{M - \mu_0}{s / \sqrt{n}} \quad 8.3$$

where:

M = mean of ratios sampled from the population,

$\mu_0 = 1$, specified population mean,

s = standard deviation of sample, and

n = sample size.

The best fit curves in the arc direction and the regression curves in axial direction and their corresponding scattered data were plotted to evaluate the curve fitting calculations. The best fit straight line also was plotted to correlate the predicted and the actual grain losses.

9. RESULTS AND DISCUSSION

Because of the non-homogeneous physical characteristics of the crop material and complicated movement of grain and MOG in the rotor, crop threshing and grain separating were random processes. Therefore, data acquisition, real time data processing and the analysis of test results were based on statistical theory.

9.1 Sensor Calibration Analysis

Data are printed in normal and bold letters (in Appendix I Table 3.1.1 to Table 3.2.3 (six Tables in total)). The bold data are the data collected under the condition of final signal conditioner reference voltages.

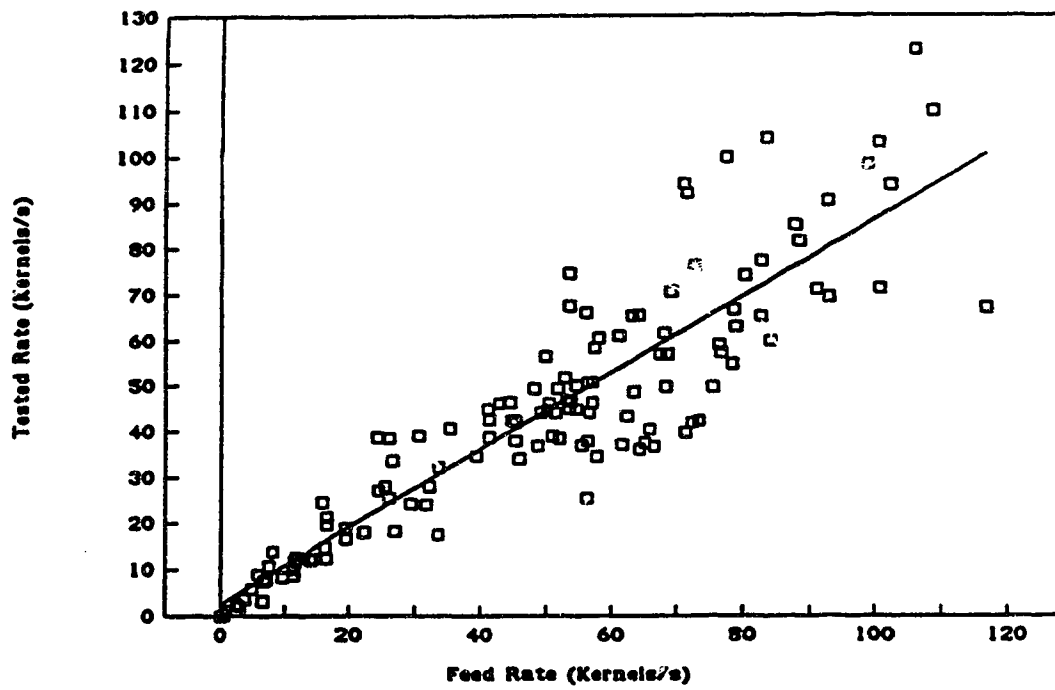
To test the effect of calibration, sensed grain counts were regressed against actual counts using straight-line, least squares regression. Overall and selected data were used to conduct the straight-line regressions and the statistics are shown in Appendix I Tables 3.4.

Straight lines were fitted to the simulation calibration result (test vs actual). The overall data (Table 3.1.1 to 3.1.3) regression had 129 observations with $R^2=0.81$ and slope=0.84. When the bold data in the same tables are taken, the regression has 48 observations with

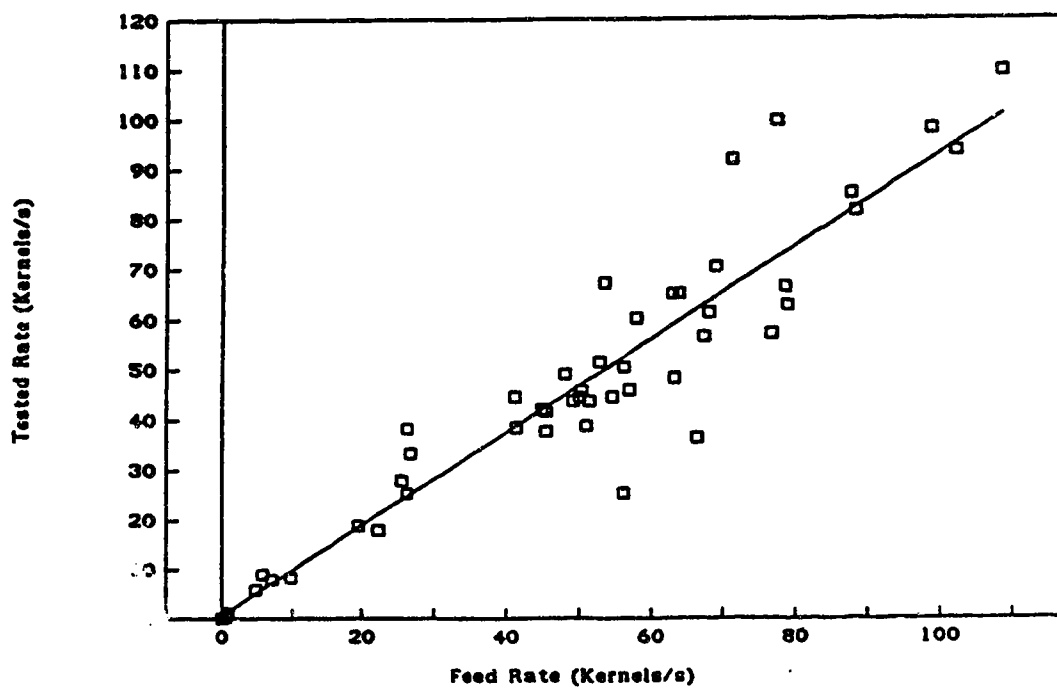
$R^2=0.87$ and slope=0.92. These results illustrate that adjusting the sensor sensitivity improved the accuracy of the sensors. Figure 9.1 shows the regression lines and the scattered data for sensor simulation calibration.

In a similar manner, straight lines were fitted to the threshing calibration results (tested vs actual) and the results are shown in Figure 9.2. The overall data straight line fit had 53 observations with $R^2=0.64$ and slope=0.72. These values were not as good as the value obtained in simulation calibration. The fact that MOG was included in the mixture could be the main reason of this low correlation. However, if data (bold type in table 3.2.1 - 3.2.3) which were obtained with final reference voltages were used for the same straight line fit, the regression had 31 observations with $R^2=0.83$ and slope=1.20. These were much better than the parameters obtained from the overall data.

As mentioned in 7.2.3.2, a calibration coefficient which was the reciprocal of above best fit straight line slope was derived. On the basis of these tests, the calibration coefficient $K_2=0.8326$. This could be entered in to the SBC for measurement of losses under similar conditions during the threshing tests.

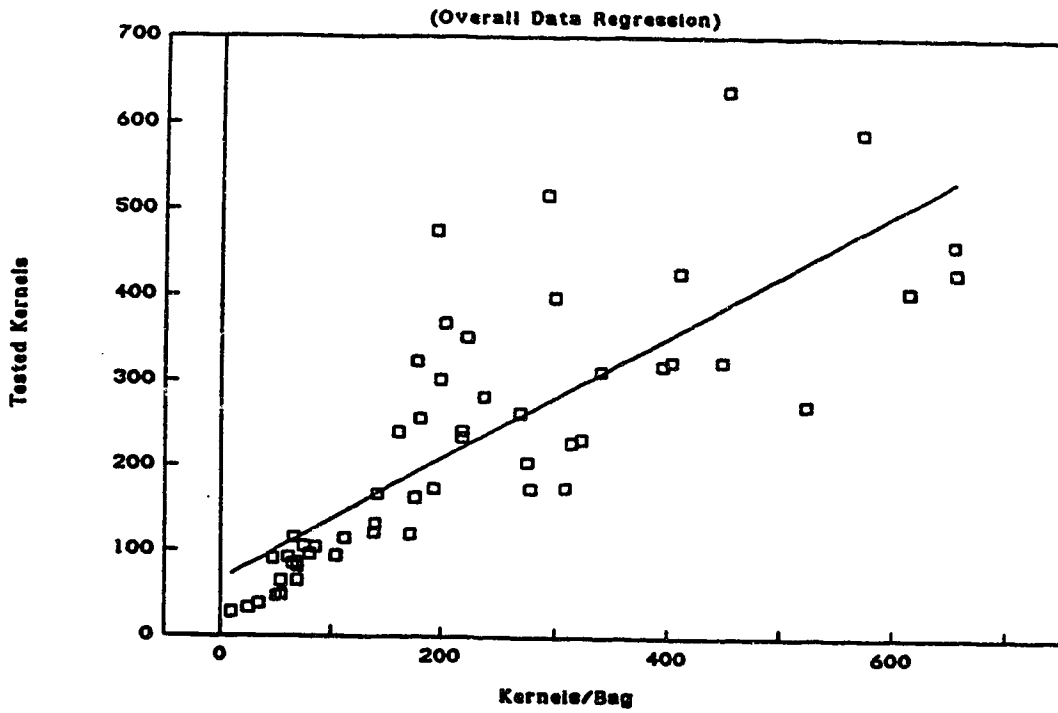


(A) Overall Data

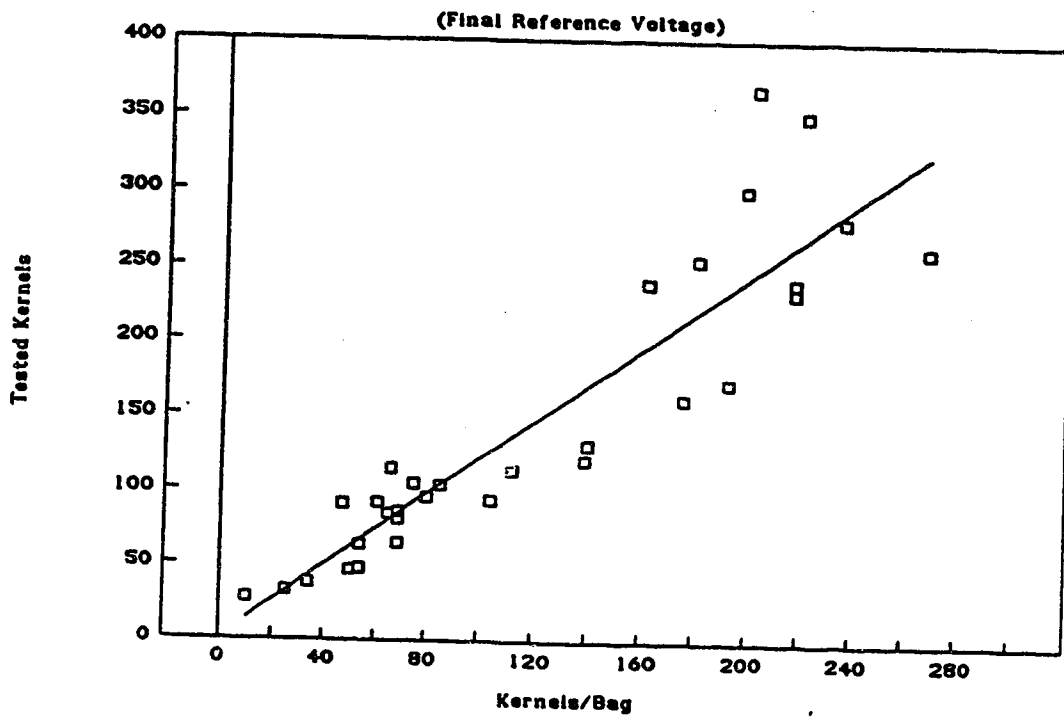


(B) Final Adjustment

Figure 9.1 Sensor Calibration Using Simulation System



(A) Overall Data



(B) Final Reference Voltage

Figure 9.2 Sensor Calibration Using Threshing Equipment

9.2 Threshing Data Analysis

Twelve runs were carried out for the threshing tests. The results are shown in Table 9.1. The data with star symbols indicate that these data were collected in the rotor filling or emptying transient processes. For each run, three such data points were rejected as bad data (usually these values were low) and the remaining samples were considered to be valid. Predicted losses of every samples were summed for each run and the sum was multiplied by the coefficient K ($K = K_1 K_2 C$). These are shown, together with actual losses in Table 9.2. In this Table, the actual and predicted losses are shown as numbers of kernels.

The hypothesis test was based on the same concept used in section 8.2.4. The 't' statistic (see equation 8.3) was 0.4797 with $M=1.033$, $\mu=1.0$, $n=12$ and $s=0.2383$ with 11 degrees of freedom. The null hypothesis was accepted with $\alpha=0.05$. The 95% confidence interval was between 0.8486 and 1.1514, that was, $\pm 15\%$ for a rotor speed of 800-1000rpm and a feed rate of 6-12t/h.

The best fit straight line of actual and predicted losses is shown in Figure 9.3 and the result shows high correlation and accuracy ($R^2=0.92$ and slope=1.02). Both predicted and actual losses illustrated that, at high rotor speeds and low feed rates, losses were low and, at low rotor speeds and high feed rates, these losses were high.

Table 9.1 Predicted Grain Loss of Ten Samples.

Sample	Run No. 1 12-1000-1	Run No. 2 6-1000-1	Run No. 3 6- 800-1	Run No. 4 12- 800-1
1	4.4255	1.4534	0.8487	2.2503
2	12.8991	1.3389	1.9342	23.5301
3	9.8913	2.0709	2.4337	21.7999
4	3.8709	2.7547	3.8404	24.7331
5	5.3398	2.2878	4.3337	9.5769
6	4.5752	2.5686	2.4384	17.2664
7	3.0365	2.2659	3.4656	20.5647
8	* 0.1929	* 0.6726	* 0.8874	* 0.9930
9	* 0.1093	* 2.5461	* 0.1409	* 1.5818
10	* 0.1063	* 0.3294	* 0.1227	* 0.1597
Sample	Run No. 5 12- 800-2	Run No. 6 12-1000-2	Run No. 7 6- 800-2	Run No. 8 6-1000-2
1	0.8532	2.7170	1.5297	0.4389
2	16.0863	14.9360	1.1075	2.8866
3	11.1840	8.5428	0.7126	4.1035
4	13.9482	6.7226	3.1266	1.6150
5	19.7022	6.9132	1.8555	0.9211
6	24.7018	3.8041	3.5630	2.9672
7	34.8644	4.6301	1.6707	2.7552
8	* 6.1248	* 0.7735	* 2.8434	* 0.7228
9	* 3.3669	* 0.2745	* 1.2387	* 0.1807
10	* 0.1978	* 0.1978	* 0.7829	* 0.2045
Sample	Run No. 9 12- 800-3	Run No.10 6- 800-3	Run No.11 12-1000-3	Run No.12 6-1000-3
1	* 0.2670	* 0.0638	1.2470	* 0.4229
2	4.7383	1.8189	7.0505	1.6595
3	5.4946	4.8724	5.0564	1.5890
4	9.3912	1.4556	8.3994	2.5204
5	9.9039	3.4729	4.6980	2.0147
6	10.8050	1.7355	7.1469	2.5865
7	5.4320	1.8975	4.4011	1.3928
8	5.3734	1.8323	* 0.7932	3.0828
9	* 1.0262	* 0.3384	* 1.1015	* 2.3134
10	* 0.1312	* 0.1437	* 0.2806	* 0.1213

* Predicted losses in transient, they were omitted.

Table 9.2 Predicted and Actual Grain Loss of 12 Runs

Run No.	Feed Rate	Rotor Speed	Rep	Actual Loss (g)	Actual Loss (kernels)	Predict Loss (kernels)	M Actual/Predict
2	6	1000	1	59	1639	2056	0.7972
8	6	1000	2	82	2277	2226	1.023
12	6	1000	3	52	1444	2017	0.6972
3	6	800	1	120	3333	2691	1.239
7	6	800	2	74	2055	2075	0.9908
10	6	800	3	71	1972	2383	0.8275
1	12	1000	1	318	8833	6156	1.435
6	12	1000	2	255	7083	6732	1.052
11	12	1000	3	212	5888	5300	1.111
4	12	800	1	511	14194	16699	0.8500
5	12	800	2	575	15972	16923	0.9438
9	12	800	3	368	10222	7132	1.433

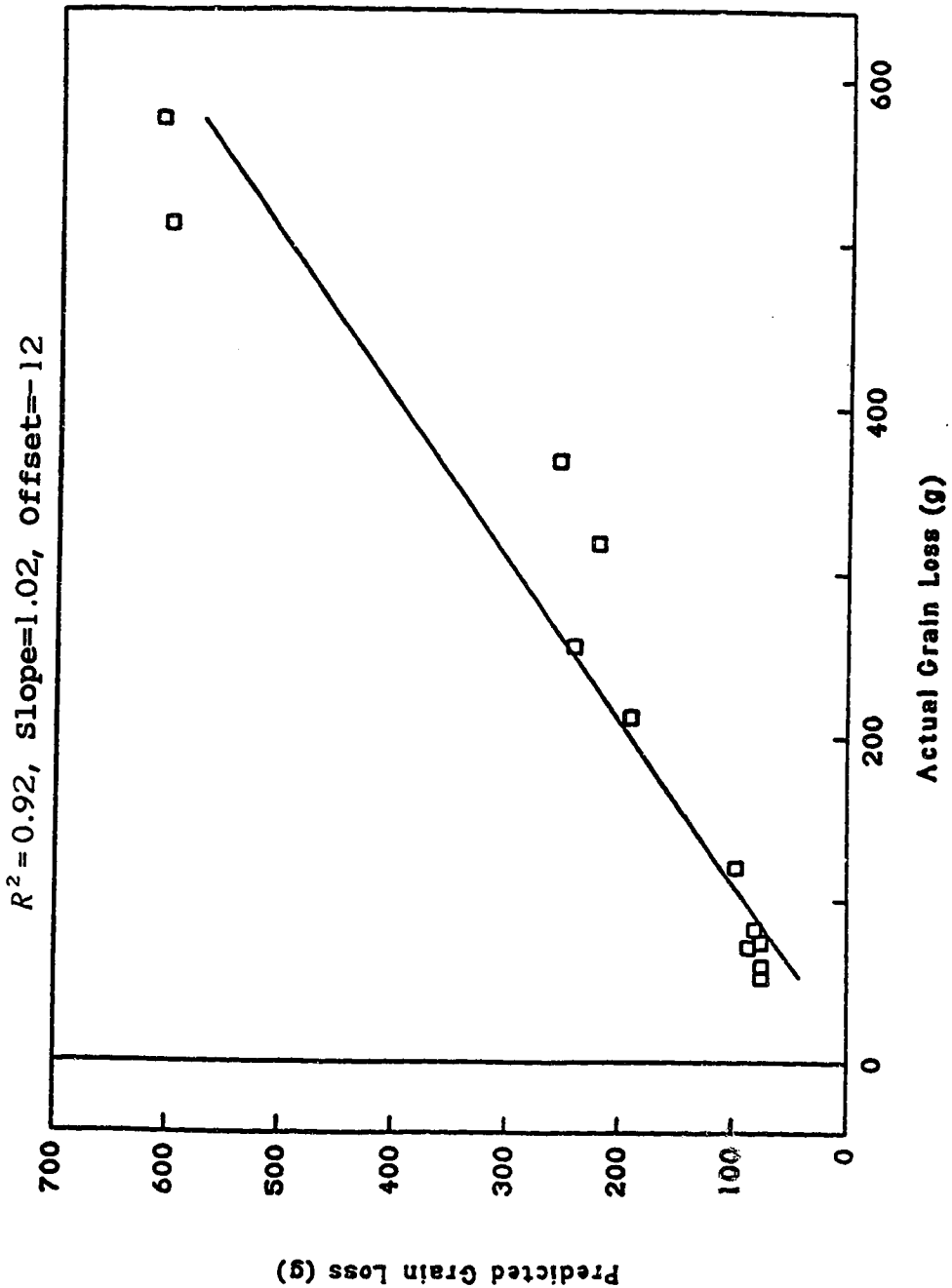


Figure 9.3 The Best Fit Straight Line

A test run was randomly selected from test runs (Run No. 4) and the real-time-calculated parameters of distribution curves were used to draw curves for both arc and axial directions. These curves are shown in Appendix V 1 and 2. The curves show that separation distribution in the axial direction was exponentially decaying, while most separation distribution in the arc direction were convex shaped curves. The three horizontal straight lines were the mean values of the second order polynomial curves in the arc direction. All these real-time-fitted curves confirmed the feasibility of the software design.

10. SUGGESTIONS FOR FURTHER WORK

The accuracy of predicted losses was affected by many factors. The effects of transient processes during threshing runs was one of the significant factors that could be reduced in some ways. The most effective method would be to increase the feed time. To do this, the best way would be to increase the length of the conveyer but the size of the building restricts this option. Appropriate increases in the thickness of the crop on the conveyer coupled with slower conveyer speeds would help.

The sensors should be calibrated before threshing in the field. The calibration coefficient could be obtained after harvesting for a short distance in the field as a calibration run. The ratio of predicted losses to actual losses could be the calibration coefficient. The multi-sensor test system was manipulated as a one-input (actual losses) and one-output (predicted losses) instrument and was calibrated by entering the calibration coefficient as a single number. This was the only way to simplify the calibration and the monitor system could be used in field harvesting.

A straw bag and cleaning equipment were needed for calibration. However, it would also be possible to clean

threshed straw by feeding discharged straw into the combine again to clean out the lost grain.

Because of the limited time available in indoor threshing runs, the RTDP was executed after each of the ten samples that had been collected in each run. If this data processing method was used for monitoring the grain loss in field harvesting, the non-uniform, multiphase materials separated in the rotor might cause the separation rate to vary and, thus, the monitor reading would vary too. To provide a stable, readable display, digital averaging could be used to store several samples in memory before using them to determine the distribution curve using least squares regression. The sample data would be scattered on both sides of the curve which would best represent the separation distribution.

Field threshing tests are necessary to verify the performance of the grain loss monitor system in real harvesting conditions.

Since this grain loss monitor was a 16-bit microprocessor-based, real-time data acquisition and processing instrument, system CPU and other interfaces have a lot of potential for further development. The execution time of data acquisition and the RTDP model occupied less than 11% of CPU time. Thus, 89% of CPU data processing

ability could be used for further useful information processing. For example: to monitor the engine performance, plot yield maps or even communicate with a host computer to access a harvest expert database system via microprocessor-controlled communication equipment.

11. CONCLUSIONS

Sounding board signal conditioners could determine grain and non-grain impacts and performed with high noise immunity. Grain impact counting accuracy could statistically be within $\pm 10\%$ for a 95% confidence interval.

The assembly language, real-time data processing was able to represent grain separation distribution both around and along the separation rotor. The real time calculation took between 55 and 110ms.

Monitoring actual grain loss from an axial-flow combine in real time by means of a microprocessor-based instrument system has been demonstrated to be feasible. The linear regression of actual and predicted losses showed a high correlation ($R^2=0.922$), and a slope very close to one (1.018).

The comparison of predicted to actual losses showed a statistically significant correlation at the level of $\alpha=0.05$ with the data from all the test runs.

The plotted curves, both in the arc direction and in the axial direction, showed that the regression model selection was reasonable. The real time data processing calculation software design provided good estimates of actual grain losses.

Prolonging the sampling and feed times could achieve higher correlations between predicted and actual losses.

Further tests using threshing runs with longer feed times and field tests are needed to evaluate both system hardware and software.

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13. APPENDIX

Appendix I.

Table 1. Basic Structure and Main Functions of the
Intelligent Instrumentation System

Name of components	Main Functions (Hardware)
CPU (8088)	Central Processing Unit
EPROM	Monitor Programs for control and data processing, look-up table, etc. are stored in EPROM.
RAM	Interrupt array, stack, input and output data, intermediate and result of calculation data are stored in RAM.
I/O Parallel	Connected to keyboard, display unit, DIP switches or sensors etc.
I/O Serial (RS-232)	Up (or down) load data or some other information to (or from) the host computer or peripheral equipment which has RS-232 interface.
I/O A/D	Data acquisition interface connected to sensors and signal conditioner outputs.
Real Time Clock	Supplies the time base for graphics or for current time display.
Programmable Interrupt Controller	Accept interrupt requirements from programmable interfaces. Interrupt priority management.
Timer and Event Counter	<p>Timer: To mark intervals of time for both the processor and external devices (e.g. baud rate generator).</p> <p>Counter: To count external events and make the counters available to the processor.</p>
Peripheral Equipment	<p>Display Unit: Display keyboard command, input coefficients, data etc.</p> <p>Keyboard: Entry of commands, coefficients, real time clock set, etc.</p> <p>Printer: Hard copy output.</p> <p>Sensors: Any transducers which could convert electrical quantities into 0-5V DC signals or TTL pulses could be used.</p>

Table 1. (continued)

	(Software)
Keyboard Monitor	Keyboard scanning and command string (ASCII) process.
Display and Printer Control	Control Program makes it possible for the display unit (LCD) and the portable printer to work in Hand Shake Mode.
Data Acquisition and Data Processing	<ol style="list-style-type: none">1. Sensor scanning interval.2. Convert sensor output into engineering units.3. Arithmetic transcendental and polynomial functions.

Table 2. Instruction Execution Time in Sampling Gaps (Liu and Gibson, 1986)

Instruction	Operation	Cycles	Instruction Number	Total Cycles
PUSH	push register into stack	11	6	66
POP	pop register off stack	8	6	48
MOV	accumulator to memory	10	9	90
MOV	immediate to register	4	30	120
MOV	register to register	2	38	76
OUT	output via fixed port	10	27	270
IN	input via fixed port	10	18	180
NOT	logic negative	3	9	27
LEA	load effective address	8	1	8
CALL	intra-segment direct	19	2	38
RET	procedure return	8	2	16
NOP	null operation	3	8	24
Total			156	963

Table 3.1.1 Sensor Calibration Using Simulation System

Vr (V)	Sensor 1				Sensor 2				Sensor 3			
	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)
0.4	829	772	-6.88	0.3	836	1038	24.2	0.5	1009	711	-29.5	0.5
0.4	728	761	4.53	0.3	711	939	32.1	0.5	765	587	-23.3	0.5
0.4	25	25	0.00	0.3	535	744	39.1	0.5	165	123	-25.5	0.5
0.4	37	36	-2.70	0.3	75	107	42.7	0.5	30	20	-33.3	0.5
0.4	430	459	6.74	0.3	244	385	57.8	0.5	537	463	-13.8	0.5
0.4	245	270	10.2	0.3	81	138	70.3	0.5	394	345	-12.4	0.5
0.4	67	75	11.9	0.3	159	245	54.0	0.5	163	147	-9.82	0.5
0.4	804	740	-7.96	0.3	1060	1228	15.8	0.5	827	651	-25.3	0.5
0.389	504	458	-9.13	0.37	528	515	-2.46	0.5	115	117	1.74	0.5
0.389	692	704	4.73	0.37	666	365	-45.2	0.5	611	607	-0.65	0.5
0.389	634	484	-23.6	0.37	562	254	-54.8	0.382	317	240	-24.3	0.382
0.389	454	417	-8.15	0.37	514	438	-14.8	0.37	6	3	-50.0	0.37
0.389	97	83	-14.4	0.37	885	815	-7.90	0.37	580	602	3.79	0.37
0.389	563	505	-10.3	0.37	501	445	-11.2	0.37	570	460	-19.3	0.37
0.389	787	665	-15.5	0.37	1024	936	-8.59	0.37	879	850	-3.30	0.37
0.389	546	446	-18.2	0.37	675	566	-16.1	0.37	641	652	1.72	0.37
0.389	492	438	-11.0	0.37	510	388	-23.9	0.37	412	446	8.25	0.37
0.389	449	421	-6.23	0.37	454	377	-17.0	0.37	481	491	2.08	0.37

Table 3.1.1.2 Sensor Calibration Using Simulation System

Sensor 4						Sensor 5						Sensor 6					
Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)		
0.4	115	117	1.74	0.43	306	389	27.1	0.3	785	546	-30.4	0.3	785	546	-30.4		
0.4	113	87	-23.0	0.43	414	423	4.34	0.3	756	495	-34.5	0.3	756	495	-34.5		
0.4	686	567	17.3	0.43	113	99	-12.4	0.3	573	581	1.40	0.3	573	581	1.40		
0.4	445	460	3.37	0.43	445	460	3.37	0.3	546	498	-8.79	0.3	546	498	-8.79		
0.4	684	495	-27.6	0.43	498	562	12.9	0.3	570	505	-11.4	0.3	570	505	-11.4		
0.4	842	597	-29.1	0.43	560	658	17.5	0.3	912	710	-22.1	0.3	912	710	-22.1		
0.4	459	338	-26.4	0.43	166	196	18.1	0.3	931	693	-25.6	0.3	931	693	-25.6		
0.4	196	165	-15.8	0.43	119	125	5.04	0.3	518	491	-5.21	0.3	518	491	-5.21		
0.4	531	467	-12.1	0.43	166	212	27.7	0.3	140	119	-0.15	0.3	140	119	-0.15		
0.4	144	123	-14.6	0.43	354	404	14.1	0.3	337	320	-5.04	0.3	337	320	-5.04		

Table 3.1.3 Sensor Calibration Using Simulation System

Sensor 7				Sensor 8				Sensor 9			
Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)
0.353	616	369	-40.0	0.34	65	31	-52.3	0.375	487	367	-24.6
0.353	659	402	-40.0	0.34	713	395	-44.6	0.375	535	448	-16.3
0.353	623	431	-30.8	0.34	724	417	-42.4	0.375	520	382	-26.6
0.33	643	356	-8.8	0.32	651	372	-41.0	0.320	322	279	-13.4
0.33	577	344	-11.4	0.32	554	368	-33.6	0.320	515	438	-15.0
0.30	563	377	-22.1	0.32	1170	668	-42.9	0.320	565	440	-22.1
0.30	734	421	-42.6	0.30	768	571	-27.4	0.307	790	628	-20.5
0.30	336	175	-47.9	0.30	223	180	-19.3	0.307	414	385	7.00
0.30	270	182	-32.6	0.30	195	189	-3.08	0.307	262	254	-3.05
0.30	294	241	-18.0	0.30	255	279	9.41	0.307	267	334	25.1
0.30	929	902	-2.90	0.30	990	981	0.909	0.307	262	383	46.2
0.30	1007	1028	2.1	0.30	1088	1096	0.740	0.307	715	919	28.5
0.28	682	613	-10.1	0.30	631	651	3.17	0.37	776	997	28.5
0.28	48	58	20.8	0.30	58	89	53.4	0.40	535	672	25.6
0.28	0	0	0	0.30	71	79	11.3	0.41	9	11	22.2

Table 3.2.1 Sensor Calibration Using Threshing Equipment

Sensor 1			Sensor 2			Sensor 3					
Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)
0.35	278	173	-37.7	0.3	613	405	-33.9	0.3	655	427	-34.8
0.29	275	204	-25.8	0.25	195	476	-31.5	0.3	340	311	-8.53
0.29	395	318	-19.5	0.25	523	271	-48.2	0.196	653	460	-29.6
0.2	218	240	10.1	0.198	572	590	31.5	0.196	203	368	81.3
0.2	218	233	6.88	0.198	452	638	41.2	0.160	292	517	77.1
0.2	162	239	47.5	0.198	410	427	4.15	0.20	299	398	33.1

Table 3.2.2 Sensor Calibration Using Threshing Equipment

Sensor 4			Sensor 5			Sensor 6					
Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)
0.35	172	119	-30.8	0.38	315	227	-27.9	0.23	448	323	-27.9
0.31	139	121	-12.9	0.30	309	174	-43.7	0.269	178	323	81.5
0.31	176	162	-7.95	0.30	323	231	-28.5	0.269	403	323	19.9
0.31	61	92	50.8	0.215	193	173	-10.4	0.222	269	262	-2.60
0.31	75	105	40.0	0.215	222	351	58.1	0.222	237	281	18.6
0.31	80	96	20.0	0.215	199	301	51.3	0.222	181	255	40.9

Table 3.2.3 Sensor Calibration Using Threshing Equipment

Sensor 7			Sensor 8			Sensor 9					
Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)	Vr (V)	Actual Number	Tested Number	Err (%)
0.308	54	48	-11.1	0.286	No Data	362		0.450	142	166	16.9
0.308	69	65	-5.80	0.286	112	114	1.79	0.462	85	104	22.4
0.308	69	86	24.6	0.286	140	131	-6.43	0.462	104	94	-9.62
0.308	25	33	32.0	0.286	47	91	93.6	0.462	69	81	17.4
0.308	34	38	11.8	0.286	65	85	30.8	0.462	66	115	74.2
0.308	10	28	1.80	0.286	54	64	18.5	0.462	50	47	-6.00

Table 3.3 Statistics of Actual and Tested Grain Impact Counts

Simulation Overall			After Calibration (Simulation)		
Const	St. Err.	Slope	Const	St. Err.	Slope
25.0	0.0364	0.837	0.648	0.517	0.923
		R ²			R ²
		0.806			0.874
Threshing Overall			After Calibration (Threshing)		
Const	St. Err.	Slope	Const	St. Err.	Slope
65.4	0.0750	0.716	2.45	0.102	1.20
		R ²			R ²
		0.641			0.826

Table 4. Straw Moisture Contents

Run No.	Wet Straw (g)	Dry Straw (g)	Moisture Contain (Wet Base %)
1	118	100	15.3
2	124	107	13.7
3	112	97	13.4
4	131	112	14.5
5	145	123	15.2
6	107	89	16.8
7	127	110	13.4
8	124	112	9.7
9	147	127	13.6
10	113	97	14.2
11	134	112	16.4
12	129	111	14.0

Moistuer Containt mean value wet base: 14.2 % .

Toshiba Microwave was used for this test. The working selection was defrozen. Drying time was 20 minutes.

Table 5. Grain Moisture Contents

Run No.	Test Time (Min)	Heating set	Moisture Contain (Wet Base %)
1	60	100	11.0
2	30	120	11.8
3	35	110	11.6
4	30	120	12.6
5	30	120	12.8
6	30	120	11.8
7	30	120	11.1
8	30	120	12.0
9	30	120	11.2
10	30	120	13.0
11	30	120	11.4
12	30	120	11.0

Moisture contain mean value wet base: 11.9 %.

CENCO Moisture Balance was used for the test (Central Scientific Company, CENCO NOS 026680 - 001) .

Table 6. Barley Sample 1000 Kernel Weights

Run No.	Samples	Weight/1000 Kernels (g)
1 - 4	1	35.77
1 - 4	2	34.83
5 - 8	3	38.52
5 - 8	4	33.55

Mean value of 1000 kernel weight is 36 g .

Table 7. The Material Weights and G/MOG

Run No.	Crop (Kg)	No. of Bundles	Straw (Kg)	Chaff (Kg)	MOG (Kg)	Grain (Kg)	G/MOG
1	80.0	29	27.9	7.03	34.9	42.0	1.20
2	39.0	12	13.4	3.86	17.3	19.7	1.14
3	40.0	13	13.8	3.63	17.4	21.1	1.21
4	80.0	22	30.2	6.12	36.3	41.5	1.14
5	80.0	23	31.1	5.67	36.8	41.3	1.12
6	80.0	21	28.8	7.26	36.1	41.6	1.15
7	39.9	11	14.3	4.31	18.6	21.8	1.17
8	42.5	11	13.8	4.99	18.8	23.6	1.26
9	81.3	22	28.8	7.03	35.8	43.3	1.21
10	41.3	7	14.7	4.99	19.7	21.1	1.07
11	80.5	21	27.7	6.80	34.5	44.0	1.28
12	39.0	10	12.2	4.08	16.3	22.5	1.38

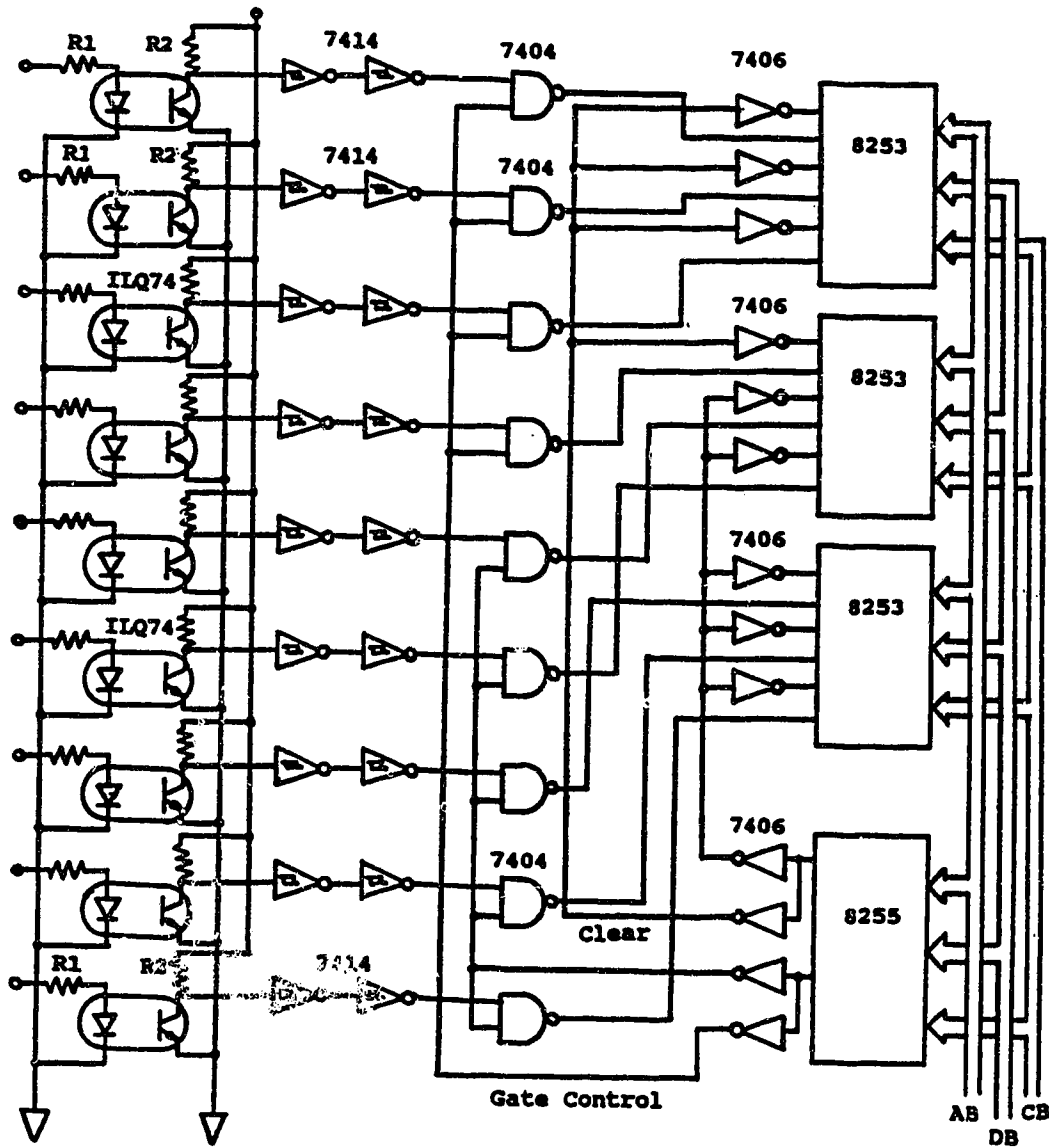
1. Memory Map

IC	Function	Address	
SRM2264	INTERRUPTS ARRAY (1024 Bytes)	0000H	
		0400H	
	DATA STORAGE AREA	0401H 1FFFH	
MK48T02	1776 Bytes RAM in Real Time Clock	2000H 26F0H	
	STACK (256 Bytes)	26F1H 27F0H	
	Reserved	27F1H 27F7H	
	RTCTRL	27F8H	
	SECOND	27F9H	
	MINUTE	27FAH	
	HOUR	27FBH	
	DAY	27FCH	
	DATE	27FDH	
	MONTH	27FEH	
	YEAR	27FFH	
		No Physical Memory	2800H BFFFH
2764	Look-up Table (EPROM 2)	C000H DFFFH	
2764	Data Acquisition and Processing Modules (EPROM 1)	E000H FFEFH	
		Boot-up (Reset)	FFF0H
		FFFFH	

2. I/O Map

IC	Function	Address
8255-1	I/O A #0 I/O B #0 I/O C #0 I/O Control #0	00H 01H 02H 03H
8251	*UART-Data UART-Control	10H 11H
8253-1	Timer #0 Timer #1 Timer #2 Timer Mode	20H 21H 22H 23H
8259	Interrupt Controller Initialization Interrupt Controller Operation	30H 31H
8253-2	Counter #1 Counter #2 Counter #3 Counter Mode #1	40H 41H 42H 43H
8255-2	I/O A #1 I/O B #1 I/O C #1 I/O Control #1	50H 51H 52H 53H
8253-3	Counter #4 Counter #5 Counter #6 Counter Mode #2	60H 61H 62H 63H
8253-4	Counter #7 Counter #8 Counter #9 Counter Mode #3	70H 71H 72H 73H
8255-3	I/O A #2 I/O B #2 I/O C #2 I/O Control #2	80H 81H 82H 83H

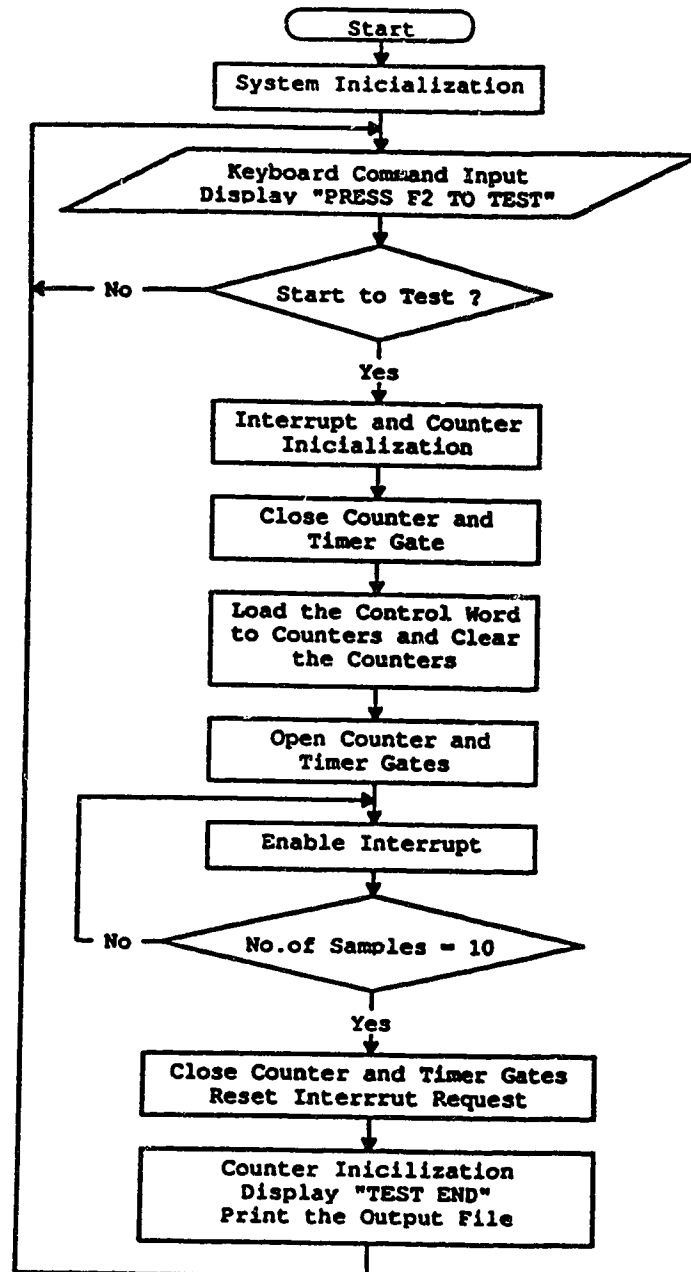
*UART: Universal Asynchronous Receiver and Transmitter



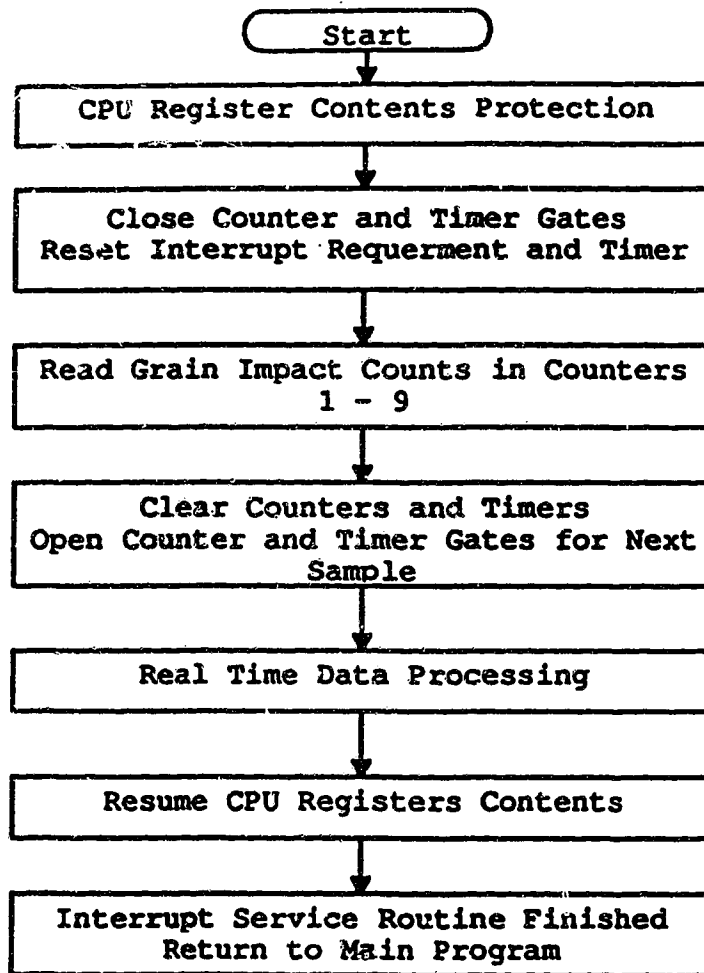
3. Nine Channel Signal Interface.

Appendix III.

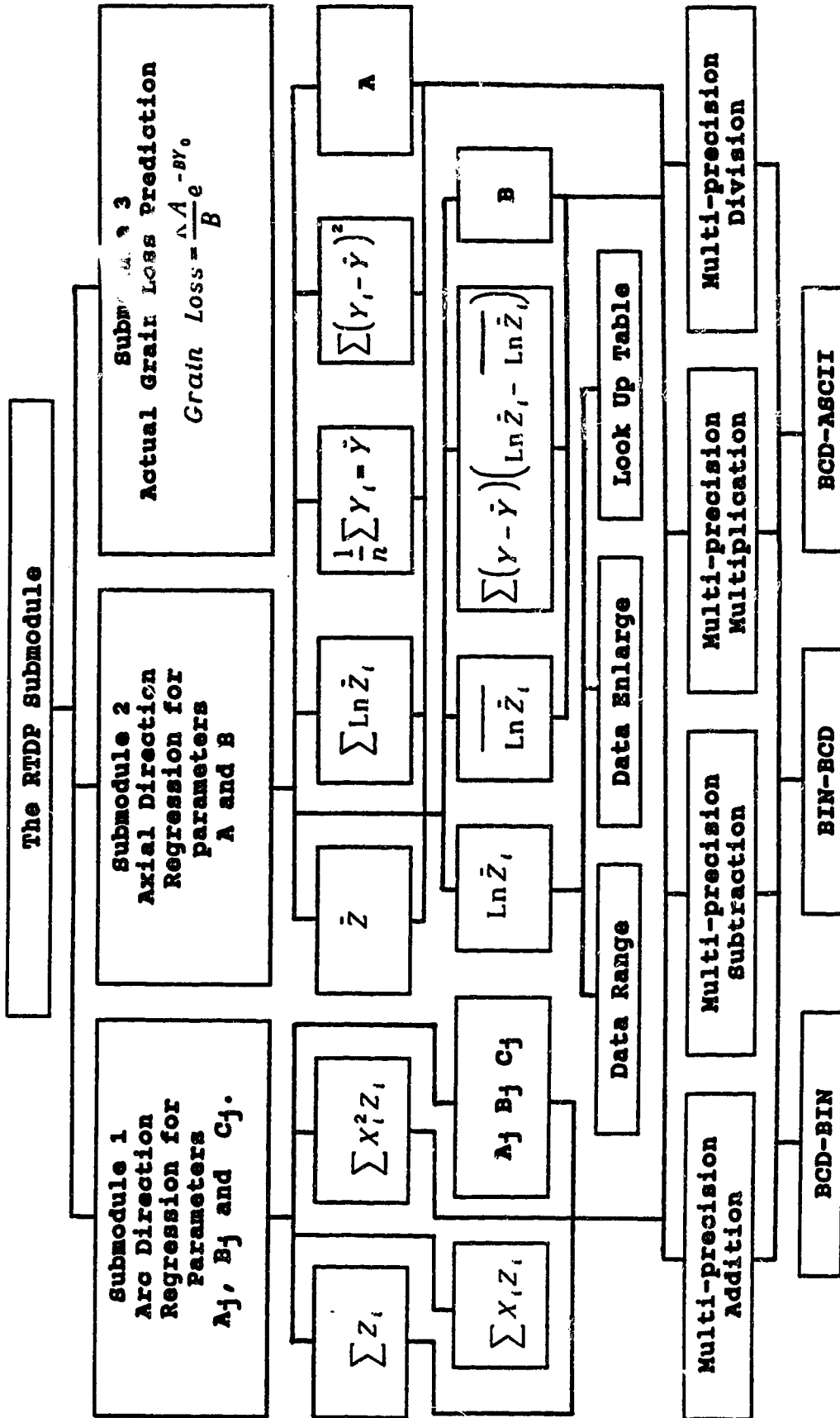
- 1. Main Program Flowchart**
- 2. Interrupt Service Routine Flowchart**
- 3. The Hierarchical Diagram for the RTDP**
- 4. Look-up Table Flowchart**



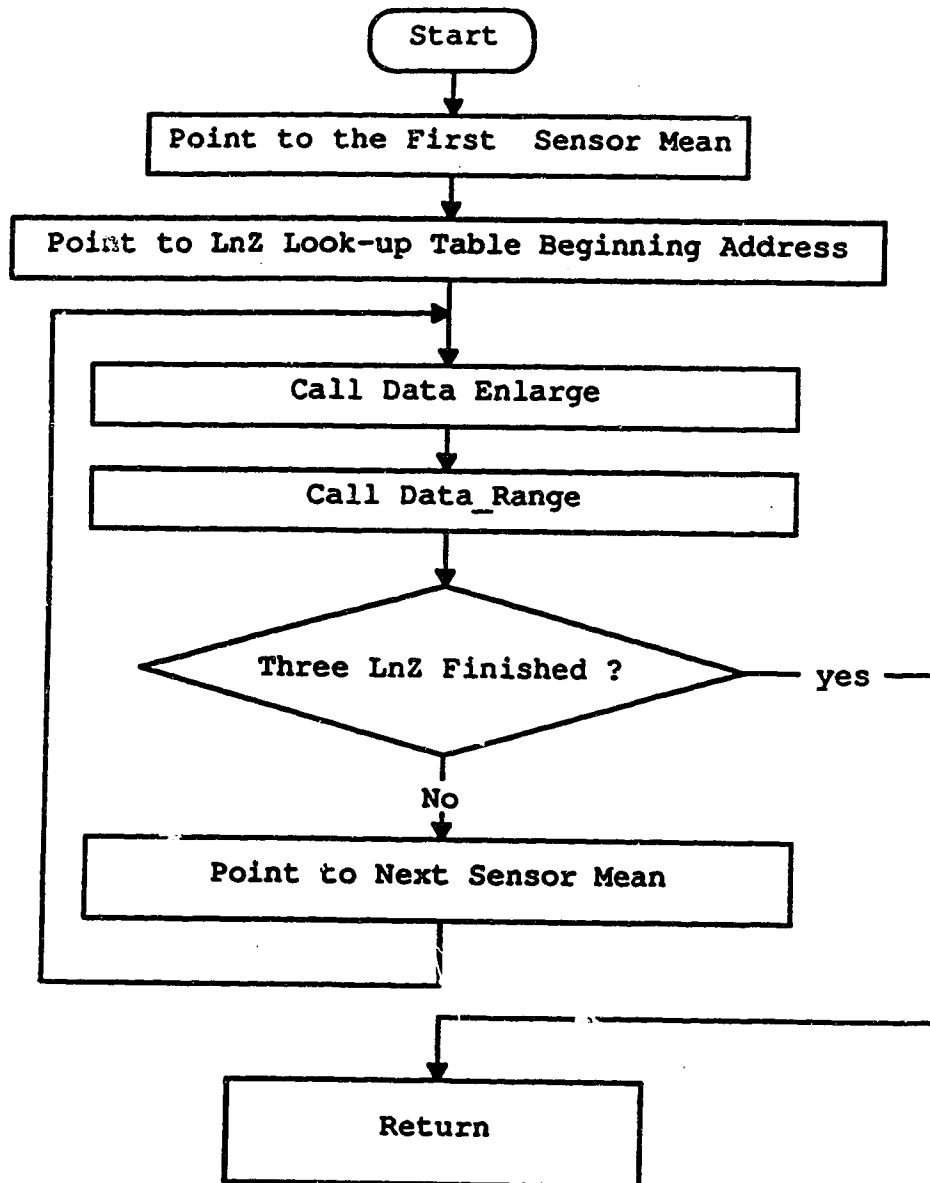
1. Main Program



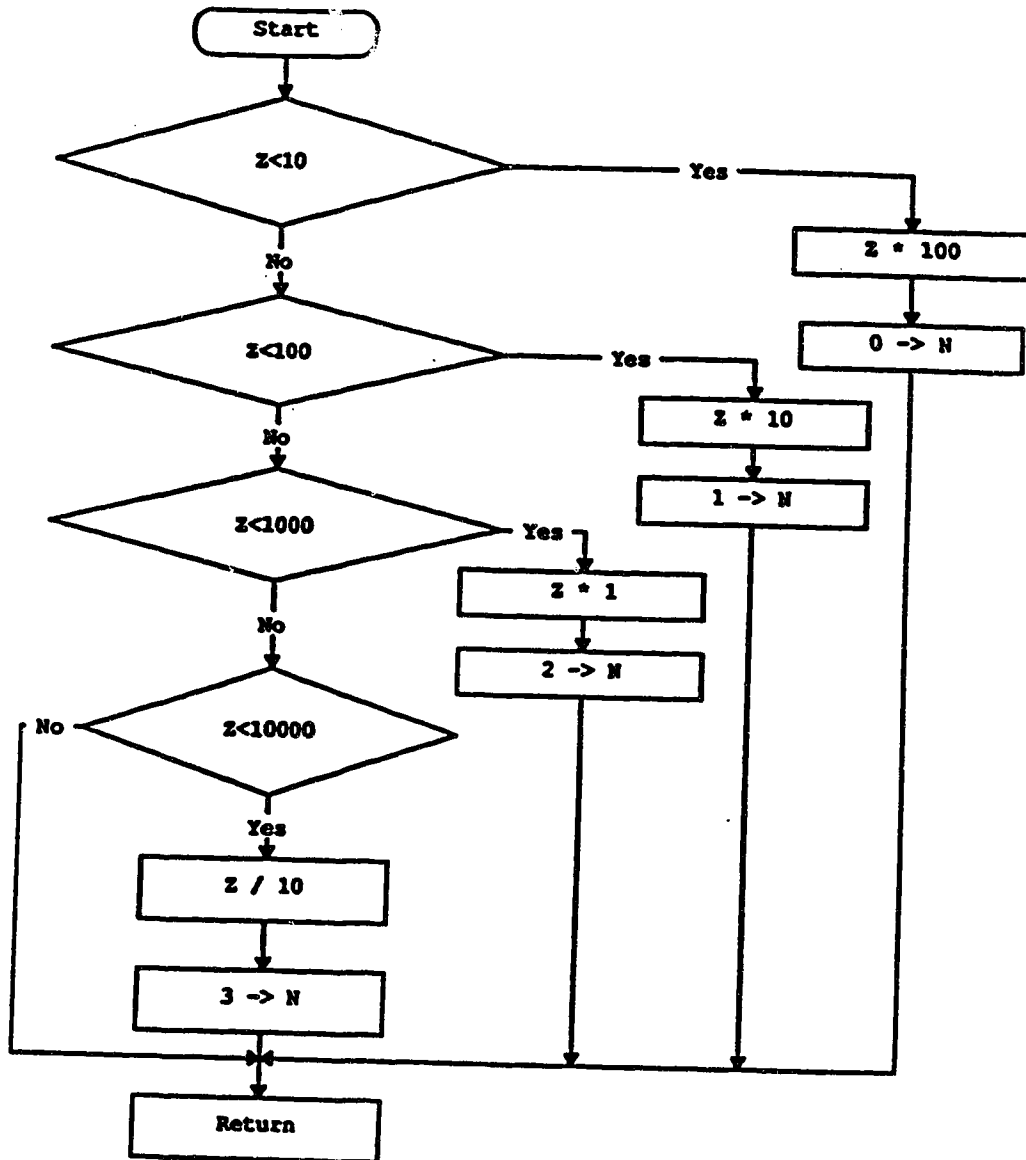
2. Interrupt Sevice Routine



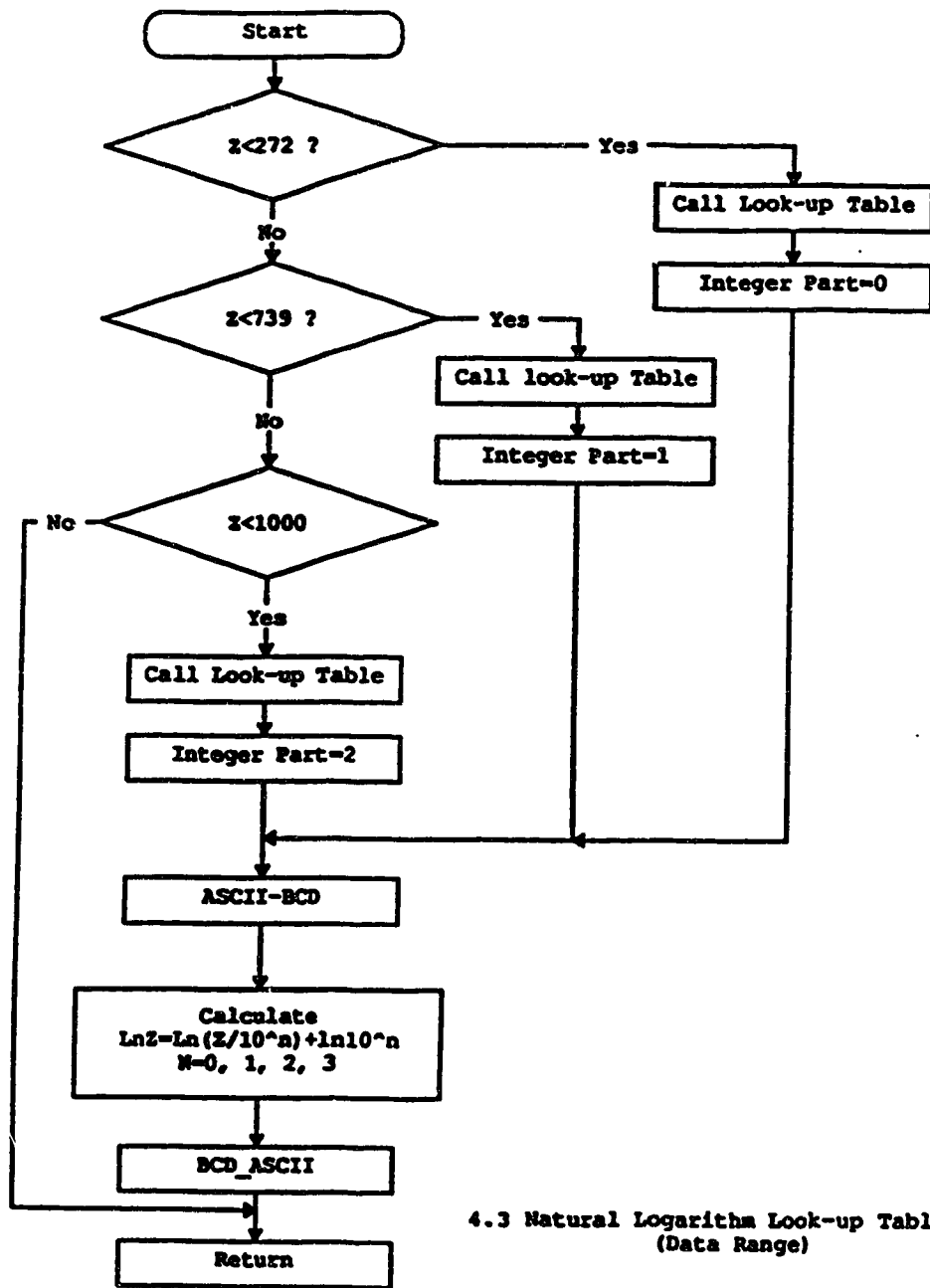
3. The Hierarchical Diagram for the RTDP.



4.1 Natural Logarithm Look-up Table (Main)



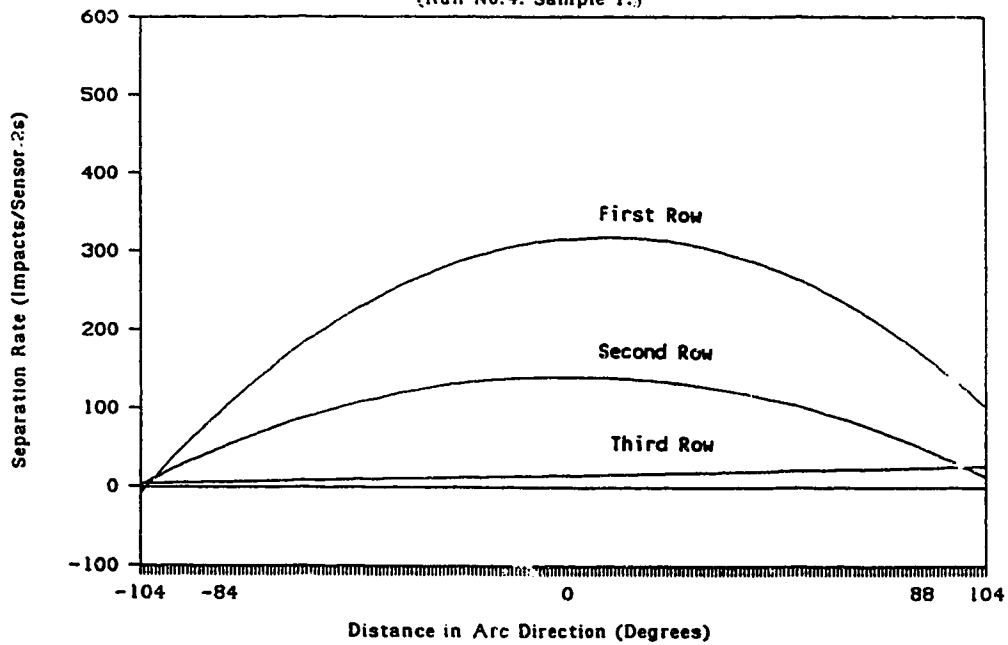
4.2 Natural Logarithm Look-up Table
(Data Enlarge)



4.3 Natural Logarithm Look-up Table
(Data Range)

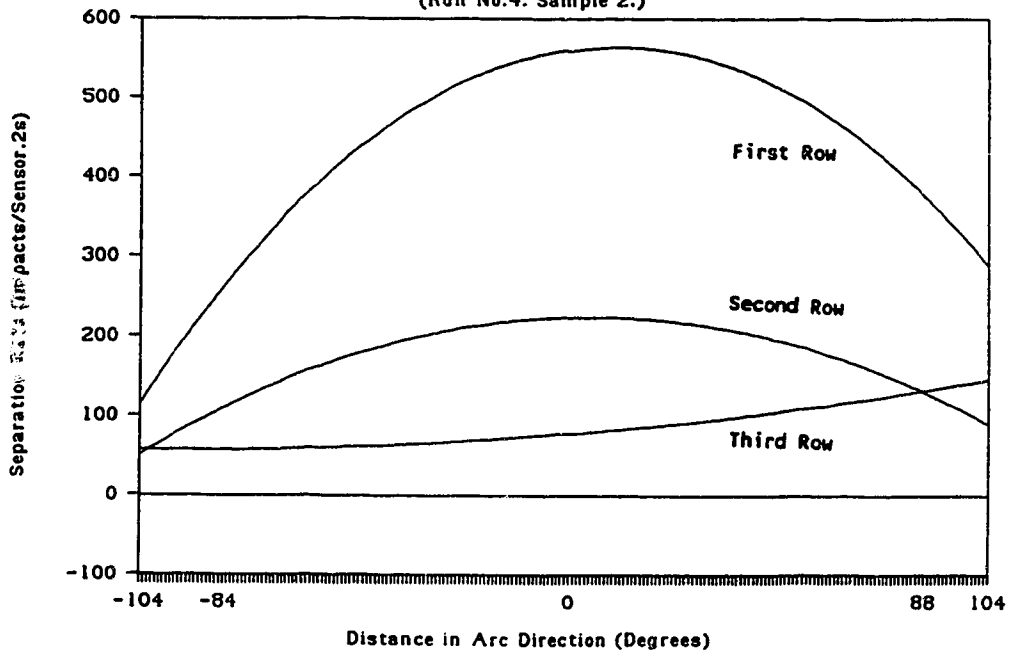
Distribution Curve in Arc Direction

(Run No.4. Sample 1.)



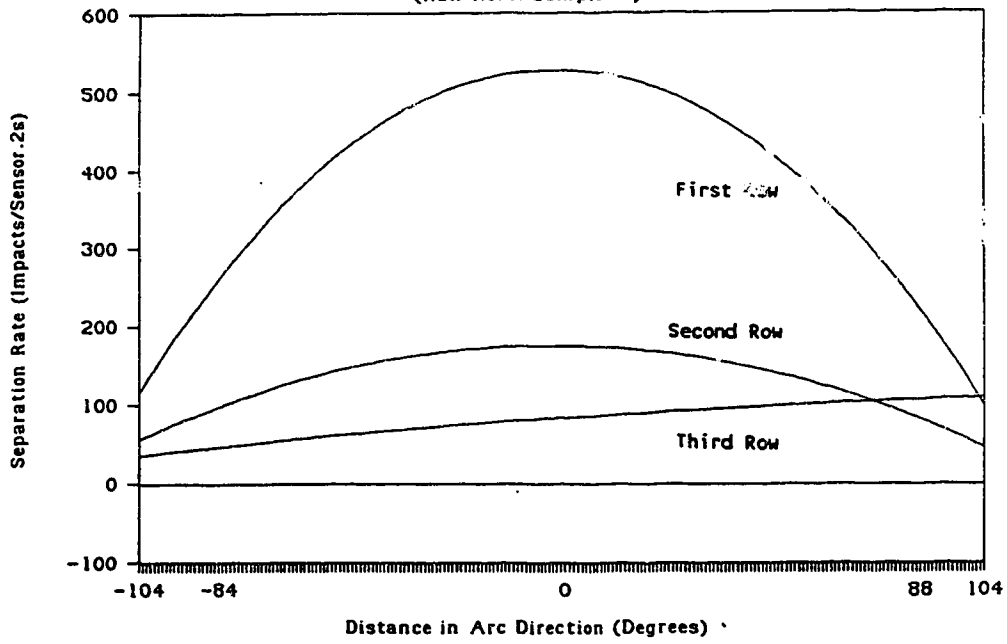
Distribution Curve in Arc Direction

(Run No.4. Sample 2.)



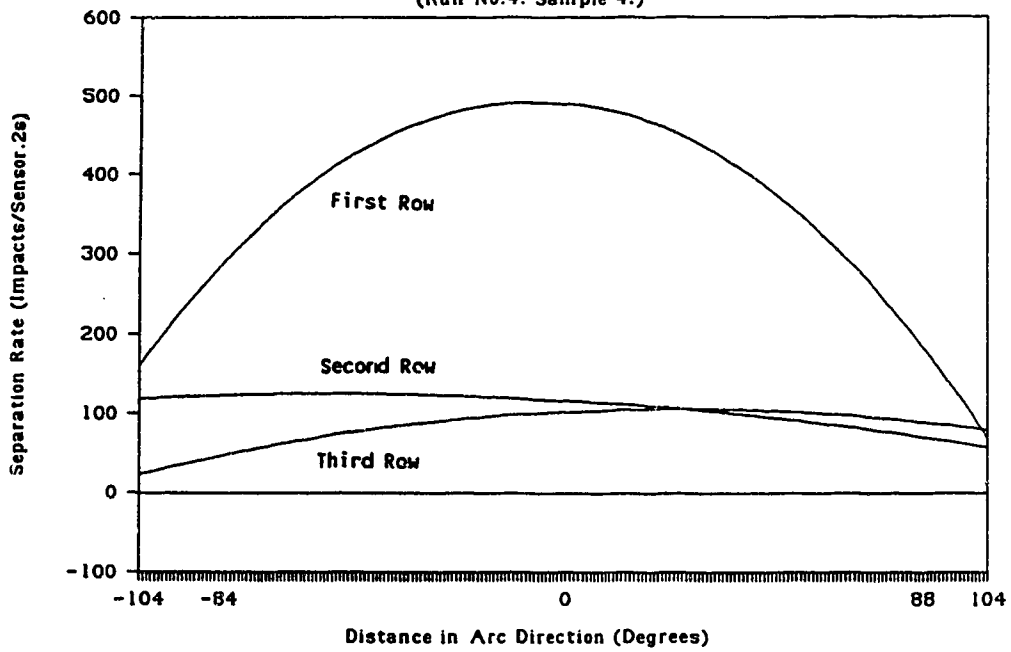
Distribution Curve in Arc Direction

(Run No.4. Sample 3.)



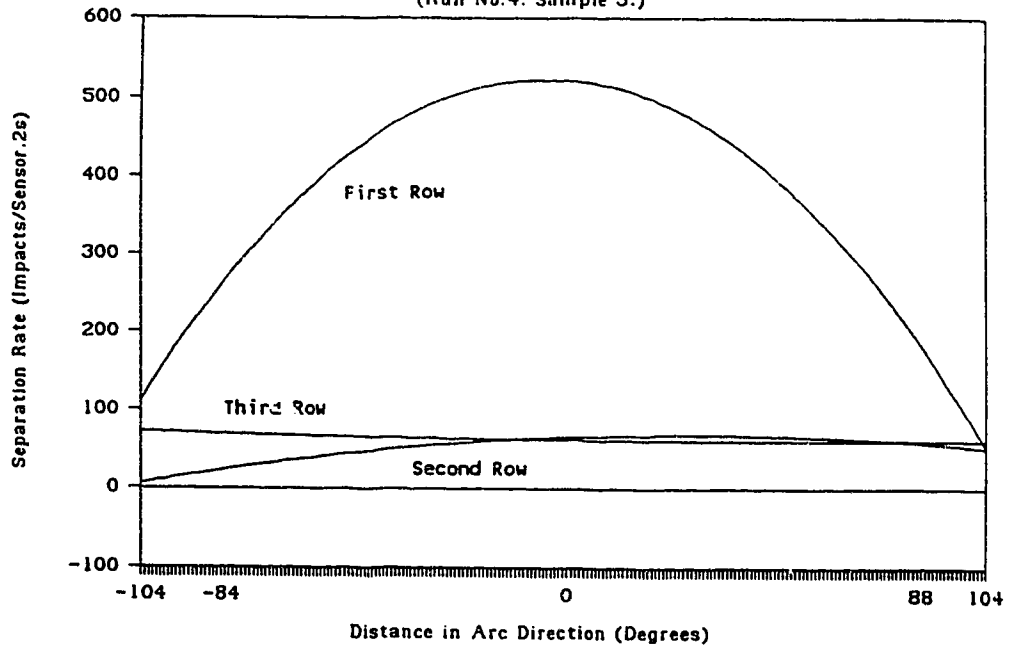
Distribution Curve in Arc Direction

(Run No.4. Sample 4.)



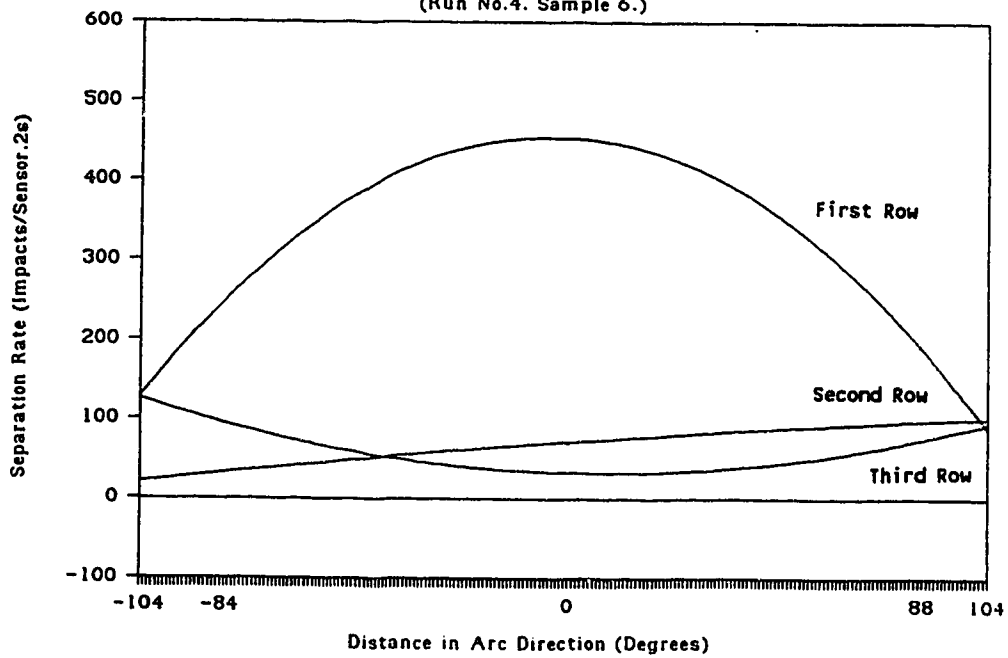
Distribution Curve in Arc Direction

(Run No.4. Sample 5.)



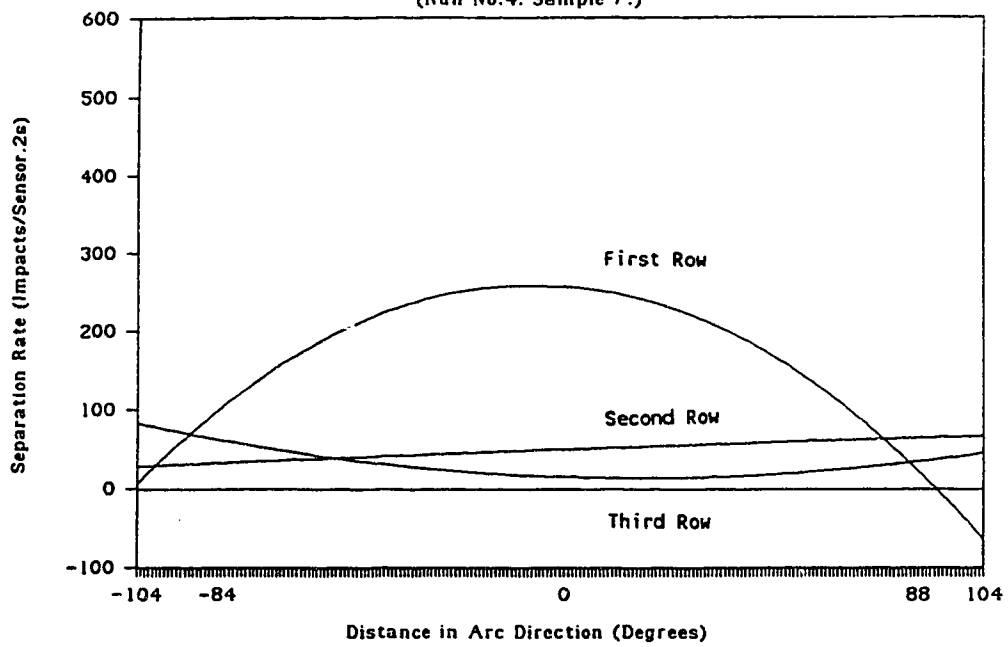
Distribution Curve in Arc Direction

(Run No.4. Sample 6.)



Distribution Curve in Arc Direction

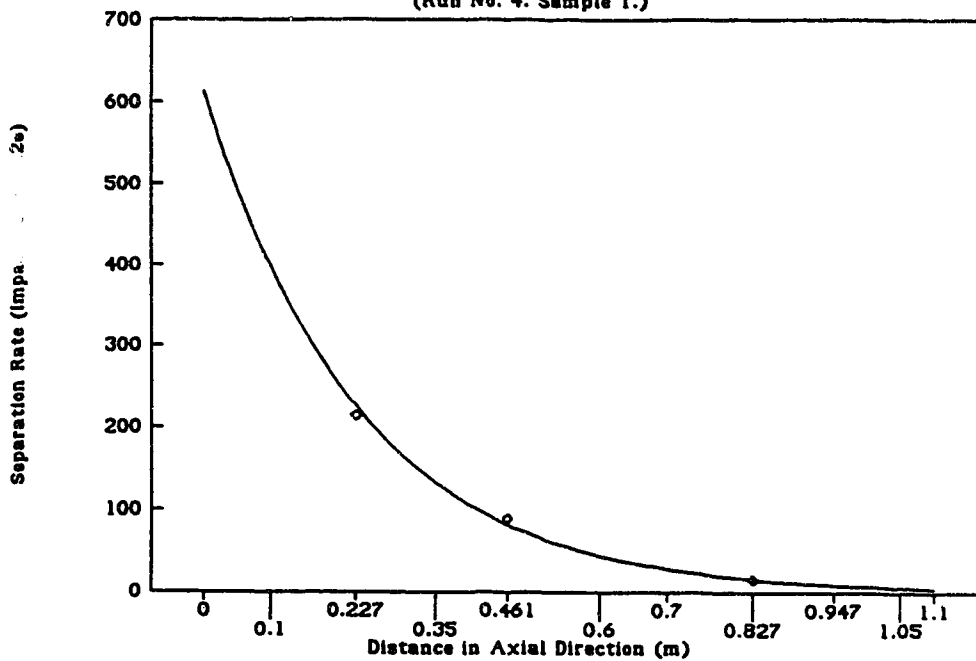
(Run No.4. Sample 7.)



Appendix IV. 2. The Best Fit Curves in Axial Direction

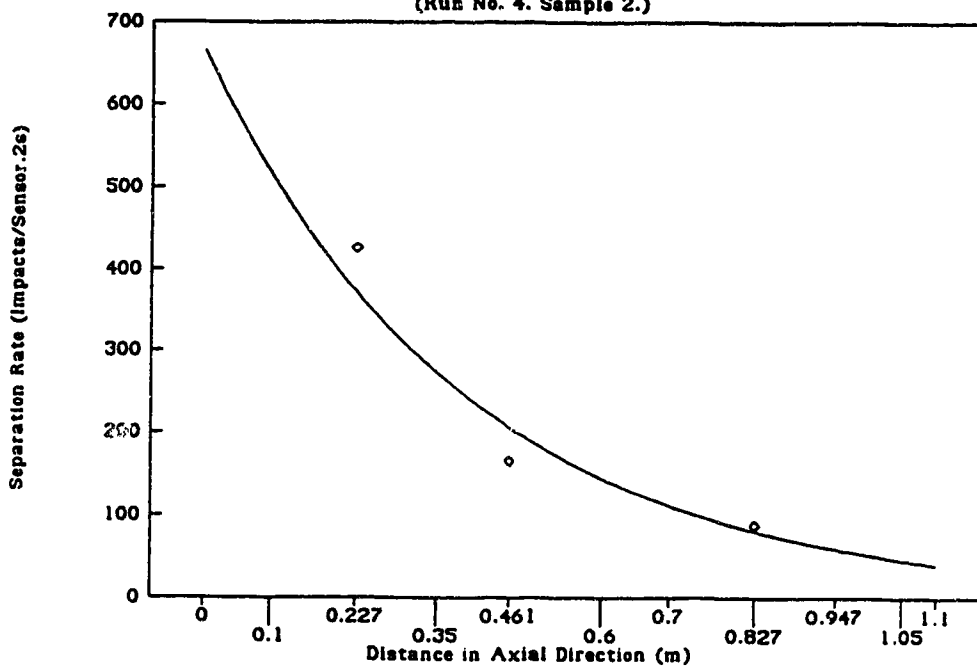
Regression Curve in Axial Direction

(Run No. 4. Sample 1.)



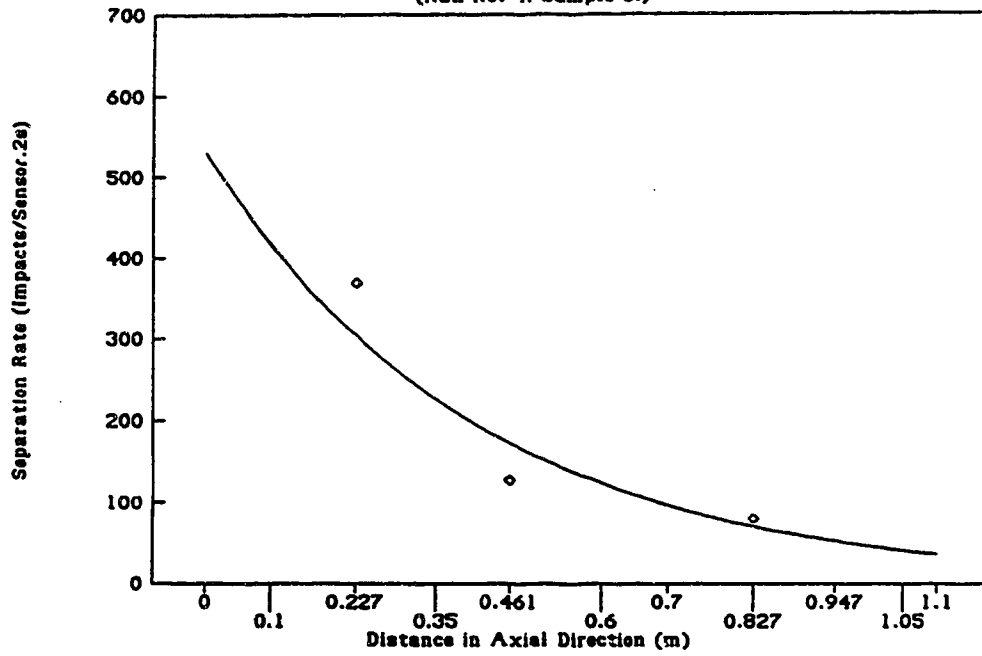
Regression Curve in Axial Direction

(Run No. 4. Sample 2.)



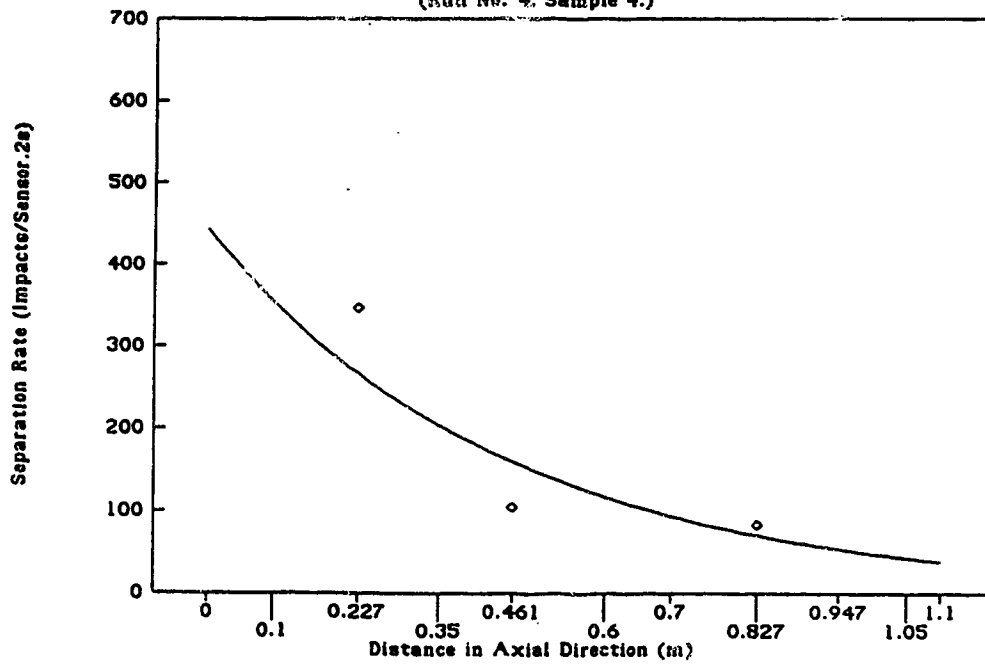
Regression Curve in Axial Direction

(Run No. 4, Sample 3.)



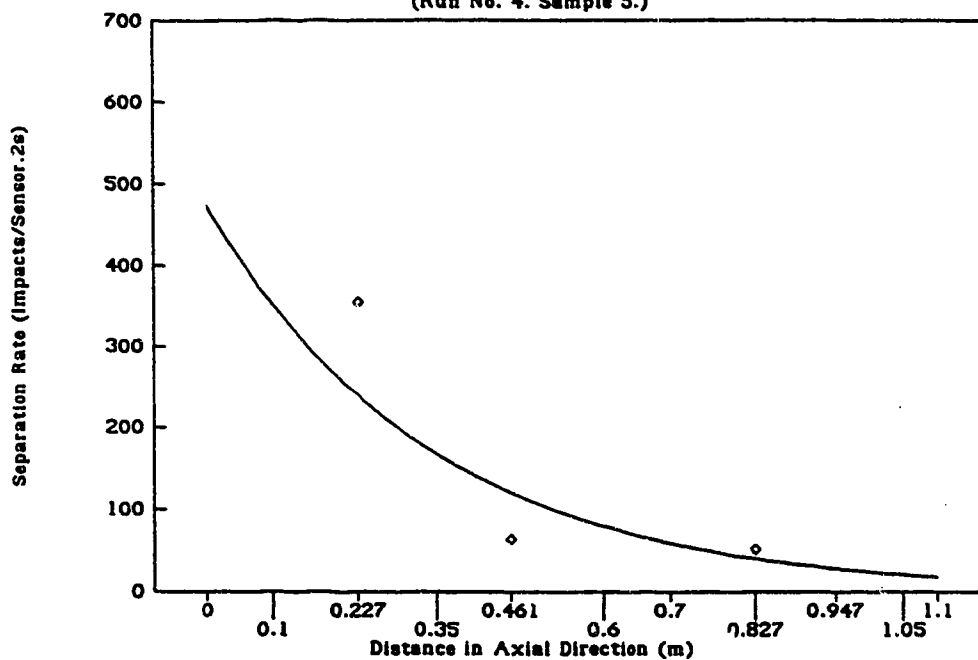
Regression Curve in Axial Direction

(Run No. 4, Sample 4.)



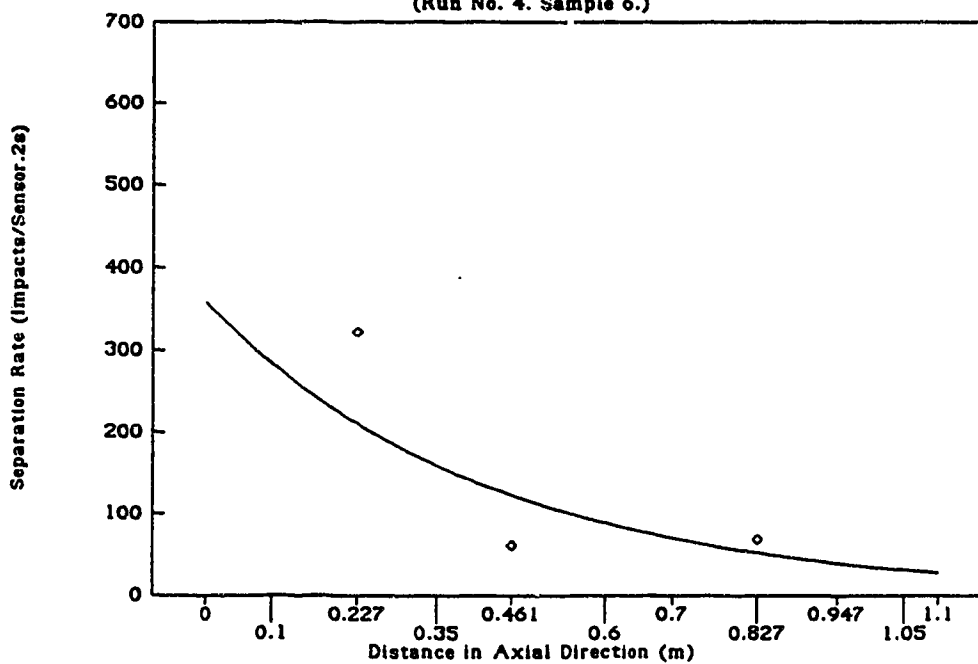
Regression Curve in Axial Direction

(Run No. 4. Sample 5.)



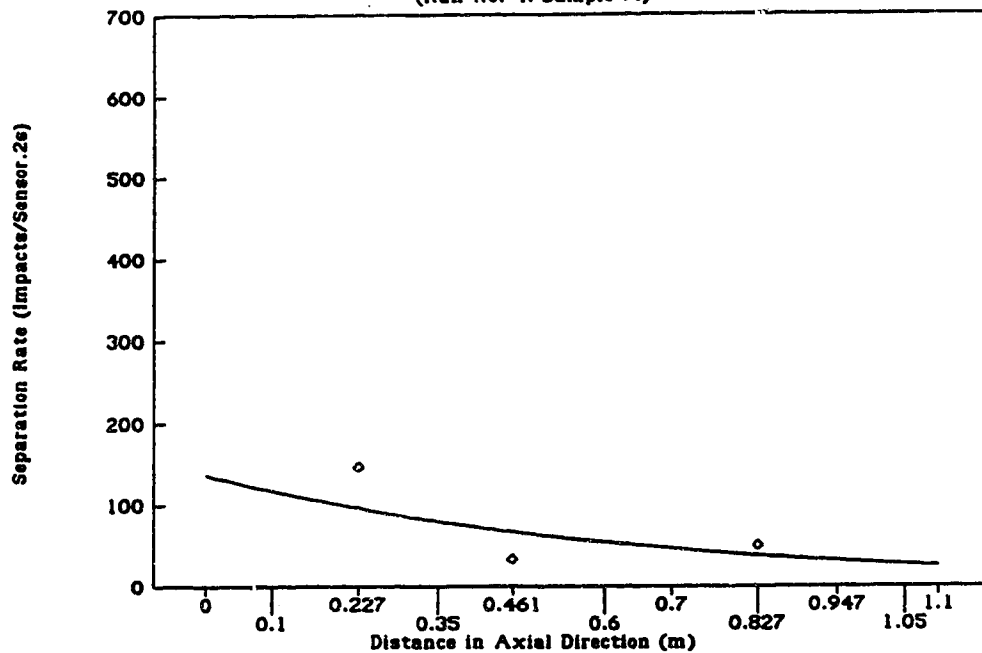
Regression Curve in Axial Direction

(Run No. 4. Sample 6.)



Regression Curve in Axial Direction

(Run No. 4. Sample 7.)



Appendix V.

Combine Grain Loss Monitoring Assembly Language Program List

Microsoft (R) Macro Assembler Version 4.00

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COMBINE GRAIN LOSS MONITOR

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```

= 0071          COUNTER_8 EQU 71H          ;SENSOR 8
= 0072          COUNTER_9 EQU 72H          ;SENSOR 9
= 0073          MODE_3     EQU 73H
= 0080          CWO00     EQU 80H          ;SIX DIFFERENT COMBINATIONS
= 0089          CWO01     EQU 89H          ;FOR I/O PORT 8255.
= 0090          CWIO0     EQU 90H          ;I - INPUT, O - OUTPUT.
= 0099          CWIOI     EQU 99H
= 0092          CWIIO     EQU 92H
= 009B          CWIII     EQU 9BH
= 0000          STACK_BS EQU 0000H        ;STACK POINT
= 0000          POINT     EQU 0000H
= 27FF          YEAR     EQU 27FFH        ;THESE VARIABLES ARE THE
= 27FE          MONTH    EQU 27FEH        ;ADDRESSES OF MEMORY UNITS IN
= 27FD          DATE     EQU 27FDH        ;REAL TIME CLOCK. THEY CAN
= 27FC          DAY      EQU 27FCH        ;BE ACCESSED AS REGULAR RAM.
= 27FB          HR       EQU 27FBH
= 27FA          MIN      EQU 27FAH
= 27F9          SEC      EQU 27F9H
= 27F8          RTCTRL   EQU 27F8H        ;REAL TIME CONTRL WORD ADDRESS.

0400          ORG 0400H
0400 1000[     GUT_PUT   DB 1000H DUP(0)  ;UP LOAD DATA AREA IN RAM.
0000          ]

2000          ORG 2000H
2000 0000     RUN_No    DW 0              ;THE NUMBER OF RUNS.
2002 0000     SAMPLE_No DW 0              ;THE NUMBER OF SAMPLES.
2004 0000     SAMPLE_No_1 DW 0           ;THE NUMBER OF SAMPLES FOR PRINT SIZE
;CALCULATE.
2006 0000     OUT_MEM   DW 0              ;KEEP THE CURRENT ADDRESS OF OUT-FILE.
2008 00       FLAG1    DB 0              ;DISPLAY LENGTH COUNTER LCD FULL IT=10H
2009 00       FLAG2    DB 0              ;AFTER CALL WORKING SET TO 1.
200A 00       FLAG3    DB 0              ;DISPLAY REAL TIME CLOCK.
200B 00       FLAG5    DB 0              ;IF SET, INTERRUPT HAS BEEN SERVICED.
200C 00       FLAG6    DB 0              ;SET YEAR OR HOUR.
200D 00       FLAG7    DB 0              ;1D33H.
200E ?????    POINT_S  DW ?              ;
2010 ?????    POINT_S1 DW ?              ;PROTECT THE POSITION WHERE THE NEXT
;LETTER DIS
2012 ??       KEY_DIS   DB ?              ;FOR PRESSED KEY DISPLAY
2013 0014[    STRING    DB 20 DUP(?)     ;FOR COMMAND STORAGE
??          ]

2027 ??       COUTER_A  DB ?              ;THIS PART WAS THE VARIABLES FOR
2028 ??       COUTER_B  DB ?              ;KEYBOARD MONITOR PROGRAM.
2029 ??       ALM       DB ?
202A ??       BLM       DB ?
202B ?????    PRESS_T  DW ?              ;TIMES THE KEYS WERE PRESSED
202D ?????    KEY_NUMBER DW ?           ;WHICH KEY WAS PRESSED
202F 0010[    YEAR_RAM  DB 16 DUP(?)     ;YEAR -- DAY IN RAM WOULD BE IN LCD
??          ]

203F 0010[    HOUR_RAM  DB 16 DUP(?)     ;HOUR -- SECOND IN RAM FOR LCD
??          ]

204F ??       I_T_V     DB ?              ;INTERVAL TIME VARIABLE
2050 ??       T_RAM1    DB ?              ;
2051 ??       T_RAM2    DB ?              ;
2052 0010[    P_DATA    DW 16 DUP(?)     ;1D34H--1D43H
????        ]

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2072 0010[          DATA_DISPLAY DB 16 DUP(0)          ;DATA TO BE DISPLAYED STORAGE
      00          ]
2082 00          LEFT          DB          0          ;RESERVED FOR DISPLAY CHANNELS
      ;NUMBER 1,3,5,7,9
2083 00          RIGHT         DB          0          ;RESERVED FOR DISPLAY CHANNELS
      ;NUMBER 2,4,6,8,0
-----
;
;          NEXT PART OF MEMORY NEEDS TO BE CLEARED
;          AFTER EACH SAMPLE DATA PROCESSING.
;
-----
2084 0002[          RANGE          DW          2 DUP(0)      ;SENSOR RANGE DETERMINATION WORD
      0000          ]
2088 0000          RANGE_1        DW          0          ;AFTER ENLARGEMENT DATA STORE HERE
208A 0000          SEN_RM          DW          0          ;SENSORS ADDR. MEMORY UNIT
208C 0000          SEN_L_RM        DW          0          ;SENSORS LOGRITHM ADDR. MEMORY UNIT
208E 0000          N              DW          0          ;N IN EQU. Ln10^N
2090 0000          N_DIVIDE        DW          0
2092 0000          Xi_M           DW          0          ;Xi ADDRESS MEMORY UNIT
2094 0000          LnY1_M          DW          0          ;LnY1 ADDRESS MEMORY UNIT
2096 00          SIGN_X           DB          0          ;THE SIGN OF SIG(Xi-Xmean)
2097 00          SIGN_Y           DB          0          ;THE SIGN OF SIG(Yi-Ymean)
2098 00          SIGN_SIGMA        DB          0          ;THE SIGN OF D
2099 0000          X1_Xm_M          DW          0          ;X1-Xm ADDR. FOR CALCULATE (Xi-Xm)^2
209B 00          ABOVE_16          DB          0          ;FLAG = 1 WHEN DIVISOR IS >=65536
209C 0004[          EXP_N          DW          4 DUP(0)      ;THE RESULT OF EXP N BIN
      0000          ]
20A4 0000          Z_MEAN_RM        DW          0          ;STORE Z_MEAN_1 ADDRESS
20A6 0000          OUT_PUT_RM        DW          0          ;STORE OUT_PUT ADDRESS
20A8 0000          DI_MEM          DW          0          ;DISTINATION ADDRESS MEMORY
20AA 0004[          S1_TEMP          DW          4 DUP(0)      ;THE FINAL RESULT TEMPORARY STORSGE
      0000          ]
20B2 0008[          TABLE_M        DW          8 DUP(0)      ;TEMPORARY LOOK_UP TABLE STORAGE UNIT
      0000          ]
20C2 0008[          PAR_PRODUCT      DW          8 DUP(0)      ;PARTIAL PRODUCT OF 8 DIGIT MULTIPLY
      0000          ]
20D2 0008[          INTERMEDIATE    DW          8 DUP(0)      ;2 BYTES FOR ADDING PARTIAL PRODUCT
      0000          ]
20E2 0008[          PRODUCT          DW          8 DUP(0)      ;PRODUCT OF EIGHT DIGIT MULTIPLY
      0000          ]
20F2 0008[          FIVE_PLUS        DW          8 DUP(0)      ;4 OMIT 5 PLUS FOR MULTIPLICATION
      0000          ]
2102 0008[          SIGMA_LnY1_M     DW          8 DUP(0)      ;16 BITS FOR SIGMA Y1 TEMPORARELY
      0000          ]
2112 0008[          MEAN_LnY1        DW          8 DUP(0)      ;16 BITS FOR MEAN VALUE OF LnY1
      0000          ]

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2122 0008[          X1      DW      8 DUP(0)  ;16 BITS FOR X1
      0000          ]
2132 0008[          X2      DW      8 DUP(0)  ;16 BITS FOR X2
      0000          ]
2142 0008[          X3      DW      8 DUP(0)  ;16 BITS FOR X3
      0000          ]
2152 0008[          X0      DW      8 DUP(0)  ;16 BITS FOR X0
      0000          ]
2162 0008[          SIGMA_X1_M DW      8 DUP(0)  ;16 BITS FOR SIGMA X1 TEMPERARELY
      0000          ]
2172 0008[          MEAN_X1   DW      8 DUP(0)  ;MEAN VALUE OF X1
      0000          ]
2182 0008[          COMPLETE  DW      8 DUP(0)  ;0000000010000000 ARE STORED
      0000          ]
2192 0008[          INTERMEDIATE_SUB DW  8 DUP(0)  ;16 BITS FOR THE RESULT OF SUB X1-Xm
      0000          ]
21A2 0008[          SIG_X1_Xm_Y1_Ym DW  8 DUP(0)  ;OR Y1-Ym
      0000          ] ;RESULT OF D's NOMINATOR
21B2 0008[          X1_Xm     DW      8 DUP(0)  ;X1 - Xm
      0000          ]
21C2 0008[          Y1_Ym     DW      8 DUP(0)  ;Y1 - Ym
      0000          ]
21D2 0008[          X1_Xm     DW      8 DUP(0)
      0000          ]
21E2 0008[          X2_Xm     DW      8 DUP(0)
      0000          ]
21F2 0008[          X3_Xm     DW      8 DUP(0)
      0000          ]
2202 0008[          X4_Xm     DW      8 DUP(0)
      0000          ]
2212 0008[          SIG_X1_Xm_SQ_2 DW  8 DUP(0) ;RASULT OF D'S DENOMINATION.
      0000          ]
2222 0008[          SIG_X1_Xm_Y1_Ym_BIN DW  8 DUP(0) ;BIN OF D'S NOMINATION
      0000          ]

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    ]
2232 0008[          SIG_Xi_Xm_BIN      DW    8 DUP(0) ;BIN OF D'S DENOMINATION
      0000          ]
2242 0008[          D_BCD             DW    8 DUP(0)  ;BCD OF D
      0000          ]
2252 0008[          D_BCD_FRACTION   DW    8 DUP(0)  ;BCD FRACTION OF D
      0000          ]
2262 0008[          D_15258          DW    8 DUP(0)  ;SET IN BIN2BCD FOR FRAGMENT PART
      0000          ]
2272 0008[          EXP_b            DW    8 DUP(0)  ;FOR EXP b BCD
      0000          ]
2282 0008[          EXPa_MUL_EXPb_INTEGER DW    8 DUP(0) ;
      0000          ]
2292 0008[          EXPa_MUL_EXPb_FRAGMENT DW    8 DUP(0) ;
      0000          ]
22A2 0008[          C_BIN             DW    8 DUP(0)  ; C = Ymean - D * Xmean
      0000          ]
22B2 0008[          C_BCD             DW    8 DUP(0)  ;
      0000          ]
22C2 0008[          MEAN_LnY1_FOR_C   DW    8 DUP(0)  ;STORE C_BCD FOR C_BIN CONVERT
      0000          ]
22D2 0004[          TIME_START        DW    4 DUP(0)  ;TO TEST THE TIME THE CALCULATE
      0000          ]
22DA 0004[          TIME_FINISH       DW    4 DUP(0)  ;EXCUTING NEEDED.
      0000          ]
22E2 0000          Z1                DW    0
22E4 0000          Z2                DW    0
22E6 0000          Z3                DW    0
22E8 0004[          SIG_Z1           DW    4 DUP(0)
      0000          ]
22F0 0003[          SIG_X1Z1         DW    3 DUP(0)
      0000          ]
22F6 0000          SYMBLE_SIGX1Z1   DW    0          ;SYMBLE 0 =+1 -- FOR SIGMA X1Z1
22F8 0004[          SIG_X1_SQ2_Z1    DW    4 DUP(0)
      0000          ]
2300 0002[          A_DIV_B          DW    2 DUP(0)  ;STORE A/B

```

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```

    0000      ]
2304 0002[      NEGA_B_X0      DW      2 DUP(0)      ;STORE -B*X0
    0000      ]
2308 0002[      EXP_N_B_X0      DW      2 DUP(0)      ;STORE EXP (-B*X0)
    0000      ]
230C 0004[      Z_MEAN          DW      4 DUP(0)
    0000      ]
2314 0003[      A_PARA          DW      3 DUP(0)
    0000      ]
231A 0000      SYMBLE_A_PARA DW      0              ;SYMBLE 0 =+1=-FOR A PAOAMETER
231C 0003[      B_PARA          DW      3 DUP(0)
    0000      ]
2322 0000      SYMBLE_B_PARA DW      0              ;SYMBLE 0 =+1=-FOR B PARAMETER
2324 0003[      C_PARA          DW      3 DUP(0)
    0000      ]
232A 0000      SYMBLE_C_PARA DW      0              ;SYMBLE 0 =+1=-FOR C PARAMETER
2330      ORG      2330H
2330 0000      SENSOR_1        DW      0              ;RAM FOR SENSORS ORIGINAL DATA
2332 0000      SENSOR_2        DW      0
2334 0000      SENSOR_3        DW      0
2336 0000      SENSOR_4        DW      0
2338 0000      SENSOR_5        DW      0
233A 0000      SENSOR_6        DW      0
233C 0000      SENSOR_7        DW      0
233E 0000      SENSOR_8        DW      0
2340 0000      SENSOR_9        DW      0
2342 0000      SENSOR_0        DW      0
2344 0003[      A_PARA_1        DW      3 DUP(0)
    0000      ]
234A 0000      SYMBLE_A_PARA_1 DW      0              ;SYMBLE 0 =+1=- FOR A PAOAMETER
234C 0003[      B_PARA_1        DW      3 DUP(0)
    0000      ]
2352 0000      SYMBLE_B_PARA_1 DW      0              ;SYMBLE 0 =+1=- FOR B PARAMETER
2354 0003[      C_PARA_1        DW      3 DUP(0)
    0000      ]
235A 0000      SYMBLE_C_PARA_1 DW      0              ;SYMBLE 0 =+1=- FOR C PARAMETER
235C 0003[      A_PARA_2        DW      3 DUP(0)
    0000      ]
2362 0000      SYMBLE_A_PARA_2 DW      0              ;SYMBLE 0 =+1=- FOR A PAOAMETER
2364 0003[      B_PARA_2        DW      3 DUP(0)
    0000      ]
    ]

```

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236A 0000          SYMBLE_B_PARA_2 DW      0          ;SYMBLE 0 ==+1== FOR B PARAMETER
236C 0003[        C_PARA_2      DW      3 DUP(0)
      0000          ]

2372 0000          SYMBLE_C_PARA_2 DW      0          ;SYMBLE 0 ==+1== FOR C PARAMETER
2374 0003[        A_PARA_3      DW      3 DUP(0)
      0000          ]

237A 0000          SYMBLE_A_PARA_3 DW      0          ;SYMBLE 0 ==+1== FOR A PARAMETER
237C 0003[        B_PARA_3      DW      3 DUP(0)
      0000          ]

2382 0000          SYMBLE_B_PARA_3 DW      0          ;SYMBLE 0 ==+1== FOR B PARAMETER
2384 0003[        C_PARA_3      DW      3 DUP(0)
      0000          ]

238A 0000          SYMBLE_C_PARA_3 DW      0          ;SYMBLE 0 ==+1== FOR C PARAMETER
238C 0004[        Z_MEAN_1      DW      4 DUP(0) ;MEAN VALUE OF SENSORS IN ARC
      0000          ]

2394 0004[        Z_MEAN_2      DW      4 DUP(0) ;DIRECTION
      0000          ]

239C 0004[        Z_MEAN_3      DW      4 DUP(0)
      0000          ]

23A4 0004[        Z_MEAN_1_L    DW      4 DUP(0) ;RAM RESERVED FOR LOGRITHM
      0000          ]

23AC 0004[        Z_MEAN_2_L    DW      4 DUP(0)
      0000          ]

23B4 0004[        Z_MEAN_3_L    DW      4 DUP(0)
      0000          ]

23BC 0004[        A_COEF        DW      4 DUP(0) ;STORE A COEF. OF A/B*EXP(-B*X0)
      0000          ]

23C4 0003[        D_BIN         DW      3 DUP(0) ;BIN OF D = B
      0000          ]

23CA 0000          SYMBLE_B          DW      0          ;SYMBLE 0 = +1 ==-FOR C PARAMETER
23CC 0004[        LOSS_DATA_1    DW      4 DUP(0) ;STORE A/B*EXP(-B*X0)
      0000          ]

23D4 0004[        LOSS_DATA      DW      4 DUP(0) ;STORE K*A/B*EXP(-B*X0)
      0000          ]

```

```

-----;
; THE FOLLOWING MEMORY WAS TO STORE THE FORMAT OF ;
; THE PRINTED FILE. THE FORMAT WOULD BE SENT TO PRINTER ;

```

```

:          (SAMPLE SHAK TP-10) WITH THE DATA FILLED IN THE BLANK
:          SPACES IN THE FORMAT FILE.
:-----:
23E0          ORG          23E0H          ;FORMAT OF PRINTED FILE
23E0 53 41 4D 50 4C 45 20 OUT_PUT_1 DB 'SAMPLE -----'
20 2D 2D 2D 2D 2D 2D 2D
2D 2D 2D 2D 2D 2D 2D 2D
20 20
23F7 20 20 20 20 20 20 20 SAMPLE DB ' '
20 20
2400 20 20 20 20 20 20 20 DB
20 20 20 20 20 20 20 20
20 20 20 20 20 20 20 20
20 20 20 20 20 20 20 20
20 20 20 20
2420 53 31 20 3D 20          DB 'S1 = '
2425 30 30 30 30 20 20 20 S1 DB '0000 S2 = '
20 20 20 20 20 53 32 20
3D 20
2435 30 30 30 30 20 20 20 S2 DB '0000 '
20 20 20 20
2440 53 33 20 3D 20          DB 'S3 = '
2445 30 30 30 30 20 20 20 S3 DB '0000 S4 = '
20 20 20 20 20 53 34 20
3D 20
2455 30 30 30 30 20 20 20 S4 DB '0000 '
20 20 20 20
2460 53 35 20 3D 20          DB 'S5 = '
2465 30 30 30 30 20 20 20 S5 DB '0000 S6 = '
20 20 20 20 20 53 36 20
3D 20
2475 30 30 30 30 20 20 20 S6 DB '0000 '
20 20 20 20
2480 53 37 20 3D 20          DB 'S7 = '
2485 30 30 30 30 20 20 20 S7 DB '0000 S8 = '
20 20 20 20 20 53 38 20
3D 20
2495 30 30 30 30 20 20 20 S8 DB '0000 '
20 20 20 20
24A0 53 39 20 3D 20          DB 'S9 = '
24A5 30 30 30 30 20 20 20 S9 DB '0000
20 20 20 20 20 20 20 20
20 20 20 20 20 20 20 20
20 20 20 20 20 20 20 20
20 20 20 20
24C0 20 20 20 20 20 20 20 DB
20 20 20 20 20 20 20 20
20 20 20 20 20 20 20 20
20 20 20 20 20 20 20 20
20 20 20 20
24E0 41 31 20 3D 20          DB 'A1 = '
24E5 2B 31 32 33 34 2E 35 A1 DB '+1234.5678 B1 = '
36 37 38 20 20 42 31
20 3D 20
24F6 2B 31 32 33 34 2E 35 B11 DB '+1234.5678'
36 37 38
2500 43 31 20 3D 20          DB 'C1 = '
2505 2B 31 32 33 34 2E 35 C11 DB '+1234.5678 Z1 = '
36 37 38 20 20 5A 31
20 3D 20
2516 20 31 32 33 34 2E 30 Z21 DB ' 1234.0000'
30 30 30
2520 20 20 20 20 20 20 20 DB
20 20 20 20 20 20 20 20
20 20 20 20 20 20 20 20
20 20 20 20 20 20 20 20
20 20 20 20
2540 41 32 20 3D 20          DB 'A2 = '

```


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```

0000 B8 0000          START:      MOV     AX,STACK_BS ;SET STACK SEGMENT.
0003 8E D0           MOV     SS,AX
0005 BC 27F0         MOV     SP,27F0H   ;SET STACK POINT
0008 B0 90           MOV     AL,CW100   ;INITIALIZATION PIO.
000A E6 03           OUT     IOCTR,AL
000C B9 0014         MOV     CX,20      ;DELAY 20mS.
000F E8 1EE8 R       CALL    DNIMS
0012 E8 1B33 R       CALL    LCD_INIT   ;INICTIONALIZATION OF LCD
0015 E8 1AEF R       CALL    DIS_TITLE  ;DISPLAY TITLE (THIS SUBROUTINE
                                ;WAS USED FOR THE SYSTEM BASIC
                                ;FUNCTION TEST.).

0018 FC             CLD
0019 BE CEC6         MOV     SI,0CEC6H ;POINT TO PRINT FILE ADDRESS.
001C 8D 3E 23E0 R   LEA     DI,OUT_PUT_1 ;THE ADDRESS OF TABLE TO BE FILLED
0020 B9 0160         MOV     CX,22*16   ;22 RAWs EACH RAW 16 WORDS
0023 F3/ A5         REP     MOVSW      ;THE SOURCE PRINT FILE WAS AT
0025                                ;EPROM
0025 B0 99           MOV     AL,CWIOI   ;COMMAND WORDS FOR 8255-2
0027 E6 53           OUT     IOCTR_2,AL ;I/O A IN, I/O B OUT, I/O C IN
0029 B0 04           MOV     AL,00000100B ;8255-2 I/O B BIT 2 OUTPUT HIGH
002B E6 51           OUT     IOB_2,AL
002D B0 70           MOV     AL,01110000B ;SET OUT(INTERRUPT REQUEST) ZERO
002F E6 23           OUT     TIMER_M,AL ;MODE 0 INTERRUPT ON COUNT
                                ;TERMINATION

0031 B0 00           MOV     AL,00H
0033 A2 2008 R       MOV     [FLAG1],AL ;COUNTER OF THE LCD POSITION
0036 A2 2009 R       MOV     [FLAG2],AL ;FLAG2 1 FOR TEST BEGIN
0039 A2 200A R       MOV     [FLAG3],AL ;REAL TIME CLOCK DIS
003C A2 200C R       MOV     [FLAG6],AL ;YEAR OR HOUR SET
003F A2 200D R       MOV     [FLAG7],AL ;INTERVAL HAS BEEN SET (FFH)
0042 A2 200B R       MOV     [FLAG5],AL ;GATE TIME = 10 S.
0045 8D 3E 2002 R   LEA     DI,SAMPLE_No ;SAMPLES NUMBER

0049 B8 0000         MOV     AX,00H
004C 89 05           MOV     [DI],AX   ;CLEAR
004E 8D 3E 2004 R   LEA     DI,SAMPLE_No_1
0052 89 05           MOV     [DI],AX

0054 8D 3E 2330 R   LEA     DI,SENSOR_1 ;CLEAR THE SENSORS AREA.
0058 B9 000A         MOV     CX,10
005B B8 0000         MOV     AX,0
005E 89 05           MOV     [DI],AX
0060 47             INC     DI
0061 47             INC     DI
0062 E2 FA           LOOP    GPPE

0064 E8 03A7 R       CALL    CLEAR_DATA_AREA ;CLEAR DATA AREA BEFOR SAMPLING

0067 B8 0000         MOV     AX,0000H
006A A3 202B R       MOV     [PRESS_T],AX ;CLEAR KEY PRESS TIMES

006D BE D24E         MOV     SI,0D24EH ;SEND TIME IN EPROM TO RAM
0070 8D 3E 202F R   LEA     DI,YEAR_RAM
0074 B9 0020         MOV     CX,32
0077 A4             MOVSB  ;BYTE PTR[DI],BYTE PTR[SI]
0078 E2 FD           LOOP    SYS

007A 8D 3E 0400 R   LEA     DI,OUT_PUT ;STORE THE FIRST ADDRESS OF
007E 89 3E 2006 R   MOV     [OUT_MEM],DI ;SAMPLE & RESULT OUTPUT FILE.

0082 8D 1E 2072 R   LEA     BX,DATA_DISPLAY ;POINT TO DATA DISPLAY UNIT
0086 B8 5250         MOV     AX,'RP'   ;DISPLAY 'PRESS F2 TO TEST'
0089 89 07           MOV     [BX],AX
008B B8 5345         MOV     AX,'SE'
008E 89 47 02       MOV     [BX+2],AX
0091 B8 2053         MOV     AX,' S'
0094 89 47 04       MOV     [BX+4],AX

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```

0097 B8 3246      MOV     AX, '2F'
009A B9 47 06     MOV     [BX+6],AX
009D B8 5420      MOV     AX, 'T '
00A0 B9 47 08     MOV     [BX+8],AX
00A3 B8 204F      MOV     AX, ' O'
00A6 B9 47 0A     MOV     [BX+10],AX
00A9 B8 4554      MOV     AX, 'ET'
00AC B9 47 0C     MOV     [BX+12],AX
00AF B8 5453      MOV     AX, 'TS'
00B2 B9 47 0E     MOV     [BX+14],AX
00B5 E8 1EBC R    CALL    DISPLAY_1      ;DIS 'PRESS F2 TO TEST' WITHOUT
                                ;1s TIME DELAY.
                                ;CHECK THE DIP SWITCH.
00B8 E4 50          K_00:   IN     AL,IOA_2
00BA B2 00          MOV     DL,00H
00BC 3A C2          CMP     AL,DL          ;IF = 00H THEN CLEAR DATA AREA.
00BE 74 F8          JZ     K_00
00C0 E4 50          K_80:   IN     AL,IOA_2      ;AT THE END OF MAIN PROGRAM
00C2 B2 80          MOV     DL,80H        ;JMP TO HERE.
00C4 3A C2          CMP     AL,DL
00C6 75 F0          JNZ    K_00
00C8 8D 1E 2009 R  LEA    BX,FLAG2      ;CHECK FLAG2 IF 1 TEST IS BEGINS.
00CC B0 01          MOV     AL,01H        ;FLAG2 WAS SET IN WORKING.
00CE 3A 07          CMP     AL,[BX]
00D0 74 04          JZ     III           ;JUMP TO INTERRUPT WAITING LOOP
00D2 FA           CLI           ;IF FLAG2 NO EQUAL TO 1,
                                ;CLEAR INTERRUPT.
00D3 E9 15ED R    JMP     KEY_SCANNING ;=80H TO KEY SCANNING
00D6 B0 FE          III:    MOV     AL,0FEH
00D8 E6 31          OUT    31H,AL        ;OCW1
00DA B0 60          MOV     AL,60H
00DC E6 30          OUT    30H,AL        ;OCW2
00DE B0 08          MOV     AL,08H
00E0 E6 30          OUT    30H,AL        ;OCW3
00E2 B0 00          MOV     AL,0          ;IF FLAG2 = 0
00E4 3A 06 2009 R  CMP     AL,[FLAG2]
00E8 74 03          JZ     INT_OFF       ;DISABLE INTERRUPT
00EA EB 05 90          JMP     INT_ON
00ED FA           INT_OFF: CLI
00EE E9 0025 R    JMP     RUN_I        ;GO TO THE BEGINNING FOR NEXT RUN
00F1 FB           INT_ON:  STI
00F2 EB E2          JMP     III
00F4          OUR_PROG  ENDP
                                ;
                                ; WORKING
                                PROC     NEAR
                                ;-----;
                                ; 1. CALL INTERRUPT_INI. 2. CALL COUNTER_INI ;
                                ; 3. SET THE FLAG2 IN TO 1. ;
                                ; 4. DISPLAY TEST ON LCD. ;
                                ;-----;
00F4 E8 0138 R    CALL    INTERRUPT_INI
00F7 E8 0182 R    CALL    COUNTER_INI
00FA E8 01DD R    CALL    PULS_GENERATE ;GENERATE A PULS TO TRIGGE COUNTER
                                ;AFTER CALL THE S & COUN GATE ARE
                                ;OPEND.
00FD 8D 3E 2009 R  LEA    DI,FLAG2
0101 C6 05 01      MOV     BYTE PTR[DI],01H ;IF THIS FLAG KEEP 1, THE
                                ;INTERRUPT WILL BE ENABLE
0104 8D 1E 2072 R  LEA    BX,DATA_DISPLAY ;POINT TO DATA DISPLAY UNIT
0108 B8 4554      MOV     AX, 'ET'

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```

010B 89 07          MOV     [BX],AX
010D B8 5453        MOV     AX,'TS'
0110 89 47 02      MOV     [BX+2],AX
0113 B8 2020        MOV     AX,' '
0116 89 47 04      MOV     [BX+4],AX
0119 B8 4542        MOV     AX,'EB'
011C 89 47 06      MOV     [BX+6],AX
011F B8 4947        MOV     AX,'IG'
0122 89 47 08      MOV     [BX+8],AX
0125 B8 204E        MOV     AX,'N'
0128 89 47 0A      MOV     [BX+10],AX
012B B8 2020        MOV     AX,' '
012E 89 47 0C      MOV     [BX+12],AX
0131 89 47 0E      MOV     [BX+14],AX
0134 E8 1EBC R     CALL    DISPLAY_1      ;DIS 'TEST BEGING'
                                ;WITHOUT 1s DELAY.

0137 C3           RET

                                WORKING      ENDP
                                ;
                                ;
0138                                INTERRUPT_INI      PROC      NEAR
                                ;-----;
                                ; THIS SUBROUTINE INITIALISE ;
                                ; 1. PROGRAMMA... CONTROLLER 8259A ;
                                ; 2. TIMER AND... ;
                                ; a) BAUD RATE GENERATOR b) SECOND SQUARE WAVE GENERATOR ;
                                ;-----;
                                ;PART 1: ... entry address.
0138 BB 0060        MOV     SI,0060H      ;ENTRY ADDRESS
013B BE FC1D        MOV     AX,0FC1DH     ;VECTOR IS 18H 18H*4=60H
013E 89 37          MOV     [BX],SI

0140 BB 0062        MOV     BX,0062H      ;SET CS VALUE FOR INTERRUPT
0143 B8 0000        MOV     AX,0000H
0146 89 07          MOV     [BX],AX

                                ;PART 2: INICIALIZE FOR 8259 INTERRRUPT FUNCTION.
0148 B0 13          MOV     AL,13H
014A E6 30          OUT     COM_WRD_1,AL ;ICW1 COMMAVD WORD 1

014C B0 18          MOV     AL,18H
014E E6 31          OUT     COM_WRD_234,AL ;ICW2

0150 B0 0D          MOV     AL,0DH
0152 E6 31          OUT     COM_WRD_234,AL ;ICW4

                                ;PART 3: INICIALIZE 8253
0154 B0 36          MOV     AL,00110110B ;INICIALIZE TIMER CHENNEL 0
0156 E6 23          OUT     TIMER_M,AL ;AS BAUD RATE GENERATER
0158 B0 04          MOV     AL,04H      ;LOAD LSB 04H
015A E6 20          OUT     TIMER_0,AL
015C B0 01          MOV     AL,01H      ;LOAD MSB 01H
015E E6 20          OUT     TIMER_0,AL

0160 B0 70          MOV     AL,01110000B ;CHENNEL 1
0162 E6 23          OUT     TIMER_M,AL ;MODE 0 INTERRUPT ON TERMINAL COUNT
0164 B0 1F          MOV     AL,1FH      ;IT IS USED TO BE 1FH FOR IS.
0166 E6 21          OUT     TIMER_1,AL ;LOAD LSB
0168 B0 C3          MOV     AL,0C3H     ;IT USED TO BE 0C3H FOR 1S.
016A E6 21          OUT     TIMER_1,AL ;LOAD MSB

016C B0 B6          MOV     AL,10110110B ;CHENNEL 2
016E E6 23          OUT     TIMER_M,AL ;MODE 3 AS A SQUARE WAVE GENERATOR
0170 B0 64          MOV     AL,64H      ;IT USED TO BE 32 FOR 1S.
0172 E6 22          OUT     TIMER_2,AL ;LOAD LSB
0174 B0 00          MOV     AL,00H

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0176 E6 22          OUT     TIMER_2,AL    ;LOAD MSB

0178 B0 99          MOV     AL,CWIOI
017A E6 53          OUT     IOCTR_2,AL
017C B0 8C          MOV     AL,10001100B ;AFTER INICIALISATION OPEN
017E E6 51          OUT     IOB_2,AL     ;THE SECOND AND SENSORS GATA.

0180 FA            CLI                      ;CLEAR INTERRUPT FLAG

0181 C3            RET

                                INTERRUPT_INI      ENDP
                                ;
                                ;
0182              ; COUNTER_INI  PROC      NEAR
                                ;-----;
                                ;PROGRAMMABLE COUNTERS 1 -- 9 ;
                                ;INICIALIZATION ;
                                ;-----;
0182 B0 30          MOV     AL,00110000B
0184 E6 43          OUT     MODE_1,AL    ;CHANNEL 1 MODE
0186 B0 00          MOV     AL,00H
0188 E6 40          OUT     COUNTER_1,AL ;LSB LOAD
018A E6 40          OUT     COUNTER_1,AL ;MSB LOAD

018C B0 70          MOV     AL,01110000B
018E E6 43          OUT     MODE_1,AL    ;CHANNEL 2 MODE
0190 B0 00          MOV     AL,00H
0192 E6 41          OUT     COUNTER_2,AL ;LSB LOAD
0194 E6 41          OUT     COUNTER_2,AL ;MSB LOAD

0196 B0 B0          MOV     AL,10110000B
0198 E6 43          OUT     MODE_1,AL    ;CHANNEL 3 MODE
019A B0 00          MOV     AL,00H
019C E6 42          OUT     COUNTER_3,AL ;LSB LOAD
019E E6 42          OUT     COUNTER_3,AL ;MSB LOAD

01A0 B0 30          MOV     AL,00110000B
01A2 E6 63          OUT     MODE_2,AL    ;CHANNEL 4 MODE
01A4 B0 00          MOV     AL,00H
01A6 E6 60          OUT     COUNTER_4,AL ;LSB LOAD
01A8 E6 60          OUT     COUNTER_4,AL ;MSB LOAD

01AA B0 70          MOV     AL,01110000B
01AC E6 63          OUT     MODE_2,AL    ;CHANNEL 5 MODE
01AE B0 00          MOV     AL,00H
01B0 E6 61          OUT     COUNTER_5,AL ;LSB LOAD
01B2 E6 61          OUT     COUNTER_5,AL ;MSB LOAD

01B4 B0 30          MOV     AL,10110000B
01B6 E6 63          OUT     MODE_2,AL    ;CHANNEL 6 MODE
01B8 B0 00          MOV     AL,00H
01BA E6 62          OUT     COUNTER_6,AL ;LSB LOAD
01BC E6 62          OUT     COUNTER_6,AL ;MSB LOAD

01BE B0 30          MOV     AL,00110000B
01C0 E6 73          OUT     MODE_3,AL    ;CHANNEL 7 MODE
01C2 B0 00          MOV     AL,00H
01C4 E6 70          OUT     COUNTER_7,AL ;LSB LOAD
01C6 E6 70          OUT     COUNTER_7,AL ;MSB LOAD

01C8 B0 70          MOV     AL,01110000B
01CA E6 73          OUT     MODE_3,AL    ;CHANNEL 8 MODE
01CC B0 00          MOV     AL,00H
01CE E6 71          OUT     COUNTER_8,AL ;LSB LOAD
01D0 E6 71          OUT     COUNTER_8,AL ;MSB LOAD

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01D2 B0 B0          MOV     AL,10110000B
01D4 E6 73          OUT     MODE_3,AL      ;CHANNEL 9 MODE
01D6 B0 00          MOV     AL,00H
01D8 EC 72          OUT     COUNTER_9,AL  ;LSB LOAD
01DA E6 72          OUT     COUNTER_9,AL  ;MSB LOAD

01DC C3            RET

COUNTER_INI ENDP
;
;
01DD              PULS_GENERATE PROC NEAR
;-----;
;THIS SUBROUTINE IS TO GENERATE A PULS ;
;TRIGGE THE COUNTERS THE FUNCTION IS ;
;EQUAL TO CLEAR COUNTERS. ;
;-----;
01DD B0 99          MOV     AL,CWIOI
01DF E6 53          OUT     IOCTR_2,AL
01E1 B0 8C          MOV     AL,10001100B
01E3 E6 51          OUT     IOB_2,AL
01E5 90            NOP
01E6 90            NOP           ;TIME DELAY
01E7 90            NOP
01E8 90            NOP
01E9 B0 88          MOV     AL,10001000B ;SEND A NEGATIVE PULS
01EB E6 51          OUT     IOB_2,AL    ;TO CLEAR COUNTER.
01ED 90            NOP
01EE 90            NOP           ;TIME DELAY.
01EF 90            NOP
01F0 90            NOP
01F1 B0 8C          MOV     AL,10001100B ;NOW COUNTERS HAS BEEN CLEAR,SD
01F3 E6 51          OUT     IOB_2,AL

01F5 C3            RET

PULS_GENERATE ENDP

;-----;
; PART 2. REAL TIME DATA ACQUISITION AND PROCESSING. ;
;-----;

01F6              REAL_TIME_DATA_PROCESSING PROC NEAR
;-----;
; This program was to conduct the best fit and regression ;
; calculation. ;
; 1. The best fit in arc direction was conducted at three ;
; different cross section positions. The results were ;
; parameters A B & C for the model  $Z = A + BX + CX^2$ . ;
; The meanvalues Z_MEAN_1, Z_MEAN_2 & Z_MEAN_3 would be ;
; obtained. ;
; 2. The axial diraction regression was conducted. The ;
; results were A & B for the model  $Z = A \text{ EXP } (-BY)$  ;
; 3. The actual grain loss then would be predicted. ;
; the formula for this calculation is: ;
;  $GL = K * A/B \text{ EXP } (-BY0)$  ;
;-----;
; LEA     BX,TIME_START ;THIS 6 INSTRUCTIONS WERE FOR
; PUSH    BX           ;TSTING THE RTDR EXECUTION TIME
; PUSH    CX
; CALL    CLOCK_READ
; POP     CX
; POP     BX

01F6 8D 36 2330 R   LEA     SI,SENSOR_1 ;IF SENSOR_1 -- 9 = 0
01FA B8 0000        MOV     AX,0         ;DO NOT CALCULATE.
01FD 39 04          CMP     [SI],AX

```

```

01FF 75 2B          JNZ     TO_CALCUL
0201 39 44 02      CMP     [SI+2],AX
0204 75 26          JNZ     TO_CALCUL
0206 39 44 04      CMP     [SI+4],AX
0209 75 21          JNZ     TO_CALCUL
020B 39 44 06      CMP     [SI+6],AX
020E 75 1C          JNZ     TO_CALCUL
0210 39 44 08      CMP     [SI+8],AX
0213 75 17          JNZ     TO_CALCUL
0215 39 44 0A      CMP     [SI+10],AX
0218 75 12          JNZ     TO_CALCUL
021A 39 44 0C      CMP     [SI+12],AX
021D 75 0D          JNZ     TO_CALCUL
021F 39 44 0E      CMP     [SI+14],AX
0222 75 08          JNZ     TO_CALCUL
0224 39 44 10      CMP     [SI+16],AX
0227 75 03          JNZ     TO_CALCUL
0229 E9 0317 R      JMP     RESULT_MOVING

022C FC           TO_CALCUL:  CLD
022D BE C2C6      MOV     SI,0CEC6H ;POINT OUT THE REAL ADDRESS OF TABLE
0230 8D 3E 23E0 R LEA     DI,OUT_PUT_1 ;THE ADDRESS OF TABLE TO BE FILLED.
0234 B9 0160      MOV     CX,22*16 ;TABLE HAS 22 ROWS EACH RAW 16 WORDS
0237 F3/ A5      REP     MOVSW ;THE SOURCE TABLE IS AT EPROM

;-----;
; NEXT PART IS BEST FIT IN ARC DIRECTION. ;
; 1. THE MODEL IS  $Z \approx A + B*X + C*X^2$  ;
; 2. THE PARAMETERS TO BE CALCULATED ARE A, B & C. ;
; 3. Z_MEAN 1 THRUUGH 3 ARE STORED IN Z_MEAN_1--Z_MEAN_3 ;
; FOR LOGARISM CALCULATION. ;
; 4. ALL THE PARAMETERS & Z MEANS ARE SENT TO OUT_PUT_1 ;
; FOR UPLOAD OR PRINT, 200H STORAGE SPACE WERE RESERVED ;
;-----;

0239 FC           CLD
023A 8D 36 2330 R LEA     SI,SENSOR_1
023E 8D 3E 22E2 R LEA     DI,Z1
0242 B9 0003      MOV     CX,03
0245 F3/ A5      REP     MOVSW ;BEFOR CALL DATA IN SENSORS,
0247 8D 3E 238C R LEA     DI,Z_MEAN_1 ;SENT DATA TO Z1 Z2 Z3.
024B 89 3E 20A4 R MOV     [Z_MEAN_RM],DI
024F E8 03DE R      CALL    ARC_REG

0252 FC           CLD
0253 8D 36 2314 R LEA     SI,A_PARA
0257 8D 3E 2344 R LEA     DI,A_PARA_1
025B B9 000C      MOV     CX,12 ;AFTER ARC DIRECTION REGRESSION
J25E F3/ A5      REP     MOVSW ;A B C ARE SENT TO OUT PUT AREA
0260 E8 040A R      CALL    CLEAR_A_B_C

0263 FC           CLD
0264 8D 36 2336 R LEA     SI,SENSOR_4
0268 8D 3E 22E2 R LEA     DI,Z1
026C B9 0003      MOV     CX,03
026F F3/ A5      REP     MOVSW ;BEFOR CALL DATA IN SENSORS
0271 8D 3E 2394 R LEA     DI,Z_MEAN_2 ;SENT DATA TO Z1 Z2 Z3 .
0275 89 3E 20A4 R MOV     [Z_MEAN_RM],DI
0279 E8 03DE R      CALL    ARC_REG

027C FC           CLD

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0317                                RESULT_MOVING:
                                ;-----NEXT PART IS RESULT MOVING TO UP LOAD AREA-----;
0317 8D 3E 2002 R                LEA    DI,SAMPLE_No ;POINT TO SAMPLE NUMBER
031B 8E 05                        MOV    AX,[DI]
031D 40                            INC    AX             ;NEXT SAMPLE
031E 37                            AAA
031F 89 05                        MOV    [DI],AX
0321 0D 3030                       OR     AX,3030H
0324 8D 36 23F9 R                LEA    SI,SAMPLE+2
0328 8B D0                        MOV    DX,AX
032A 8A C6                        MOV    AL,DX
032C 8A E2                        MOV    AH,DL
032E 89 04                        MOV    [SI],AX
0330 BA 3131                       MOV    DX,3131H
0333 3B C2                        CMP    AX,DX         ;SAMPLES NUMBER = 10 ?
0335 75 03                        JNZ   KFT           ;NO, CONTINUE.

0337 EB 58 90                    JMP    KFT_1        ;AFTER TEST AND PRINT OUT GO TO
                                ;CLEAR DATA AREA.
033A EB 1442 R                    KFT:   CALL   SENSOR_MOVING ;MOVE SENSOR DATA TO UP LODING AREA
033D EB 14B6 R                    CALL   ABC_MOVING   ;MOVE A B & C PARAMETERS TO UP LOAD
0340 EB 152F R                    CALL   Z_MEAN_Ln_MOV ;MOVE Z_MEAN Ln VALUE TO UP LOAD

0343 8D 36 23BC R                LEA    SI,A_COEF    ;THE DATA TO BE CONVERTED
0347 8D 3E 2645 R                LEA    DI,AA
034B 89 3E 20A8 R                MOV    [DI_MEM],DI
034F 8D 1E 20AA R                LEA    BX,S1_TEMP   ;THE FINAL RESULT TEMPORARY STORSGE
0353 8D 3E 2252 R                LEA    DI,D_BCD_FRACTION ;DATA IN [D BCD FRACTION]
                                ; NEED TO * 0.000015258

0357 EB 0A1A R                    CALL   BIN_BCD
035A EB 157A R                    CALL   M_F

035D 8D 36 23C4 R                LEA    SI,D_BIN
0361 8D 3E 2656 R                LEA    DI,BB
0365 89 3E 20A8 R                MOV    [DI_MEM],DI
0369 8D 1E 20AA R                LEA    BX,S1_TEMP
036D 8D 3E 2252 R                LEA    DI,D_BCD_FRACTION
0371 EB 0A1A R                    CALL   BIN_BCD
0374 EB 157A R                    CALL   M_F

0377 8D 36 23CC R                LEA    SI,LOSS_DATA_1
037B 8D 3E 2665 R                LEA    DI,GGLL
037F 89 3E 20A8 R                MOV    [DI_MEM],DI
0383 8D 1E 20AA R                LEA    BX,S1_TEMP
0387 8D 3E 2252 R                LEA    DI,D_BCD_FRACTION
038B EB 0A1A R                    CALL   BIN_BCD
038E EB 157A R                    CALL   M_F

0391 EB 03A7 R                    KFT_1: CALL   CLEAR_DATA_AREA ;CLEAR DATA AREA
                                ;AFTER EVERY SAMPLES.

                                ;-----NEXT PART IS TO MOVE BLOCK TO OUT_PUT-----;
0394 FC                            GLD
0395 8D 36 23E0 R                LEA    SI,OUT_PUT_1
0399 8B 3E 2006 R                MOV    DI,[OUT_MEM]
039D B9 0160                       MOV    CX,16*22
03A0 F3/ A5                        REP    MOVSW
03A2 89 3E 2006 R                MOV    [OUT_MEM],DI

                                ;
                                ; LEA    BX,TIME_FINISH ;THIS PART IS TO CHECK THE SYSTEM
                                ; PUSH   BX             ;CLOCK AFTER THE RTTP WAS END.
                                ; PUSH   CX
                                ; CALL  CLOCK_READ
                                ; POP    CX
                                ; POP    BX

03A6 C3                            RET

```

```

;-----;
; THE RTDP PROGRAM END HERE. ;
;-----;
REAL_TIME_DATA_PROCESSING ENDP
;-----;
; THE NEXT 46 SUBROUTINES WERE CALLED BY REAL TIME DATA PROCESSING. ;
; THE STRUCTURE WERE HIERARCHICAL AND NESTED MIXTURE. ;
;-----;
03A7 CLEAR_DATA_AREA PROC NEAR ;SUBROUTINE No.1 FOR THE RTDP
;-----;
; CLEAR DATA AREA AFTER EVERY SAMPLES ;
;-----;
03A7 8D 3E 2C84 F LEA DI,RANGE
03AB B9 0153 MOV CX,339
03AE 88 0000 ALL: MOV AX,0
03B1 89 05 MOV [DI],AX
03B3 47 INC DI
03B4 47 INC DI
03B5 E2 F7 LOOP ALL

03B7 8D 3E 2330 F LEA DI,SENSOR_1
03BE B9 0053 MOV CX,538
03BE 88 0000 ALL_1: MOV AX,0
03C1 89 05 MOV [DI],AX
03C3 47 INC DI
03C4 47 INC DI
03C5 E2 F7 LOC: ALL_1

03C7 C3 RET

CLEAR_DATA_AREA ENDP
;
;
03C8 ARC_REGRESSION PROC NEAR ;SUBROUTINE No.2 FOR THE RTDP.
03C8 EB 0FA0 R CALL SIGMA_Z1 ;CALCULATE SIGMA Z1(1-1--3)
;SENSOR'S DATA
03CB EB 0FB3 R CALL SIGMA_X1Z1 ;X1(1-1--3) ARE THE LOCATIONS OF
;THE SENEORS
03CE EB 1010 R CALL SIGMA_X1_SQ_2_Z1
03D1 EB 1040 R CALL A_PARAMETER ;CALCULATE PARAMETER A
03D4 EB 1149 R CALL B_PARAMETER ;CALCULATE PARAMETER B
03D7 EB 1230 R CALL C_PARAMETER ;CALCULATE PARAMETER C
03DA EB 1338 R CALL Z_MEAN_VALUE ;CALCULATE MEAN VALUE OF Z1

03DD C3 RET

ARC_REGRESSION ENDP
;
;
03DE ARC_REG PRGC NEAR ;SUBROUTINE No.3 FOR RTDP
;-----;
;THIS SUBROUTINE IS TO CONDUCT ARC REGRESSION ;
; 1. BEFOR CALLING, 3 SENSORS DATA ARE STORED IN Z1, Z2, Z3. ;
; 2. Z_MEAN_1 ADDRESS IS STORED IN [Z_MEAN_RM] ;
; 3. OUT_PUT_1 ADDRESS FOR PRINT IS ALSO STORED IN [OUT_PUT_RM];
;-----;
03DE EB 03C8 R CALL ARC_REGRESSION
03E1 8D 36 230C R LEA SI,Z_MEAN
03E5 8B 04 MOV AX,[SI]
03E7 BA 8000 MOV DX,8000H
03EA 3B C2 CMP AX,DX ;IF AX EQUAL TO OR ABOVE .8000H(0.5)

03EC 73 03 JAE FUL
03EE EB 10 90 JMP FUM
03F1 FF 44 02 FUL: INC WORD PTR[SI+2] ;Z_MEAN PLUS 1
03F4 8B 44 02 MOV AX,[SI+2] ;Z_MEAN IN AX
03F7 8B 3E 20A4 R MOV DI,[Z_MEAN_RM]

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03FB 89 05          MOV     [DI],AX      ;Z_MEAN NOW IN 2_MEAN_1, _2, _3
03FD EB 0A 90      JMP     DOA
                                ;
0400 8B 44 02      FUM:    MOV     AX,[SI+2]   ;Z_MEAN IN AX
0403 8B 3E 20A4 R  MOV     DI,[Z_MEAN_RM]
0407 89 05          MOV     [DI],AX     ;Z_MEAN NOW IN 2_MEAN_1, _2, _3

0409 C3           DOA:    RET
                                ;
                                ARC_REG ENDP
                                ;
040A              CLEAR_A_B_C PROC NEAR      ;SUBROUTINE No.4 FOR THE RTDP.
                                ;
040A B9 000C        MOV     CX,12
040D B8 0000        MOV     AX,0
0410 8D 1E 2314 R  LEA     BX,A_PARA
0414 89 07          KLD:    MOV     [BX],AX    ;CLEAR DATA AREA FOR NEXT TIME USE
0416 43            INC     BX
0417 43            INC     BX
0418 E2 FA          LOOP    KLD

041A C3           RET
                                ;
                                CLEAR_A_B_C ENDP
                                ;
041B              SENSOR_LOOK PROC NEAR     ;SUBROUTINE No.5 FOR THE RTDP.
                                ;
041B B9 0003        MOV     CX,3        ;THE NUMBER OF Z_MEAN
041E 8D 1E 238C R  LEA     BX,Z_MEAN_1 ;POINT THE FIRST SENSOR
0422 89 1E 208A R  MOV     [SEN_RM],BX ;SENSOR ADDRESS IN RAM

0426 8D 1E 23A4 R  LEA     BX,Z_MEAN_1_L ;POINT TO FIRST Ln(Z_MEAN_1)
042A 89 1E 208C R  MOV     [SEN_L_RM],BX ;ADDRESS OF LnX IN RAM

042E 8B 1E 208A R  SEN_1: MOV     BX,[SEN_RM] ;POINT TO SENSOR
0432 8B 07          MOV     AX,[BX]
0434 A3 2084 R      MOV     [RANGE],AX ;ORIGANAL DATA IN [RANGE]

0437 EB 049C R      CALL    DATA_ENLARGE ;DATA*100 (0 - 9); DATA*10 (10 -99)

043A 51            PUSH   CX           ;DATA_RANGE WILL USE CX
043B EB 04FF R      CALL    DATA_RANGE ;+0 OR +10000 OR +20000
043E 59            POP     CX

043F 8B 1E 208A R  MOV     BX,[SEN_RM] ;GET Z_MEAN_1 -- 3 ADDRESS
0443 83 C3 08      ADD     BX,8        ;POINT TO NEXT ADDRESS
0446 89 1E 208A R  MOV     [SEN_RM],BX ;KEEP NEXT ADDRESS IN RAM

044A 8D 1E 20B2 R  LEA     BX,TABLE_M  ;POINT TO TEMPERORY LOOK_UP
                                ;TABLE STORAGE UNIT
044E 8B 07          MOV     AX,[BX]     ;FIRST TABLE WORD
0450 9B 1E 208C R  MOV     BX,[SEN_L_RM] ;IN RAM
0454 89 07          MOV     [BX],AX
0456 43            INC     BX
0457 43            INC     BX
0458 53            PUSH   BX
0459 8D 1E 20B4 R  LEA     BX,TABLE_M+2 ; POINT NEXT WORD
045D 8B 07          MOV     AX,[BX]
045F 5B            POP     BX
0460 89 07          MOV     [BX],AX
0462 43            INC     BX
0463 43            INC     BX
0464 53            PUSH   BX
0465 8D 1E 20B6 R  LEA     BX,TAELE_M+4 ;POINT TO INTEGER (*.)
0469 8B 07          MOV     AX,[BX]

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046B 5B          POP     BX
046C 89 07       MOV     [BX],AX
046E 43          INC     BX
046F 43          INC     BX
0470 53          PUSH    BX
0471 8D 1E 20B8 R LEA     BX,TABLE_M+6 ;POINT TO INTEGER (*.)
0475 8B 07       MOV     AX,[BX]
0477 5B          POP     BX
0478 89 07       MOV     [BX],AX

047A B8 3030     MOV     AX,3030H ;CLEAR INTEGER MEMORY UNIT FOR
047D A3 20B6 R    MOV     [TABLE_M+4],AX ;NEXT TIME USE.

0480 83 C3 02     ADD     BX,2 ; POINT TO NEXT Lnx ADDRESS
0483 89 1E 208C R MOV     [SEN_L_RM],BX

0487 E2 A5       LOOP    SEN_1

;-----;
; THIS PART IS FOR CHANGE ASCII CODE INTO BCD ;
; FOR CNOVINEINCE OF FOURTHER CALCULATION. ;
;-----;

0489 B9 0018     MOV     CX,24 ;CHANGE 3 X 8 BYTES ASCII IN TO BCD
048C 8D 1E 23A4 R LEA     BX,Z_MEAN_1_L
0490 B0 0F       MOV     AL,0FH
0492 8A 17       KS:    MOV     DL,[BX]
0494 22 D0       AND     DL,AL
0496 88 17       MOV     [BX],DL
0498 43          INC     BX
0499 E2 F7       LOOP    KS

049B C3          RET

SENSOR_LOOK ENDP
;
;
049C          DATA_ENLARGE PROC NEAR ;SUBROUTINE No.6 FOR THE RTDP.

049C 8D 1E 2084 R LEA     BX,RANGE
04A0 8B 07       MOV     AX,[BX]
04A2 3D 000A     CMP     AX,10 ; DATA BELOW 10 THEN *100
04A5 72 12       JB     DATA_1
04A7 3D 0064     CMP     AX,100 ; DATA BELOW 100 THEN *10
04AA 72 1E       JB     DATA_10
04AC 3D 03E8     CMP     AX,1000 ; DATA BELOW 1000 THEN *1
04AF 72 2A       JB     DATA_100
04B1 3D 2710     CMP     AX,10000 ; DATA BELOW 10000 THEN *0.1
04B4 72 37       JB     DATA_DIV_10

04B6 EB 46 90     JMP     DATA_END ; ABOVE 10000 THEN RETURN

04B9 BB 0064     DATA_1: MOV     BX,100
04BC F7 E3       MUL     BX
04BE A3 2088 R    MOV     [RANGE_1],AX
04C1 B8 0000     MOV     AX,00H
04C4 A3 208E R    MOV     [N],AX
04C7 EB 35 90     JMP     DATA_END

04CA BB 000A     DATA_10: MOV     BX,10
04CD F7 E3       MUL     BX
04CF A3 2088 R    MOV     [RANGE_1],AX
04D2 B8 0001     MOV     AX,01
04D5 A3 208E R    MOV     [N],AX
04D8 EB 24 90     JMP     DATA_END

04DB B8 0002     DATA_100: MOV     AX,02H
04DE A3 208E R    MOV     [N],AX

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04E1 8D 1E 2088 R      LEA    BX,RANGE_1
04E5 A1 2084 R      MOV    AX,[RANGE]
04E8 89 07          MOV    [BX],AX
04EA EB 12 90      JMP    DATA_END

04ED 55 000A      DATA_DIV_10: MOV    BX,10
04F0 BA 0000      MOV    DX,0000H      ;DX FOR SAVE DIV REMAINDER IF
04F3 F7 F3        DIV    BX              ;NO ZERO OVERFLOW.
04F5 A3 2088 R      MOV    [RANGE_1],AX

04FB B8 0003      MOV    AX,03H
04FB A3 208E R      MOV    [N],AX

04FE C3          DATA_END:  RET

DATA_ENLARGE ENDP
;
;
04FF          DATA_RANGE PROC NEAR      ;SUBROUTINE No.7 FOR THE RTDP.

04FF 8D 1E 2088 R      LEA    BX,RANGE_1      ;SENSORS' DATA STORE IN [RANGE_1]
0503 8B 07          MOV    AX,[BX]         ;BEFOR RANGE DETERMINATION.
0505 3D 0110      CMP    AX,272
0508 72 0A          JB     LOOK            ;IF DATA BELOW 271 LOOK_UP TABLE
050A 3D 02E3      CMP    AX,739          ;(LnX)
050D 72 16          JB     LOOK_1         ;IF DATA BELOW 739
050F 3D 03E8      CMP    AX,1000         ;& ABOUVE 271 +10000.
0512 72 22          JB     LOOK_2         ;IF DATA BELOW 999
                                ;& ABOUVE 739 +20000.

0514 E8 06BC R      LOOK:    CALL   LOOK_UP
0517 8D 1E 20B6 R      LEA    BX,TABLE_M+4
0518 8B 07          MOV    AX,[BX]
051D 0D 0030      OR     AX,'0'
0520 89 07          MOV    [BX],AX
0522 EB 20 90      JMP    LOOK_END

0525 E8 06BC R      LOOK_1:  CALL   LOOK_UP
0528 8D 1E 20B6 R      LEA    BX,TABLE_M+4
052C 8B 07          MOV    AX,[BX]
052E 0D 0031      OR     AX,'1'          ;ADD    AX,10000
0531 89 07          MOV    [BX],AX
0533 EB 0F 90      JMP    LOOK_END

0536 E8 06BC R      LOOK_2:  CALL   LOOK_UP
0539 8D 1E 20B6 R      LEA    BX,TABLE_M+4
053D 8B 07          MOV    AX,[BX]
053F 0D 0032      OR     AX,'2'          ;ADD    AX,20000
0542 89 07          MOV    [BX],AX

;-----;
;THE NEXT PART IS LnY=LnY/10^n+Ln10^n ;
;FIRST STEP TABLE_M 0 -- 7 ASCII TO BCD ;
;SECOND STEP +Ln10^n ;
;-----;

0544 89 0004      LOOK_END: MOV    CX,4
0547 8D 1E 20B2 R      LEA    BX,TABLE_M      ; ASCII --- BCD
054B 8B 07          AS_BCD: MOV    AX,[BX]
054D 25 0F0F      AND    AX,0FOFH
0550 89 07          MOV    [BX],AX
0552 43          INC    BX
0553 43          INC    BX
0554 E2 F5          LOOP   AS_BCD

0556 B8 0000      MOV    AX,00
0559 3B 06 208E R      CMP    AX,[N]
055D 74 15          JZ     N 0
055F 40          INC    AX
0560 3B 06 208E R      CMP    AX,[N]

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0564 74 11          JZ      N_1
0566 40             INC     AX
0567 3B 06 208E R   CMP     AX,[N]
0568 74 17          JZ      N_2
056D 40             INC     AX
056E 3B 06 208E R   CMP     AX,[N]
0572 74 1D          JZ      N_3

0574 EB 25 90      N_0:    JMP     D_END

0577 8D 1E 20B2 R   N_1:    LEA     BX,TABLE_M
057B BE CE10        MOV     SI,0CE10H ;LEA     SI,Ln10_1+100H
057E EB 05CD R     CALL   NINE_BYTE_ADD
0581 EB 18 90      JMP     D_END

0584 8D 1E 20B2 R   N_2:    LEA     BX,TABLE_M
0588 BE CE18        MOV     SI,0CE18H ;LEA     SI,Ln10_2+100H
058B EB 05CD R     CALL   NINE_BYTE_ADD
058E EB 0B 90      JMP     D_END

0591 8D 1E 20B2 R   N_3:    LEA     BX,TABLE_M
0595 BE CE20        MOV     SI,0CE20H ;LEA     SI,Ln10_3+100H
0598 EB 05CD R     CALL   NINE_BYTE_ADD

059B 8D 1E 208E R   D_END:  LEA     BX,N
059F B8 0000        MOV     AX,00H
05A2 89 07          MOV     [BX],AX

05A4 B9 0004        MOV     CX,04
05A7 8D 1E 20B2 R   BCD_AS: LEA     BX,TABLE_M ; BCD --- ASCII
05AB 8B 07          MOV     AX,[BX]
05AD 0D 3030        OR      AX,3030H
05B0 89 07          MOV     [BX],AX
05B2 43             INC     BX
05B3 43             INC     BX
05B4 E2 F5          LOOP   BCD_AS

05B6 C3             RET

DATA_RANGE ENDP
;
;
05B7 EIGHT_BYTE_ADD PROC NEAR ;SUBROUTINE No. 8 FOR THE RTDP.
;-----
; BEFOR CALL THIS PROCEDURE
; 1. TOW ADDRESS (LSB) SHOULD BE MOV INTO BX & SI RESPECTIVELY.
; 2. THE RESULT IS SENT TO [BX]
; 3. AFTER CALLING SI POINT TO [BX]+7
; 4. BEFOR CALLING THIS PROCEIDURE PUSH CX IS RECONMANDED.
;-----

05B7 8A 07          MOV     AL,BYTE PTR[BX] ;LSB IS SENT TO AL
05B9 02 04          ADD     AL,BYTE PTR[SI] ;ADD AL WITH THE BYTE POINTE
; BY SI
05BB 37             AAA     ;ASCII ADD ADJUSTED
05BC 8B 07          MOV     [BX],AL ;RESULT IN [BX]
05BE B9 0007        MOV     CX,07H ;ANOTHER 7 BYTE OTHER THAN LSB
05C1 43             INC     BX ;POINT TO NEXT FYTE
05C2 46             INC     SI
05C3 8A 07          MOV     AL,BYTE PTR[BX] ;NEXT BYTE TO AL
05C5 12 04          ADC     AL,BYTE PTR[SI] ;ADD WITH CARRY
05C7 37             AAA     ;ADJUST
05C8 8B 07          MOV     [BX],AL ;RESULT IN [BX]
05CA E2 F5          LOOP   HJ

05CC C3             RET

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EIGHT_BYTE_ADD ENDP
;
;
05CD      NINE_BYTE_ADD PROC NEAR          ;SUBROUTINE No. 9 FOR THE RTDP.
;-----;
; BEFOR CALL THIS PROCEDURE
; 1. TOW ADDRESS (LSB) SHOULD BE MOV INTO BX & SI RESPECTIVE
; 2. THE RESULT IS SENT TO [BX]
; 3. BEFOR CALLING THIS PROCEIDURE PUSH CX IS RECONMANDED.
;-----;

05CD  8A 07      MOV     AL, BYTE PTR[BX] ;LSB IS SENT TO AL
05CF  02 04      ADD     AL, BYTE PTR[SI] ;ADD AL WITH THE BYTE POINTED BY
05D1  37         AAA     ;ASCII ADD ADJUSTED
05D2  88 07      MOV     [BX], AL          ;RESULT IN [BX]
05D4  B9 0008    MOV     CX, 08H         ;ANOTHER 7 BYTE OTHER THAN LSB
05D7  43         HIJ:    INC     BX              ;POINT TO NEXT BYTE
05D8  46         INC     SI
05D9  8A 07      MOV     AL, BYTE PTR[BX] ;NEXT BYTE TO AL
05DB  12 04      ADC     AL, BYTE PTR[SI] ;ADD WITH CARRY
05DD  37         AAA     ;ADJUST
05DE  88 07      MOV     [BX], AL       ;RESULT IN [BX]
05E0  E2 F5      LOOP    HIJ

05E2  C3         RET

NINE_BYTE_ADD ENDP
;
;
05E3      SIXTEEN_BYTE_ADD PROC NEAR      ;SUBROUTINE No. 10 FOR THE RTDP.
;-----;
; 1. BEFOR CALL THIS PROCEDURE TOW ADDRESS (LSB) SHOUL.D BE
; MOV INTO BX & SI RESPECTIVELY.
; 2. THE RESULT IS SENT TO [BX].
; 3. BEFOR CALLING THIS PROCEIDURE PUSH CX IS RECONMANDED.
;-----;

05E3  8A 07      MOV     AL, BYTE PTR[BX] ;LSB IS SENT TO AL
05E5  02 04      ADD     AL, BYTE PTR[SI] ;ADD AL WITH THE BYTE POINTED
; BY SI
05E7  37         AAA     ;ASCII ADD ADJUSTED
05E8  88 07      MOV     [BX], AL        ;RESULT IN [BX]
05EA  B9 000F    MOV     CX, 15         ;ANOTHER 15 BYTE OTHER THAN LSB
05ED  43         HHJ:    INC     BX              ;POINT TO NEXT BYTE
05EE  46         INC     SI
05EF  8A 07      MOV     AL, BYTE PTR[BX] ;NEXT BYTE TO AL
05F1  12 04      ADC     AL, BYTE PTR[SI] ;ADD WITH CARRY
05F3  37         AAA     ;ADJUST
05F4  88 07      MOV     [BX], AL       ;RESULT IN [BX]
05F6  E2 F5      LOOP    HHJ

05F8  C3         RET

SIXTEEN_BYTE_ADD ENDP
;
;
05F9      EIGHT_BYTE_SUB PROC NEAR         ;SUBROUTINE No. 11 FOR THE RTDP.
;-----;
; BEFOR CALL THIS PROCEDURE TOW ADDRESSES SHOULD BE
; MOV INTO BX & SI RESPECTIVELY. THE RESULT IS IN [BX].
; BEFOR CALLING THIS PROCEIDURE PUSH CX IS RECONMANDED
; [BX] - [SI] => [BX]
;-----;

05F9  8A 07      MOV     AL, BYTE PTR[BX] ;LSB IS SENT TO AL
05FB  2A 04      SUB     AL, BYTE PTR[SI] ;SUBTRACT AL WITH THE BYTE
; POINTED BY SI
05FD  3F         AAS    ;ASCII ADJUST FOR SUBTRUCTION

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05FE 88 07          MOV     [BX],AL      ;RESULT IN [BX]
0600 B9 0007        MOV     CX,07H      ;ANOTHER 7 BYTE OTHER THAN LSB
0603 43             THJ:    INC     BX        ;POINT TO NEXT BYTE
0604 46             INC     SI
0605 8A 07          MOV     AL,BYTE PTR[BX] ;NEXT BYTE TO AL
0607 1A 04          SBB     AL,BYTE PTR[SI] ;SUBTRACT WITH BORROW
0609 3F             AAS     ;ASCII ADJUST FOR SUBTRUCTION
060A 88 07          MOV     [BX],AL      ;RESULT IN [BX]
060C E2 F5          LOOP    THJ

060E C3             RET

EIGHT_BYTE_SUB     ENDP
;
;
060F             SIXTEEN_BYTE_SUB PROC NEAR ;SUBROUTINE No. 12 FOR THE RTDP.
;-----
; BEFOR CALL THIS PROCEDURE TOW ADDRESSES SHOULD BE
; MOV INTO BX & SI RESPECTIVELY. THE RESULT IS IN [BX].
; BEFOR CALLING THIS PROCEDURE PUSH CX IS RECOMMANDED
; [BX] - [SI] => [BX]
;-----
060F 8A 07          MOV     AL,BYTE PTR[BX] ;LSB IS SENT TO AL
0611 2A 04          SUB     AL,BYTE PTR[SI] ;SUBTRACT AL WITH THE BYTE
; POINTED BY SI
0613 3F             AAS     ;ASCII ADJUST FOR SUBTRUCTION
0614 88 07          MOV     [BX],AL      ;RESULT IN [BX]
0616 B9 000F        MOV     CX,15       ;ANOTHER 15 BYTE OTHER THAN LSB
0619 43             GHJ:    INC     BX        ;POINT TO NEXT BYTE
061A 46             INC     SI
061B 8A 07          MOV     AL,BYTE PTR[BX] ;NEXT BYTE TO AL
061D 1A 04          SBB     AL,BYTE PTR[SI] ;SUBTRACT WITH BORROW
061F 3F             AAS     ;ASCII ADJUST FOR SUBTRUCTION
0620 88 07          MOV     [BX],AL      ;RESULT IN [BX]
0622 E2 F5          LOOP    GHJ

0624 C3             RET

SIXTEEN_BYTE_SUB   ENDP
;
;
0625             EIGHT_MUL_ONE PROC NEAR ;SUBROUTINE No. 13 FOR THE RTDP.
;-----
; THIS PROCEDURE WAS FOR 8 DIGITS X 1 DIGIT ASCII MULTIPLICATION.
; THE ADDRESS OF THE 8 DIGIT DATA MUST BE SENT TO SI AND 1 DIGIT
; MUST BE SENT TO DL REGISTER, BEFOR CALLING THIS PROCEDURE.
; THE RESULT WAS SENT TO [PAR_PRODUCT].
; PUSH AX BX CX DX SI ARE RECOMMANDED BEFOR CALLING.
;-----
0625 8D 1E 20C2 R   LEA     BX,PAR_PRODUCT ;POINT TO PARTIAL PRODUCT
0629 B8 0000          MOV     AX,00H
062C 8A 04          MOV     AL,[SI]      ;LSB IS AT [SI+0]
062E F6 E2          MUL     DL           ;1 DIGIT IS AT DL
0630 D4 0A          AAM     ;ASCII ADJUSTMENT FOR
; MULTIPLICATION
0632 88 07          MOV     [BX],AL      ;BX POINTS TO PAR_PRODUCT
0634 8A F4          MOV     DH,AH        ;KEEP HIGH DIGIT PRODUCED
; BY AAM IN DH
0636 B9 0008        MOV     CX,08H       ;1 OF 8 DIGITS HAS BEEN
; CALCULATED, BUT THE CARRY MUST
; BE CONSIDERED
0639 46             RE_CAL: INC     SI        ;POINT TO NEXT DIGIT
063A 8A 04          MOV     AL,[SI]
063C F6 E2          MUL     DL
063E D4 0A          AAM     ;ASCII ADJUSTMENT FOR
; MULTIPLICATION
0640 02 C6          ADD     AL,DH        ;NEXT LSB IN AL

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0642 37          AAA          ;ASCII ADJUSTMENT FOR AEDATION
0643 43          INC          BX          ;POINT TO NEXT LSB OF PAR_PRODUCT
0644 88 07       MOV          [BX],AL
0646 8A F4       MOV          DH,AH      ;KEEP HIGH DIGIT PRODUCED
                                         ;BY AAM IN DH

0648 E2 EF       LOOP         RE_CAL

064A C3          RET

EIGHT_MUL_ONE  ENDP
;
;
064B          EIGH_MUL_EIGH  PROC  NEAR      ;SUBROUTINE No. 14 FOR THE RTDP.
;-----
; THIS PROCEDURE WAS FOR TOW EIGH-DIGIT ASCII (BCD) MULTIPLICATION
; 1. 16 UNITS ARE RESERVED FOR PARTIAL PRODUCTS [PAR_PRODUCT]+0 -- +15
; 2. AFTER PARTIAL PRODUCTS ARE ADDED TOGETHER. (THIS RESULTS WERE
;    CALLED INTERMEDIATE AND STORED IN [INTERMEDIATE] +0 -- +15)
; 3. THE PROCEDURE WOULD CHECK THE 5th DIGIT OF THE FRACTIONAL PART,
;    IF IT WAS < 4 THEN OMITTED, IF IT WAS >6 THEN 4th DIGIT OF THE
;    FRACTIONAL PART PLUS 1.
; 4. THE PRODUCT OF MULTIPLICATION WAS STORED IN A 16 DIGIT UNITS
;    [PRODUCT]+0 -- +15.
; 5. THE FINAL RESULT WOULD BE SENT TO [PRODUCT]
;-----
; [SI]{8 DIGITS} * [DI]{8 DIGITS} = [BX]{16 DIGITS}
; [INTERMEDIATE]+PAR_PRODUCT+...+ => 4 OMMI; 6 PLUS --> [PRODUCT]
;-----
064B 8D 1E 20D2 R LEA          BX,INTERMEDIATE
064F B9 0008      MOV          CX,08H
RE_MULTI: 0652 8A 15      MOV          DL,[DI]      ;LSB TO DL
0654 53          PUSH         BX          ;[BX] = ADDRESS: INTERMEDIATE
0655 51          PUSH         CX
0656 56          PUSH         SI
0657 EB 0625 R    CALL         EIGHT_MUL_ONE ;THE RESULT IS AT [PAR_PRODUCT]
065A 5E          POP          SI
065B 59          POP          CX
065C 5B          POP          BX          ;[BX] = ADDRESS: INTERMEDIATE

065D 53          PUSH         BX
065E 51          PUSH         CX
065F 56          PUSH         SI
0660 8D 36 20C2 R LEA          SI,PAR_PRODUCT ;PART PRODUCTION ADD PROPRAIRATION
0664 EB 05CD R    CALL         NINE_BYTE_ADD ;RESULT WAS IN
                                         ;[INTERMEDIATION]=[BX]]

0667 5E          POP          SI
0668 59          POP          CX
0669 5B          POP          BX
066A 43          INC          BX          ;POINT TO NEXT LSB OF
                                         ;INTERMIDINATION
066B 47          INC          DI          ;POINT TO NEXT LSB OF "* XXXXXXXX"

066C E2 E4       LOOP         RE_MULTI

066E 8D 1E 20D2 R LEA          BX,INTERMEDIATE ;4 OMMITED, 6 PLUS 1 IN 4th DIGIT
0672 B8 0000      MOV          AX,00H
0675 8A 47 03     MOV          AL,BYTE PTR[BX+3] ;TEST 5th DIGIT
0678 3D 0005      CMP          AX,05H
067B 72 02       JB          OMIT          ;BELOW OR EQUAL 5 OMMITED
067D 77 11       JA          PLUS         ;ABOUBE 5 PIUS 1 ON 4th DIGIT

067F FC          OMMIT:      CLD          ;SET DF=0 TO MOVE FORWARD
0680 8D 36 20D6 R LEA          SI,INTERMEDIATE+4
0684 8D 3E 20E2 R LEA          DI,PRODUCT
0688 B9 000C      MOV          CX,12
068B F3/ A4      REP          MOVSB        ;MOVES 12 BYTE FROM [SI] TO [DI]
068D EB 1E 90     JMP          EME

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0690 FC          PLUS:  CLD                ;SET DF=0 TO MOVE FORWARD
0691 8D 36 20D6 R LEA          SI,INTERMEDIATE+4
0695 8D 3E 20E2 R LEA          DI,PRODUCT
0699 B9 000C      MOV          CX,12
069C F3/ A4      REP          MOVSB        ;MOVES 12 BYTE FROM [SI] TO [DI]

069E 8D 36 20F2 R LEA          SI,FIVE_PLUS    ;ONLY 1 IN THE LSB {FIVE_PLUS+0}
06A2 8D 1E 20E2 R LEA          BX,PRODUCT
06A6 B0 01       MOV          AL,01H
06A8 88 04       MOV          [SI],AL
06AA E8 05E3 R   CALL         SIXTEEN_BYTE_ADD ;THE DATA AT [PRODUCT] LOOKS
                                ;LIKE
                                ; X X X X . X X X X X _ _ _ _ _ MSB
                                ;LSB  POINT

06AD B9 0010      EME:    MOV          CX,16    ;** AFTER CALL EIGH_MUL_EIGH MUST**
06B0 B0 00       MOV          AL,00H    ;CLEAR INTERMEDIATE
06B2 8D 1E 20D2 R LEA          BX,INTERMEDIATE
06B6 88 07      C_INER:  MOV          [BX],AL
06B8 43          INC          BX
06B9 E2 FB      LOOP         C_INER

06BB C3          RET

EIGH_MUL_EIGH ENDP
;
;
06B7          ;LOOK_UP  PROC          NEAR          ;SUBROUTINE No. 15 FOR THE RTDP.
;-----;
; DATA IN [RANGE] MUL BY 4 PLUS A_0 -- TABLE ADDRESS ;
; AFTER LOOK UP Lnx STORE IN TABLE_M TEMPORRVLY ;
;-----;
MOV          BX,0C000H ;LEA BX,A_0+100H THE EFFECTIVE
PUSH        BX        ;ADDRESS OF FIRST WORD
LEA          BX,RANGE_1 ;ENLARGED ORANGINAL SENSOR DATA
MOV          AX,[BX]   ;SENSORS DATA = RELATIVE ADDR IN DI
SUB          AX,100    ;THE FIRST ADDRESS OF THE TABLE 100
MOV          BX,4      ;4 ASCII CHARECTERS
MUL         BX        ;VALU*4= REAL ADDRESS
MOV          DI,AX     ;OFFSET IN DI
POP         BX        ;TABLE BEGINNING ADDRESS
MOV          DX,WORD PTR[BX][DI] ; FETCH **
MOV          AH,DL     ;EXCHANGE ASCII BITS
MOV          AL,DI
MOV          DX,AX
06D9 89 16 20B4 R MOV          [TABLE_M+2],DX ;Lnx IS AT TABLE_M+2 (MSB)
06DD 47          INC          DI          ;POINT TO NEXT WORD
06DE 47          INC          DI
06DF 8B 11      MOV          DX,WORD PTR[BX][DI] ; FETCH **
06E1 8A E2      MOV          AH,DL     ;EXCHANGE ASCII BITS
06E3 8A C6      MOV          AL,DI
06E5 8B D0      MOV          DX,AX
06E7 89 16 20B2 R MOV          [TABLE_M],DX ;Lnx IS AT TABLE_M

06EB C3          RET

LOOK_UP      ENDP
;
;
06EC          ;SIGMA_LnYi  PROC          NEAR          ;SUBROUTINE No. 16 FOR THE RTDP.
;-----;
; THIS SUBROUTINE WAS FOR CALCULATE SIGMA LnYi (i=0 -- n) ;
; 1. THE RESULT OF THE CALCULATION ARE STORE IN SIGMA_LnYi_M ;
; 2. BEFOR RET SI POINT TO NEXT Yi AUTOMATICALLY. ;
;-----;
06EC B9 0003      MOV          CX,03          ;FOUR SENSORS ARE IN ONE LINE

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06EF 8D 1E 2102 R      LEA    BX,SIGMA LnY1_M ;SIGMA RESULT ADDRESS IN BX
06F3 8D 36 23A4 R      LEA    SI,2_MEAN_1_L   ;LnY1 ADDRESS

06F7 51                AGAIN_ADD: PUSH   CX          ;EIGH BYTE ADD USE CX
06F8 E8 05B7 R          CALL   EIGHT_BYTE_ADD ;8 DIGIT ADD
06FB 59                POP    CX
06FC 8D 1E 2102 R      LEA    BX,SIGMA LnY1_M ;SIGMA RESULT ADDRESS IN BX
0700 46                INC    SI             ;POINT TO NEXT SOURCE BYTE
0701 E2 F4                LOOP   AGAIN_ADD

0703 C3                RET

SIGMA_LnY1  ENDP
;
;
0704                MEAN_VALUE_Y1 PROC    NEAR          ;SUBROUTINE No. 17 FOR THE RTDP.
;-----;
; THIS SUBROUTINE WAS FOR LnY1 MEAN VALUE CALCULATION. ;
; 1. IT WAS 8 DIGITS DIVIDED BY 1 DIGIT ASCII DIVISION ;
; 2. THE SEQUENCE OF CALCULATION WAS FROM MSB TO LSB ;
; 3. THE RESULT WOULD BE PUT IN THE MEAN_LnY1. ;
; 4. BEFOR CALLING THIS PROCEIDURE PUSH CX WAS ;
; RECONMANDED. ;
; NOMINATOR / DENOMINATOR = QUOTINET + REMAINDER ;
;-----;
0704 8D 36 2109 R      LEA    SI,SIGMA LnY1 M+7 ;POINT TO SOURCE ADDRESS (MSB)
0708 8D 1E 2119 R      LEA    BX,MEAN_LnY1+7 ;POINT TO RESULT UNIT ADDR (MSB)
070C B8 0003            MOV    AX,03           ;DENOMINATOR REPRESENTED
070F A3 2090 R          MOV    [N_DIVIDE],AX  ;THE SENSORS No. 4 SENSORS
0712 B4 00            MOV    AH,00H         ;CLEAR AH FOR THE REMAINDER
0714 8A 04            MOV    AL,BYTE PTR[SI];NOMINATOR IN AL

0716 B9 0008            MOV    CX,08H         ;NOMINATOR IS A 8 DIGIT ASCII
;NUMBER

0719 F6 36 2090 R      AGAIN_DIVIDE:DIV    BYTE PTR[N_DIVIDE] ;DIVYDING
071D 88 07            MOV    [BX],AL        ;SAVE THE QUOTIENT
071F 4B                DEC    BX             ;POINT TO NEXT RESULT
0720 4E                DEC    SI             ;POINT TO NEXT DENOMINATOR
0721 8A 04            MOV    AL,BYTE PTR[SI];NEXT DIGIT IS SENT TO AL
0723 D5 0A            AAD                    ;ASCII ADJUSTMENT FOR DIVIDE
;:(AL)*10+(AL), (AH) <-- 0

0725 E2 F2                LOOP   AGAIN_DIVIDE

0727 C3                RET

MEAN_VALUE_Y1  ENDP          ;SUBROUTINE No.  FOR THE RTDP
;
;
0728                MEAN_VALUE_X1 PROC    NEAR          ;SUBROUTINE No. 18 FOR THE RTDP
;-----;
; 1. DU TO X1 ARE FIXT POSITIONS IN LOGITUDINAL DIRECTION. ;
; 2. MEAN VALUE OF X1 WAS CALCULATED BY HAND. ;
; 3. IN THIS SUBROUTINE MEANVALUE OF X1 WAS SIMPLY MOVED ;
; IN TO [MEAN_X1+0] -- [MEAN_X1+7]. I.e. 0000.5050 ;
; 4. X1 ARE ALSO SENT TO X1 -- X3. ;
;-----;
;PART 1: STORE MEAN X1 = 0000.5050
0728 8D 1E 2172 R      LEA    BX,MEAN_X1     ;POINT TO RESULT UNIT (MSB)
072C B8 0500            MOV    AX,0500H
072F 89 07            MOV    [BX],AX
0731 43                INC    BX
0732 43                INC    BX
0733 B8 0500            MOV    AX,0500H      ;00 00 00 00 . 05 00 05 00
0736 89 07            MOV    [BX],AX

;PART 2: STORE X1=0000.2270; X2=0000.4610; X3=0000.8270;
; X0=0000.F26FH

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0738 8D 1E 2122 R      LEA     BX,X1
073C B8 0700          MOV     AX,0700H
073F 89 07            MOV     [BX],AX
0741 43              INC     BX
0742 43              INC     BX
0743 B8 0202          MOV     AX,0202H
0746 89 07            MOV     [BX],AX      ;X1=0000.2270

0748 8D 1E 2132 R      LEA     BX,X2
074C B8 0100          MOV     AX,0100H
074F 89 07            MOV     [BX],AX
0751 43              INC     BX
0752 43              INC     BX
0753 B8 0406          MOV     AX,0406H
0756 89 07            MOV     [BX],AX      ;X2=0000.4610

0758 8D 1E 2142 R      LEA     BX,X3
075C B8 0700          MOV     AX,0700H
075F 89 07            MOV     [BX],AX
0761 43              INC     BX
0762 43              INC     BX
0763 B8 0802          MOV     AX,0802H
0766 89 07            MOV     [BX],AX      ;X3=0000.8270

0768 8D 1E 2152 R      LEA     BX,X0
076C B8 F26F          MOV     AX,0F26FH    ;0.F26FH = 0.9470
076F 89 07            MOV     [BX],AX

0771 8D 1E 2162 R      LEA     BX,SIGMA_X1_M
0775 B8 0500          MOV     AX,0500H     ;SIGMA_X1_M = 1.5150
0778 89 07            MOV     [BX],AX
077A 43              INC     BX
077B 43              INC     BX
077C B8 0501          MOV     AX,0501H
077F 89 07            MOV     [BX],AX
0781 43              INC     BX
0782 43              INC     BX
0783 B8 0001          MOV     AX,0001H
0786 89 07            MOV     [BX],AX

0788 C3              RET

MEAN_VALUE_X1 ENDP
;
;
0789 D_NOMINATION PROC    NEAR      ;SUBROUTINE No. 19 FOR THE R7DP
;-----
; THIS SUBROUTINE WAS FOR CALCULATING NOMINATION OF THE PRAMETER D ;
; SIGMA (X1 - Xmean) (Y1 - Ymean), i= 1 -- n ;
; 1. THE RESULT WAS STORED IN SIG_X1_Xm_Y1_Ym ( 8W, 16 BYTE RAM ) ;
; 2. THE INTERMIDIATES WERE STORED IN (X1-Xm) & (Y1-Ym) RESPECTIVELY;
; 3. AFTER FINISHING (X1-Xm)*(Y1-Ym) THE PRODUCT WAS ADDED ON ;
; SIG_X1_Xm_Y1_Ym . ;
; 4. THE SIGN OF D NOMINATION ONLY DEPENDED ON THE VALUE OF ;
; [SIGN_SIGMA], THAT WAS THE SIGN OF (X1-Xm)(Y1-Ym). ;
;-----
0789 B9 0003          MOV     CX,3          ;3 SENSORS IN A LINE
078C B8 1E 2122 R      LEA     BX,X1          ;X1
0790 89 1E 2092 R      MOV     [X1_M],BX     ;SAVE ADDRESS FOR FORTHER USE
0794 8D 1E 23A4 R      LEA     BX,Z_MEAN_1_L ;LnY1
0798 89 1E 2094 R      MOV     [LnY1_M],BX   ;SAVE ADDRESS FOR FORTHER USE
079C 8D 1E 21D2 R      LEA     BX,X1_Xm      ;X1-Xm
07A0 89 1E 2099 R      MOV     [X1_Xm_M],BX  ;SAVE ADDRESS FOR FORTHER USE

07A4 51              SG_AGAIN:  PUSH     CX          ;SAVE CX
;----- CALCULATE (X1 - Xmean) -----

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07A5 B9 0008          MOV     CX,8           ;MOVE X1 TO INTERMEDIATE_SUB FOR
07A8 8D 3E 2192 R    LEA     DI,INTERMEDIATE_SUB ;SUB
07AC 8B 36 2092 R    MOV     SI,[X1_M]
07B0 F3/ A4          REPZ   MOVSB

07B2 8D 1E 2192 R    LEA     BX,INTERMEDIATE_SUB ;GET X1 ADDRESS
07B6 8D 36 2172 R    LEA     SI,MEAN_X1
07BA E8 05F9 R      CALL    EIGHT_BYTE_SUB ;[BX] - [SI] => [BX]

07BD 8A 07          MOV     AL,BYTE PTR[BX] ;TEST MSB
07BF 3C 09          CMP     AL,09H         ;EQUALS TO 9?
07C1 75 42          JNZ     S_RESULT_X     ;NO, SEND RESULT

07C3 8D 3E 2182 R    LEA     DI,COMPLETE     ;YES RESULT IS MINUS ( - )
07C7 C6 45 03 01     MOV     BYTE PTR[DI+8],01H ;PROPARE FOR SUBTRACT
07CB 8B DF          MOV     BX,DI
07CD 8D 36 2192 R    LEA     SI,INTERMEDIATE_SUB ;[BX] - [SI] = [BX]
07D1 E8 05F9 R      CALL    EIGHT_BYTE_SUB ;CALCU. ABSOLUT VALU

07D4 B9 0008          MOV     CX,8           ;8 BYTE MOVING
07D7 8D 3E 21B2 R    LEA     DI,X1_Xm       ;RESULT DESTINATION
07DB 8D 36 2182 R    LEA     SI,COMPLETE     ;GET 100,000,000 ADDRESS
07DF F3/ A4          REPZ   MOVSB           ;RESULT NOW IN (X1_Xm)

07E1 B9 0008          MOV     CX,8           ;8 BYTE MOVING
07E4 8B 3E 2099 R    MOV     DI,[X1_Xm_M]   ;DISTINATION FOR CALCU (X1-Xm) ^2
07E8 8D 36 2182 R    LEA     SI,COMPLETE     ;GET 100,000,000 ADDRESS
07EC F3/ A4          REPZ   MOVSB           ;RESULT NOW IN (X1_Xm)
                                ;OR (X2-Xm)...

07EE B9 0010          MOV     CX,16          ;CLEAR [COMPLETE] FOR NEXT TIME
07F1 8D 1E 2182 R    LEA     BX,COMPLETE
07F5 C6 07 00          MOV     [BX],BYTE PTR 00H ;USE
07F8 43          INC     BX
07F9 E2 FA          LOOP   CAA

07FB 8D 3E 2096 R    LEA     DI,SIGN_X      ;SIGN OF SUB RESULT
07FF C6 05 01          MOV     BYTE PTR[DI],01H ;IF 1 MINUS
0802 EB 22 90          JMP     CAL_Y

0805 8D 3E 2096 R    S_RESULT_X: LEA     DI,SIGN_X
0809 C6 05 00          MOV     BYTE PTR[DI],0

080C B9 0008          MOV     CX,8           ;8 BYTE MOVING
080F 8D 3E 21B2 R    LEA     DI,X1_Xm       ;RESULT DESTINATION
0813 8D 36 2192 R    LEA     SI,INTERMEDIATE_SUB ;GET X1-Xm ADDRESS
0817 F3/ A4          REPZ   MOVSB           ;RESULT NOW IN (X1_Xm)

0819 B9 0008          MOV     CX,8           ;8 BYTE MOVING
081C 8B 3E 2099 R    MOV     DI,[X1_Xm_M]   ;DISTINATION FOR CALCU (X1-Xm) ^2
0820 8D 36 2192 R    LEA     SI,INTERMEDIATE_SUB ;GET X1-Xm ADDRESS
0824 F3/ A4          REPZ   MOVSB           ;RESULT NOW IN (X1_Xm)
                                ;OR (X2-Xm)...

;----- CALCULATE (Y1 - Ymean) -----;

0826 B9 0008          CAL_Y:  MOV     CX,8           ;MOVE LnY1 TO INTERMEDIATE_SUB
0829 8D 3E 2192 R    LEA     DI,INTERMEDIATE_SUB ;FOR SUB
082D 8B 36 2094 R    MOV     SI,[LnY1_M]
0831 F3/ A4          REPZ   MOVSB

0833 8D 1E 2192 R    LEA     BX,INTERMEDIATE_SUB
0837 8D 36 2112 R    LEA     SI,MEAN_LnY1
083B E8 05F9 R      CALL    EIGHT_BYTE_SUB ;[BX] -[SI] => [BX]

083E 8A 07          MOV     AL,BYTE PTR[BX] ;TEST MSB
0840 3C 09          CMP     AL,09H         ;EQUALS TO 9?

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0842 75 35                JNZ     S_RESULT_Y      ;NO, SEND RESULT
0844 8D 3E 2182 R        LEA     DI,COMPLETE     ;YES RESULT IS MINUS ( - )
0848 C6 45 08 01        MOV     BYTE PTR[DI+8],01H ;PROPARE FOR SUBTRUCT
084C 8B DF                MOV     BX,DI
084E 8D 36 2192 R        LEA     SI,INTERMEDIATE_SUB
0852 E8 05F9 R           CALL    EIGHT_BYTE_SUB

0855 B9 0008                MOV     CX,8           ;8 BYTE MOVING
0858 8D 3E 21C2 R        LEA     DI,Yi_Ym       ;RESULT DESTINATION
085C 8D 36 2182 R        LEA     SI,COMPLETE     ;GET Xi ADDRESS
0860 F3/ A4                REPZ   MOVSB           ;RESULT NOW IN (Xi_Xm)

0862 B9 0010                MOV     CX,16
0865 8D 1E 2182 R        LEA     FX,COMPLETE     ;CLEAR [COMPLETE] FOR NEXT TIME
0869 C6 07 00                CAB:   MOV     [BX],BYTE PTR 00H ;USE
086C 43                    INC     BX
086D E2 FA                LOOP   CAB

086F 8D 3E 2097 R        LEA     DI,SIGN_Y       ;SIGN OF SUB RESULT
0873 C6 05 01                MOV     BYTE PTR[DI],01H ;IF 1 MINUS
0876 EB 15 90                JMP     CAL_MUL

0879 8D 3E 2097 R        S_RESULT_Y: LEA     DI,SIGN_Y       ;NO, THE SIGN IS PLUS ( + )
087D C6 05 00                MOV     BYTE PTR[DI],0

0880 B9 0008                MOV     CX,8           ;8 BYTE MOVING
0883 8D 3E 21C2 R        LEA     DI,Yi_Ym       ;RESULT DESTINATION
0887 8D 36 2192 R        LEA     SI,INTERMEDIATE_SUB ;GET LnYi ADDRESS
088B F3/ A4                REPZ   MOVSB           ;THE RESULT NOW IN (Yi_Ym)

;-----;
; NEXT PART WAS MULTIPLICATION ;
; BEFOR CALCULATING LOGIC CALCULATION MUST BE DONE i.e. ;
; SIGN_X XOR SIGN_Y IF = 0 THEN PLUS IF 1 THEN MINUS ;
;-----;
088D A0 2096 R                CAL_MUL: MOV     AL,[SIGN_X]
0890 8A 0E 2097 R        MOV     CL,[SIGN_Y]
0894 32 C1                XOR     AL,CL
0896 8D 1E 2098 R        LEA     BX,SIGN_SIGMA   ;[SIGN_SIGMA] IS THE SIGN OF
089A 88 07                MOV     [BX],AL         ;Xi-Xm)(Yi-Ym)

089C 8D 36 21B2 R        LEA     SI,Xi_Xm
08A0 8D 3E 21C2 R        LEA     DI,Yi_Ym
08A4 8D 1E 20D2 R        LEA     BX,INTERMEDIATE

08A8 E8 064B R           CALL    EIGH_MUL_EIGH   ;(Xi - Xmean)*(Yi - Ymean)

;-----;
;NEXT PART WAS CALCULATE SIGMA (Xi-Xm)(Yi-Yi) ;
;-----;
08AB 8D 1E 21A2 R        LEA     BX,SIG_Xi_Ym_Yi_Ym ;RESULT ADDRESS
08AF 8D 36 20E2 R        LEA     SI,PRODUCT      ;ADDRESS OF MULTIPLICATION

08B3 B0 00                MOV     AL,00H
08B5 3A 06 2098 R        CMP     AL,[SIGN_SIGMA]
08B9 75 06                JNZ     MULTY_SUB       ;IF (Xi-Xm)(Yi-Ym)<0, THEN
;SUBTRACT
08BB E8 05E3 R           CALL    SIXTEEN_BYTE_ADD ;ELSE ADDITION
08BE EB 04 90                JMP     FF
08C1 E8 060F R                MULTY_SUB: CALL    SIXTEEN_BYTE_SUB

08C4 8B 1E 2092 R        FF:   MOV     BX,[Xi_M]      ;GET THE Xi ADDRESS
08C8 83 C3 10                ADD     BX,16           ;POINT TO NEXT Xi
08CB 89 1E 2092 R        MOV     [Xi_M],BX

08CF 8B 1E 2094 R        MOV     BX,[LnYi_M]    ;GET THE LnYi ADDRESS

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08D3 83 C3 08          ADD     BX,08H          ;POINT TO NEXT LnY1
08D6 89 1E 2094 R     MOV     [LnY1_M],BX

08DA C3 1E 2099 R     MOV     BX,[X1_Xm_M]   ;GET ADDRESS OF X1-Xm --> X4-Xm
08DE 83 C3 10          ADD     BX,16          ;POINT TO NEXT UNIT
08E1 89 1E 2099 R     MOV     [X1_Xm_M],BX

08E5 59                POP     CX
08E6 E2 03             LOOP   SG_AGAIN_1
08E8 EB 04 90          JMP     LA
08EB E9 07A4 R         SG_AGAIN_1: JMP     SG_AGAIN

;-----;
; NEXT PART WAS CHECK THE SIGN OF SIGMA(X1-Xm)(Y1-Ym) ;
; 1. IF>=0 RET. [SIGN SIGMA]=0. ;
; 2. IF<0, 1 0000 0000 - SIGMA(X1-Xm)(Y1-Ym) ;
; [SIGN SIGMA]=1. ;
; THE FINAL RESULT WAS STILL STORED IN SIG_X1_Xm_Y1_Ym. ;
;-----;
08EE 8D 1E 21A2 R     LA:      LEA     BX,SIG_X1_Xm_Y1_Ym
08F2 B0 09             MOV     AL,9
08F4 3A 47 07          CMP     AL,[BX]+7     ;CHECK 8th DIGIT IF 9 MINUS,
08F7 75 3C             JNZ     PL            ;IF 0 PLUS, IF PLUS RET.

08F9 8D 3E 2182 R     LEA     DI,COMPLETE   ;YES RESULT IS MINUS ( - )
08FD CA 45 08 01      MOV     MOV     PTR[DI+8],01H ;PROPARE FOR SUBTRACT
0901 8B DF             MOV     BX,DI
0903 8D 3E 21A2 R     LEA     SI,SIG_X1_Xm_Y1_Ym ;CALCULATE THE OBSOLUTE VALUE
0907 84 05F9 R         CALL    EIGHT_BYTE_SUB ;-|OBSU|

090A B9 0008           MOV     CX,8          ;8 BYTE MOVING
090D 8D 3E 21A2 R     LEA     DI,SIG_X1_Xm_Y1_Ym ;RESULT DISTINATION
0911 8D 3E 2182 R     LEA     SI,COMPLETE   ;GET X1 ADDRESS
0915 F3 / A4           REPZ   MOVSB          ;RESULT NOW IN [SIG_X1_Xm_Y1_Ym]

0917 89 0010           MOV     CX,16
091A 8D 1E 2182 R     LEA     BX,COMPLETE   ;CLEAR [COMPLETE] FOR NEXT TIME
091E C6 07 00          CAC:    MOV     [BX],BYTE PTR 00H ;USE
0920 41                INC     BX
0922 83 FA             LOOP   CAC

0924 8D 1E 2098 R     LEA     BX,SIGN_SIGMA ;[SIGN_SIGMA]=1
0928 8D 3E 23CA R     LEA     DI,SYMBLE_B
092C 83 01             MOV     AL,1
092E C6 07           MOV     [BX],AL
0930 8B 05             MOV     [DI],AL
0932 EB 0F 90          JMP     PLL

0935 8D 1E 2098 R     PL:     LEA     BX,SIGN_SIGMA ;[SIGN_SIGMA]=1
0939 8D 3E 23CA R     LEA     DI,SYMBLE_B
093D B0 00             MOV     AL,0
093F 8B 07             MOV     [BX],AL
0941 8B 05             MOV     [DI],AL

0943 C3                PLL:    RET

D_NOMINATION ENDP
;
;
0944 D_DENOMINATION PROC NEAR ;SUBROUTINE No. 20 FOR THE RTDP
;-----;
; THIS PROGRAM WAS TO CALCULATE SIGMA (X1-Xm) ;
; 1. GET THE DATA FROM (X1_Xm) -- (X4_Xm) ;
; 2. (X1-Xm)^2 CALCULATION RESULT IN PRODUCT. ;
; 3. THE PRODUCTS ARE ADDED ON SIG_X1_Xm^2 ;
;-----;
0944 B9 0003           MOV     CX,03          ;SIGMA I = 1 -- 4

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0947 8D 1E 21D2 R      LEA    BX,X1_Xm
094B 89 1E 2099 R      MOV    [X1_Xm_M],BX    ;X1_XM ADDRESS STORAGE

094F 51                PZ:    PUSH   CX
0950 8B 36 2099 R      MOV    SI,[X1_Xm_M]
0954 8B FE             MOV    DI,SI
0956 8D 1E 20D2 R      LEA    BX,INTERMEDIATE

095A E8 064B R          CALL   EIGH_MUL_EIGH    ;THE RESULT WAS AT PRODUCTION.

095D 8D 1E 2212 R      LEA    BX,SIG_X1_Xm_SQ_2 ;GET THE ADDRESS OF
0961 8D 36 20E2 R      LEA    SI,PRODUCT      ;SIGMA (X1-Xm)^2
0965 51                PUSH   CX
0966 E8 05CD R          CALL   NINE_BYTE_ADD
0969 59                POP    CX
096A 8B 1E 2099 R      MOV    BX,[X1_Xm_M]    ;X1_XM ADDRESS STORAGE
096E 83 C3 10          ADD    BX,16
0971 89 1E 2099 R      MOV    [X1_Xm_M],BX    ;X1_XM ADDRESS STORAGE
0975 59                POP    CX
0976 E2 D7             LOOP   PZ

0978 C3                RET

D_DENOMINATION ENDP
;
;
D_RESULT      PROC      NEAR      ;SUBROUTINE No. 21 FOR THE RTDP.
;-----
; THIS SUBROUTINE WAS TO CALCULATE THE PARAMETER D IN BINARY:
; 1.e. D'S NOMINATION / D'S DENOMINATION=D (BIN)
; IT WAS 32 BIT DIVIDED BY 32 BIT CALCULATION
; 1. THE DIVISOR WAS AT [DI] -- [DI+5]
; IF THE DIVISOR WAS EQUAL OR ABOVE 65535
; THEN DIVISOR/16, THEN DIVIDEND/16 AGAIN.
; 2. THE DIVIDEND WAS AT [SI] -- [SI+5]
; 3. THE QUOTINET WAS AT [BX] -- [BX+5] THE REMAINDER IS
;-----
0979 8B 45 02          MOV    AX,[DI+2]      ;TEST THE DIVISOR
097C 3D 0001          CMP    AX,1
097F 73 03            JAE    DIVISOR_16
0981 EB 1F 90          JMP    NORMAL

0984 8B 05            DIVISOR_16: MOV    AX,[DI]      ;THE ACTION EQUALS TO DATA/16
0986 B1 04            MOV    CL,4
0988 D3 E8            SHR    AX,CL
098A 50                PUSH   AX
098B 8B 45 02          MOV    AX,[DI+2]
098E B1 0C            MOV    CL,12
0990 D3 E0            SHL    AX,CL
0992 8B C8            MOV    CX,AX
0994 58                POP    AX
0995 0B C1            OR     AX,CX
0997 89 05            MOV    [DI],AX

0999 53                PUSH   BX
099A 8D 1E 209B R      LEA    BX,ABOVE_16
099E C6 07 01          MOV    BYTE PTR[BX],1
09A1 5B                POP    BX

;----- INTEGER PART -----
09A2 BA 0000          NORMAL:  MOV    DX,00H      ;CLEAR DX FOR STORING REMAINDER
09A5 8B 44 02          MOV    AX,[SI+2]    ;FETCH THE MSW OF DIVIDEND
09A8 8B 0D            MOV    CX,[DI]      ;FETCH THE DIVISOR
09AA F7 F1            DIV    CX            ;DX:AX/CX = AX .....DX

09AC 89 47 04          MOV    [BX+4],AX    ;THE QUOTINET MSW
09AF 8B 04            MOV    AX,[SI]      ;FETCH THE LSW OF DIVIDEND
09B1 F7 F1            DIV    CX            ;DX:AX/CX = AX .....DX

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09B3 89 47 02      MOV     [BX+2],AX
09B6 B8 0000      MOV     AX,00H      ;CLEAR AX FOR DECIMAL FRACTION
09B9 F7 F1        DIV     CX
09BB 89 07        MOV     [BX],AX     ;DECIMAL PART IN [BX]

09BD 53          PUSH    BX
09BE 8D 1E 209B R LEA     BX,ABOVE_16 ;CHECK FLAG
09C2 B0 01        MOV     AL,1
09C4 3A 07        CMP     AL,[BX]
09C6 5B          POP     BX
09C7 75 1C        JNZ     NORMAL_1    ;IF 1 DIVISOR/16, IF 0 NORMAL_1

09C9 BA 0000      MOV     DX,00H     ;DIVISOR/16
09CC 8B 47 04      MOV     AX,[BX+4]
09CF B9 0010      MOV     CX,16
09D2 F7 F1        DIV     CX
09D4 89 47 04      MOV     [BX+4],AX

09D7 8B 47 02      MOV     AX,[BX+2]
09DA F7 F1        DIV     CX
09DC 89 47 02      MOV     [BX+2],AX

09DF 8B 07        MOV     AX,[BX]
09E1 F7 F1        DIV     CX
09E3 89 07        MOV     [BX],AX

09E5 53          NORMAL_1: PUSH    BX
09E6 8D 1E 209B R LEA     BX,ABOVE_16 ;RESET THE FLAG FOR NEXT TIME USE
09EA C6 07 00      MOV     BYTE PTR[BX],0
09ED 5B          POP     BX

09EE C3          RET

D_RESULT      ENDP
;
;
C_RESULT      PROC    NEAR      ;SUBROUTINE No. 22 FOR THE RTDP.
;-----
; THIS SUBROUTINE WAS TO CALCULATE THE PARAMETER C (BCD) .;
; C = MEAN_LnY1 + D * MEAN_X1
; 1. D * MEAN_X1
; 2. MEAN_LnY1 + D * MEAN_X1
;-----
;----- CALCULATE D * MEAN_X1 -----
09EF 8D 36 2242 R LEA     SI,D_BCD    ;POINT TO D_BCD
09F3 8D 3E 2172 R LEA     DI,MEAN_X1
09F7 8D 1E 20D2 R LEA     BX,INTERMEDIATE
09FB E8 064B R     CALL    EIGH_MUL_EIGH ;NOW THE RESULT WAS IN [PRODUTOIN]

09FE FC          CLD          ;SET DF=0 TO MOVE FORWARD
09FF 8D 36 2112 R LEA     SI,MEAN_LnY1 ;MOV THIS DATA TO NEXT DATA AREA
0A03 8D 3E 22C2 R LEA     DI,MEAN_LnY1_FOR_C ;TO KEEP THE MEAN_LnY1 VALUE
0A07 B9 0010      MOV     CX,16
0A0A F3/ A4      REP     MOVSB     ;MOVES 16 BYTE FROM [SI] TO [DI]

0A0C 8D 36 20E2 R LEA     SI,PRODUCT
0A10 8D 1E 22C2 R LEA     BX,MEAN_LnY1_FOR_C
0A14 51          PUSH    CX
0A15 E8 05E3 R     CALL    SIXTEEN_BYTE_ADD ;NOW THE RESULT OF C WAS
0A18 59          POP     CX      ;IN [MEAN_LnY1_FOR_C].

0A19 C3          RET

C_RESULT      ENDP
;
;

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O01A          BIN_BCD      PROC      NEAR      ;SUBROUTINE No. 23 FOR THE RIDP.
;-----
;THIS PROGRAM WAS TO CONVERT A BINARY DATA INTO 8 DIGIT
;BCD DATA
; 1. THE DATA TO BE CONVERTED WAS AT [SI] -- [SI+3] 2 WORDS
;
;      i.e.  WORD . WORD
;-----
; 2. [SI+3] -- [SI+2] ARE THE INTEGER PART ( WORD )
;    [SI+1] -- [SI]  ARE DISIMAL FRACTION PART ( WORD )
; 3. DIGIMAL PART BIN-BCD STORE IN [DI] -- [DI+4] TEMPERARELY
; 4. THE RESULT WILL BE STORED AT [BX] -- [BX+8]
;-----

;----- INTERGR PART -----
O01A  BA 0000      MOV     DX,0
O01D  8B 44 02     MOV     AX,[SI+2]
O020  B9 2710     MOV     CX,10000
O023  F7 F1      DIV     CX
O025  88 47 08     MOV     [BX+8],AL

O028  8B C2      MOV     AX,DX
O02A  BA 0000     MOV     DX,00H
O02D  B9 03E8     MOV     CX,1000
O030  F7 F1      DIV     CX
O032  88 47 07     MOV     [BX+7],AL

O035  8B C2      MOV     AX,DX
O037  BA 0000     MOV     DX,00H
O03A  B9 0C62     MOV     CX,100
O03D  F7 F1      DIV     CX
O03F  88 47 06     MOV     [BX+6],AL

O042  8B C2      MOV     AX,DX
O044  BA 0000     MOV     DX,00H
O047  B9 000A     MOV     CX,10
O04A  F7 F1      DIV     CX
O04C  88 47 05     MOV     [BX+5],AL

O04F  88 57 04     MOV     [BX+4],DL

;----- DISIMAL FRACTION PART -----
; 1. CONVERT BIN TO BCD
; 2. BCD * 0.000015258
;-----

O052  BA 0000     MOV     DX,00H
O055  8B 04      MOV     AX,[SI]
O057  B9 2710     MOV     CX,10000
O05A  F7 F1      DIV     CX
O05C  88 45 04     MOV     [DI+4],AL

O05F  8B C2      MOV     AX,DX
O061  BA 0000     MOV     DX,00H
O064  B9 03E8     MOV     CX,1000
O067  F7 F1      DIV     CX
O069  88 45 03     MOV     [DI+3],AL

O06C  8B C2      MOV     AX,DX
O06E  BA 0000     MOV     DX,00H
O071  B9 0064     MOV     CX,100
O074  F7 F1      DIV     CX
O076  88 45 02     MOV     [DI+2],AL

O079  8B C2      MOV     AX,DX
O07B  BA 0000     MOV     DX,00H
O07E  B9 000A     MOV     CX,10
O081  F7 F1      DIV     CX

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OB64 8B C2      MOV     AX,DX
OB66 BA 0000    MOV     DX,00H
OB69 B9 000A    MOV     CX,10
OB6C F7 F1      DIV     CX
OB6E 0C 30      OR      AL,30H
OB70 88 47 03   MOV     [BX+3],AL
OB73 80 CA 30   OR      DL,30H
OB76 88 57 04   MOV     [BX+4],DL

OB79 C3        RET

BIN_BCD_INTEGER      ENDP
:
:
BCD_BIN_C      PROC     NEAR      ;SUBROUTINE No. 26 FOR THE RTDP.
;-----
;THIS SUBROUTINE WAS TO CONVERT ONE 6 DIGIT BCD DATA ;
;IN TO BINARY DATA. X X . X X X X ;
; 1.THE DATA TO BE CONVERTED WAS AT [SI] -- [SI]+8 ;
; 2.THE RESULT WILL BE PUT IN [BX+2].[BX] WORD ;
;-----
OB7A 8A 04      MOV     AL,BYTE PTR[SI] ;LSB OF FRAGMENT PART OF
OB7C B4 00      MOV     AH,0
OB7E B9 0006    MOV     CX,6H           ;THE DATA TO BE CONVERTED
OB81 F7 E1      MUL     CX               ;THE DIGIT WAS MULTIPLIED
OB83 89 07      MOV     [BX],AX         ;BY 0.0007H, RESULT WAS IN [BX].

OB85 46        INC     SI
OB86 8A 04      MOV     AL,BYTE PTR[SI] ;SECOND LSB OF THE DATA
OB88 B4 00      MOV     AH,0
OB8A B9 0042    MOV     CX,42H          ;THE DIGIT WAS MULTIPLIED BY 0.0042H
OB8D F7 E1      MUL     CX               ;CONVERTED DATA ADDS LSB
OB8F 03 07      ADD     AX,[BX]         ;SEND TO RAM
OB91 89 07      MOV     [BX],AX

OB93 46        INC     SI
OB94 8A 04      MOV     AL,BYTE PTR[SI] ;THIRD LSB OF THE DATA TO BE
OB96 B4 00      MOV     AH,0           ;CONVERTED
OB98 B9 028FH   MOV     CX,28FH        ;THE DIGIT WAS MULTIPLIED BY 0.028FH
OB9B F7 E1      MUL     CX               ;CONVERTED DATA ADDS LSB
OB9D 03 07      ADD     AX,[BX]         ;SEND TO RAM
OB9F 89 07      MOV     [BX],AX

OBA1 46        INC     SI
OBA2 8A 04      MOV     AL,BYTE PTR[SI] ;FOURTH LSB OF THE DATA TO BE
OBA4 B4 00      MOV     AH,0           ;CONVERTED
OBA6 B9 199AH   MOV     CX,199AH       ;THE DIGIT WAS MULTIPLIED BY 0.199AH
OBA9 F7 E1      MUL     CX               ;CONVERTED DATA ADDS LSB
OBAB 03 07      ADD     AX,[BX]         ;SEND TO RAM
OBAD 89 07      MOV     [BX],AX

OBAF 46        INC     SI
OBB0 8A 04      MOV     AL,BYTE PTR[SI] ;LSB OF THE INTEGER PART
OBB2 B4 00      MOV     AH,0
OBB4 B9 47 02   MOV     [BX+2],AX      ;SEND TO RAM

OBB7 46        INC     SI           ;SIXTH DIGIT OF DATA
OBB8 8A 04      MOV     AL,BYTE PTR[SI]
OBBA B4 00      MOV     AH,0
OBBC B9 000A    MOV     CX,10
OBBF F7 E1      MUL     CX
OBC1 03 47 02   ADD     AX,[BX+2]
OBC4 89 47 02   MOV     [BX+2],AX

OBC7 C3        RET

```

```

BCD_BIN_C      ENDP
;
;
;
A_COEF_A_D_B  PROC      NEAR      ;SUBROUTINE No. 27 FOR THE RTDP.
;-----;
; THIS PROCEDURE WAS TO CALCULATE A COEF AND A/B ;
; BECAUSE C = LnA, COEF. A = EXP(C) = EXP(a+b) ;
; EXP(a+b) = EXPa * EXPb. EXPa: LOOK UP TABLE; ;
; 1. EXPb WAS CALCULATED WITH INTERACTIVE OPERATION.; ;
; 2. THE RESULT WILL BE IN [EXP_N+2].[EXP_N] ; ;
; 3. A WILL BE IN [A_COEF].[A_COEF+2] ; ;
; 4. A/B WILL BE IN [A_DIV_B+2].[A_DIV_B] ; ;
;-----;
OBC8  8D 36 22A2 R      LEA     SI,C_BIN
OBC9  8D 1E 2272 R      LEA     BX,EXP_b
OBDD  E8 0CAD R        CALL    EXP_a_PLUS_b ;CALCULATE EXP a+b WITH
;INTERACTIVE OPERATION
;POINT TO A COEFFICIENT
OBD3  8D 3E 23BC R      LEA     DI,A_COEF ;MOVE A_COEF FOR FOUTHER PROCESS
OBD7  8D 36 209C R      LEA     SI,EXP_N
OBD8  8B 04            MOV     AX,[SI]
OBD9  89 05            MOV     [DI],AX
OBDF  8B 44 02         MOV     AX,[SI+2]
OBE2  89 45 02         MOV     [DI+2],AX ;A_COEF WAS IN [A_COEF+2].[A_COEF]
;CLEAR [EXP_N] FOR NEXT CALCULAT
OBE5  8B 0000         MOV     AX,0
OBE8  89 04            MOV     [SI],AX
OBEA  89 44 02         MOV     [SI+2],AX
;POINT TO A COEF
;POINT TO B COEF
;POINT TO RESULT ADDRESS A/B
OBED  8D 36 23BC R      LEA     SI,A_COEF
OBF1  8D 3E 23C4 R      LEA     DI,D_BIN
OBF5  8D 1E 2300 R      LEA     BX,A_DIV_B
;PROTECT DATA IN [DI+2].[DI]
;BORROW THOS AREA
OBF9  53
OBF9  8B 05            MOV     AX,[DI]
OBF9  8D 1E 20B2 R      LEA     BX,TABLE_M
OC00  89 07            MOV     [BX],AX
OC02  8B 45 02         MOV     AX,[DI+2]
OC05  89 47 02         MOV     [BX+2],AX
OC08  5B            POP     BX
;CALCULATE A/B. THE RESULT NOW IN
;[A_DIV_B+2].[A_DIV_B]
;RESUME THE ORIGINAL DATA.
OC09  E8 0979 R        CALL    D_RESULT
;POINT TO A COEF
;POINT TO B_BIN
OC0C  8D 1E 20B2 R      LEA     BX,TABLE_M
OC10  8D 3E 23C4 R      LEA     DI,D_BIN
OC14  8B 07            MOV     AX,[BX]
OC16  89 05            MOV     [DI],AX
OC18  8B 47 02         MOV     AX,[BX+2]
OC1B  89 45 02         MOV     [DI+2],AX
;
;
;
A_COEF_A_D_B  ENDP
;
;
;
NEGA_B_MUL_XO PROC      NEAR      ;SUBROUTINE No. 28 FOR THE RTDP.
;-----;
; THIS SUBROUTINE WAS TO CALCULATE -B*XO ;
; THE RESULT WILLBE IN NEGA_B_XO ;
;-----;
OC1F  8D 36 2152 R      LEA     SI,XO ;CALCULATE -B*XO
OC23  8D 1E 23C4 R      LEA     BX,D_BIN ;D=B
OC27  8D 3E 2304 R      LEA     DI,NEGA_B_XO ;THE RESULT WILL BE IN
;[NEGA_B_XO+2].[NEGA_B_XO]
;XO FRAGMENT PART ONLY
OC2E  8B 04            MOV     AX,[SI] ;B'S FRAGMENT PART IN CX
OC2D  8B 0F            MOV     CX,[BX] ;DX:AX FRAGMENT:FRAGMENT AX
OC2F  F7 E1            MUL     CX ;OMITTED
OC31  89 15            MOV     [DI],DX

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0C33 8B 04          MOV     AX,[SI]
0C35 8B 4F 02       MOV     CX,[BX+2]      ;B'S INTEGER PART IN CX
0C38 F7 E1         MUL     CX             ;DX:AX INTEGER:FRAGMENT
0C3A 03 05         ADD     AX,[DI]
0C3C 89 05         MOV     [DI],AX
0C3E 13 55 02       ADC     DX,[DI+2]
0C41 89 55 02       MOV     [DI+2],DX

0C44 C3           RET

      NEGA_B_MUL_X0  ENDP
      ;
      ;
0C45          EXP_NEGA_B_X0  PROC  NEAR          ;SUBROUTINE No. 29 FOR THE RTDP.

0C45 8D 1E 2098 R   LEA     BX,SIGN_SIGMA  ;TEST + OR - SYMBLE OF B=D
0C49 80 01         MOV     AL,1           ;SINCE D DENOMINATION WAS +
0C4B 3A 07         CMP     AL,BYTE PTR[BX] ;D NOMINATION WAS - OR +
0C4D 74 03         JZ     FU
0C4F EB 0F 90       JMP     ZHENG

FU:      0C52 8D 36 2304 R   LEA     SI,NEGA_B_X0
0C56 8D 1E 2272 R   LEA     BX,EXP_b
0C5A E8 0E7A R     CALL    EXP_a_PLUS_b_NEGA
0C5D EB 0C 90       JMP     FU_1

ZHENG:   0C60 8D 36 2304 R   LEA     SI,NEGA_B_X0
0C64 8D 1E 2272 R   LEA     BX,EXP_b
0C68 E8 0CAD R     CALL    EXP_a_PLUS_b

FU_1:   0C6B 8D 3E 2308 R   LEA     DI,EXP_N_B_X0
0C6F 8D 3E 209C R   LEA     SI,EXP_N
0C73 8B 04         MOV     AX,[SI]
0C75 89 05         MOV     [DI],AX
0C77 8B 44 02       MOV     AX,[SI+2]
0C7A 89 45 02       MOV     [DI+2],AX

0C7D C3           RET

      EXP_NEGA_B_X0  ENDP
      ;
      ;
0C7E          LOSS      PROC  NEAR          ;SUBROUTINE No. 30 FOR THE RTDP.
      ;-----
      ;THIS SUBROUTINE WAS TO CALCULATE A/B*EXP(-B*X0)
      ; 1. A_DIV_B * EXP_N_B_X0 = LOSS_DATA_1
      ; 2. THE RESULT WILL BE IN [LOSS_DATA_1+2].[LOSS_DATA_1]
      ;-----
0C7E 8D 36 2300 R   LEA     SI,A_DIV_B    ;POINT TO A/B
0C82 8D 1E 2308 R   LEA     BX,EXP_N_B_X0 ;POINT TO EXP(-B*X0)
0C86 8D 3E 23CC R   LEA     DI,LOSS_DATA_1 ;POINT TO RESULT LOSS_DATA_1
0C8A 8B 04         MOV     AX,[SI]       ;FRAGMENT PART OF A/B
0C8C F7 27         MUL     WORD PTR[BX]  ;MUL FRAGMENT PART OF EXP(-B*X0)
0C8E 89 15         MOV     [DI],DX       ;AX WAS OMITTED
0C90 8B 44 02       MOV     AX,[SI+2]     ;INTEGER PART OF A/B
0C93 F7 27         MUL     WORD PTR[BX]  ;MUL FRAGMENT OF EXP(-B*X0)
0C95 03 05         ADD     AX,[DI]       ;DX:AX INTEGER:FRAGMENT
0C97 89 05         MOV     [DI],AX
0C99 13 55 02       ADC     DX,[DI+2]
0C9C 89 55 02       MOV     [DI+2],DX

0C9F 8B 44 02       MOV     AX,[SI+2]     ;INTEGER PART OF A/B
0CA2 F7 67 02       MUL     WORD PTR[BX+2] ;MUL INTEGER PART OF EXP(-B*X0)
0CA5 03 45 02       ADD     AX,[DI+2]
0CAB 89 45 02       MOV     [DI+2],AX

0CAB C3           RET

```

```

LOSS      ENDP
:
:
OCAC      GRAIN_LOSS PROC    NEAR
:
OCAC C3    RET
:
GRAIN_LOSS ENDP
:
:
OCAD      EXP_a_PLUS_b PROC    NEAR      ;SUBROUTINE NO. 31 FOR THE RIDP.
:-----
: THIS SUBROUTINE WAS TO CALCULATE EXP (a+b). a AND b ARE:
: INTEGER AND DISIMAL PART RESPECTIVELY.
: 1.EXP a WILL BE FOUND IN LOOK UP TABLE
: 2.EXP b WILL BE CALCULATED WITH INTERACTIVE OPERATION
: 3.BEFOR CALCULATION THE DATA TO BE CONVERTED WAS AT
: [SI+2].[SI]
: 4.THE RESULT THEN WAS PUT IN [BX] I.E. [EXP_N] FRAC
: [EXP_N+2] INTEGER
:-----
:-----THE FIRST PART WAS EXP(b)-----
OCAD 8D 1E 209E R    LEA    BX,EXP_N+2    ;RESULT INTEGER ADDRESS
OCB1 B8 0001        MOV    AX,01          ;THE FIRST ITEM
OCB4 89 07          MOV    [BX],AX        ;INTEGER PART
OCB6 8D 1E 209C R    LEA    BX,EXP_N      ;FRACTION PART
OCBA 8B 04          MOV    AX,[SI]        ;+D BIN+...
OCBC 89 07          MOV    [BX],AX        ;RESULT IN [EXP_N] LOOKS LIKE 1.b
OCBE 8B 04          MOV    AX,[SI]        ;FETCH b (BIN)
OCC0 BA 0000        MOV    DX,0           ;CLEAR DX FOR DIV REMAINDER
OCC3 B9 0001        MOV    CX,1           ; 2
OCC6 E8 0F92 R      CALL   DATA_POWER    ; DATA POWER
OCC9 B9 0002        MOV    CX,CM_2        ; 2!
OCCC F7 F1          DIV    CX              ; DATA POWER / 2!
OCCE 03 07          ADD    AX,[BX]        ; +D BIN^2/2!
OCD0 89 07          MOV    [BX],AX        ;THE RESULT NOW IN [EXP_N]
OCD2 8B 47 02       MOV    AX,[BX+2]
OCD5 15 0000        ADC    AX,0           ;ADD THE CARRY
OCD8 89 47 02       MOV    [BX+2],AX     ;NEW INTEGER PART

OCDB 8B 04          MOV    AX,[SI]        ;FETCH b (BIN)
OCDD BA 0000        MOV    DX,0           ;CLEAR DX FOR DIV REMAINDER
OCED B9 0002        MOV    CX,2           ; 3
OCE3 E8 0F92 R      CALL   DATA_POWER    ; DATA POWER
OCE6 B9 0006        MOV    CX,CM_3        ; 3!
OCE9 F7 F1          DIV    CX              ; DATA POWER / 3!
OCEB 8D 1E 209C R    LEA    BX,EXP_N      ; +D BIN^2/3!
OCEF 03 07          ADD    AX,[BX]        ;THE RESULT NOW IN [EXP_N]
OCF1 89 07          MOV    [BX],AX
OCF3 8B 47 02       MOV    AX,[BX+2]
OCF6 15 0000        ADC    AX,0           ;ADD THE CARRY
OCF9 89 47 02       MOV    [BX+2],AX     ;NEW INTEGER PART

OCFC 8B 04          MOV    AX,[SI]        ;FETCH b (BIN)
OCFE BA 0000        MOV    DX,0           ;CLEAR DX FOR DIV REMAINDER
OD01 B9 0003        MOV    CX,3           ; 4
OD04 E8 0F92 R      CALL   DATA_POWER    ; DATA POWER
OD07 B9 0018        MOV    CX,CM_4        ; 4!
OD0A F7 F1          DIV    CX              ; DATA POWER / 4!
OD0C 8D 1E 209C R    LEA    BX,EXP_N      ; +D BIN^2/4!
OD10 03 07          ADD    AX,[BX]        ;THE RESULT NOW IN [EXP_N]
OD12 89 07          MOV    [BX],AX
OD14 8B 47 02       MOV    AX,[BX+2]
OD17 15 0000        ADC    AX,0           ;ADD THE CARRY
OD1A 89 47 02       MOV    [BX+2],AX     ;NEW INTEGER PART

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OD1D 8B 04          MOV     AX,[SI]          ;FETCH b (BIN)
OD1F BA 0000        MOV     DX,0            ;CLEAR DX FOR DIV REMAINDER
OD22 B9 0004        MOV     CX,4            ; 5
OD25 E8 0F92 R     CALL    DATA_POWER    ; DATA POWER
OD28 B9 0078        MOV     CX,CX_5        ; 5!
OD2B F7 F1         DIV     CX              ; DATA POWER / 5!
OD2D 8D 1E 209C R  LEA    BX,EXP_N
OD31 03 07         ADD     AX,[BX]        ; +D_BIN^2/5!
OD33 89 07         MOV     [BX],AX       ;THE RESULT NOW IN [EXP_N]
OD35 8B 47 02      MOV     AX,[BX+2]
OD38 15 0000       ADC     AX,0           ;ADD THE CARRY
OD3B 89 47 02      MOV     [BX+2],AX     ;NEW INTEGER PART

OD3E 8B 04          MOV     AX,[SI]          ;FETCH b (BIN)
OD40 BA 0000        MOV     DX,0            ;CLEAR DX FOR DIV REMAINDER
OD43 B9 0005        MOV     CX,5            ; 6
OD46 E8 0F92 R     CALL    DATA_POWER    ; DATA POWER
OD49 B9 02D0       MOV     CX,CX_6        ; 6!
OD4C F7 F1         DIV     CX              ; DATA POWER / 6!
OD4E 8D 1E 209C R  LEA    BX,EXP_N
OD52 03 07         ADD     AX,[BX]        ; +D_BIN^2/6!
OD54 89 07         MOV     [BX],AX       ;THE RESULT NOW IN [EXP_N]
OD56 8B 47 02      MOV     AX,[BX+2]
OD59 15 0000       ADC     AX,0           ;ADD THE CARRY
OD5C 89 47 02      MOV     [BX+2],AX     ;NEW INTEGER PART

OD5F 8B 04          MOV     AX,[SI]          ;FETCH b (BIN)
OD61 BA 0000        MOV     DX,0            ;CLEAR DX FOR DIV REMAINDER
OD64 B9 0006        MOV     CX,6            ; 7
OD67 E8 0F92 R     CALL    DATA_POWER    ; DATA POWER
OD6A B9 13B0       MOV     CX,CX_7        ; 7!
OD6D F7 F1         DIV     CX              ; DATA POWER / 7!
OD6F 8D 1E 209C R  LEA    BX,EXP_N
OD73 03 07         ADD     AX,[BX]        ; +D_BIN^2/7!
OD75 89 07         MOV     [BX],AX       ;THE RESULT NOW IN [EXP_N]
OD77 8D 1E 209E R  LEA    BX,EXP_N+2
OD7B 8B 47 02      MOV     AX,[BX+2]
OD7E 15 0000       ADC     AX,0           ;ADD THE CARRY
OD81 89 47 02      MOV     [BX+2],AX     ;NEW INTEGER PART

OD84 8B 04          MOV     AX,[SI]          ;FETCH b (BIN)
OD86 BA 0000        MOV     DX,0            ;CLEAR DX FOR DIV REMAINDER
OD89 B9 0007        MOV     CX,7            ; 8
OD8C E8 0F92 R     CALL    DATA_POWER    ; DATA POWER
OD8F B9 9DB0       MOV     CX,CX_8        ; 8!
OD92 F7 F1         DIV     CX              ; DATA POWER / 8!
OD94 8D 1E 209C R  LEA    BX,EXP_N
OD98 03 07         ADD     AX,[BX]        ; +D_BIN^2/8!
OD9A 89 07         MOV     [BX],AX       ;THE RESULT NOW IN [EXP_N]
OD9C 8B 47 02      MOV     AX,[BX+2]
OD9F 15 0000       ADC     AX,0           ;ADD THE CARRY
ODA2 89 47 02      MOV     [BX+2],AX     ;NEW INTEGER PART

;--- SO FAR THE RESULT OF EXP b WAS STORED IN [EXP_N+2].[EXP_N] ---;
; NEXT STEP WAS TO CALCULATE (EXP a) * (EXP b) ;
; 1. EXP a, a = 1--15, ARE DEFINED DATA AREA (2 X DD OR 8 BYTE). ;
; 2. EXP a * EXP b (INTEGER) + EXP a * EXP b(FRAGMENT) ;
; 3. THE RESULT WAS STILL STORED IN [EXP_N+4 ] [EXP_N+2].[EXP_N] ;
;-----;
ODA5 8B 5C 02      MOV     BX,[SI+2]      ;BX WAS BASE ADDRESS FOR LOOK UP
;EXP_N
ODA8 BE CE30      MOV     SI,0CE30H     ;LEA SI,EXP_0+100H THE FIRST
;ADDRESS OF LOOK UP TABLE
ODAB 8B C3        MOV     AX,BX         ;PREPARE BASE * No. OF BYTE
ODAD B9 0008      MOV     CX,8          ;
ODB0 F7 E1       MUL     CX            ;BASE * No. OF BYTE
ODB2 8B D8       MOV     BX,AX

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ODB4 8B 00          MOV     AX,[BX][SI]      ;POINT TO THE TABLE

;-----MULTIPLY THE INTEGER PART OF EXP b-----
ODB6 8D 3E 209E R  LEA     DI,EXP_N+2      ;INTEGER ADDRESS OF EXPb
ODBA BA 0000        MOV     DX,0
ODBD 8B 0D          MOV     CX,[DI]
ODBF F7 E1          MUL     CX              ;NOW THE RESULT WAS IN DX:AX
ODC1 53            PUSH    BX              ;SAVE BASE ADDRESS
ODC2 8D 1E 2282 R  LEA     BX,EXPa_MUL_EXPb_INTEGER
ODC6 89 07          MOV     [BX],AX
ODC8 89 57 02        MOV     [BX+2],DX
ODCB 5B            POP     BX              ;RESUME BASE ADDRESS

ODCC 8B 40 02        MOV     AX,[BX][SI+2]   ;NEXT WORD
ODCF BA 0000        MOV     DX,0
ODD2 F7 E1          MUL     CX
ODD4 53            PUSH    BX              ;SAVE BASE ADDRESS
ODD5 8D 1E 2282 R  LEA     BX,EXPa_MUL_EXPb_INTEGER
ODD9 03 47 02        ADD     AX,[BX+2]      ; DX:AX
ODDC 89 47 02        MOV     [BX+2],AX     ; + DX:AX ;<---[BX]
ODDF 83 D2 00        ADC     DX,0           ;-----
ODE2 89 57 04        MOV     [BX+4],DX
ODE5 5B            POP     BX              ;RESUME BASE ADDRESS

ODE6 8B 40 04        MOV     AX,[BX][SI+4]   ;NEXT WORD
ODE9 BA 0000        MOV     DX,0
ODEC F7 E1          MUL     CX
ODEE 53            PUSH    BX
ODEF 8D 1E 2282 R  LEA     BX,EXPa_MUL_EXPb_INTEGER
ODF3 03 47 04        ADD     AX,[BX+4]     ; DX:AX
ODF6 89 47 04        MOV     [BX+4],AX     ; + DX:AX ;<---[BX]
ODF9 83 D2 00        ADC     DX,0           ;+DX:AX
ODFC 89 57 06        MOV     [BX+6],DX     ;-----
ODFF 5B            POP     BX

OE00 8B 00          MOV     AX,[BX][SI]     ;POINT TO THE TABLE
OE02 8D 3E 209C R  LEA     DI,EXP_N       ;FRAGMENT ADDRESS OF EXPb
OE06 BA 0000        MOV     DX,0
OE09 8B 0D          MOV     CX,[DI]
OE0B F7 E1          MUL     CX              ;NOW THE RESULT WAS IN DX:AX
OE0D 53            PUSH    BX              ;SAVE BASE ADDRESS
OE0E 8D 1E 2292 R  LEA     BX,EXPa_MUL_EXPb_FRAGMENT
OE12 89 07          MOV     [BX],AX
OE14 89 57 02        MOV     [BX+2],DX
OE17 5B            POP     BX              ;RESUME BASE ADDRESS

OE18 8B 40 02        MOV     AX,[BX][SI+2]   ;NEXT WORD
OE1B BA 0000        MOV     DX,0
OE1E F7 E1          MUL     CX
OE20 53            PUSH    BX              ;SAVE BASE ADDRESS
OE21 8D 1E 2292 R  LEA     BX,EXPa_MUL_EXPb_FRAGMENT
OE25 03 47 02        ADD     AX,[BX+2]     ; DX:AX
OE28 89 47 02        MOV     [BX+2],AX     ; + DX:AX ;<---[BX]
OE2B 83 D2 00        ADC     DX,0           ;-----
OE2E 89 57 04        MOV     [BX+4],DX
OE31 5B            POP     BX              ;RESUME BASE ADDRESS

OE32 8B 40 04        MOV     AX,[BX][SI+4]   ;NEXT WORD
OE35 BA 0000        MOV     DX,0
OE38 F7 E1          MUL     CX
OE3A 53            PUSH    BX
OE3B 8D 1E 2292 R  LEA     BX,EXPa_MUL_EXPb_FRAGMENT
OE3F 03 47 04        ADD     AX,[BX+4]     ; DX:AX
OE42 89 47 04        MOV     [BX+4],AX     ; + DX:AX ;<---[BX]
OE45 83 D2 00        ADC     DX,0           ;+DX:AX
OE48 89 57 06        MOV     [BX+6],DX     ;-----
OE4B 5B            POP     BX

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;-----EXP a * EXP b INTEGER PLUS EXP a * EXP b FRAGMENT-----
0E4C 8D 36 2282 R      LEA     SI,EXP a_MUL_EXP b_INTEGER
0E50 8D 3E 2294 R      LEA     DI,EXP a_MUL_EXP b_FRAGMENT+2 ;KEEP 16 BIT FRAGMENT
0E54 8D 1E 209C R      LEA     BX,EXP_N

0E58 8B 04             MOV     AX,[SI]
0E5A 03 05             ADD     AX,[DI]
0E5C 89 07             MOV     [BX],AX

0E5E 8B 44 02         MOV     AX,[SI+2]
0E61 13 45 02         ADC     AX,[DI+2]
0E64 89 47 02         MOV     [BX+2],AX

0E67 8B 44 04         MOV     AX,[SI+4]
0E6A 13 45 04         ADC     AX,[DI+4]
0E6D 89 47 04         MOV     [BX+4],AX

0E70 8B 44 06         MOV     AX,[SI+6]
0E73 13 45 06         ADC     AX,[DI+6]
0E76 89 47 06         MOV     [BX+6],AX

0E79 C3               RET

EXP_a_PLUS_b ENDP
;
;
0E7A                   EXP_a_PLUS_b_NEGA PROC     NEAR     ;SUBROUTINE No. 32 FOR THE RTDP.
;-----
; THIS SUBROUTINE WAS TO CALCULATE EXP (a+b). a+b<0
; a & b ARE INTEGER AND DISIMAL PART RESPECTIVELY.
; 1.EXP a WILL BE FOUND IN LOOK UP TABLE
; 2.EXP b WILL BE CALCULATED WITH INTERACTIVE OPERATION
; 3.BEFOR CALCULATION THE DATA TO BE CONVERTED WAS AT
; [SI]
; 4.THE RESULT THEN WAS PUT IN [BX] i.e. [EXP_N] FRAC
; [EXP_N+2] INTEGER
;-----
;-----THE FIRST PART WAS EXP(b) -----
0E7A 8D 1E 209C R      LEA     BX,EXP_N           ;RESULT INTEGER ADDRESS
0E7E B8 0001          MOV     AX,01             ;THE FIRST ITEM
0E81 89 47 02          MOV     [BX+2],AX         ;[EXP_N+2]:[EXP_N]
; INTEGER:FRAGMENT
; CLEAR AX FOR SUBTRACT
0E84 B8 0000          MOV     AX,0              ;1-D_BIN+...
0E87 2B 04            SUB     AX,[SI]           ;RESULT IN [EXP_N] LOOKS LIKE 1.b
0E89 89 07            MOV     [BX],AX
0E8B B8 0000          MOV     AX,0
0E8E 8B 57 02         MOV     DX,[BX+2]         ;INTEGER PART IN DX
0E91 1B D0            SBB    DX,AX              ;SUBTRACT THE CARRY
0E93 89 57 02         MOV     [BX+2],DX        ;INTEGRER PART

0E96 8B 04            MOV     AX,[SI]           ;FETCH b (BIN)
0E98 BA 0000          MOV     DX,0              ;CLEAR DX FOR DIV REMAINDER
0E9B B9 0001          MOV     CX,1              ; 2
0E9E E8 0F92 R      CALL    DATA_POWER      ; DATA POWER
0EA1 B9 0002          MOV     CX,CM_2           ; 2!
0EA4 F7 F1            DIV     CX                 ; DATA POWER / 2!
0EA6 03 07            ADD     AX,[BX]           ; +D_BIN^2/2!
0EA8 89 07            MOV     [BX],AX          ;THE RESULT NOW IN [EXP_N]
0EAA 8B 47 02         MOV     AX,[BX+2]         ;INTEGER PART IN AX
0EAD 15 0000          ADC     AX,0              ;ADD THE CARRY
0EB0 89 47 02         MOV     [BX+2],AX        ;NEW INTEGER PART

0EB3 8B 04            MOV     AX,[SI]           ;FETCH b (BIN)
0EB5 BA 0000          MOV     DX,0              ;CLEAR DX FOR DIV REMAINDER
0EB8 B9 0002          MOV     CX,2              ; 3
0EBB E8 0F92 R      CALL    DATA_POWER      ; DATA POWER

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OEBE B9 0006      MOV     CX,CM_3      ; 3!
OEC1 F7 F1      DIV     CX           ; DATA POWER / 3!
OEC3 8B 17      MOV     DX,[BX]
OEC5 2B D0      SUB     DX,AX       ; -D_BIN^2/3!
OEC7 89 17      MOV     [BX],DX    ; THE RESULT NOW IN [EXP_N]
OEC9 8B 57 02   MOV     DX,[BX+2]  ; INTEGER PART IN DX
OECB B8 0000   MOV     AX,0       ; ADD THE CARRY
OECF 1B D0      SBB     DX,AX      ; SUB BORROW
OED1 89 57 02   MOV     [BX+2],DX  ; NEW INTEGER PART

OED4 8B 04      MOV     AX,[SI]    ; FETCH b (BIN)
OED6 BA 0000   MOV     DX,0       ; CLEAR DX FOR DIV REMAINDER
OED9 B9 0003   MOV     CX,3       ; 4
OEDC E8 0F92 R  CALL    DATA_POWER ; DATA POWER
OEDF B9 0018   MOV     CX,CM_4    ; 4!
OEE2 F7 F1      DIV     CX         ; DATA POWER / 4!
OEE4 03 07      ADD     AX,[BX]    ; +D_BIN^2/4!
OEE6 89 07      MOV     [BX],AX   ; THE RESULT NOW IN [EXP_N]
OEE8 8B 47 02   MOV     AX,[BX+2] ; ADD THE CARRY
OEEA 15 0000   ADC     AX,0       ; NEW INTEGER PART
OEEC 89 47 02   MOV     [BX+2],AX

OEF1 8B 04      MOV     AX,[SI]    ; FETCH b (BIN)
OEF3 BA 0000   MOV     DX,0       ; CLEAR DX FOR DIV REMAINDER
OEF6 B9 0004   MOV     CX,4       ; 5
OEF9 E8 0F92 R  CALL    DATA_POWER ; DATA POWER
OEFB B9 0078   MOV     CX,CM_5    ; 5!
OEFF F7 F1      DIV     CX         ; DATA POWER / 5!
OF01 8B 17      MOV     DX,[BX]
OF03 2B D0      SUB     DX,AX      ; -D_BIN^5/5!
OF05 89 17      MOV     [BX],DX   ; THE RESULT NOW IN [EXP_N]
OF07 8B 57 02   MOV     DX,[BX+2] ; INTEGER PART ADDRESS
OF0A B8 0000   MOV     AX,0
OF0C 1B D0      SBB     DX,AX      ; ADD THE CARRY
OF0F 89 57 02   MOV     [BX+2],DX ; NEW INTEGER PART

OF12 8B 04      MOV     AX,[SI]    ; FETCH b (BIN)
OF14 BA 0000   MOV     DX,0       ; CLEAR DX FOR DIV REMAINDER
OF17 B9 0005   MOV     CX,5       ; 6
OF1A E8 0F92 R  CALL    DATA_POWER ; DATA POWER
OF1D B9 02D0   MOV     CX,CM_6    ; 6!
OF20 F7 F1      DIV     CX         ; DATA POWER / 6!
OF22 03 07      ADD     AX,[BX]    ; +D_BIN^2/6!
OF24 89 07      MOV     [BX],AX   ; THE RESULT NOW IN [EXP_N]
OF26 8B 47 02   MOV     AX,[BX+2] ; ADD THE CARRY
OF29 15 0000   ADC     AX,0       ; NEW INTEGER PART
OF2C 89 47 02   MOV     [BX+2],AX

OF2F 8B 04      MOV     AX,[SI]    ; FETCH b (BIN)
OF31 BA 0000   MOV     DX,0       ; CLEAR DX FOR DIV REMAINDER
OF34 B9 0006   MOV     CX,6       ; 7
OF37 E8 0F92 R  CALL    DATA_POWER ; DATA POWER
OF3A B9 1380   MOV     CX,CM_7    ; 7!
OF3D F7 F1      DIV     CX         ; DATA POWER / 7!
OF3F 8B 17      MOV     DX,[BX]
OF41 2B D0      SUB     DX,AX      ; -D_BIN^7 / 7!
OF43 89 17      MOV     [BX],DX
OF45 8B 57 02   MOV     DX,[BX+2] ; INTEGER PART ADDRESS
OF48 B8 0000   MOV     AX,0
OF4B 1B D0      SBB     DX,AX      ; ADD THE CARRY
OF4D 89 57 02   MOV     [BX+2],DX ; NEW INTEGER PART

OF50 8B 04      MOV     AX,[SI]    ; FETCH b (BIN)
OF52 BA 0000   MOV     DX,0       ; CLEAR DX FOR DIV REMAINDER
OF55 B9 0007   MOV     CX,7       ; 8
OF58 E8 0F92 R  CALL    DATA_POWER ; DATA POWER
OF5B B9 9D80   MOV     CX,CM_8    ; 8!

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OF5E F7 F1          DIV      CX          ; DATA POWER / 8!
OF60 03 07          ADD      AX,[BX]        ; +D BIN^2/8!
OF62 89 07          MOV      [BX],AX        ; THE RESULT NOW IN [EXP_N]
OF64 8B 47 02       MOV      AX,[BX+2]      ;
OF67 15 0000        ADC      AX,0           ; ADD THE CARRY
OF6A 89 47 02       MOV      [BX+2],AX      ; NEW INTEGER PART

;--- SO FAR THE RESULT OF EXP b WAS STORED IN [EXP_N+2].[EXP_N] -----;
; NEXT STEP WAS TO CALCULATE (EXP a) * (EXP b) ;
; 1. EXP a(a=0 -- -10) ARE DEFINED BY DATA AREA (2 X DD OR 8 BYTE). ;
; 2. EXP a * EXP b (FRAGMENT). RASON: EXPa<1, EXPb<1 (a,b<0). ;
; 3. THE RESULT WAS STORED IN [EXP_N] OF [EXP_N+4 ] [EXP_N+2].[EXP_N] ;
;-----;
OF6D 8B 5C 02       MOV      BX,[SI+2]      ; BX WAS BASE ADDRESS FOR LOOK UP
; EXP N ;
OF70 BE CE80        MOV      SI,0CE80H     ; LEA SI,EXP_N0+100H THE FIRST
; ADDRESS OF LOOK UP TABLE ;
OF73 8B C3          MOV      AX,BX          ; PREPARE BASE * No. OF BYTE
OF75 B9 0002        MOV      CX,2           ;
OF78 F7 E1          MUL      CX             ; BASE * No. OF BYTE
OF7A 8B DB          MOV      BX,AX          ;
OF7C 8B 00          MOV      AX,[BX][SI]    ; POINT TO THE TABLE

;-----MULTIPLY THE FRAGMENT PART OF EXP b-----;
OF7E 8D 3E 209C R   LEA      DI,EXP_N       ; INTEGER ADDRESS OF EXPb
OF82 BA 0000        MOV      DX,0           ;
OF85 8B 0D          MOV      CX,[DI]        ;
OF87 F7 E1          MUL      CX             ; NOW THE RESULT WAS IN DX:AX
OF89 89 15          MOV      [DI],DX      ;
OF8B B8 0000        MOV      AX,0           ;
OF8E 89 45 02       MOV      [DI+2],AX     ;

OF91 C3            RET

EXP_a_PLUS_b_NEGA  ENDP
;
;
OF92                DATA_POWER  PROC      NEAR          ;SUBROUTINE No. 33 FOR THE RTDP.
;-----;
; THIS SUBROUTINE WAS TO CALCULATE THE POWER ;
; OF A DATA ;
; 1. BEFOR CALLING N --> CX, DATA ADDRESS -->SI ;
; 2. THE RESULT WAS REMAINED IN AX ;
;-----;

OF92 51             AM:          PUSH     CX
OF93 8B 0C          MOV      CX,[SI]
OF95 F7 E1          MUL      CX
OF97 8B C2          MOV      AX,DX
OF99 BA 0000        MOV      DX,0
OF9C 59             POP      CX
OF9D E2 F3          LOOP     AM

OF9F C3            RET

DATA_POWER         ENDP
;
;
OFA0                SIGMA_Z1    PROC      NEAR          ;SUBROUTINE No. 34 FOR THE RTDP.
;-----;
; THIS PROGAM WAS TO CALCULATE SISGMA Z1. ;
; Z1 WAS THE DATA COLLECTED BY THE SENSORS. ;
; 1. BEFOR CALCULATE THE DATA SHOULD BE SENT TO ;
; Z1, Z2, Z3 IN RAM ;
; 2. THE RESULT SHOULD BE SENT TO SIG_Z1 ;
; 3. THE RESULT WILL BE POSITIVE. ;
;-----;

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OFA0 8D 36 22E2 R      LEA    SI,Z1          ;POINT TO FIRST DATA
OFA4 8B 04             MOV    AX,[SI]
OFA6 03 44 02         ADD    AX,[SI+2]      ;ADD THE 1st AND THE 2nd DATA
OFA9 03 44 04         ADD    AX,[SI+4]      ;ADD THE 1st THROUGH THE 3rd DATA
OFAC 8D 3E 22E8 R      LEA    DI,SIG_Z1     ;POINT TO RESULT ADDRESS SIGMA Z1
OFB0 89 05             MOV    [DI],AX

OFB2 C3              RET

                SIGMA_Z1 ENDP
                ;
                ;
OFB3              SIGMA_X1Z1 PROC NEAR ;SUBROUTINE No. 35 FOR THE RTDP.
                ;-----
                ;THIS PROGRAM WAS TO CALCULATE SIGMA X1Z1 X1 ARE THE
                ;LOCATIONS OF THE SENSORS.
                ; SIGMA X1Z1 = -0.D70AH Z1 + 0.E148H Z3
                ; 1. THE RESULT WAS SENT TO [SIG_X1Z1]
                ; 2. DATA IN [SIG_X1Z1] WAS FRAGMENT PART AND THE DATA
                ;    IN [SIG_X1Z1+2] WAS INTEGER PART.
                ; 3. SYMBLE SIGX1Y1 PLUS (0) OR MINUS (0).
                ;-----
OFB3 8D 36 22E2 R      LEA    SI,Z1          ;POINT TO Z1
OFB7 8B 04             MOV    AX,[SI]
OFB9 BA 0000          MOV    DX,00H
OFBC B9 D70A          MOV    CX,0D70AH     ;THIS VALUE WAS FRAGMENT TOO
OFBF F7 E1             MUL    CK
OFC1 8D 3E 22F0 R      LEA    DI,SIG_X1Z1   ;POINT TO RESULT DESTINATION
OFC5 89 05             MOV    [DI],AX
OFC7 89 55 02         MOV    [DI+2],DX

OFC8 8D 36 22E6 R      LEA    SI,Z3          ;POINT TO Z3
OFC8 8B 04             MOV    AX,[SI]
OFC9 BA 0000          MOV    DX,00H        ;CLEAR DX FOR MULTIPLICATION.
OFCB B9 E148          MOV    CX,0E148H     ;THIS VALUE WAS FRAGMENT
OFC6 F7 E1             MUL    CK

OFD8 2B 05             SUB    AX,[DI]
OFDA 1B 55 02         SBB   DX,[DI+2]      ;SUBTRACT WITH BORROW
OFDD 89 05             MOV    [DI],AX       ;THE RESULT NOW WAS IN [SIG_X1Z1]
OFDF 89 55 02         MOV    [DI+2],DX

OFE2 7C 03             JL     NEGA           ;IF NGATIVE
OFE4 EB 21 90          JMP    POSI           ;IF POSITIVE

NEGA:              NEG    WORD PTR[DI]
OFE7 F7 1D             MOV    AX,0
OFE9 B8 0000          CMP    AX,WORD PTR[DI] ;IF NEG [DI]=0 CARRY
OFE8 3B 05             JZ     NKD           ;NEG [0000H]=FFFFH+1=0000H+CARRY
OFE6 74 06             NOT   WORD PTR[DI+2]
OFF0 F7 55 02         JMP    NKD_1
OFF3 EB 07 90          NOT   WORD PTR[DI+2]
OFF6 F7 55 02         JMP    NKD
OFF9 FF 45 02         INC   WORD PTR[DI+2]
OFFC 8D 3E 22F6 R      LEA    DI,SYMBLE SIGX1Z1 ;SYMBLE OF PARAMETER C
1000 C7 05 0001       MOV    WORD PTR[DI],1 ;NEGATIVE
1004 EB 09 90          JMP    HIN

1007 8D 3E 22F6 R      LEA    DI,SYMBLE SIGX1Z1 ;PLUS
100B C7 05 0000       MOV    WORD PTR[DI],0

100F C3              HIN:              RET

                SIGMA_X1Z1 ENDP
                ;
                ;
1010              SIGMA_X1_SQ_2_Z1 PROC NEAR ;SUBROUTINE No. 36 FOR THE RTDP.
                ;-----

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;THIS PROGRAM WAS TO CALCULATE SIGMA X1^2*Z1
; 1. THE RESULT WILL BE PUT IN SIG_X1_SQ_2_Z1
; 2. DATA IN [SIG_X1_SQ_2_Z1] WAS FRAGMENT PART AND
;    THE DATA IN [SIG_X1_SQ_2_Z1+2] WAS INTEGER PART.
; 3. THE RESULT WILL BE POSITIVE, BECAUSE OF X1^2.
;-----;
1010 8D 36 22E2 R      LEA    SI,Z1          ;POINT TO DATA IN Z1.
1014 BA 0000          MOV    DX,00H
1017 8B 04           MOV    AX,[SI]
1019 B9 B4A2          MOV    CX,0B4A2H
101C F7 E1           MUL    CX
101E 8D 3E 22F8 R      LEA    DI,SIG_X1_SQ2_Z1 ;POINT TO DESTINATION STORAGE.
1022 89 05           MOV    [DI],AX        ;FRAGMENT PART IN AX
1024 89 55 02          MOV    [DI+2],DX      ;INTEGER PART IN DX

1027 8D 36 22E6 R      LEA    SI,Z3          ;POINT TO THE DATA IN Z3
102B BA 0000          MOV    DX,00H
102E 8B 04           MOV    AX,[SI]
1030 B9 C63F          MOV    CX,0C63FH
1033 F7 E1           MUL    CX
1035 03 05           ADD    AX,[DI]
1037 13 55 02          ADC    DX,[DI+2]
103A 89 05           MOV    [DI],AX        ;SEND THE RESULT (FRAGMENT)
; TO DESTINATION
103C 89 55 02          MOV    [DI+2],DX      ;SEND THE RESULT (INTEGER)
; TO DESTINATION

103F C3               RET

SIGMA_X1_SQ_2_Z1 ENDP
;
;
1040 A_PARAMETER PROC NEAR ;SUBROUTINE No. 37 FOR THE RTDP.
;-----;
; THIS SUBROUTINE WAS TO CALCULATE THE PARAMETER A FOR CONCAVE;
; ARC DIRECTION REGRESSION.
; A = SIG Z1 + 0.DDCH * SIG_X1Z1 - 1.5A44H * SIG_X1^2 Z1
; 1. THE RESULT WILL BE SENT TO [A_PARA] FRAGMENT & [A_PARA+2]
;    INTEGER.
; 2. CHECK MSB OF [DI+2]:[DI], IF 1, CALCULATE COMPLIMENT.
; 3. SEND 1 IN [SYMBLE_A_PARA] IF NEGATIVE, OR 0 IF POSITIVE.
;-----;
1040 8D 36 22E8 R      LEA    SI,SIG_Z1      ;POINT TO SIGMA Z1
1044 8B 04           MOV    AX,[SI]
1046 8D 3E 2314 R      LEA    DI,A_PARA     ;POIN TO THE RESULT STORAGE ADDR
104A 89 45 02          MOV    [DI+2],AX     ;THERE WAS ONLY INTEGER PART
104D BA 0000          MOV    DX,0          ;CLEAR THE FRAGMENT PART
1050 89 15           MOV    [DI],DX

;-----THIS PART WAS TO CALCULATE THE FRAGMENT PART-----;
1052 B8 0000          MOV    AX,0
1055 8D 1E 22F6 R      LEA    BX,SYMBLE_SIGX1Z1
1059 3B 07           CMP    AX,[BX]       ;SIG_X1Z1 PLUS OR MINUS
105B 74 03           JZ    PLUS_1        ;IF POSITIVE
105D EB 33 90          JMP    MINUS_1       ;IF NEGATIVE

1060 8D 36 22F0 R      PLUS_1: LEA    SI,SIG_X1Z1    ;POINT TO SIGMA X1Z1 FRAGMENT
1064 BA 0000          MOV    DX,00H
1067 8B 04           MOV    AX,[SI]       ;FRAGMENT PART
1069 B9 0DDC          MOV    CX,0DDCH      ;0.0DDCH
106C F7 E1           MUL    CX             ;RESULT NOW IN DX:AX (FRAGMENT)
; AX WAS OMITTED (IT IS TOO SMALL)
106E 03 15           ADD    DX,[DI]       ;ADD DATA (FRAGMENT) IN A_PARA
1070 8B C2           MOV    AX,DX         ;FRAGMENT PART WAS STILL IN AX
1072 8B 55 02          MOV    DX,[DI+2]     ;INTEGER PART
1075 83 D2 00          ADC    DX,00H        ;ADD THE CARRY
1078 89 05           MOV    [DI],AX       ;SENT THE DATA TO [A_PARA]
107A 89 55 02          MOV    [DI+2],DX     ;SENT THE DATA TO [A_PARA+2]

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;-----THIS PART WAS TO CALCULATE THE INTGER PART-----;
107D 8D 36 22F2 R      LEA    SI,SIG_X1Z1+2 ;POINT TO SIGMA X1Z1 FRAGMENT
1081 8B 04             MOV    AX,[SI]
1083 F7 E1             MUL    CX                ;THE RESULT NOW IN
                        ;DX:AX INTEGER:FRAGMENT
1035 03 05             ADD    AX,[DI]          ;ADD THE FRAGMENT PART
1087 13 55 02         ADC    DX,[DI+2]        ;ADD THE INTEGER PART
108A 89 05             MOV    [DI],AX         ;SENT THE FRAGMENT PART
108C 89 55 02         MOV    [DI+2],DX       ;SENT THE INTEGER PART
108F EB 33 90         JMP    BIC

1092 8D 36 22F0 R      MINUS_1: LEA    SI,SIG_X1Z1
1096 8B 04             MOV    AX,[SI]         ;FRAGMENT PART
1098 B9 0DDC          MOV    CX,0DDCH        ;0.0DDCH
109B F7 E1             MUL    CX                ;RESULT NOW IN DX:AX (FRAGMENT)
                        ;AX WAS OMITTED (IT IS TOO SMALL)
109D 8B 1D             MOV    BX,[DI]
109F 2B DA             SUB    BX,DX            ;SUBTRACT FRAGMENT PART
10A1 89 1D             MOV    [DI],BX
10A3 8B 5D 02         MOV    BX,[DI+2]       ;INTEGER PART
10A6 BA 0000          MOV    DX,00H
10A9 1B DA             SBB   BX,DX            ;SUBTRACT INTEGER PART WITH CARRY
10AB 89 5D 02         MOV    [DI+2],BX

10AE 8D 36 22F2 R      LEA    SI,SIG_X1Z1+2 ;POINT TO INTEGER PART
10B2 8B 04             MOV    AX,[SI]
10B4 F7 E1             MUL    CX
10B6 8B 1D             MOV    BX,[DI]
10B8 2B D8             SUB    BX,AX
10BA 89 1D             MOV    [DI],BX
10BC 8B 5D 02         MOV    BX,[DI+2]
10BF 1B DA             SBB   BX,DX
10C1 89 5D 02         MOV    [DI+2],BX

;NEXT PART 1: (A_PARA) - SIG X1^2Z1 * 1
; PART 2: (A_PARA) - SIG X1^2Z1 * 0.5A44H
;-----
;PART 1.
10C4 8D 36 22F8 R      BIC:   LEA    SI,SIG_X1_SQ2_Z1 ;POINT TO SIGMA X1^2 Z1
10C8 8B 05             MOV    AX,[DI]         ;THE FRAGMENT OF A_PARA
10CA 2B 04             SUB    AX,[SI]
10CC 8B 55 02         MOV    DX,[DI+2]       ;THE INTEGER OF A_PARA
10CF 1B 54 02         SBB   DX,[SI+2]        ;INTEGER-INTEGER WITH BORROW
10D2 89 05             MOV    [DI],AX         ;SENT THE RESULT TO A_PARA
10D4 89 55 02         MOV    [DI+2],DX

;PART 2.
;-----THIS PART WAS TO CALCULATE THE FRAGMENT PART---;
10D7 8D 36 22F8 R      LEA    SI,SIG_X1_SQ2_Z1 ;POINT TO SIGMA X1^2 Z1
10DB BA 0000          MOV    DX,00H
10DE 8B 04             MOV    AX,[SI]         ;FRAGMENT PART
10E0 B9 5A44          MOV    CX,5A44H        ;0.0DDCH
10E3 F7 E1             MUL    CX                ;RESULT NOW IN DX:AX (FRAGMENT)
                        ;AX WAS OMITTED
10E5 8B 05             MOV    AX,[DI]         ;A_PARAMETER NOW WAS IN AX
10E7 2B C2             SUB    AX,DX            ;SUBTRACT THE DATA (FRAGMENT)
10E9 8B 55 02         MOV    DX,[DI+2]       ;IN A_PARA INTEGER PART
10EC 83 DA 00         SBB   DX,00H           ;SUBTRACT THE BORROW
10EF 89 05             MOV    [DI],AX         ;SENT THE DATA TO [A_PARA]
10F1 89 55 02         MOV    [DI+2],DX       ;SENT THE DATA TO [A_PARA+2]

;-----THIS PART WAS TO CALCULATE THE INTGER PART-----;
10F4 8D 36 22FA R      LEA    SI,SIG_X1_SQ2_Z1+2 ;POINT TO SIGMA X1^2 Z1
10F8 8B 04             MOV    AX,[SI]         ;FRAGMENT
10FA F7 E1             MUL    CX                ;RESULT NOW IN DX:AX
                        ;IN:GGER:FRAGMENT

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10FC 52          PUSH    DX          ;PROTECT DX
10FD 88 15      MOV     DX,[DI]      ;FRAGMENT PART OF A PARAMETER
10FF 2B D0      SUB     DX,AX        ;SUBTRACT THE FRAGMENT PART
1101 8B C2      MOV     AX,DX        ;FRAGMENT PART NOW IN AX
1103 8B 4D 02   MOV     CX,[DI+2]   ;INTEGER PART IN CX
1106 5A          POP     DX
1107 1B CA      SBB    CX,DX        ;SUBTRACT INTEGER WITH BORROW
1109 8B D1      MOV     DX,CX       ;THE INTEGER PART NOW IN DX
110B 89 05      MOV     [DI],AX     ;SENT THE FRAGMENT PART
110D 89 55 02   MOV     [DI+2],DX   ;SENT THE INTEGER PART

1110 8B 45 02   MOV     AX,[DI+2]
1113 BA 8000    MOV     DX,8000H
1116 23 C2      AND    AX,DX
1118 3D 8000    CMP    AX,8000H
111B 74 03      JZ     NEGATIVE    ;IF [DI+2]:[DI] NEGATIVE.
111D EB 21 90    JMP    POSITIVE

1120 F7 1D      NEGATIVE: NEG     WORD PTR[DI]
1122 B8 0000    MOV     AX,0
1125 3B 05      CMP    AX,WORD PTR[DI] ;IF NEG [DI]=0 CARRY
1127 74 06      JZ     MKD         ;NEG [0000H]=-FFFFH+1=0000H+CARRY
1129 F7 55 02   NOT    WORD PTR[DI+2]
112C EB 07 90    JMP    MKD_1
112F F7 55 02   MKD:    NOT    WORD PTR[DI+2]
1132 FF 45 02   INC    WORD PTR[DI+2]
1135 8D 3E 231A R MKD_1:  LEA   DI,SYMBLE_A_PARA ;SYMBLE OF PARAMETER C
1139 C7 05 0001 MOV    WORD PTR[DI],1 ;NEGATIVE
113D EB 09 90    JMP    SHIN

1140 8D 3E 231A R POSITIVE: LEA   DI,SYMBLE_A_PARA ;PLUS
1144 C7 05 0000 MOV    WORD PTR[DI],0

1148 C3          SHIN:    RET

A_PARAMETER ENDP
;
;
1149          B_PARAMETER PROC NEAR ;SUBROUTINE No. 38 FOR THE RTDP.
;-----
; THIS SUBROUTINE WAS TO CALCULATE THE PARAMETER B FOR CONCAVE ;
; ARC DIRECTION REGRASSION. ;
; B=0.DDCH * SIG_Z1 + 0.AE91H * SIG_X1Z1 - 0.20CFH * SIG_X1^2 Z1 ;
; 1. THE RESULT WILL BE SENT TO [B_PARA] FRAGMENT & [B_PARA+2] ;
; INTEGER. ;
; 2. CHECK MSB OF [DI+2]:[DI], IF 1, CALCULATE COMPLIMENT. ;
; 3. SEND 1 IN [SYMBLE_B_PARA] IF NEGITIVE, OR 0 IF POSITIVE. ;
;-----
;-----PART 1: 0.DDCH * SIG_Z1
1149 8D 36 22E8 R LEA    SI,SIG_Z1 ;POINT TO SIGMA Z1
114D 8B 04      MOV    AX,[SI]
114F B9 0DDC    MOV    CX,0DDCH ;0.DDCH --> CX
1152 F7 E1      MUL    CX        ;PRODUCT NOW IN DX:AX
;INTEGER:FRAGMENT
1154 8D 3E 231C R LEA    DI,B_PARA ;POINT RESULT DESTINATION B_PARA
1158 89 05      MOV    [DI],AX  ;SEND FRAGMENT
115A 89 55 02   MOV    [DI+2],DX ;SEND INTEGER

;-----PART 2: +0.A9E1H * SIG_X1Y1
115D 8D 1E 22F6 R LEA    BX,SYMBLE_SIGX1Z1
1161 B8 0000    MOV    AX,0
1164 3B 07      CMP    AX,[BX]  ;CHECK THE SYMBLE OF SIG X1Z1:
1166 74 03      JZ     PLUS_3  ;0 PLUS, 1 MINUS IF POSITIVE
1168 EB 2B 90    JMP    MINUS_2 ;IF HEGATIVE

116B 8D 36 22F0 R PLUS_3: LEA    SI,SIG_X1Z1 ;POINT TO SIGMA X1Z1
116F 8B 04      MOV    AX,[SI]

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1171 B9 AE91      MOV     CX,0AE91H      ;0.AE91H --> CX
1174 F7 E1      MUL     CX             ;DX:AX ARE FRAGMENT AX WAS
                          ;OMMITTED
1176 03 15      ADD     BX,[DI]       ;ADD FRAGMENT
1178 89 15      MOV     [DI],DX
117A BA 0000     MOV     DX,0
117D 13 55 02    ADC     DX,[DI+2]
1180 89 55 02    MOV     [DI+2],DX     ;SEND INTEGER

1183 8B 44 02    MOV     AX,[SI+2]     ;INTEGER PART OF SIG X121 IN AX
1186 F7 E1      MUL     CX             ;DX:AX ARE INTEGER:FRAGMENT
1188 03 05      ADD     AX,[DI]
118A 13 55 02    ADC     DX,[DI+2]
118D 89 05      MOV     [DI],AX
118F 89 55 02    MOV     [DI+2],DX
1192 EB 30 90    JMP     BID

1195 8D 36 22F0 R  MINUS_2:  LEA     SI,SIG_X121   ;POINT TO SIGMA X121
1199 8B 04      MOV     AX,[SI]
119B 1 AE91     MOV     CX,0AE91H     ;0.AE91H --> CX
119E F7 E1      MUL     CX             ;DX:AX ARE FRAGMENT AX WAS
                          ;OMMITTED.

11A0 8B 1D      MOV     BX,[DI]
11A2 2B DA      SUB     BX,DX
11A4 89 1D      MOV     [DI],BX
11A6 BA 0000     MOV     DX,0
11A9 8B 5D 02    MOV     BX,[DI+2]
11AC 1B DA      SBB     BX,DX
11AE 89 5D 02    MOV     [DI+2],BX     ;SEND INTEGER

11B1 8B 44 02    MOV     AX,[SI+2]     ;INTEGER PART OF SIG X121 IN AX
11B4 F7 E1      MUL     CX             ;DX:AX ARE INTEGER:FRAGMENT
11B6 8B 1D      MOV     BX,[DI]
11B8 2B D8      SUB     BX,AX
11BA 89 1D      MOV     [DI],BX
11BC 8B 5D 02    MOV     BX,[DI+2]
11BF 1B DA      SBB     BX,DX
11C1 89 5D 02    MOV     [DI+2],BX

;-----PART 3: -0.20CF * SIG X1^2 Z1
;-----CALCULATE FRAGMENT PART
11C4 8D 36 22F8 R  BID:      LEA     SI,SIG_X1_SQ2_Z1 ;POINT TO SIGMA X1^2 Z1
11C8 8B 04      MOV     AX,[SI]
11CA B9 20CF     MOV     CX,20CFH      ;0.20CFH --> CX
11CD F7 E1      MUL     CX             ;DX:AX ARE FRAGMENT AX WAS
                          ;OMMITTED.
11CF 8D 3E 231C R  LEA     DI,B_PARA     ;POINT TO RESULT DISTINATION B_PARA

11D3 8B 1D      MOV     BX,[DI]       ;FRAGMENT --> BX
11D5 2B DA      SUB     BX,DX         ;SUBTRACT FRAGMENT
11D7 89 1D      MOV     [DI],BX
11D9 8B 5D 02    MOV     BX,[DI+2]     ;ADD INTEGER
11DC BA 0000     MOV     DX,00H        ;SEND FRAGMENT
11DF 1B DA      SBB     BX,DX
11E1 89 5D 02    MOV     [DI+2],BX     ;SEND INTEGER

;-----CALCULATE INTEGER PART
11E4 8B 44 02    MOV     AX,[SI+2]     ;INTEGER OF SIG X1^2 Z1 IN AX
11E7 F7 E1      MUL     CX             ;DX:AX ARE INTEGER:FRAGMENT
11E9 8B 1D      MOV     BX,[DI]
11EB 2B D8      SUB     BX,AX
11ED 89 1D      MOV     [DI],BX
11EF 8B 5D 02    MOV     BX,[DI+2]
11F2 1B DA      SBB     BX,DX
11F4 89 5D 02    MOV     [DI+2],BX

11F7 8B 45 02    MOV     AX,[DI+2]
11FA BA 8000     MOV     DX,8000H

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11FD 23 C2          AND     AX,DX
11FF 3D 8000        CMP     AX,8000H
1202 74 03          JZ     NEGATIVE_1 ;IF [DI+2]:[DI] NEGATIVE.
1204 EB 21 90       JMP     POSITIVE_1

NEGATIVE_1: NEG   WORD PTR[DI]
1207 F7 1D         MOV     AX,0
1209 B8 0000        CMP     AX,WORD PTR[DI] ;IF NEG [DI]=0 CARRY
120C 3B 05          JZ     MKD_2       ;NEG [0000H]=FFFFH+1=0000H+CARRY
120E 74 06          JZ     MKD_2
1210 F7 55 02      NOT     WORD PTR[DI+2]
1213 EB 07 90       JMP     MKD_3
1216 F7 55 02      NOT     WORD PTR[DI+2]
1219 FF 45 02        INC     WORD PTR[DI+2]
121C 8D 3E 2322 R   MKD_3: LEA     DI,SYMBLE_B PARA ;SYMBLE OF PARAMETER C
1220 C7 05 0001     MOV     WORD PTR[DI],1 ;NEGATIVE
1224 EB 09 90       JMP     SHIN_1

1227 8D 3E 2322 R   POSITIVE_1: LEA    DI,SYMBLE_B PARA ;PLUS
122B C7 05 0000     MOV     WORD PTR[DI],0

122F C3             SHIN_1:  RET

B_PARAMETER ENDP
;
;
1230              C_PARAMETER PROC NEAR ;SUBROUTINE No. 39 FOR THE RTDP.
;-----
; THIS SUBROUTINE WAS TO CALCULATE THE PARAMETER C FOR CONCAVE ;
;ARC DIRECTION REGRASSION.
; C=-1.5A44H * SIG Z1 -0.20CFH * SIG X1Z1 +2.BECCH * SIG X1^2 Z1 ;
; 1. THE RESULT WILL BE SENT TO [C_PARA] FRAGMENT & [C_PARA+2] ;
; INTEGER.
; 2. THE SYMBLE OF SIG X1Z1 DETERMIN + OR - OF .20CF*SIG X1Z1 ;
; 3. CHECK MSB OF [DI+2]:[DI], IF 1, CALCULATE COMPLIMENT. ;
; 4. SEND 1 IN [SYMBLE_C_PARA] IF NEGITIVE, OR 0 IF POSITIVE. ;
;-----
;PART 1. +2.BECCH * SIG X1^2 Z1
;-----1) CALCULATE 2.0*SIG X1^2 Z1
1230 8D 36 22F8 R   LEA     SI,SIG_X1_SQ2_Z1 ;POINT TO SIG X1^2 Z1
1234 8D 3E 2324 R   LEA     DI,C_PARA ;POINT TO RESULT ADDRESS
1238 B8 04          MOV     AX,[SI] ;FRAGMENT PART OF SIG X1^2Z1
123A B9 0C02       MOV     CX,2
123D F7 E1         MUL     CX ;THE RESULT NOW IN DX:AX
123F 03 05         ADD     AX,[DI]
1241 13 55 02      ADC     DX,[DI+2]
1244 89 05         MOV     [DI],AX
1246 89 55 02      MOV     [DI+2],DX

1249 8B 44 02      MOV     AX,[SI+2] ;INTEGER PART OF SIG X1^2 Z1
124C F7 E1         MUL     CX
124E 03 45 02      ADD     AX,[DI+2]
1251 89 45 02      MOV     [DI+2],AX

;-----2. CALCULATE 0.BECC * SIG X1^2 Z1
1254 8B 04         MOV     AX,[SI] ;FRAGMENT PART IN AX
1256 B9 BECC       MOV     CX,0BECCH
1259 F7 E1         MUL     CX ;DX:AX ARE FRAGMENT AX WAS ;OMMITED.

125B 03 15         ADD     DX,[DI]
125D 89 15         MOV     [DI],DX
125F BA 0000       MOV     DX,0
1262 13 55 02      ADC     DX,[DI+2] ;INTEGER PART ADD THE CARRY
1265 89 55 02      MOV     [DI+2],DX

1268 8B 44 02      MOV     AX,[SI+2] ;INTEGERPART OF SIGMA X1^2 Z1
126B F7 E1         MUL     CX ;DX:AX INTEGER:FRAGMENT
126D 03 05         ADD     AX,[DI]

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126F 13 55 02          ADC     DX,[DI+2]
1272 89 05             MOV     [DI],AX
1274 89 55 02          MOV     [DI+2],DX

;PART 2: -(1.0 + 0.5A44H) * SIG Z1-----
1277 8D 36 22E8 R     LEA     SI,SIG Z1      ;SIG Z1 INTEGER ONLY
127B 8B 04             MOV     AX,[SI]
127D B9 5A44           MOV     CX,5A44H      ;0.5A44 --> CX
1280 F7 E1             MUL     CX             ;PRODUCT NOW IN DX:AX
1282 8B 1D             MOV     BX,[DI]       ;FRAGMENT PART IN BX
1284 2B D8             SUB     BX,AX
1286 89 1D             MOV     [DI],BX
1288 8B 5D 02          MOV     BX,[DI+2]     ;INTEGER PART IN BX
128B 1B DA             SBB     BX,DX
128D 89 5D 02          MOV     [DI+2],BX
1290 8B 55 02          MOV     DX,[DI+2]
1293 2B 14             SUB     DX,[SI]
1295 89 55 02          MOV     [DI+2],DX

;PART 3: -(0.20CFH * SIG X1Z1)
;------(1) CALCULATE FRAGMENT PART OF SIG X1Z1
1298 8D 1E 22F6 R     LEA     BX,SYMBL_SIGX1Z1
129C B8 0000           MOV     AX,0
129F 3B 07             CMP     AX,[BX]
12A1 74 03             JZ      PLUS_2
12A3 EB 33 90          JMP     MINUS_3

12A6 8D 36 22F0 R     LEA     SI,SIG X1Z1   ;POINT TO SIG X1Z1
12AA 8B 04             MOV     AX,[SI]      ;FRAGMENT PART
12AC B9 20CF           MOV     CX,20CFH
12AF F7 E1             MUL     CX             ;PRODUCT DX:AX WAS FRAGMENT
;AX OMITTED
;FRAGMENT PART NOW IN BX
12B1 8B 1D             MOV     BX,[DI]
12B3 2B DA             SUB     BX,DX
12B5 89 1D             MOV     [DI],BX
12B7 8B 5D 02          MOV     BX,[DI+2]    ;INTEGERPART NOW IN BX
12BA BA 0000           MOV     DX,0
12BD 1B DA             SBB     BX,DX
12BF 89 5D 02          MOV     [DI+2],BX

;------(2) CALCULATE INTEGER PART OF SIG X1Z1
12C2 8B 44 02          MOV     AX,[SI+2]    ;INTEGER PART
12C5 F7 E1             MUL     CX             ;PRODUCT DX:AX = INTEGER:FRAGMENT
12C7 8B 1D             MOV     BX,[DI]      ;FRAGMENT PART NOW IN BX
12C9 2B D8             SUB     BX,AX
12CB 89 1D             MOV     [DI],BX
12CD 8B 5D 02          MOV     BX,[DI+2]    ;INTEGER PART NOW IN BX
12D0 1B DA             SBB     BX,DX
12D2 89 5D 02          MOV     [DI+2],BX
12D5 EB 28 90          JMP     HEI

12D8 AD 36 22F0 R     LEA     SI,SIG X1Z1   ;POINT TO SIG X1Z1
12DC 8B 04             MOV     AX,[SI]      ;FRAGMENT PART
12DE B9 20CF           MOV     CX,20CFH
12E0 F7 E1             MUL     CX             ;PRODUCT DX:AX WAS FRAGMENT
;AX OMITTED
12E1 ADD     DX,[DI]
12E3 MOV     [DI],DX
12E5 MOV     DX,0
12E7 ADC     DX,[DI+2]
12EA MOV     [DI+2],DX
12ED ;-----INTEGER PART
12F0 8B 46             MOV     AX,[SI+2]
12F3 F7 E1             MUL     CX
12F5 03 05             ADD     AX,[DI]
12F7 13 55 02          ADC     DX,[DI+2]
12FA 89 05             MOV     [DI],AX
12FC 89 55 02          MOV     [DI+2],DX

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12FF 8B 45 02      HEI:      MOV      AX,[DI+2]
1302 BA 8000      MOV      DX,8000H
1305 23 C2        AND      AX,DX
1307 3D 8000      CMP      AX,8000H
130A 74 03        JZ       NEGATIVE_2      ;IF [DI+2]:[DI] NEGATIVE.
130C EB 21 90      JMP      POSITIVE_2      ;JL IF LESS
130F F7 AD        NEGATIVE_2: NEG     WORD PTR[DI]
1311 B8 00 00      MOV      AX,0
1314 3B 00        CMP      AX,WORD PTR[DI] ;IF NEG [DI]=0 CARRY
1316 74 06        JZ       MKD_4           ;NEG [0000H]=FFFFH+1=0000H+CARRY
1318 F7 55 02      NOT     WORD PTR[DI+2]
131B EB 07 90      JMP      MKD_5
131E F7 55 02      MKD_4:   NOT     WORD PTR[DI+2]
1321 FF 45 02      INC     WORD PTR[DI+2]
1324 8D 3E 232A R  MKD_5:   LEA     DI,SYMBLE_C_PARA ;SYMBLE OF PARAMETER C
1328 C7 55 0001     MOV     WORD PTR[DI],1 ;NEGATIVE
132C EE 09 90      JMP     SHIN_2

132F 8D 3E 232A R  POSITIVE_2: LEA     DI,SYMBLE_C_PARA ;PLUS
1333 C7 05 0000     MOV     WORD PTR[DI],0

1334 90          SHIN_2:   RET

C_PARAMETER ENDP
;
;
1338          Z_MEAN_VALUE PROC      NEAR          ;SUBROUTINE No. 40 FOR THE RTDP.
;-----
; THIS SUBROUTINE WAS TO CALCULATE THE MEAN VALUE OF Z1
; Z_MEAN = A_PARA + 0.8F6H * B_PARA + 0.68B2H * C_PARA
; 1. THE SYMBLES OF A B & C MUST BE CONSIDERD, THESE SYMBLES
; WILL DETERMIN THE CALCULATION WAS ADD OR SUB.
; 2. THE RESULT WILL BE SENT TO [Z_MEAN] FRAGMENT & [Z_MEAN+2]
; INTEGER.
; 3. CHECK [Z_MEAN], IF IT WAS EQUAL OR ABOVE 0.1000H (0.5),
; [Z_MEAN+2]+1, OTHERWISE [Z_MEAN] WAS OMITTED.
;-----
;PART 1. A PARA
1338 8D 1E 231A R  LEA     BX,SYMBLE_A_PARA ;POINT TO A'S SYMBLE
133C 8B 07        MOV     AX,[BX]
133E 3D 0000      CMP     AX,0
1341 74 03        JZ     PLUS_4
1343 EB 16 90      JMP     MINUS_4

1346 8D 36 2314 R  PLUS_4:  LEA     SI,A_PARA      ;POINT TO A PARAMETER
134A 8D 3E 230C R  LEA     DI,Z_MEAN      ;POINT TO MEAN VALUE OF Z1
134E 8B 04        MOV     AX,[SI]        ;SEND A PARA TO Z_MEAN
1350 89 05        MOV     [DI],AX        ;(FRAGMENT PART)
1352 8B 44 02     MOV     AX,[SI+2]      ;SEND A PARAMETER INTEGER PART
1355 89 45 02     MOV     [DI+2],AX
1358 EB 19 90      JMP     PART_2

135B 8D 36 2314 R  MINUS_4: LEA     SI,A_PARA
135F 8D 3E 230C R  LEA     DI,Z_MEAN
1363 B8 0000      MOV     AX,00H
1366 BA 0000      MOV     DX,00H
1369 2B 04        SUB     AX,[SI]        ;SUBTRACT FRAGMENT PART
136B 1B 54 02     SBB     DX,[SI+2]      ;SUBTRACT INTEGER PART
136E 89 05        MOV     [DI],AX
1370 89 55 02     MOV     [DI+2],DX

;PART 2. 0.8F6H * B PARA
1373 8D 1E 2322 R  PART_2:  LEA     BX,SYMBLE_B_PARA ;POINT TO A'S SYMBLE
1377 8B 07        MOV     AX,[BX]
1379 3D 0000      CMP     AX,0
137C 74 03        JZ     PLUS_5

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137E EB 2B 90                                JMP     MINUS_5
1381 8D 36 231C R                            PLUS_5: LEA     SI,B_PARA      ;POINT TO B PARAMETER
1385 8B 04                                    MOV     AX,[SI]       ;FRAGMENT PART IN AX
1387 B9 08F6                                  MOV     CX,8F6H
138A F7 E1                                    MUL     CX             ;DX:AX ARE FRAGMENT AX WAS
                                           ;OMMITED.
138C 03 15                                    ADD     DX,[DI]
138E 89 15                                    MOV     [DI],DX      ;FRAGMENT OF RESULT
1390 BA 0000                                  MOV     DX,0
1393 13 55 02                                ADC     DX,[DI+2]    ;INTEGER PART ADD THE CARRY
1396 89 55 02                                MOV     [DI+2],DX   ;SEND INTEGER RESULT
1399 8B 44 02                                MOV     AX,[SI+2]   ;INTEGER PART OF B_PARA IN AX
139C F7 E1                                    MUL     CX           ;DX:AX ARE INTEGER:FRAGMENT
139E 03 05                                    ADD     AX,[DI]
13A0 13 55 02                                ADC     DX,[DI+2]
13A3 89 05                                    MOV     [DI],AX
13A5 89 55 02                                MOV     [DI+2],DX
13A8 EB 30 90                                JMP     PART_3
13AB 8D 36 231C R                            MINUS_5: LEA     SI,B_PARA      ;POINT TO B PARAMETER
13AF 8B 04                                    MOV     AX,[SI]     ;FRAGMENT PART IN AX
13B1 B9 08F6                                  MOV     CX,8F6H
13B4 F7 E1                                    MUL     CX           ;DX:AX ARE FRAGMENT AX WAS
                                           ;OMMITED.
13B6 8B 1D                                    MOV     BX,[DI]
13B8 2B DA                                    SUB     BX,DX
13BA 89 1D                                    MOV     [DI],BX    ;FRAGMENT SEND TO BX
13BC BA 0000                                  MOV     DX,0
13BF 8B 5D 02                                MOV     BX,[DI+2]
13C2 1B DA                                    SBB    BX,DX       ;INTEGER PART SUB WITH THE BORROW
13C4 89 5D 02                                MOV     [DI+2],BX  ;SEND INTEGER RESULT
13C7 8B 44 02                                MOV     AX,[SI+2]   ;INTEGER PART OF B_PARA IN AX
13CA F7 E1                                    MUL     CX           ;DX:AX ARE INTEGER:FRAGMENT
13CC 8B 1D                                    MOV     BX,[DI]
13CE 2B D8                                    SUB     BX,AX
13D0 89 1D                                    MOV     [DI],BX
13D2 8B 5D 02                                MOV     BX,[DI+2]
13D5 1B DA                                    SBB    BX,DX
13D7 89 5D 02                                MOV     [DI+2],BX
13DA 8D 1E 232A R                            PART_3: LEA     BX,SYMBL_C_PARA ;POINT TO C'S SYMBLE
13DE 8B 07                                    MOV     AX,[BX]
13E0 3D 0000                                  CMP     AX,0
13E3 74 03                                    JZ     PLUS_6
13E5 EB 2B 90                                JMP     MINUS_6
13E8 8D 36 2324 R                            PLUS_6: LEA     SI,C_PARA      ;POINT TO C PARAMETER
13EC 8B 04                                    MOV     AX,[SI]     ;FRAGMENT PART OF C PARA IN AX
13EE B9 6882                                  MOV     CX,6882H
13F1 F7 E1                                    MUL     CX           ;DX:AX ARE FRAGMENT AX WAS
                                           ;OMMITED.
13F3 03 15                                    ADD     DX,[DI]
13F5 89 15                                    MOV     [DI],DX
13F7 BA 0000                                  MOV     DX,0
13FA 13 55 02                                ADC     DX,[DI+2]
13FD 89 55 02                                MOV     [DI+2],DX
1400 8B 44 02                                MOV     AX,[SI+2]   ;INTEGER PART OF C_PARA IN AX
1403 F7 E1                                    MUL     CX           ;DX:CX ARE INTEGER:FRAGMENT
1405 03 05                                    ADD     AX,[DI]
1407 13 55 02                                ADC     DX,[DI+2]
140A 89 05                                    MOV     [DI],AX
140C 89 55 02                                MOV     [DI+2],DX

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1496 83 C7 10          ADD     DI,16
1499 89 3E 20A8 R      MOV     [DI_MEM],DI
149D EB 14 90          JMP     FFI_1
14A0 83 F9 03          FFI_4: CMP     CX,3
14A3 7E 03              JLE    FFI_5
14A5 EB 0C 90          JMP     FFI_1
14A8 8B 3E 20A8 R      FFI_5: MOV     DI,[DI_MEM]
14AC 83 C7 60          ADD     DI,32*3
14AF 89 3E 20A8 R      MOV     [DI_MEM],DI

14B3 E2 9C          FFI_1: LOOP   ZPP

14B5 C3              RET

SENSOR_MOVING      ENDP
;
;
14B6          ABC_MOVING  PROC      NEAR          ;SUBROUTINE No. 42 FOR THE RTDP.
;-----;
; MOVING / B & C PARAMETERS TO OUTPUT AREA ;
;-----;
14B6 8D 36 2344 R      LEA     SI,A_PARA_1 ;THE DATA TO BE CONVERTED
14BA 8D 3E 24E5 R      LEA     DI,A1        ;DISTRIBUTION IN TABLE
14BE 89 3E 20A8 R      MOV     [DI_MEM],DI ;STORE IN [DI_MEM]
14C2 B9 0009          MOV     CX,9         ;9 PARAMETERS (A1---C3)
14C5 8D 1E 20AA R      FPFZ:  LEA     BX,S1_TEMP ;THE FINAL RESULT TEMPORARY
;STORSGE
14C9 8D 3E 2252 R      LEA     DI,D_BCD_FRACTION ;DATA IN [D_BCD_FRACTION] NEED
; TO * 0.000015258

14CD 51              PUSH   CX
14CE 56              PUSH   SI
14CF EB 0A1A R      CALL   BIN_BCD
14D2 5E              POP     SI           ;POINT TO DATA TO BE CONVERTED
14D3 8B 44 06          MOV     AX,[SI+6]    ;FETCH THE SIGN WORD
14D6 3D 0001          CMP     AX,01
14D9 74 03              JZ     MINUS_SIGN
14DB EB 0A 90          JMP     POSI_SIGN
14DE 8B 3E 20A8 R      MINUS_SIGN: MOV    DI,[DI_MEM]
14E2 B0 2D              MOV     AL,'-'
14E4 EB 07 90          JMP     S_SIGN
14E7 8B 3E 20A8 R      POSI_SIGN: MOV    DI,[DI_MEM]
14EB B0 2B              MOV     AL,'+'
14ED 88 05              S_SIGN: MOV     [DI],AL
14EF 83 C6 18          ADD     SI,18H      ;POINT TO NEXT PARAMETER
14F2 56              PUSH   SI
14F3 E8 157A R      CALL   M_F
14F6 83 C7 60          ADD     DI,32*3
14F9 89 3E 20A8 R      MOV     [DI_MEM],DI ;NEXT DISTRIBUTION ADDRESS
;IN [DI_MEM]

14FD 5E              POP     SI
14FE 59              POP     CX
14FF 83 F9 07          CMP     CX,7
1502 74 03              JZ     NDJ
1504 EB 0D 90          JMP     NDJ_1
1507 8D 36 234C R      NDJ:   LEA     SI,B_PARA_1
150B 8D 3E 24F6 R      LEA     DI,B11
150F 89 3E 20A8 R      MOV     [DI_MEM],DI
1513 83 F9 04          NDJ_1: CMP     CX,4
1516 74 03              JZ     NDJ_2
1518 EB 12 90          JMP     NDJ_3
151B 8D 36 2354 R      NDJ_2: LEA     SI,C_PARA_1
151F 8D 3E 2505 R      LEA     DI,C11
1523 89 3E 20A8 R      MOV     [DI_MEM],DI
1527 EB 03 90          JMP     NDJ_3
152A EB 99              PPP:   JMP     PPFZ
152C E2 FC          NDJ_3: LOOP   PPP

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152E C3                                RET
                                        ABC_MOVING ENDP
                                        ;
                                        ;
152F                                Z_MEAN_Ln_MOV PROC NEAR          ;SUBROUTINE No. 43 FOR THE RTDP.
                                        ;-----;
                                        ; 1. CONVERT Ln Z_MEAN TO ASCII ;
                                        ; 2. MOV ASCII TO UP LOAD AREA ;
                                        ;-----;
152F B9 000C                          MOV     CX,12          ;12 WORDS
1532 8D 36 23A4 R                      LEA     SI,Z_MEAN_1_L ;POINT TO DATA
1536 BA 3030                            MOV     DX,3030H
1539 8B 04                                ZSS:    MOV     AX,[SI]
153B 0B C2                                OR      AX,DX
153D 89 04                                MOV     [SI],AX
153F 46                                    INC     SI             ;POINT TO NEXT DATA
1540 46                                    INC     SI
1541 E2 F6                                LOOP   ZSS
1543 8D 3E 260E R                      LEA     DI,LnZ1+8
1547 8D 36 23A4 R                      LEA     SI,Z_MEAN_1_L ;POINT TO DATA
154B E8 1565 R                          CALL    F_UP

154E 8D 3E 261F R                      LEA     DI,LnZ2+8
1552 8D 36 23AC R                      LEA     SI,Z_MEAN_2_L ;POINT TO DATA
1556 E8 1565 R                          CALL    F_UP

1559 8D 3E 262E R                      LEA     DI,LnZ3+8
155D 8D 36 23B4 R                      LEA     SI,Z_MEAN_3_L ;POINT TO DATA
1561 E8 1565 R                          CALL    F_UP

1564 C3                                RET

                                        Z_MEAN_Ln_MOV ENDP
                                        ;
                                        ;
1565                                F_UP PROC NEAR          ;SUBROUTINE No. 44 FOR THE RTDP.
1565 B9 0008                          MOV     CX,8
1568 83 F9 04                          ZSS_1:  CMP     CX,4
156B 74 03                              JE      F_U_1
156D EB 02 90                          JMP     F_U_2
1570 4F                                F_U_1:  DEC     DI
1571 8A 04                          F_U_2:  MOV     AL,[SI]
1573 88 05                          MOV     [DI],AL
1575 46                                    INC     SI
1576 4F                                DEC     DI
1577 E2 EF                                LOOP   ZSS_1

1579 C3                                RET

                                        F_UP ENDP
                                        ;
                                        ;
157A                                M_F PROC NEAR          ;SUBROUTINE No. 45 FOR THE RTDP.
157A 8B 3E 20A8 R                      MOV     DI,[DI_MEM]
157E A1 2242 R                          MOV     AX,[D_BCD]   ;FRAGMENT PART
1581 0D 3030                            OR      AX,3030H     ;BCD-ASCII
1584 A3 20AA R                          MOV     [SI_TEMP],AX
1587 88 45 09                          MOV     [DI+9],AL
158A 88 65 08                          MOV     [DI+8],AH
158D A1 2244 R                          MOV     AX,[D_BCD+2]
1590 0D 3030                            OR      AX,3030H
1593 A3 20AC R                          MOV     [SI_TEMP+2],AX
1596 88 45 07                          MOV     [DI+7],AL
1599 88 65 06                          MOV     [DI+6],AH

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159C 8D 36 20AE R      LEA     SI,S1 TEMP+4      ;INTEGRER PART
15A0 8B 04             MOV     AX,[SI]           ;BCD--ASCII
15A2 0D 3030           OR      AX,3030H
15A5 89 04             MOV     [SI],AX
15A7 88 45 04         MOV     [DI+4],AL
15AA 88 65 03         MOV     [DI+3],AH
15AD 8B 44 02         MOV     AX,[SI+2]
15B0 0D 3030           OR      AX,3030H
15B3 89 44 02         MOV     [SI+2],AX
15B6 88 45 02         MOV     [DI+2],AL
15B9 88 65 01         MOV     [DI+1],AH

15BC C3               RET

M_F      ENDP
;
;
-----
; PART 3. MINI-OPERATION SYSTEM
-----
15BD      KEY_SCANNING PROC      NEAR
; This program was for keyboard and liquid crystal display.
; When the key was pressed the corresponding letter will be
; displaid on LCD.
-----
15BD B0 90      COUN:      MOV     AL,CWIOO      ;8255-1 I/O A IN, I/O B, C OUT
15BF E6 03      OUT     IOCTR,AL

15C1 B0 00      MOV     AL,00H
15C3 A2 2027 R  MOV     [COUNTER_A],AL ;ROL TIMES FOR IOA
15C6 A2 2028 R  MOV     [COUNTER_B],AL ;ROL TIMES FOR IOB
15C9 B8 0000      MOV     AX,0000H      ;CLEAR KEY NUMBER
15CC A3 202D R  MOV     [KEY_NUMBER],AX

15CF B0 FE      MOV     AL,1111110B
15D1 A2 2029 R  MOV     [ALM],AL      ;KEEP THE FIRST KEY SCANNING
15D4 A2 202A R  MOV     [BLM],AL      ;STATUS

15D7 A0 202A R  PORT_B:  MOV     AL,[BLM]      ;3 MSB OF PORT B ARE LCD CONTROL
15DA 24 7F      AND     AL,0111111B   ;MASK 1 MSB
15DC E6 01      OUT     IOB,AL       ;LINE FIRST LINE CONNECTED TO B=0

15DE E4 00      PORT_A:  IN      AL,IOA      ;PORT A SCANNING
15E0 3A 06 2029 R  CMP     AL,[ALM]      ;COLUMN CONNECTED TO A PRESSED?
15E4 75 23      JNZ     RCL_A         ; NO ROTAT PORT A
15E6 8B 3E 202D R  MOV     DI,[KEY_NUMBER] ;KEY NUMBER INC ONE
15EA 47      INC     DI
15EB 89 3E 202D R  MOV     [KEY_NUMBER],DI
15EF E8 1644 R      CALL    LOOK_UP_1     ;LOOK UP TABLE SUBROUTINE
15F2 B9 0014      MOV     CX,14H        ;BOUNCING AVOID
15F5 E8 1EE8 R      CALL    DN1MS
15F8 E4 00      PORT_A:  IN      AL,IOA      ;WAS THE KEY RELEASED?
15FA 3A 06 2029 R  CMP     AL,[ALM]
15FE 74 F8      JZ      POR_A         ;NO, TEST AGAIN.
1600 B9 0014      MOV     CX,0014H      ;YES PROVENT FROM BOUNCING
1603 E8 1EE8 R      CALL    DN1MS
1606 EB 0A 90      JMP     RCL_A1        ;A INSTRUCTION INC DI HAS EXECUTED

1609 8B 3E 202D R  RCL_A:  MOV     DI,[KEY_NUMBER]
160D 47      INC     DI
160E 89 3E 202D R  MOV     [KEY_NUMBER],DI

1612 A0 2029 R      RCL_A1:  MOV     AL,[ALM]      ;ROTATE [ALM] FOR NEXT COLUMN
1615 B1 01      MOV     CL,01H
1617 D2 C0      ROL     AL,CL
1619 A2 2029 R      MOV     [ALM],AL

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161C FE 06 2027 R      INC      [COUNTER_A] ;COLUMN NUMBER IN [COUNTER_A]
1620 A0 2027 R      MOV      AL,[COUNTER_A]
1623 3C 08          CMP      AL,08H ;COLUMN NO. 8?
1625 75 B7          JNZ     PORT_A ;NO, SCANNING CONTINUOSLLY

1627 B0 00          MOV      AL,00H ;YES,
1629 A2 2027 R      MOV      [COUNTER_A],AL ;CLEAR COLUMN NUMBER STORAGE

162C A0 202A R      MOV      AL,[BLM] ;POART A SCANNING FINISHED
162F B1 01          MOV      CL,01H ;TURN TO PORT B SCANNING
1631 D2 C0          ROL     AL,CL
1633 A2 202A R      MOV      [BLM],AL
1636 FE 06 2028 R      INC     [COUNTER_B] ;LINE NUMBER INC ONE
163A A0 2028 R      MOV     AL,[COUNTER_B]
163D 3C 05          CMP     AL,05H ;LINE 5 FINISHED ?
163F 75 96          JNZ     PORT_B ;NO, LINE SCANNING CONTINUOSLLY,

1641 E9 00C0 R      JMP     K_80

                                KEY_SCANNING
                                ;
                                ;
1644                                LOOK_UP_1 PROC NEAR

1644 A1 202B R      MOV     AX,[PRESS_T] ;HOW MANY TIMES HAS PRESSED?
1647 40          INC     AX
1648 A3 202B R      MOV     [PRESS_T],AX
164B 3C 11          CMP     AL,17 ;OUT OF LCD RANG?
164D 74 4F          JZ     CLR_LXK ;YES, CLEAR LCD

164F BB D1F6          MOV     BX,0D1F6H ;POINT ASCII LIST. FIRST ADDRESS-1
1652 8B 3E 202D R      MOV     DI,[KEY_NUMBER] ;KEY NUMBER
1656 8A 01          MOV     AL,[BX][DI] ;LOOK UP ASCII LIST TO FIND OUT THE
1658 3C 21          CMP     AL,'I' ;LETTER BEING PRESSED, LRTTER IN AL
165A 74 2A          JZ     COMMAND ;IT WAS F1
165C 3C 23          CMP     AL,'#'
165E 74 38          JZ     F_3 ;IT WAS F3
1660 3C 24          CMP     AL,'S'
1662 74 2E          JZ     F_2 ;IT WAS F2

1664 8D 1E 2012 R      LEA     BX,KEY_DIS ;POINT TO KEY DISPLAY BUFFER
1668 88 07          MOV     [BX],AL ;SEND LETTER TO DISPLAY BUFFER
166A 8D 1E 2013 R      LEA     BX,STRING ;STRING EQU 1CF1H
166E A1 202B R      MOV     AX,[PRESS_T]
1671 3C 01          CMP     AL,01H ;FIRST PRESS?
1673 74 06          JZ     PRE ;YES,

1675 48          DEC     AX ;NO FIRST PRESS

1676 8B C8          MOV     CX,AX ;POINT TO THE POSITION WHERE
1678 43          INC     BX ;THE LETTER SHOULD BE DISPLAYED
1679 E2 FD          LOOP  PPE

167B A0 2012 R      PRE:   MOV     AL,[KEY_DIS] ;FIND THE LETTER IN DIS BUFFER
167E 88 07          MOV     [BX],AL ;SEND LETTER TO STRING AREA

1680 E8 1740 R      CALL  DIS_KEY ;PRESS_TIME AS POSITION OF DIS
1683 EB 1C 90          JMP  LK_END

1686 E8 16A2 R      COMMAND: CALL  STRING_C

1689 B8 0000          MOV     AX,0000H ;AFTER EXCUSE COMMAND CLEAR PRESS
168C A3 202B R      MOV     [PRESS_T],AX ;TIME

168F EB 10 90          JMP  LK_END

1692 E8 00F4 R      F_2:  CALL  WORKING ;INTERRUPT & COUNTER INICIALIZATION

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1695 EB 0A 90                JMP     LK_END
1698 E8 1BBF R              F_3:   CALL   END_TEST    ;F3 WAS THE COMMAND END TEST.
169B EB 04 90                JMP     LK_END
169E E8 1A78 R              CLR_LXX: CALL   CLEAR_LCD
16A1 C3                      LK_END: RET
                                LOOK_UP_1 ENDP
                                ;
                                ;
16A2                        STRING_C  PROC   HEAR
                                ;-----;
                                ; COMMAND AND REAL TIME CLOCK PROGRAM ARE ALSO INCLUDED. ;
                                ; 1. CHECK PRESS KEY TIMES, IF 5(TYPE) 6(CLOCK) 10 CLOCK ;
                                ;   SET 9(SET 11-11-88 & 12 37 00) 14(INTERVAL TIME) ;
                                ;   3(00 -- 99 MINUTSET) ;
                                ; 2. IF THE COMMAND WAS VALID THEN CALL FUCTION SUBROUTINE;
                                ;   IF IT WAS NOT VALID THEN CALL BAD COMMAND ! ;
                                ;-----;
16A2 A1 202B R              MOV     AX,[PRESS_T]
16A5 3D 0005                CMP     AX,5
16A8 74 70                   JZ     TY_PE         ;TYPE THE LIST FILE
16AA 3D 0006                CMP     AX,6
16AD 74 52                   JZ     CL_CK         ;CLOCK READ
16AF 3D 000A                CMP     AX,10
16B2 74 3A                   JZ     CL_SE         ;CLOCK SET
16B4 3D 0009                CMP     AX,9
16B7 74 2C                   JZ     SET           ;SET YEAR MONTH --- SECOND
16B9 3D 000E                CMP     AX,14
16BC 74 0E                   JZ     INTER        ;INTERVAL TIME SET
16BE 3D 0003                CMP     AX,3
16C1 74 06                   JZ     INT_TT
                                ;
16C3 F8 1AB2 R              CALL   BAD_COMMAND  ;IT WAS NOT VALID PRESS TIMES
16C6 EB 77 90                JMP     PPP2         ;JMP TO RET
                                ;
16C9 E9 19C9 R              INT_TT: JMP     INT_TIME    ;GO TO INTERVAL TIME SET
                                ;
16CC A1 202B R              INTER:  MOV     AX,[PRESS_T] ;PRESS TIMES -1 BECAUSE
16CF 48                       DEC     AX           ;THERE WAS A RETURN KEY AT
16D0 8B C8                   MOV     CX,AX        ;THE END OF THE COMMAND
16D2 BF D241                 MOV     DI,0D241H   ;POINT TO COMMAND ASCII STRING
16D5 8D 36 2013 R           LEA     SI,STRING    ;POINT TO STRING TO BE ENTERED
16D9 FC                       CLD                    ;STRING COMPAR
16DA A6                       CMPS   BYTE PTR[DI],BYTE PTR[SI]
16DB 75 5F                   JNE    PPP1         ;INVALID THEN BAD COMMAND !
16DD E2 FB                   LOOP   REP_4
16DF E8 19C3 R              CALL   INT_TT
16E2 EB 5B 90                JMP     PPP2
                                ;
16E5 E9 1924 R              SET:   JMP     C_SET     ;SET THE REAL TIME CLOCK
                                ;
16E8 A1 202B R              CL_SE:  MOV     AX,[PRESS_T] ;PRESS TIMES
16EB 48                       DEC     AX           ;-1 BECAUSE THERE WAS A RETURN KEY AT
16EC 8B C8                   MOV     CX,AX        ;THE END OF THE COMMAND
16EE BF D234                 MOV     DI,0D234H   ;POINT TO COMMAND ASCII STRING
16F1 8D 36 2013 R           LEA     SI,STRING    ;POINT TO STRING TO BE ENTERED
                                ;STRING COMPAR
                                ;CLEAR DF FLAG DI SI ARE INCREASED
16F5 FC                       CLD
16F6 A6                       CMPS   BYTE PTR [DI],BYTE PTR [SI]
16F7 75 43                   JNE    PPP1         ;INVALID THEN BAD COMMAND !
16F9 E2 FB                   LOOP   REP_1
16FB E8 191E R              CALL   CLOCK_SET    ;VALID CLOCK SET
16FE EB 3F 90                JMP     PPP2         ;END CLOCK SET RET

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1701 A1 202B R      CL CK:  MOV     AX,[PRESS_T]      ;PRESS TIMES
1704 48             DEC     AX                ;-1 BECAUSE THERE WAS A RETURN KEY AT
1705 8B C8          MOV     CX,AX                ;THE END OF THE COMMAND
1707 BF D22F        MOV     DI,CD22FH          ;POINT TO COMMAND ASCII STRING
170A 8D 36 2013 R   LEA     SI,STRING          ;POINT TO STRING TO BE ENTERED
170E FC             CLD                     ;STRING COMPAR
170F A6             REP_2:  CMPS    BYTE PTR [DI],BYTE PTR [SI]
1710 75 2A          JNE     PPP1                ;INVALID THEN BAD COMMAND !
1712 E2 FB          LOOP   REP_2
1714 EB 183E R      CALL   CLOCK_DIS          ;VALID CLOCK DISPLAY
1717 EB 26 90       JMP     PPP2                ;END CLOCK DISPLAY RET

171A A1 202B R      TY PE:  MOV     AX,[PRESS_T]      ;PRESS TIMES
171D 48             DEC     AX                ;-1 BECAUSE THERE WAS A RETURN KEY AT
171E 8B C8          MOV     CX,AX                ;THE END OF THE COMMAND
1720 BF D23D        MOV     DI,0D23DH          ;POINT TO COMMAND ASCII STRING
1723 8D 36 2013 R   LEA     SI,STRING          ;POINT TO STRING TO BE ENTERED
1727 FC             CLD                     ;STRING COMPAR
1728 A6             REP_3:  CMPS    BYTE PTR [DI],BYTE PTR [SI]
1729 75 11          JNE     PPP1                ;INVALID THEN BAD COMMAND !
172B E2 FB          LOOP   REP_3

172D E8 17FB R      CALL   RS_232              ;VALID RS 232 INCIALISATION
1730 BF 0400        MOV     DI,0400H          ;THE BIGINNING ADDRESS OF LIST FILE
1733 B9 02C0        MOV     CX,22*32          ;THE NUMBER OF BYTE TO BE PRINT
1736 E8 1818 R      CALL   TEST_TX            ;FILE TRANSMISSION VIA RS 232
1739 EB 04 90       JMP     PPP2

173C E8 1AB2 R      PPP1:  CALL   BAD_COMMAND
173F C3             RET

STRING_C          ENDP
;
;
DIS_KEY           PROC     NEAR
;-----;
;DISPLAY THE LETTER WHICH WAS PRESSED AT KEYBOARD;
;-----;
1740 B0 80          MOV     AL,80H
1742 E6 01          OUT     IOB,AL
1744 B0 0F          MOV     AL,0FH           ;TURN LCD ON
1746 E6 02          OUT     IOC,AL
1748 B0 00          MOV     AL,00H
174A E6 01          OUT     IOB,AL

174C 8D 1E 2012 R   LEA     BX,KEY_DIS        ;POINT TO DISPLAY BUFFER
1750 8B 16 202B R   MOV     DX,[PRESS_T]      ;SET POSITION POINT
;POSITION=[PRESS_TIMES-1]
1754 89 16 2010 R   MOV     [POINT_S1],DX     ;PROTECT POINT
1758 E8 1764 R      CALL   PO_SI              ;PROCEDURE FOR SELECT LCD
;ADDRESS
175B 8B 07          MOV     AX,[BX]           ;THE LETTER TO BE DISPLAY NOW
;IN AX
175D E8 1A29 R      CALL   DATA_D            ;DISPLAY THE LETTER
1760 E8 1A48 R      CALL   CHECK              ;CHECK THE BUSY STATUS

1763 C3             RET

DIS_KEY           ENDP
;
;
PO_SI             PROC     NEAR           ;LCD address selecting
1764 B0 90          MOV     AL,CWIOO
1766 E6 03          OUT     IOCTR,AL

1768 8B 16 2010 R   POS:   MOV     DX,[POINT_S1]     ;THE POSITION WHERE THE LETTER

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176C 83 FA 01          POS_1:  CMP     DX,0001H      ; DISPLAYED
176F 75 16             JNZ     DX_EQU8
1771 B0 00             MOV     AL,00H      ;SET LCD ADDRESS 00H
1773 E6 01             OUT     IOB,AL
1775 B0 80             MOV     AL,80H
1777 E6 01             OUT     IOB,AL
1779 B0 80             MOV     AL,80H      ;SET ADDRESS DB7=1
177B E6 02             OUT     IOC,AL
177D B0 00             MOV     AL,00H
177F E6 01             OUT     IOB,AL
1781 E8 1A48 R        CALL    CHECK       ;CHECK HAND SHAKE SIGNAL
1784 EB 24 90         JMP     POS_BACK

1787 83 FA 09          DX_EQU8: CMP     DX,0009H
178A 75 16             JNZ     DX_EQU16
178C B0 00             MOV     AL,00H      ;SET LCD ADDRESS 40H
178E E6 01             OUT     IOB,AL
1790 B0 80             MOV     AL,80H
1792 E6 01             OUT     IOB,AL
1794 B0 C0             MOV     AL,0C0H     ;SET ADDRESS INSTRUCTION DB7=1
1796 E6 02             OUT     IOC,AL
1798 B0 00             MOV     AL,00H
179A E6 01             OUT     IOB,AL
179C E8 1A48 R        CALL    CHECK       ;CHECK HAND SHAKE SIGNAL
179F EB 09 90         JMP     POS_BACK

17A2 83 FA 10          DX_EQU16: CMP    DX,0016
17A5 75 03             JNZ     POS_BACK
17A7 BA 0000          MOV     DX,0000H

17AA C3               POS_BACK: RET

PO_SI               ENDP
;
;
17AB                POSITION   PROC    NEAR      ;LCD ADDRESS SELECTION

17AB B0 90             MOV     AL,CWIOO
17AD E6 03             OUT     IOCTR,AL

17AF 8B 16 200E R    POSI_1: MOV     DX,[POINT_S]  ;RESUME POINT
17B3 83 FA 00        CMP     DX,0000H
17E6 75 16             JNZ     DX_EQU7
17B8 B0 00             MOV     AL,00H      ;SET LCD ADDRESS 00H
17BA E6 01             OUT     IOB,AL
17BC B0 80             MOV     AL,80H
17BE E6 01             OUT     IOB,AL
17C0 B0 80             MOV     AL,80H      ;SET ADDRESS INSTRUCTION DB7=1
17C2 E6 02             OUT     IOC,AL
17C4 B0 00             MOV     AL,00H
17C6 E6 01             OUT     IOB,AL
17C8 E8 1A48 R        CALL    CHECK       ;CHECK HAND SHAKE SIGNALS
17CB EB 28 90         JMP     DX_INC

17CE 83 FA 08          DX_EQU7: CMP     DX,0008H
17D1 75 18             JNZ     DX_EQU47
17D3 B0 00             MOV     AL,00H      ;SET LCD ADDRESS 40H
17D5 E6 01             OUT     IOB,AL
17D7 B0 80             MOV     AL,80H
17D9 E6 01             OUT     IOB,AL
17DB B0 C0             MOV     AL,0C0H     ;SET ADDRESS INSTRUCTION DB7=1
17DD E6 02             OUT     IOC,AL
17DF B2 40             MOV     DL,40H
17E1 B0 00             MOV     AL,00H
17E3 E6 01             OUT     IOB,AL
17E5 E8 1A48 R        CALL    CHECK       ;CHECK HAND SHAKE SIGNAL
17E8 EB 0B 90         JMP     DX_INC

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17EB 83 FA 48          DX_EQU47:  CMP     DX,0048H
17EE 75 05            JNZ     DX_INC
17F0 BA 0000          MOV     DX,0000H

17F3 EB BE            JMP     POSI_1

17F5 42              DX_INC:   INC     DX
17F6 89 16 200E R    MOV     [POINT_S],DX

17FA C3              PRD_BACK: RET

POSITION            ENDP
;
;
17FB                RS_232  PROC     NEAR
;-----;
; 1. 8253 TIMER COUNTER AS BAUD RATE GENERATER. ;
; 2. THE PROGRAMMEL UART 8251 AS RS-232 ;
;-----;
;PART 1: INICIALIZATION OF TIMER UPD8253

17FB B0 36            MOV     AL,00110110B ;CONTROL WORDS
17FD E6 23            OUT     23H,AL
17FF B0 04            MOV     AL,04H ;DATA WILL BE SEND INTO COUNTER
1801 E6 20            OUT     20H,AL ;LSB=04H FIRST, MSB=01H SECOND.
1803 B0 01            MOV     AL,01H
1805 E6 20            OUT     20H,AL

;PART 2: UPD8251 INICIALIZATION
1807 BA 0011          MOV     DX,UART_CTRL ;RESET
180A B0 00            MOV     AL,00H
180C EE              OUT     DX,AL
180D EE              OUT     DX,AL
180E EE              OUT     DX,AL
180F B0 50            MOV     AL,01010000B ;COMMAND:INTERNAL RESET,
1811 EE              OUT     DX,A' ;CLEAR ERROR BITS.
1812 B0 CE            MOV     AL,11001110B ;MODE:2 STOP BIT, NO PARRITY BIT
;8 DATA BITS, BAUD RATE FACTER=16

1814 EE              OUT     DX,AL
1815 B0 33            MOV     AL,00110011B ;COMMAND: RTS` ACTIV. CLEAR ERROR
;DTR` OUTPUT LOW, TRANSMITTER WAS
;ENABLED.

1817 C3              RET

RS_232              ENDP
;
;
1818                TEST_TX  PROC     NEAR
;-----;
; 1. THE BEGINNING ADDRSS OF THE PRINT FILE WAS IN DI ;
; 2. THE NUMBER OF BYTES TO BE PRINTED WAS IN CX ;
;-----;

1818 B0 9B            MOV     AL,CWIII
181A E6 53            OUT     IOCTR_2,AL ;IOB_2 SERVE AS HANDSHAKING INPUT
181C 51              BEGIN:  PUSH   CX
181D B0 33            MOV     AL,00110011B
181F E6 11            OUT     UART_CTRL,AL
1821 8A 05            MOV     AL,[DI]
1823 E6 10            OUT     UART_DATA,AL

1825 E4 51            RTS:    IN     AL,IOB_2 ;TEST THE BUZY STATUE, IF IT WAS 0
1827 24 01            AND     AL,01H ;CONTINUE TO TEST.
1829 3C 01            CMP     AL,01H
182B 75 F8            JNZ     RTS

182D E4 51            RETEST: IN     AL,IOB_2 ;TEST THE BUSY STATUS

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182F 24 01      AND     AL,01H      ;MASK REST OF THE BITS
1831 3C 01      CMP     AL,01H
1833 74 F8      JZ      RETEST

1835 47         INC     DI          ;POINT TO NEXT LETTER
1836 59         POP     CX
1837 E2 E3      LOOP   BEGIN

1839 B0 99      MOV     AL,CWIOI
183B E6 53      OUT    IOCTR_2,AL  ;IOB_2 SERVE AS COUNTERS & TIMER
                        ;CONTROL AFTER TYPING.

183D C3         RET

TEST_TX      ENDP
:
:
183E          CLOCK_DIS PROC      NEAR

183E B9 0004     MOV     CX,04H      ;DISPLAY CLOCK FOR FOUR TIMES
1841 51         PUSH   CX
1842 B0 40      MOV     AL,01000000B ;WRITE CONTROL WORDS FOR REAL TIME CLOCK

1844 BB 27F8     MOV     BX,RTCTRL
1847 88 07      MOV     [BX],AL

1849 8D 1E 202F R LEA     BX,YEAR_RAM ;1D0DH WOVE DATA IN RTCLOCK TO RAM
184D BF 27FF     MOV     DI,YEAR    ;:27FFH
1850 8A 05      MOV     AL,[DI]
1852 E8 1A95 R  CALL   BCD_ASCII_CL
1855 88 67 08   MOV     [BX]+8,AH
1858 88 47 09   MOV     [BX]+9,AL

185B BF 27FE     MOV     DI,MONTH   ;:27FEH
185E 8A 05      MOV     AL,[DI]
1860 E8 1A95 R  CALL   BCD_ASCII_CL
1863 88 27      MOV     [BX],AH
1865 88 47 01   MOV     [BX]+1,AL

1868 BF 27FD     MOV     DI,DATE    ;:27FDH
186B 8A 05      MOV     AL,[DI]
186D E8 1A95 R  CALL   BCD_ASCII_CL
1870 88 67 03   MOV     [BX]+3,AH
1873 88 47 04   MOV     [BX]+4,AL

:MOV     DI,DAY     ;:27FCH
:MOV     AL,[DI]
:CALL   BCD_ASCII_CL
:MOV     [BX]+12,AH
:MOV     [BX]+13,AL

1876 8D 1E 203F R LEA     BX,HOUR_RAM ;1D1DH

187A BF 27FB     MOV     DI,HR      ;:27FBH
187D 8A 05      MOV     AL,[DI]
187F E8 1A95 R  CALL   BCD_ASCII_CL
1882 88 67 04   MOV     [BX]+4,AH
1885 88 47 05   MOV     [BX]+5,AL

1888 BF 27FA     MOV     DI,MIN     ;:27FAH
188B 8A 05      MOV     AL,[DI]
188D E8 1A95 R  CALL   BCD_ASCII_CL
1890 88 67 07   MOV     [BX]+7,AH
1893 88 47 08   MOV     [BX]+8,AL

1896 BF 27F9     MOV     DI,SEC     ;:27F9H
1899 8A 05      MOV     AL,[DI]
189B E8 1A95 R  CALL   BCD_ASCII_CL
189E 88 67 0A   MOV     [BX]+10,AH

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18A1 88 47 0B          MOV      [BX]+11,AL

18A4 B0 80          C00:    MOV      AL,80H
18A6 E6 01          OUT     IOB,AL
18A8 B0 0C          MOV     AL,0CH
18AA E6 02          OUT     IOC,AL
18AC B0 00          MOV     AL,00H
18AE E6 01          OUT     IOB,AL

18B0 8D 1E 202F R    C0:     LEA     BX,YEAR_RAM      ;DIS YEAR--DAY
18B4 BA 0000          MOV     DX,POINT
18B7 89 16 200E R    MOV     [POINT_S],DX

18BB E8 17AB R      C1:     CALL   POSITION
18BE 8B 07          MOV     AX,[BX]
18C0 E8 1A29 R      CALL   DATA_D
18C3 E8 1A48 R      CALL   CHECK
18C6 43            INC     BX
18C7 B0 10          MOV     AL,10H
18C9 FE 06 2008 R    INC     [FLAG1]
18CD 3A 06 2008 R    CMP     AL,[FLAG1]
18D1 75 E8          JNZ    C1
18D3 B9 03E8          MOV     CX,1000
18D6 E8 1EE8 R      CALL   DNIMS

18D9 B0 00          MOV     AL,00H      ;DIS HOUR--SECND
18DB A2 2008 R      MOV     [FLAG1],AL
18DE BA 0000          MOV     DX,POINT
18E1 89 16 200E R    MOV     [POINT_S],DX

18E5 8D 1E 203F R    C2:     LEA     BX,HOURL_RAM
18E9 E8 17AB R      CALL   POSITION
18EC 8B 07          MOV     AX,[BX]
18EE E8 1A29 R      CALL   DATA_D
18F1 E8 1A48 R      CALL   CHECK
18F4 43            INC     BX
18F5 B0 10          MOV     AL,10H
18F7 FE 06 2008 R    INC     [FLAG1]
18FB 3A 06 2008 R    CMP     AL,[FLAG1]
18FF 75 E8          JNZ    C2

1901 B0 00          MOV     AL,00H
1903 A2 2008 R      MOV     [FLAG1],AL

1906 B0 00          MOV     AL,00000000H ;START CLOCK
1908 BB 27F8          MOV     BX,RTCTRL
190B 88 07          MOV     [BX],AL

190D B9 03E8          MOV     CX,1000
1910 E8 1EE8 R      CALL   DNIMS

1913 59            POP     CX      ;DIS TIME FOR 4 TIMES
1914 49            DEC     CX
1915 74 03          JZ     CED
1917 E9 1841 R      JMP     RT

191A E8 1A78 R      CED:    CALL   CLEAR_LCD
191D C3            RET

CLOCK_DIS ENDP
;
;
191E          CLOCK_SET PROC      NEAR

191E E8 1A78 R      CALL   CLEAR_LCD
1921 E9 15BD R      JMP     COUN      ;TO KEY SCANNING

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;      MOV      BX,X_TIMEE      ;START TIME 058DH
;      MOV      [BX],AH
;      MOV      [BX]+1,AL

1989  E8 1AA6 R      CALL      ASCII_BCD_CL

198C  BB 27FB      MOV      BX,HR
198F  88 07      MOV      [BX],AL

1991  8A 65 03      MOV      AH,[DI]+3
1994  8A 45 04      MOV      AL,[DI]+4

;      MOV      BX,X_TIMEE+3      ;0590H
;      MOV      [BX],AH
;      MOV      [BX]+1,AL

1997  E8 1AA6 R      CALL      ASCII_BCD_CL

199A  BB 27FA      MOV      BX,MIN
199D  88 07      MOV      [BX],AL

199F  8D 1E 2050 R  LEA      BX,T_RAM1
19A3  88 07      MOV      [BX],AL      ;STORE OLD TIME

19A5  8A 65 06      MOV      AH,[DI]+6
19A8  8A 45 07      MOV      AL,[DI]+7

;      MOV      BX,X_TIMEE+6      ;0593H
;      MOV      [BX],AH
;      MOV      [BX]+1,AL

19AB  E8 1AA6 R      CALL      ASCII_BCD_CL

19AE  BB 27F9      MOV      BX,SEC
19B1  88 07      MOV      [BX],AL

19B3  B0 00      MOV      AL,00H
19B5  A2 200C R    MOV      [FLAG6],AL

19B8  B0 00      MOV      AL,00000000B      ;START CLOCK
19BA  BB 27F8      MOV      BX,RTCTRL
19BD  88 07      MOV      [BX],AL

19BF  E8 1A78 R      CALL      CLEAR_LCD
19C2  C3      RET

      CLOCK_SET ENDP
;
;
19C3      IN_TE_T  PROC      NEAR

19C3  E8 1A78 R      CALL      CLEAR_LCD
19C6  E9 15BD R      JMP      COUN      ;TO KEY SCANNING

19C9  8D 3E 2013 R  INT_TIME: LEA      DI,STRING      ;SENT 01--60 MINUTS TO RAM
19CD  8A 25      MOV      AH,[DI]
19CF  8A 45 01      MOV      AL,[DI]+1
19D2  E8 1AA6 R      CALL      ASCII_BCD_CL
19D5  8D 1E 204F R  LEA      BX,I_T_V      ;STOER INTERVAL
19D9  88 07      MOV      [BX],AL
19DB  E8 1A78 R      CALL      CLEAR_LCD
19DE  B0 FF      MOV      AL,OFFH      ;IF INTERVAL TIME HAS BEEN SET
19E0  A2 200D R    MOV      [FLAG7],AL      ;SET THE FLAG7

19E3  C3      RET

      IN_TE_T  ENDP

```

```

;
;
TIME_CHECK PROC NEAR
19E4
19E4 B0 40          MOV     AL,01000000B    ;WRITE CONTROL WORDS FOR REAL TIME CLOCK
19E6 BB 27F8       MOV     BX,RTCTRL
19E9 88 07         MOV     [BX],AL
19EB 8D 1E 203F R  LEA     BX,HOURL_RAM    ;1D1DH
19EF BF 27FB       MOV     DI,HR           ;27FBH
19F2 8A 05         MOV     AL,[DI]
19F4 E8 1A95 R    CALL    BCD_ASCII_CL
19F7 88 67 04     MOV     [BX]+4,AH
19FA 88 47 05     MOV     [BX]+5,AL
19FD BF 27FA       MOV     DI,MIN         ;27FAH
1A00 8A 05         MOV     AL,[DI]
1A02 53           PUSH    BX
1A03 8D 1E 2051 R  LEA     BX,T_RAM2
1A07 88 07         MOV     [BX],AL       ;CURRENT TIME-->[T_RAM2]
1A09 E8 1A95 R    CALL    BCD_ASCII_CL
1A0C 5B           POP     BX
1A0D 88 67 07     MOV     [BX]+7,AH
1A10 88 47 08     MOV     [BX]+8,AL
1A13 BF 27F9       MOV     DI,SEC         ;27F9H
1A16 8A 05         MOV     AL,[DI]
1A18 E8 1A95 R    CALL    BCD_ASCII_CL
1A1B 88 67 0A     MOV     [BX]+10,AH
1A1E 88 47 0B     MOV     [BX]+11,AL
1A21 B0 00         MGV    AL,00000000B
1A23 BB 27F8       MOV     BX,RTCTRL
1A26 88 07         MOV     [BX],AL
1A28 C3           RET
TIME_CHECK ENDP
;
;
DATA_DIS PROC NEAR
1A29
1A29 50           DATA_D: PUSH    AX
1A2A B0 90         MOV     AL,CWIOO
1A2C E6 03         OUT    IOCTR,AL
1A2E B0 00         MOV     AL,00H
1A30 E6 01         OUT    IOB,AL
1A32 90           NOP
1A33 B0 20         MOV     AL,20H
1A35 E6 01         OUT    IOB,AL
1A37 90           NOP
1A3E B0 A0         MOV     AL,0A0H
1A3A E6 01         OUT    IOB,AL
1A3C 58           POP     AX
1A3D E6 02         OUT    IOC,AL
1A3F B0 20         MOV     AL,20H
1A41 E6 01         OUT    IOB,AL
1A43 B0 00         MOV     AL,00H
1A45 E6 01         OUT    IOB,AL
1A47 C3           RET
DATA_DIS ENDP
;

```


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1A48                CHECK      PROC      NEAR      ;THIS WAS THE LCD BUSY STATUS CHECK
                                      ;PROCEDURE.

1A48 B0 99          MOV        AL,CWIOI
1A4A E6 03          OUT        IOCTR,AL

1A4C B0 40          CHE:      MOV        AL,40H
1A4E E6 01          OUT        IOB,AL
1A50 90             NOP
1A51 B0 C0          MOV        AL,0C0H
1A53 E6 01          OUT        IOB,AL
1A55 E4 02          IN         AL,IOC      ;CHECK BUSY STATUS.
1A57 E4 02          IN         AL,IOC
1A59 24 80          AND        AL,80H
1A5B 75 EF          JNZ        CHE
1A5D E4 02          IN         AL,IOC
1A5F 24 80          AND        AL,80H
1A61 75 E9          JNZ        CHE
1A63 E4 02          IN         AL,IOC
1A65 E4 02          IN         AL,IOC
1A67 24 80          AND        AL,80H
1A69 75 E1          JNZ        CHE

1A6B B0 40          MOV        AL,40H
1A6D E6 01          OUT        IOB,AL
1A6F B0 00          MOV        AL,00H
1A71 E6 01          OUT        IOB,AL

1A73 B0 90          MOV        AL,CWIOO
1A75 E6 03          OUT        IOCTR,AL

1A77 C3            RET

CHECK      ENDP
;
;
1A78                CLEAR_LCD PROC      NEAR

1A78 B0 00          MOV        AL,00H      ;CLEAR LCD
1A7A E6 01          OUT        IOB,AL
1A7C B0 80          MOV        AL,80H
1A7E E6 01          OUT        IOB,AL
1A80 B0 01          MOV        AL,01H
1A82 E6 02          OUT        IOC,AL
1A84 B0 00          MOV        AL,00H
1A86 E6 01          OUT        IOB,AL

1A88 B9 00A0        MOV        CX,160
1A8B E8 1EE8 R      CALL       DN1MS

1A8E B8 0000        MOV        AX,0000H
1A91 A3 202B R      MOV        [PRESS_T],AX ;CLEAR PRESS TIMES

1A94 C3            RET

CLEAR_LCD ENDP
;
;
1A95                BCD_ASCII_CL PROC      NEAR

1A95 B4 00          MOV        AH,00H
1A97 B1 04          MOV        CL,04H
1A99 8A D0          MOV        DL,AL
1A9B D2 CA          ROR        DL,CL
1A9D 0A E2          OR         AH,DL
1A9F 25 0F0F        AND        AX,0F0FH
1AA2 0D 3030        OR         AX,3030H

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```

1AA5 C3                                RET
                                        BCD_ASCII_CL ENDP
                                        ;
                                        ;
1AA6                                ASCII_BCD_CL PROC        NEAR
1AA6 25 0F0F                            AND     AX,0F0FH
1AA9 8A D4                               MOV     DL,AH
1AAB B1 04                               MOV     CL,04H
1AAD D2 C2                               ROL    DL,CL
1AAF 0A C2                               OR     AL,DL
                                        RET
                                        ASCII_BCD_CL ENDP
                                        ;
                                        ;
1AB2                                BAD_COMMAND PROC        NEAR
                                        ;-----;
                                        ; IF THE COMMAND ENTERED WAS WRONG, BAD COMMAND! ;
                                        ; WOULD BE DISPLAYED ON THE LCD ;
                                        ;-----;
1AB2 B0 80                                B00:   MOV     AL,80H
1AB4 E6 01                                OUT    IOB,AL
1AB6 B0 0C                                MOV     AL,0CH
1AB8 E6 02                                OUT    IOC,AL
1ABA B0 00                                MOV     AL,00H
1ABC E6 01                                OUT    IOB,AL

1ABE BB D21F                            B0:    MOV     BX,0D21FH
1AC1 BA 0000                            DIS_DIS: MOV    DX,POINT
1AC4 89 16 200E R                        MOV    [POINT_S],DX

1AC8 E8 17AB R                            B1:    CALL   POSITION
1ACB 8E 07                                MOV    AX,[BX]
1ACD E8 1A29 R                            CALL  DATA_D
1AD0 E8 1A48 R                            CALL  CHECK
1AD3 43                                    INC   BX
1AD4 B0 10                                MOV   AL,10H
1AD6 FE 06 2008 R                        INC   [FLAG1]
1ADA 3A 06 2008 R                        CMP   AL,[FLAG1]
1ADE 75 E8                                JNZ  B1
1AE0 B9 03E8                            MOV   CX,1000
1AE3 E8 1EE8 R                            CALL  DN1MS
1AE6 E8 1A78 R                            CALL  CLEAR_LCD
1AE9 B0 00                                MOV   AL,00H
1AEB A2 2008 R                            MOV   [FLAG1],AL
                                        RET
                                        BAD_COMMAND ENDP
                                        ;
                                        ;
1AEF                                DIS_TITLE   PROC        NEAR        ;DISPLAY TITLE & FORMS.
1AEF B0 80                                MOV     AL,80H
1AF1 E6 01                                OUT    IOB,AL
1AF3 B0 0C                                MOV     AL,0CH        ;TURN LCD ON
1AF5 E6 02                                OUT    IOC,AL
1AF7 B0 00                                MOV     AL,00H
1AF9 E6 01                                OUT    IOB,AL

1AFB BB D186                            DO:    MOV     BX,0D186H    ;POINT TO TITLE
1AFE BA 0000                            MOV    DX,POINT        ;SET POSITION POINT
1B01 89 16 200E R                        MOV    [POINT_S],DX    ;PROTECT POINT

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```

1B05 E8 17AB R      D1:      CALL    POSITION      ;SELECT LCD POSITION
1B08 8B 07          MOV     AX,[BX]      ;LETTER TO BE DISPLAYED IN AX
1B0A E8 1A29 R      CALL    DATA_D
1B0D E8 1A48 R      CALL    CHECK
1B10 43            DD2:      INC     BX           ;DISPLAY NEXT LETTER OF THE TITLE
1B11 B0 10          MOV     AL,10H
1B13 FE 06 2008 R   INC     [FLAG1]
1B17 3A 06 2008 R   CMP     AL,[FLAG1]   ;DIS FULL?
1B1B 75 0B          JNZ    D2            ;NO, GO ON.
1B1D B9 03E8       MOV     CX,1000
1B20 E8 1EE8 R     CALL   DN1MS        ;YES DELAY 1 SECOND
1B23 B0 00          MOV     AL,00H
1B25 A2 2008 R     MOV     [FLAG1],AL  ;CLEAR POSITION COUNTER

1B28 BF D1F6       D2:      MOV     DI,0D1F6H
1B2B 3B DF          CMP     BX,DI        ;TITLE FINISHED?
1B2D 75 D6          JNZ    D1            ;NO
1B2F E8 1A78 R     CALL   CLEAR_LCD    ;YES

1B32 C3            RET

DIS_TITLE        ENDP
;
;
LCD_INI          PROC    NEAR

1B33 B0 00          MOV     AL,00H
1B35 E6 01          OUT    IOB,AL
1B37 B0 80          MOV     AL,80H
1B39 E6 01          OUT    IOB,AL
1B3B B0 38          MOV     AL,38H      ;THE LCD INITIALIZATION.
1B3D E6 02          OUT    IOC,AL      ;8 BIT
1B3F B0 00          MOV     AL,00H
1B41 E6 01          OUT    IOB,AL
1B43 B9 000A       MOV     CX,10       ;10 ms
1B46 E8 1EE8 R     CALL   DN1MS

1B49 B0 80          MOV     AL,80H
1B4B E6 01          OUT    IOB,AL
1B4D B0 38          MOV     AL,38H      ;SAME AS ABOVE
1B4F E6 02          OUT    IOC,AL
1B51 B0 00          MOV     AL,00H
1B53 E6 01          OUT    IOB,AL
1B55 B9 0001       MOV     CX,1        ;1ms
1B58 E8 1EE8 R     CALL   DN1MS

1B5B B0 80          MOV     AL,80H
1B5D E6 01          OUT    IOB,AL
1B5F B0 38          MOV     AL,38H      ;REPEAT ABOVE INSTRUCTION AGAIN
1B61 E6 02          OUT    IOC,AL
1B63 B0 00          MOV     AL,00H
1B65 E6 01          OUT    IOB,AL

1B67 B0 80          MOV     AL,80H
1B69 E6 01          OUT    IOB,AL
1B6B B0 38          MOV     AL,38H      ;REPEAT
1B6D E6 02          OUT    IOC,AL
1B6F B0 00          MOV     AL,00H
1B71 E6 01          OUT    IOB,AL

1B73 B0 80          MOV     AL,80H
1B75 E6 01          OUT    IOB,AL
1B77 B0 01          MOV     AL,01H      ;DIS CLEAR
1B79 E6 02          OUT    IOC,AL
1B7B B0 00          MOV     AL,00H
1B7D E6 01          OUT    IOB,AL

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```

1B7F B0 80      MOV     AL,80H
1B81 E6 01      OUT     IOB,AL
1B83 B0 0F      MOV     AL,0FH           ;ACT DIS,CURSOR BLINK LETTER
1B85 E6 02      OUT     IOB,AL
1B87 B0 00      MOV     AL,00H
1B89 E6 01      OUT     IOB,AL

1B8B B0 80      MOV     AL,80H
1B8D E6 01      OUT     IOB,AL
1B8F B0 06      MOV     AL,06H           ;MODE SET INCREASE NO SHIFT
1B91 E6 02      OUT     IOB,AL
1B93 B0 00      MOV     AL,00H
1B95 E6 01      OUT     IOB,AL

1B97 B9 03E8     MOV     CX,1000         ;TO SEE LCD HAVING BEEN CLEARED
1B9A E8 1EE8 R   CALL    DN1MS          ;FOR 1 SECOND

1B9D C3         RET

LCD_INI      ENDP
;
;
;
1B9E          PROC     NEAR
;-----;
;BEEP N TIMES FOR TROUBLE SHOUTING. ;
;N MUST BE PUT IN CX BEFOR CALL ;
;CAUTION! AFTER CALLING MODE IS 'III';
;-----;
1B9E B0 99      MOV     AL,CWIOI
1BA0 E6 53      OUT     IOCTR_2,AL
1BA2 51          PUSH    CX
1BA3 B0 00      MOV     AL,00000000B
1BA5 E6 51      OUT     IOB_2,AL
1BA7 B9 0032     MOV     CX,50
1BAA E8 1EE8 R   CALL    DN1MS          ;PB2 AS OUTPUT PORT FOR BEEP
1BAD B0 04      MOV     AL,00000100B
1BAF E6 51      OUT     IOB_2,AL
1BB1 B9 0032     MOV     CX,50
1BB4 E8 1EE8 R   CALL    DN1MS
1BB7 59          POP     CX
1BB8 E2 E8      LOOP   NHVKJH
1BBA B0 9B      MOV     AL,CWIII
1BBC E6 53      OUT     IOCTR_2,AL

1BBE C3         RET

BEEP_N      ENDP
;
;
;
1BBF          PROC     NEAR
;-----;
;COMMAND SUBROUTINE ;
; 1. UNABLE INTERRUPT ;
; 2. CLOSE THE TIMER AND THE COUNTERS GATES ;
; 3. PRINT OUT THE LIST FILE. ;
; 4. LOAD FLAG2 WITH 0 ;
;-----;
1BBF FA          CLI
1BC0 B0 99      MOV     AL,CWIOI
1BC2 E6 53      OUT     IOCTR_2,AL
1BC4 B0 04      MOV     AL,00000100B ;CLOSE THE TIMER AND
1BC6 E6 51      OUT     IOB_2,AL ;COUNTERS GATES
1BC8 B0 70      MOV     AL,01110000B ;SET OUT(INTERRUPT REQUEST) TO 0
1BCA E6 23      OUT     TIMER_M,AL ;MODE 0 INTERRUPT ON TERMINAL COUNT

1BCC 8D 1E 2072 R LEA     BX,DATA_DISPLAY ;POINT TO DATA DISPLAY UNIT

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```

1BD0 B8 4554      MOV     AX,'ET'
1BD3 89 07        MOV     [BX],AX
1BD5 B8 5453      MOV     AX,'TS'
1BD8 89 47 02     MOV     [BX+2],AX
1BDB B8 2020      MOV     AX,' '
1BDE 89 47 04     MOV     [BX+4],AX
1BE1 B8 4520      MOV     AX,'E '
1BE4 89 47 06     MOV     [BX+6],AX
1BE7 B8 444E      MOV     AX,'DN'
1BEA 89 47 08     MOV     [BX+8],AX
1BED B8 2020      MOV     AX,' '
1BF0 89 47 0A     MOV     [BX+10],AX
1BF3 89 47 0C     MOV     [BX+12],AX
1BF6 89 47 0E     MOV     [BX+14],AX
1BF9 E8 1EBC R    CALL    DISPLAY_1      ;DIS 'TEST  END' WITHOUT 1S DELAY.

1BFC E8 17FB R    CALL    RS 232         ;VALID RS 232 INCIALISATION
1BFF BF 0400      MOV     DI,0400H      ;THE BIGINNING ADDRESS OF LIST FILE
1C02 B9 0200      MOV     CX,22*32      ;THE NUMBER OF BYTE TO BE PRINT
1C05 8D 36 2004 R LEA     SI,SAMPLE_No_1 ;POINT TO SAMPLE NUMBER
1C09 8B C1        MOV     AX,CX
1C0B 8B 1C        MOV     BX,[SI]      ;SAMPLE NUMBER --> BX
1C0D F7 E3        MUL     BX           ;DX:AX = AX * BX
1C0F 8B C8        MOV     CX,AX        ;THE NUMBER OF BYTE TO BE PRINTED
                            ;IN CX
1C11 E8 1818 R    CALL    TEST_TX      ;FILE TRANSMISSION VIA RS 232

1C14 8D 1E 2009 R LEA     BX,FLAG2      ;LOAD FLAG2 WITH 0H
1C18 B0 00        MOV     AL,00H
1C1A 88 07        MOV     [BX],AL

1C1C C3          RET

                            END_TEST      ENDP
                            ;
                            .LIST
                            ;
1C1D                                READ_SENSORS PROC      NEAR
                            ;-----;
                            ;THIS PROGRAM WAS AN INTERRUPT SERVICE ROUTINE. ;
                            ; 1. CLOSE THE GATES AND RESET INTERRUPT ERQUIRMENT. ;
                            ;   RESET TIMER. ;
                            ; 2. READ THE DATA IN COUNTERS 1--9. ;
                            ; 3. RESET THE COUNTERS & CLARE THE SENSORS AREA. ;
                            ; 4. INC SAMPLE_No_1 = 10 ? IF YES FFLAG2 = 0. ;
                            ;-----;
1C1D FA          CLI
1C1E 50          PUSH    AX
1C1F 53          PUSH    BX
1C20 51          PUSH    CX
1C21 52          PUSH    DX
1C22 56          PUSH    SI
1C23 57          PUSH    DI
                            .LIST
                            ;PART 1: CLOSE THE GATES AND RESET INTERRUPT ERQUIRMENT & TIMER
1C24 B0 99      MOV     AL,CWIOI
1C26 E6 53      OUT     IOCTR_2,AL
1C28 B0 84      MOV     AL,10000100B ;AFTER INTERRUPT CLOSE THE
                            ;SECOND GATE.
1C2A E6 51      OUT     IOB_2,AL ;COUNTERS GATES STILL OPEN

1C2C B0 70      MOV     AL,01110000B ;SET OUT(INTERRUPT REQUEST) 0
1C2E E6 23      OUT     TIMER_M,AL ;MODE 0 INTERRUPT ON COUNTING
                            ;TERMINATION
1C30 B0 1F      MOV     AL,1FH      ;IT USED TO BE 1FH FOR 1S.
1C32 E6 21      OUT     TIMER_1,AL ;LOAD LSB
1C34 B0 C3      MOV     AL,0C3H     ;IT USED TO BE 0C3H FOR 1S.

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1C36 E6 21          OUT     TIMER_1,AL      ;LOAD MSB
1C38 B0 B6          MOV     AL,10110110B    ;CHENNEL 2
1C3A E6 23          OUT     TIMER_1,AL      ;MODE 3 SQUARE WAVE GENERATOTR
1C3C B0 64          MOV     AL,64H          ;IT USED TO BE 32H FOR 1S.
1C3E E6 22          OUT     TIMER_2,AL      ;LOAD LSB
1C40 B0 00          MOV     AL,00H
1C42 E6 22          OUT     TIMER_2,AL      ;LOAD MSB

1C44 B9 0003        MOV     CX,3
1C47 EB 1B9E R      CALL    BEEP_N

;PART 2: READ THE DATA IN COUNTERS 1--9
1C4A 8D 3E 2330 R   LEA     DI,SENSOR_1
1C4E E4 40          IN      AL,COUNTER_1    ;READ LSB
1C50 8A D0          MOV     DL,AL
1C52 E4 40          IN      AL,COUNTER_1    ;READ MSB
1C54 8A F0          MOV     DH,AL           ;NOM THE DATA WAS IN DX
1C56 8B C2          MOV     AX,DX
1C58 F7 D0          NOT     AX
1C5A 89 05          MOV     [DI],AX

1C5C E4 41          IN      AL,COUNTER_2    ;READ LSB
1C5E 8A D0          MOV     DL,AL
1C60 E4 41          IN      AL,COUNTER_2    ;READ MSB
1C62 8A F0          MOV     DH,AL           ;NOM THE DATA WAS IN DX
1C64 8B C2          MOV     AX,DX
1C66 F7 D0          NOT     AX
1C68 89 45 02       MOV     [DI+2],AX

1C6B E4 42          IN      AL,COUNTER_3    ;READ LSB
1C6D 8A D0          MOV     DL,AL
1C6F E4 42          IN      AL,COUNTER_3    ;READ MSB
1C71 8A F0          MOV     DH,AL           ;NOM THE DATA WAS IN DX
1C73 8B C2          MOV     AX,DX
1C75 F7 D0          NOT     AX
1C77 89 45 04       MOV     [DI+4],AX

1C7A E4 60          IN      AL,COUNTER_4    ;READ LSB
1C7C 8A D0          MOV     DL,AL
1C7E E4 60          IN      AL,COUNTER_4    ;READ MSB
1C80 8A F0          MOV     DH,AL           ;NOM THE DATA WAS IN DX
1C82 8B C2          MOV     AX,DX
1C84 F7 D0          NOT     AX
1C86 89 45 06       MOV     [DI+6],AX

1C89 E4 61          IN      AL,COUNTER_5    ;READ LSB
1C8B 8A D0          MOV     DL,AL
1C8D E4 61          IN      AL,COUNTER_5    ;READ MSB
1C8F 8A F0          MOV     DH,AL           ;NOM THE DATA WAS IN DX
1C91 8B C2          MOV     AX,DX
1C93 F7 D0          NOT     AX
1C95 89 45 08       MOV     [DI+8],AX

1C98 E4 62          IN      AL,COUNTER_6    ;READ LSB
1C9A 8A D0          MOV     DL,AL
1C9C E4 62          IN      AL,COUNTER_6    ;READ MSB
1C9E 8A F0          MOV     DH,AL           ;NOM THE DATA WAS IN DX
1CA0 8B C2          MOV     AX,DX
1CA2 F7 D0          NOT     AX
1CA4 89 45 0A       MOV     [DI+10],AX

1CA7 E4 70          IN      AL,COUNTER_7    ;READ LSB
1CA9 8A D0          MOV     DL,AL
1CAB E4 70          IN      AL,COUNTER_7    ;READ MSB
1CAD 8A F0          MOV     DH,AL           ;NOM THE DATA WAS IN DX
1CAF 8B C2          MOV     AX,DX

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1CB1 F7 D0          NOT     AX
1CB3 89 45 0C      MOV     [DI+12],AX

1CB6 E4 71          IN     AL,COUNTER_8      ;READ LSB
1CB8 8A D0          MOV     DL,AL
1CBA E4 71          IN     AL,COUNTER_8      ;READ MSB
1CBC 8A F0          MOV     DH,AL          ;FROM THE DATA WAS IN DX
1CBE 8B C2          MOV     AX,DX
1CC0 F7 D0          NOT     AX
1CC2 89 45 0E      MOV     [DI+14],AX

1CC5 E4 72          IN     AL,COUNTER_9      ;READ LSB
1CC7 8A D0          MOV     DL,AL
1CC9 E4 72          IN     AL,COUNTER_9      ;READ MSB
1CCB 8A F0          MOV     DH,AL          ;FROM THE DATA WAS IN DX
1CCD 8B C2          MOV     AX,DX
1CCF F7 D0          NOT     AX
1CD1 89 45 10      MOV     [DI+16],AX

;PART 3: RESET THE COUNTERS OPEN TIMER COUNTERS GATE
1CD4 E8 0182 R      CALL    COUNTER_INI      ;RESET THE COUNTERS 1 -- 9
1CD7 E8 01DD R      CALL    PULS_GENERATE    ;GENERATE PULS TO CLEAR COUNTERS
;S & COUNTERS GATES ARE OPEND

;PART 4: THE RTDP
1CDA E8 01F6 R      CALL    REAL_TIME_DATA_PROCESSING

;PART 5: INC SAMPLE_No_1 = 10 ? IF YES, CLOSE THE GATE; RESET TIMER
;AND COUNTERS;
1CDD 8D 1E 2004 R   LEA     BX,SAMPLE_No_1
1CE1 FF 07          INC     WORD PTR[BX]
1CE3 83 3F 0A      CMP     WORD PTR[BX],10
1CE6 75 12          JNZ     ON_NEXT

1CE8 B0 99          MOV     AL,CWIOI
1CEA E6 53          OUT     IOCTR_2,AL
1CEC B0 04          MOV     AL,00000100B
1CEE EC 51          OUT     IOB_2,AL

1CF0 B0 70          MOV     AL,01110000B      ;SET OUT(INTERRUPT REQUEST) 0
1CF2 E6 23          OUT     TIMER_M,AL      ;MODE 0 INTERRUPT ON COUNTING
;TERMINATION
1CF4 E8 0182 R      CALL    COUNTER_INI      ;RESET THE COUNTERS 1 -- 9
1CF7 E8 1BBF R      CALL    END_TEST

;IF NO, CLEAR SENSORS
1CFA 8D 3E 2330 R   ON_NEXT: LEA     DI,SENSOR_1      ;CLEAR THE SENSORS AREA.
1CFE B9 000A        MOV     CX,10
1D01 B8 0000        MOV     AX,0
1D04 89 05        GPE_1: MOV     [DI],AX
1D06 47            INC     DI
1D07 47            INC     DI
1D08 E2 FA        LOOP   GPE_1

1D0A 5F            POP     DI
1D0B 5E            POP     SI
1D0C 5A            POP     DX
1D0D 59            POP     CX
1D0E 5B            POP     BX
1D0F 58            POP     AX

1D10 FB            STI
1D11 CF            IRET

READ_SENSORS ENDP

```

```

1D12          ; TEST_59      PROC      NEAR
;-----;
;THIS PROGRAM WAS FOR TEST 8088 INTERRUPT FUNCTION;
; 1. BOTH IN 8259 AND IN SOFTWARE MODE          ;
; 2. THE ORG ADDRESSES ARE DEPENDS              ;
;-----;
1D12 FA      CLI
1D13 50      PUSH     AX
1D14 53      PUSH     BX
1D15 51      PUSH     CX
1D16 52      PUSH     DX

          .LIST

1D17 B0 99   ;PART 1: CLOSE THE GATS AND RESET INTERRUPT ERQUIRMENT
1D19 E6 53   MOV      AL,CWIOI
1D1E B0 04   OUT      IOCTR_2,AL
1D1D E6 51   MOV      AL,00000100B ;AFTER INTERRUPT CLOSE THE
;SECOND AND COUNTERS GATES

1D1F B0 70   MOV      AL,01110000B ;SET OUT(INTERRUPT REQUEST) 0
1D21 E6 23   OUT      TIMER_M,AL ;MODE 0 INTERRUPT ON COUNTING
;TERMINATION

1D23 B0 1F   MOV      AL,1FH
1D25 E6 21   OUT      TIMER_1,AL ;LOAD LSB
1D27 B0 C3   MOV      AL,0C3H
1D29 E6 21   OUT      TIMER_1,AL ;LOAD MSB

1D2B B0 B6   MOV      AL,10110110B ;CHENNEL 2
1D2D E6 23   OUT      TIMER_M,AL ;MODE SQUARE WAVE GENERATOTR
1D2F B0 32   MOV      AL,32H
1D31 E6 22   OUT      TIMER_2,AL ;LOAD LSB
1D33 B0 00   MOV      AL,00H
1D35 E6 22   OUT      TIMER_2,AL ;LOAD MSB

;PART 2: READ THE DATA IN COUNTERS 1--9
1D37 8D 3E 2330 R LEA     DI,SENSOR_1
1D3B E4 40   IN      AL,COUNTER_1 ;READ LSB
1D3D 8A D0   MOV     DL,AL
1D3F E4 40   IN      AL,COUNTER_1 ;READ MSB
1D41 8A F0   MOV     DH,AL ;NOM THE DATA WAS IN DX
1D43 8B C2   MOV     AX,DX
1D45 F7 D8   NEG     AX
1D47 89 05   MOV     [DI],AX

1D49 E4 41   IN      AL,COUNTER_2 ;READ LSB
1D4B 8A D0   MOV     DL,AL
1D4D E4 41   IN      AL,COUNTER_2 ;READ MSB
1D4F 8A F0   MOV     DH,AL ;NOM THE DATA WAS IN DX
1D51 8B C2   MOV     AX,DX
1D53 F7 D8   NEG     AX
1D55 89 45 02 MOV     [DI+2],AX

1D58 E4 42   IN      AL,COUNTER_3 ;READ LSB
1D5A 8A D0   MOV     DL,AL
1D5C E4 42   IN      AL,COUNTER_3 ;READ MSB
1D5E 8A F0   MOV     DH,AL ;NOM THE DATA WAS IN DX
1D60 8B C2   MOV     AX,DX
1D62 F7 D8   NEG     AX
1D64 89 45 04 MOV     [DI+4],AX

1D67 E4 60   IN      AL,COUNTER_4 ;READ LSB
1D69 8A D0   MOV     DL,AL
1D6B E4 60   IN      AL,COUNTER_4 ;READ MSB
1D6D 8A F0   MOV     DH,AL ;NOM THE DATA WAS IN DX
1D6F 8B C2   MOV     AX,DX
1D71 F7 D8   NEG     AX
1D73 89 45 06 MOV     [DI+6],AX

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1D76 E4 61      IN      AL,COUNTER_5      ;READ LSB
1D78 8A D0      MOV     DL,AL
1D7A E4 61      IN      AL,COUNTER_5      ;READ MSB
1D7C 8A F0      MOV     DH,AL              ;NOW THE DATA WAS IN DX
1D7E 8B C2      MOV     AX,DX
1D80 F7 D8      NEG     AX
1D82 89 45 08    MOV     [DI+8],AX

1D85 E4 62      IN      AL,COUNTER_6      ;READ LSB
1D87 8A D0      MOV     DL,AL
1D89 E4 62      IN      AL,COUNTER_6      ;READ MSB
1D8B 8A F0      MOV     DH,AL              ;NOW THE DATA WAS IN DX
1D8D 8B C2      MOV     AX,DX
1D8F F7 D8      NEG     AX
1D91 89 45 0A    MOV     [DI+10],AX

1D94 E4 70      IN      AL,COUNTER_7      ;READ LSB
1D96 8A D0      MOV     DL,AL
1D98 E4 70      IN      AL,COUNTER_7      ;READ MSB
1D9A 8A F0      MOV     DH,AL              ;NOW THE DATA WAS IN DX
1D9C 8B C2      MOV     AX,DX
1D9E F7 D8      NEG     AX
1DA0 89 45 0C    MOV     [DI+12],AX

1DA3 E4 71      IN      AL,COUNTER_8      ;READ LSB
1DA5 8A D0      MOV     DL,AL
1DA7 E4 71      IN      AL,COUNTER_8      ;READ MSB
1DA9 8A F0      MOV     DH,AL              ;NOW THE DATA WAS IN DX
1DAB 8B C2      MOV     AX,DX
1DAD F7 D8      NEG     AX
1DAF 89 45 0E    MOV     [DI+14],AX

1DB2 E4 72      IN      AL,COUNTER_9      ;READ LSB
1DB4 8A D0      MOV     DL,AL
1DB6 E4 72      IN      AL,COUNTER_9      ;READ MSB
1DB8 8A F0      MOV     DH,AL              ;NOW THE DATA WAS IN DX
1DBA 8B C2      MOV     AX,DX
1DBC F7 D8      NEG     AX
1DBE 89 45 10    MOV     [DI+16],AX

;PART 5: CONVERT CHANNELS 1 --9 DATA INTO ASCII
;AND DISPLAY IT ON LED
1DC1 8D 1E 2072 R LEA     BX,DATA_DISPLAY ;POINT TO THE ADDRESS OF
1DC5 B9 0008      MOV     CX,8             ;DISPLAYING PROPRE TO DISPLAY
1DC8 B8 2020      MOV     AX,' '           ; |* 00032* 00456|
1DCB 89 07      MOV     [BX],AX
1DCD 43      INC     BX
1DCE 43      INC     BX
1DCF E2 FA      LOOP    CMZ              ;NOW THE DATA_DISPLAY EMPTY

1DD1 B0 31      MOV     AL,'1'           ;STORE SENSORS NUMBER IN RAM
1DD3 A2 2082 R    MOV     [LEFT],AL        ;LEFT SIDE OF LCD
1DD6 B0 32      MOV     AL,'2'           ;
1DD8 A2 2083 R    MOV     [RIGHT],AL       ;RIGHT SIDE OF LCD

1ddb 8D 36 2330 R LEA     SI,SENSOR_1      ;POINT TO SENSOR 1
1DDF 8D 1E 2072 R LEA     BX,DATA_DISPLAY ;POINT TO FIRST ADDRESS OF LCD

1DE3 B9 0005      MOV     CX,5             ;DISPLAY 9 + 1 PLACES
1DE6 51      PUSH    CX
1DE7 56      PUSH    SI
1DE8 53      PUSH    BX
1DE9 83 C9 03    ADD     BX,3             ;POINT TO FIRST DATA POSITION
1DEC E8 1E50 R    CALL   BIN_BCD_ASCII_D ;NOW RESULT IN [DATA_DISPLAY+3]
1DEF 5B      POP     BX
1DF0 5E      POP     SI              ;RESUME LCD FIRST ADDRESS
;RESUME SENSOR ADDRESS

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1DF1 46          INC     SI           ;POINT TO NEXT SENSOR
1DF2 46          INC     SI           ;SAVE NEW SENSOR ADDRESS
1DF3 56          PUSH    SI           ;SAVE LCD FIRST ADDRESS
1DF4 33          PUSH    BX           ;POINT TO SECOND DATA ADDRESS
1DF5 83 C3 0B    ADD     BX,11        ;NOW RESULT IN [DATA_DISPLAY+11]
1DF8 E8 1E50 R   CALL    BIN_BCD_ASCII_D ;RESUME LCD 1st ADDR FOR DISPLAY
1DFB 5B          POP     BX           ;RESUME SI AND
1DFC 5E          POP     SI           ;POINT TO NEXT SENSOR.
1DFD 46          INC     SI
1DFE 46          INC     SI
1DFF 56          PUSH    SI
1E00 53          PUSH    BX
1E01 E8 1E35 R   CALL    SENSOR_NUMBER ;CHANGE THE SENSORS NUMBER
1E04 E8 1E92 R   CALL    DISPLAY       ;DISPLAY THE DATA ON LCD
1E07 5B          POP     BX
1E08 5E          POP     SI
1E09 59          POP     CX
1E0A E2 DA      LOOP   UNN

1E0C B0 99      MOV     AL,CWIOI
1E0E E6 53      OUT    IOCTR_2,AL
1E10 B0 8C      MOV     AL,10001100B ;AFTER DISPLAY DATA OPEN THE
1E12 E6 51      OUT    IOB_2,AL      ;TIMER AND SENSORS GATA.

1E14 E8 0182 R   CALL    COUNTER_INI  ;RESET THE COUNTERS 1 -- 9

1E17 8D 3E 2330 R LEA    DI,SENSOR_1   ;CLEAR THE SENSORS AREA.
1E1B B9 000A     MOV     CX,23
1E1E B8 0000     MOV     AX,00H
1E21 89 05      MOV     [DI],AX
1E23 47          INC     DI
1E24 47          INC     DI
1E25 E2 FA      LOOP   GPE

1E27 8D 1E 2009 R LEA    BX,FLAG2      ;IF FLAG5 WAS SET TO 1,
;SERVICES
;HAVE BEEN DONF

1E2B B0 01      MOV     AL,1
1E2D 88 07      MOV     [BX],AL

1E2F 5A          POP     DX
1E30 59          POP     CX
1E31 5B          POP     BX
1E32 58          POP     AX

1E33 FB          STI

1E34 CF          IRET

TEST_59      ENDP
;
;
1E35          PROC     NEAR
;-----;
;DISPLAY THE SENSORS NUMBER ;
;THE FIRST DISPLAY ADDRESS MUST BE IN BX ;
;-----;
1E35 A0 2082 R   MOV     AL,[LEFT]    ;SENSORS 1, 3, 5, 7, 9
1E38 88 47 01   MOV     [BX+1],AL
1E3B 40          INC     AX
1E3C 40          INC     AX
1E3D A2 2082 R   MOV     [LEFT],AL
1E40 A0 2083 R   MOV     AL,[RIGHT]   ;SENSORS 2, 4, 6, 8
1E43 88 47 09   MOV     [BX+9],AL
1E46 40          INC     AX
1E47 40          INC     AX
1E48 37          AAA
1E49 0D 3030   OR     AX,3030H

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1E4C A2 2083 R          MOV     [RIGHT],AL
1E4F C3                RET

        SENSOR_NUMBER   ENDP
        ;
        ;
1E50        BIN_BCD_ASCII_D   PROC     NEAR
        ;-----;
        ; 1. BIN IN [SI] WAS A WORD TO BE CONVERDED ;
        ; 2. RESULT IN [BX] -- [BX+4] ARE 5 DIGITS ASCII CODE ;
        ;-----;
1E50 BA 0000          MOV     DX,0
1E53 8B 04          MOV     AX,[SI]
1E55 B9 2710        MOV     CX,10000
1E58 F7 F1          DIV     CX
1E5A 0C 30          OR     AL,30H
1E5C 88 07          MOV     [BX],AL

1E5E 8B C2          MOV     AX,DX
1E60 BA 0000        MOV     DX,00H
1E63 B9 03E8        MOV     CX,1000
1E66 F7 F1          DIV     CX
1E68 0C 30          OR     AL,30H
1E6A 88 47 01       MOV     [BX+1],AL

1E6D 8B C2          MOV     AX,DX
1E6F BA 0000        MOV     DX,00H
1E72 B9 0064        MOV     CX,100
1E75 F7 F1          DIV     CX
1E77 0C 30          OR     AL,30H
1E79 88 47 02       MOV     [BX+2],AL

1E7C 8B C2          MOV     AX,DX
1E7E BA 0000        MOV     DX,00H
1E81 B9 000A        MOV     CX,10
1E84 F7 F1          DIV     CX
1E86 0C 30          OR     AL,30H
1E88 88 47 03       MOV     [BX+3],AL
1E8B 80 CA 30       OR     DL,30H
1E8E 88 57 04       MOV     [BX+4],DL

1E91 C3                RET

        BIN_BCD_ASCII_D   ENDP
        ;
        ;
1E92        DISPLAY        PROC     NEAR
        ;-----;
        ; THIS PROCEDURE WAS TO DISPLAY 16 ASCII CHARACTERS ON LCD ;
        ; 1. THE CHARACTERS ADDRESS WAS IN BX ;
        ; 2. AFTER DISPLAY THE MESSAGE WILL KEEP ON LCD FOR 1 SECOND ;
        ; 3. PUSH CX WAS RECOMMENDED BEFOR CALLING. ;
        ;-----;
1E92 BA 0000          MOV     DX,POINT
1E95 89 16 200E R    MOV     [POINT_S],DX

1E99 E8 17AB R      CCCC1:  CALL   POSITION
1E9C 8B 07          MOV     AX,[BX]
1E9E E8 1A29 R      CALL   DATA_D
1EA1 E8 1A48 R      CALL   CHECK
1EA4 43            INC     BX
1EA5 B0 10          MOV     AL,10H
1EA7 FE 06 2008 R   INC     [FLAG1]
1EAB 3A 06 2008 R   CMP     AL,[FLAG1]
1EAF 75 E8          JNZ    CCCC1
1EB1 B9 03E8        MOV     CX,1000

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```

1EB4 E8 1EE8 R          CALL    DN1MS
1EB7 B0 00             MOV     AL,00H          ;DIS HOUR--SECND
1EB9 A2 2008 R         MOV     [FLAG1],AL

        DISPLAY      ENDP
        ;
        ;
1EBC          DISPLAY_1  PROC    NEAR
        ;-----;
        ; THIS PROCEDURE WAS TO DISPLAY 16 ASCII CHARACTERS ON LCD ;
        ; 1. THE CHARACTERS ADDRESS WAS IN BX ;
        ; 2. PUSH CX WAS RECOMMENDED BEFOR CALLING. ;
        ;-----;
1EBC BA 0000          MOV     DX,POINT
1EBF 89 16 200E R     MOV     [POINT_S],DX

CCCC11:  CALL     POSITION
        MOV     AX,[BX]
        CALL    DATA_D
        CALL    CHECK
        INC     BX
1EC3 E8 17AB R         MOV     AL,10H
1EC6 8B 07           INC     [FLAG1]
1EC8 E8 1A29 R         INC     AL,[FLAG1]
1ECB E8 1A48 R         CMP     AL,[FLAG1]
1ECE 43              JNZ     CCCC11
1ECF B0 10           MOV     AL,00H          ;DIS HOUR--SECND
1ED1 FE 06 2008 R     MOV     [FLAG1],AL
1ED5 3A 06 2008 R     MOV     [FLAG1],AL
1ED9 75 E8

1EDB B0 00           MOV     AL,00H          ;DIS HOUR--SECND
1EDD A2 2008 R         MOV     [FLAG1],AL

        DISPLAY_1  ENDP
        ;
        ;
1EE0          ONE_MS   PROC    NEAR
        ;-----;
        ; THIS PROGRAM EXECUTION TIME WAS ABOUT 1 mS ;
        ;-----;
1EE0 B9 0106         D1MS:   MOV     CX,0106H
1EE3 FE CE         D1MS1:  DEC     DH
1EE5 E2 FC         LOOP   D1MS1

        RET

        ONE_MS   ENDP
        ;
        ;
1EE8          N_MS    PROC    NEAR
        ;-----;
        ; IF THE DELAY TIME WAS N*1ms, ;
        ; LET CX = N AND CALL N_MS. ;
        ;-----;
1EE8 51             ))N1MS:  PUSH    CX
1EE9 E8 1EE0 R     CALL    D1MS
1EEC 59             POP     CX
1EED E2 F9         LOOP   DN1MS

        RET

        N_MS    ENDP
        ;
        ;
1FF0          ORG     1FF0H
        ;-----;
        ; RESET ;
        ;-----;
1FF0          RESET   PROC    NEAR
1FF0 E9 0000 R     JMP     START

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```

                                RESET      ENDP
                                ;
1FF3                            GRAIN      ENDS
                                END        START
```